

silicon systems[™]

Data Book

Analog/Digital
Bipolar/CMOS
Integrated Circuits

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MICROPERIPHERAL
PRODUCTS

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CUSTOM/
SEMICUSTOM

Advanced and Preliminary Information

In this data book the following conventions are used in designating a data sheet "Advanced" or "Preliminary.":

Advanced— indicates a product still in the design cycle, and any specifications are based on design goals only. Sample availability is indicated in the text.

Preliminary— indicates a product not completely released to production. The specifications are based on preliminary past evaluations and are not guaranteed. Small quantities are available, and SSI should be consulted for current information.

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STANDARD
CELLS

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Section 1

TELECOMMUNICATION PRODUCTS



TELECOMMUNICATIONS CIRCUITS

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SSI Telecommunications Capabilities

Silicon Systems offers a broad line of standard telecommunications circuits aimed at providing cost-effective solutions for common customer application problems. At the heart of SSI's efforts in the communications market is its pioneering work with CMOS switched capacitor filters. Our early success with the DTMF receiver has enabled us to develop a family of chips utilizing the switched capacitor filter technology.

As a trendsetter in the field, Silicon Systems is leading the way towards a whole new era of VLSI circuits for telecommunications. Our broad selection of DTMF receivers demonstrates not only technological leadership in our own semiconductor field but also our capability to anticipate the growing needs of the fast-paced telecommunications marketplace.

Here are a few completed circuits that demonstrate our broad telecommunications IC capability:

BIPOLAR

| Integrated Circuit Function | Application |
|-----------------------------------|-----------------------------|
| Audio System Receiver | Telephone Answering Machine |
| VHF/UHF Gain Mixer | Radio Receiver |
| Pulse Width Modulator | Switching Power Supply |
| Controller | Home Appliance |
| Digital Receiver | Remote Control |
| PCM Encoder/Decoder | Telecom System |
| Digital Correlator/ Integrator | Radio Telescope |

PROCESSES

Silicon Systems offers circuits in junction-isolated, bipolar, single and double-layer metal. Plus, SSI has a CMOS capability that includes not only a metal-gate process but also a silicon-gate process that produces circuits packed with more functions in a smaller size for high-speed, low-power performance. These are the most popular and reliable processes in the two basic technologies, and SSI's advanced ultra-clean wafer fab produces higher yields than ordinary facilities.

PRODUCT QUALITY

Silicon Systems has made a major investment in product test and in-line quality control equipment. For example, a state-of-the-art LTX CP80 is used for functional and parametric testing of sophisticated analog, digital, and combination A/D circuits. In this way, SSI is dedicated to the delivery of complex VLSI circuits to meet the incoming quality level you require.

MOS

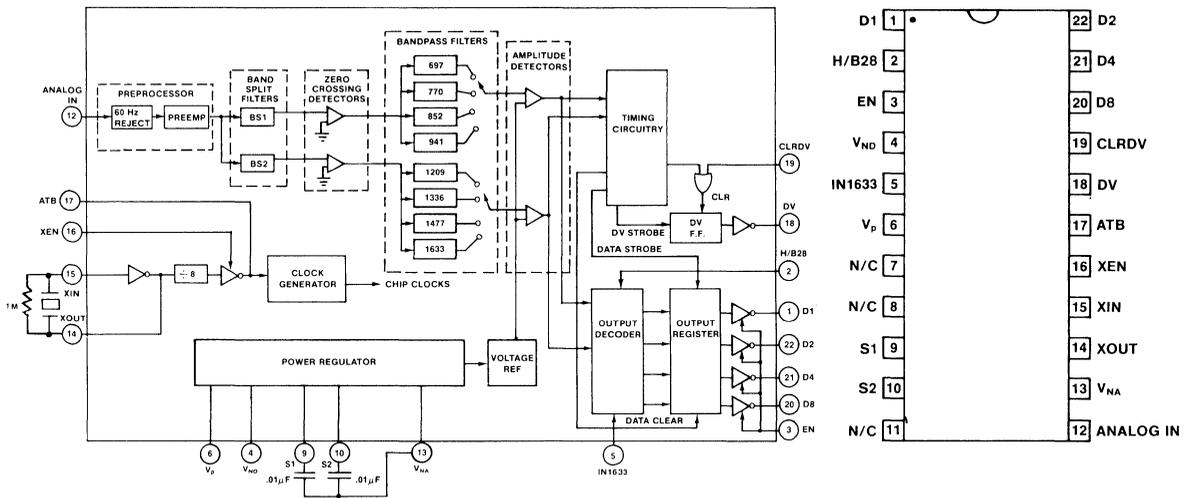
| Integrated Circuit Function | Application |
|-------------------------------------|---|
| DTMF Receiver | *Decodes Touch-Tone® Telephone Signals |
| 300 Baud Modem | Data Transmission |
| 1200/2400 Baud Receiver | FSK/PSK Modem |
| Error Corrector | Military Radio |
| Remote Transmitter | Telephone Answering Machine |
| Phoneme Based Speech Synthesizer | Text-to-Speech |
| Display Timing Generator | TV Sets |
| Video Processor | Infrared Video System |
| 16 Channel Switching Matrix | Bank Communications System |
| Digital Loop Detector | Traffic Signal Control |
| Programmable Digital Receiver | Home Appliance Remote Control |
| Vocal Tract System | Speech Synthesis |

CUSTOMER SERVICE

Silicon Systems provides individualized service for every customer. Our Customer Service Department is dedicated to responsive service and is staffed with personnel trained to consider our customers' needs as their most urgent requirement. Product quality and service are both viewed as cornerstones for SSI's continued growth.

No responsibility is assumed by SSI for use of these products nor for any infringements of patents and trademarks or other rights of third parties resulting from its use. No license is granted under any patents, patent rights or trademarks of SSI. SSI reserves the right to make changes in specifications at any time and without notice.

Data Sheet



SSI 201 Block Diagram

SSI 201 Pin Out
(Top View)

FEATURES

- Central office quality
- NO front-end band-splitting filters required
- Single, low-tolerance, 12-volt supply
- Detects either 12 or 16 standard DTMF digits
- Uses inexpensive 3.579545-MHz crystal for reference
- Excellent speech immunity
- 22-pin DIP package for high system density
- Output in either 4-bit hexadecimal code or binary coded 2 of 8
- Synchronous or handshake interface
- Three-state outputs

DESCRIPTION

The SSI 201 is a complete Dual Tone Multiple Frequency (DTMF) receiver detecting a selectable group of 12 or 16 standard digits. No front-end pre-filtering is needed. The only externally required components are an inexpensive 3.58-MHz television "colorburst" crystal (for frequency reference) and two low-tolerance bypass capacitors. Extremely high system density is made possible by using the clock output of a crystal connected SSI 201 receiver to drive the time bases of additional receivers. The SSI 201 is a monolithic integrated circuit fabricated with low-power, complementary symmetry MOS (CMOS) processing. It requires only a single low tolerance voltage supply and is packaged in a standard 22 pin DIP.

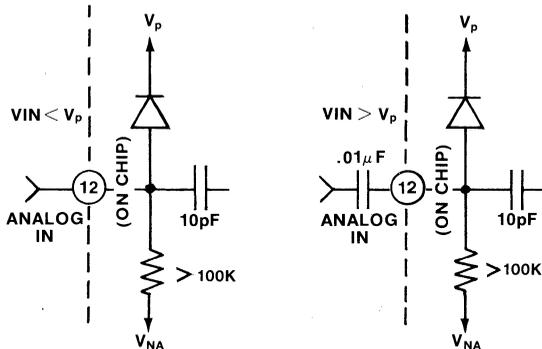
The SSI 201 employs state-of-the-art circuit technology to combine digital and analog functions on the same CMOS chip using a standard digital semiconductor process. The analog input is pre-processed by 60-Hz reject and band splitting filters and then hard-limited to provide AGC. Eight bandpass filters detect the individual tones. The digital post-processor times the tone durations and provides the correctly coded digital outputs. Outputs interface directly to standard CMOS circuitry, and are three-state enabled to facilitate bus-oriented architectures.

Integrated DTMF Receiver

SSI 201

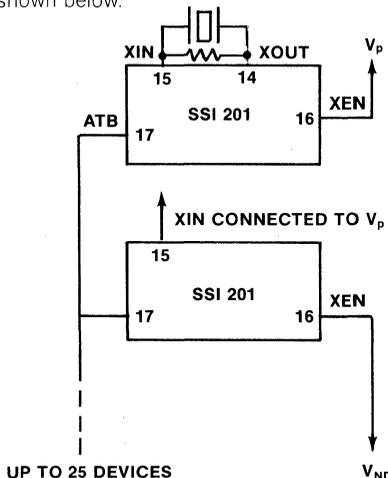
ANALOG IN (pin 12)

This pin accepts the analog input. It is internally biased so that the input signal may be AC coupled. The input may be DC coupled as long as it does not exceed the positive supply. Proper input coupling is illustrated below.



CRYSTAL OSCILLATOR

The SSI 201 contains an onboard inverter with sufficient gain to provide oscillation when connected to a low-cost television "color-burst" crystal. The crystal oscillator is enabled by tying XEN (pin 16) high. The crystal is connected between XIN (pin 15) and XOUT (pin 14). A 1 MEGΩ 10% resistor is also connected between these pins. In this mode, ATB (pin 17) is a clock frequency reference by tying their ATB pins to the ATB of a crystal connected device. XIN and XEN of the auxiliary devices must then be tied high and low respectively. Twenty-five devices may run off a single crystal-connected SSI 201 as shown below.



H/B28 (pin 2)

This pin selects the format of the digital output code. When H/B28 is tied high, the output is hexadecimal. When tied low, the output is binary coded 2 of 8. The table below describes the two output codes.

| Digit | Hexadecimal | | | | Binary Coded 2 of 8 | | | |
|-------|-------------|----|----|----|---------------------|----|----|----|
| | D8 | D4 | D2 | D1 | D8 | D4 | D2 | D1 |
| 1 | 0 | 0 | 0 | 1 | 0 | 0 | 0 | 0 |
| 2 | 0 | 0 | 1 | 0 | 0 | 0 | 0 | 1 |
| 3 | 0 | 0 | 1 | 1 | 0 | 0 | 1 | 0 |
| 4 | 0 | 1 | 0 | 0 | 0 | 1 | 0 | 0 |
| 5 | 0 | 1 | 0 | 1 | 0 | 1 | 0 | 1 |
| 6 | 0 | 1 | 1 | 0 | 0 | 1 | 1 | 0 |
| 7 | 0 | 1 | 1 | 1 | 1 | 0 | 0 | 0 |
| 8 | 1 | 0 | 0 | 0 | 1 | 0 | 0 | 1 |
| 9 | 1 | 0 | 0 | 1 | 1 | 0 | 1 | 0 |
| 0 | 1 | 0 | 1 | 0 | 1 | 1 | 0 | 1 |
| * | 1 | 0 | 1 | 1 | 1 | 1 | 0 | 0 |
| # | 1 | 1 | 0 | 0 | 1 | 1 | 1 | 0 |
| A | 1 | 1 | 0 | 1 | 0 | 0 | 1 | 1 |
| B | 1 | 1 | 1 | 0 | 0 | 1 | 1 | 1 |
| C | 1 | 1 | 1 | 1 | 1 | 0 | 1 | 1 |
| D | 0 | 0 | 0 | 0 | 1 | 1 | 1 | 1 |

IN1633 (pin 5)

When tied high, this pin inhibits detection of tone pairs containing the 1633-Hz component. For detection of all 16 standard digits, IN1633 must be tied low.

OUTPUTS D1, D2, D4, D8 (pins 1, 22, 21, 20) and EN (pin 3)

Outputs D1, D2, D4, D8 are CMOS push-pull when enabled (EN high) and open circuited (high impedance) when disabled by pulling EN low. These digital outputs provide the code corresponding to the detected digit in the format programmed by the H/B28 pin. The digital outputs become valid after a tone pair has been detected and they are then cleared when a valid pause is timed.

DV (pin 18) and CLRDV (pin 19)

DV signals a detection by going high after a valid tone pair is sensed and decoded at the output pins D1, D2, D4, D8. DV remains high until a valid pause occurs or the CLRDV is raised high, whichever is earlier.

INTERNAL BYPASS PINS

S1, S2 (pins 9, 10)

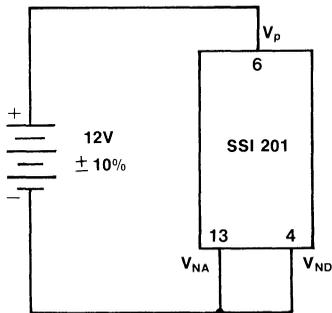
In order for the SSI 201 DTMF Receiver to function properly, these pins must be bypassed to V_{NA} with $0.01 \mu F \pm 20\%$ capacitors.

POWER SUPPLY PINS

V_p (pin 6) V_{NA} (pin 13) V_{ND} (pin 4)

The analog (V_{NA}) and digital (V_{ND}) supplies are brought out separately to enhance analog noise immunity on the chip. V_{NA} and V_{ND} should be connected externally as shown below.

12V SYSTEM



N/C PINS (pins 7, 8, 11)

These pins have no internal connection and may be left floating.

DTMF DIALING MATRIX

| | Col 0 | Col 1 | Col 2 | Col 3 |
|-------|-------|-------|-------|-------|
| Row 0 | 1 | 2 | 3 | A |
| Row 1 | 4 | 5 | 6 | B |
| Row 2 | 7 | 8 | 9 | C |
| Row 3 | * | 0 | # | D |

Note: Column 3 is for special applications and is not normally used in telephone dialing.

DETECTION FREQUENCY

| Low Group f_o | High Group f_o |
|-----------------|--------------------|
| Row 0 = 697 Hz | Column 0 = 1209 Hz |
| Row 1 = 770 Hz | Column 1 = 1336 Hz |
| Row 2 = 852 Hz | Column 2 = 1477 Hz |
| Row 3 = 941 Hz | Column 3 = 1633 Hz |



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ABSOLUTE MAXIMUM RATINGS*

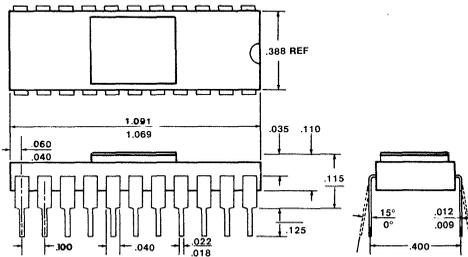
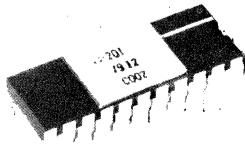
DC Supply Voltage V_p +16 Volts
 (Referenced to V_{NA} , V_{ND})
 Operating Temperature.....0°C to 70°C Ambient
 Storage Temperature.....-65°C to 150°C
 Power Dissipation (25°C).....1 Watt
 (Derate above $T_A = 25^\circ\text{C}$ @ 10mW/°C)

Input Voltage($V_p + .5V$) to ($V_{ND} - .5V$)
 (All inputs except ANALOG IN)
 ANALOG IN Voltage.....($V_p + .5V$) to ($V_p - 22V$)
 DC Current into any Input..... $\pm 1.0\text{mA}$
 Lead Temperature 300°C
 (soldering, 10 sec.)

*Operation above absolute maximum ratings may damage the device
 Note: All SSI 201 unused inputs must be connected to V_p or V_{ND} ,
 as appropriate.

ELECTRICAL CHARACTERISTICS ($0^\circ\text{C} \leq T_A \leq 70^\circ\text{C}$, $V_D - V_{ND} = V_p - V_{NA} = 12V \pm 10\%$)

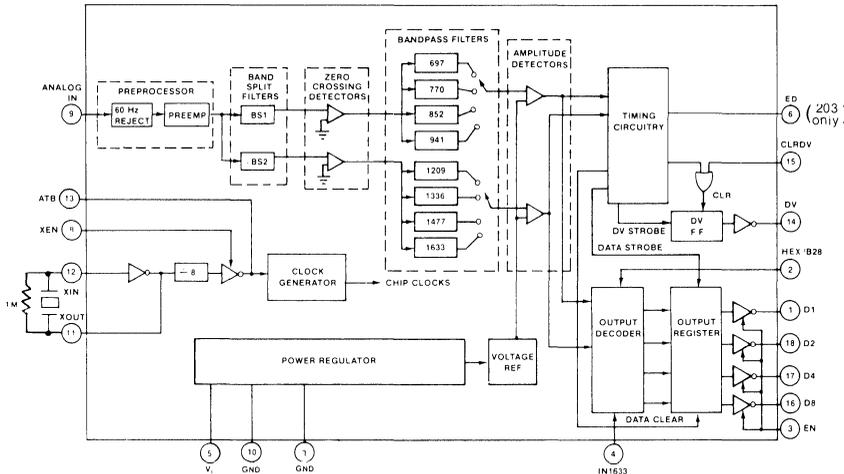
| Parameter | Conditions | Min | Typ | Max | Units |
|---------------------------------------|--|--------------------------------------|-----------|--------------------------------------|---|
| Frequency Detect Bandwidth | | $\pm(1.5 + 2 \text{ Hz})$ | ± 2.3 | ± 3.0 | % of f_o |
| Amplitude for Detection | each tone | -24 | | +6 | dBm referenced to 600 Ω |
| Minimum Acceptable Twist | twist = $\frac{\text{high tone}}{\text{low tone}}$ | -8 | | +4 | dB |
| Detection Time | | 20 | 25 | 40 | mSec |
| Pause Time | | 25 | 32 | 40 | mSec |
| 60-Hz Tolerance | | | | 2 | Vrms |
| Dial Tone Tolerance | "precise" dial tone | | | 0 dB | dB referenced to lower amplitude tone |
| Talk Off | MITEL tape #CM 7290 | | 2 | | hits |
| Digital Outputs (except XOUT) | "0" level, 750 μA load "1" level, 750 μA load | V_{ND} $V_p - 0.5$ | | $V_{ND} + 0.5$ V_o | Volts Volts |
| Digital Inputs (except H/B28, XEN) | "0" level "1" level | V_{ND} $V_p - .3(V_p - V_{ND})$ | | $V_{ND} + .3(V_p - V_{ND})$ V_o | Volts Volts |
| Digital Inputs H/B28, XEN | "0" level "1" level | V_{ND} $V_p - 1$ | | $V_{ND} + 1$ V_p | Volts Volts |
| Power Supply Noise | wide band | | | 25 | mV p-p |
| Supply Current | $T_A = 25^\circ\text{C}$ $V_p - V_{NA} = V_p - V_{ND} = 12V \pm 10\%$ | | 29 | 50 | mA |
| Noise Tolerance | MITEL tape #CM 7290 | | | -12 | dB referenced to lowest amplitude tone |
| Input Impedence | $V_p \geq V_{in} \geq V_p - 22$ | 100K Ω /15pF | | | |



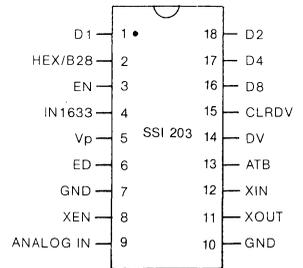
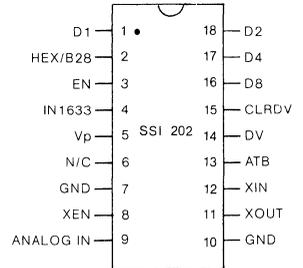
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Data Sheet



SSI 202/203 Block Diagram



SSI 202/203 Pin Out
(Top View)

FEATURES

- Central office quality
- NO front-end band-splitting filters required
- Single, low-tolerance, 5-volt supply
- Detects either 12 or 16 standard DTMF digits
- Uses inexpensive 3.579545 -MHz crystal for reference
- Excellent speech immunity
- Output in either 4-bit hexadecimal code or binary coded 2 of 8

- 18-pin DIP package for high system density
- Synchronous or handshake interface
- Three-state outputs
- Early detect output (SSI 203 only)

SPECIAL OPTIONS

- Industrial temperature range available, -40°C to +85°C

DESCRIPTION

The SSI 202 and 203 are complete Dual Tone Multiple Frequency (DTMF) receivers detecting a selectable group of 12 or 16 standard digits. No front-end pre-filtering is needed. The only externally required components are an inexpensive 3.58-MHz television "colorburst" crystal (for frequency reference) and a bias resistor. Extremely high system density is made possible by using the clock output of a crystal connected SSI 202 or 203 receiver to drive the time bases of additional receivers. Both are monolithic integrated circuits fabricated with low-power, complementary symmetry MOS (CMOS) processing. They require only a single low tolerance voltage supply and are packaged in a standard 18 pin plastic DIP.

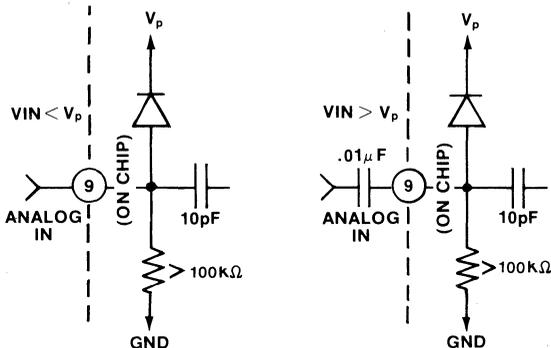
The SSI 202 and 203 employ state-of-the-art circuit technology to combine digital and analog functions on the same CMOS chip using a standard digital semiconductor process. The analog input is pre-processed by 60-Hz reject and band splitting filters and then hard-limited to provide AGC. Eight bandpass filters detect the individual tones. The digital post-processor times the tone durations and provides the correctly coded digital outputs. Outputs interface directly to standard CMOS circuitry, and are three-state enabled to facilitate bus-oriented architectures.

5V Low-Power DTMF Receiver

SSI 202/203

ANALOG IN

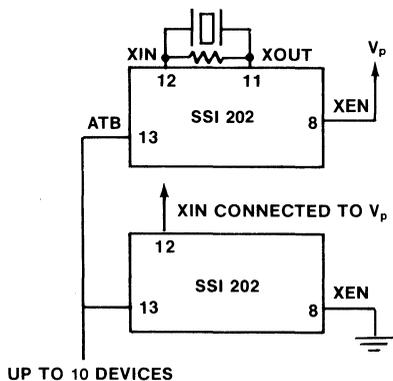
This pin accepts the analog input. It is internally biased so that the input signal may be AC coupled. The input may be DC coupled as long as it does not exceed the positive supply. Proper input coupling is illustrated below.



The SSI 202 is designed to accept sinusoidal input wave forms but will operate satisfactorily with any input that has the correct fundamental frequency with harmonics greater than 20 dB below the fundamental.

CRYSTAL OSCILLATOR

The SSI 202 and 203 contain an onboard inverter with sufficient gain to provide oscillation when connected to a low-cost television "color-burst" crystal. The crystal oscillator is enabled by tying XEN high. The crystal is connected between XIN and XOUT. A 1 MΩ 10% resistor is also connected between these pins. In this mode, ATB is a clock frequency output. Other SSI 202's (or 203's) may use the same frequency reference by tying their ATB pins to the ATB of a crystal connected device. XIN and XEN of the auxiliary devices must then be tied high and low respectively. Ten devices may run off a single crystal-connected SSI 202 or 203 as shown below.



HEX/B28

This pin selects the format of the digital output code. When HEX/B28 is tied high, the output is hexadecimal. When tied low, the output is binary coded 2 of 8. The table below describes the two output codes.

| Digit | Hexadecimal | | | | Binary Coded 2 of 8 | | | |
|-------|-------------|----|----|----|---------------------|----|----|----|
| | D8 | D4 | D2 | D1 | D8 | D4 | D2 | D1 |
| 1 | 0 | 0 | 0 | 1 | 0 | 0 | 0 | 0 |
| 2 | 0 | 0 | 1 | 0 | 0 | 0 | 0 | 1 |
| 3 | 0 | 0 | 1 | 1 | 0 | 0 | 1 | 0 |
| 4 | 0 | 1 | 0 | 0 | 0 | 1 | 0 | 0 |
| 5 | 0 | 1 | 0 | 1 | 0 | 1 | 0 | 1 |
| 6 | 0 | 1 | 1 | 0 | 0 | 1 | 1 | 0 |
| 7 | 0 | 1 | 1 | 1 | 1 | 0 | 0 | 0 |
| 8 | 1 | 0 | 0 | 0 | 1 | 0 | 0 | 1 |
| 9 | 1 | 0 | 0 | 1 | 1 | 0 | 1 | 0 |
| 0 | 1 | 0 | 1 | 0 | 1 | 1 | 0 | 1 |
| * | 1 | 0 | 1 | 1 | 1 | 1 | 0 | 0 |
| # | 1 | 1 | 0 | 0 | 1 | 1 | 1 | 0 |
| A | 1 | 1 | 0 | 1 | 0 | 0 | 1 | 1 |
| B | 1 | 1 | 1 | 0 | 0 | 1 | 1 | 1 |
| C | 1 | 1 | 1 | 1 | 1 | 0 | 1 | 1 |
| D | 0 | 0 | 0 | 0 | 1 | 1 | 1 | 1 |

IN1633

When tied high, this pin inhibits detection of tone pairs containing the 1633-Hz component. For detection of all 16 standard digits, IN1633 must be tied low.

OUTPUTS D1, D2, D4, D8 and EN

Outputs D1, D2, D4, D8 are CMOS push-pull when enabled (EN high) and open circuited (high impedance) when disabled by pulling EN low. These digital outputs provide the code corresponding to the detected digit in the format programmed by the HEX/B28 pin. The digital outputs become valid after a tone pair has been detected and they are then cleared when a valid pause is timed.

DV and CLRDV

DV signals a detection by going high after a valid tone pair is sensed and decoded at the output pins D1, D2, D4, D8. DV remains high until a valid pause occurs or the CLRDV is raised high, whichever is earlier.

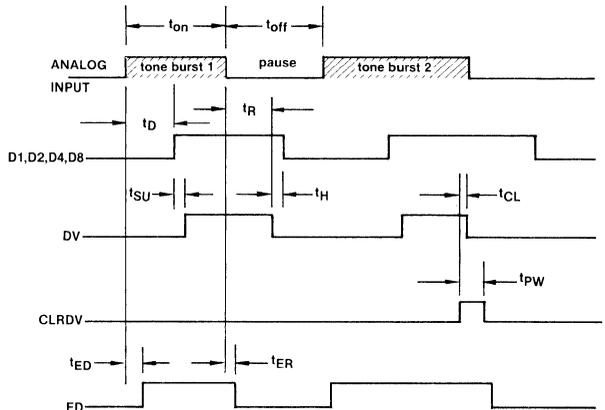
ED (SSI 203 only)

The ED output goes high as soon as the SSI 203 begins to detect a DTMF tone pair and falls when the 203 begins to detect a pause. The D1, D2, D4, and D8 outputs are guaranteed to be valid when DV is high, but are not necessarily valid when ED is high.

N/C PINS

These pins have no internal connection and may be left floating.

SSI 202/203 TIMING



DTMF DIALING MATRIX

| | Col 0 | Col 1 | Col 2 | Col 3 |
|-------|-------|-------|-------|-------|
| Row 0 | 1 | 2 | 3 | A |
| Row 1 | 4 | 5 | 6 | B |
| Row 2 | 7 | 8 | 9 | C |
| Row 3 | * | 0 | # | D |

Note: Column 3 is for special applications and is not normally used in telephone dialing.

DETECTION FREQUENCY

| Low Group f_o | High Group f_o |
|-----------------|--------------------|
| Row 0 = 697 Hz | Column 0 = 1209 Hz |
| Row 1 = 770 Hz | Column 1 = 1336 Hz |
| Row 2 = 852 Hz | Column 2 = 1477 Hz |
| Row 3 = 941 Hz | Column 3 = 1633 Hz |

| PARAMETER | SYMBOL | MIN. | TYP. | MAX. | UNITS |
|---|-----------|------|------|------|---------|
| TONE TIME: for detection | t_{ON} | 40 | — | — | mS |
| for rejection | t_{ON} | — | — | 20 | mS |
| PAUSE TIME: for detection | t_{OFF} | 40 | — | — | mS |
| for rejection | t_{OFF} | — | — | 20 | mS |
| DETECT TIME | t_D | 25 | — | 46 | mS |
| RELEASE TIME | t_R | 35 | — | 50 | mS |
| DATA SETUP TIME | t_{SU} | 7 | — | — | μ S |
| DATA HOLD TIME | t_H | 4.2 | — | 5.0 | mS |
| DV CLEAR TIME | t_{CL} | — | 160 | 250 | nS |
| CLR DV pulse width | t_{PW} | 200 | — | — | nS |
| ED Detect Time | t_{ED} | 7 | — | 22 | mS |
| ED Release Time | t_{ER} | 2 | — | 18 | mS |
| OUTPUT ENABLE TIME | — | — | 200 | 300 | nS |
| $C_L = 50\text{pF}$ $R_L = 1\text{K}\Omega$ | | | | | |
| OUTPUT DISABLE TIME | — | — | 150 | 200 | nS |
| $C_L = 35\text{pF}$ $R_L = 500\Omega$ | | | | | |
| OUTPUT RISE TIME | — | — | 200 | 300 | nS |
| $C_L = 50\text{pF}$ | | | | | |
| OUTPUT FALL TIME | — | — | 160 | 250 | nS |
| $C_L = 50\text{pF}$ | | | | | |

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ABSOLUTE MAXIMUM RATINGS*

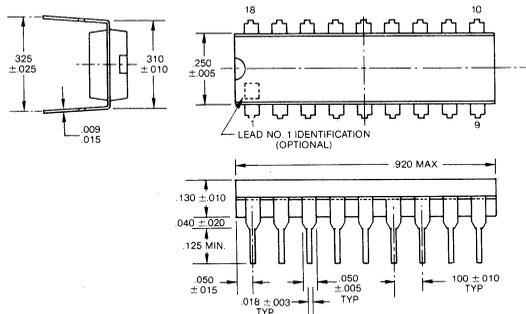
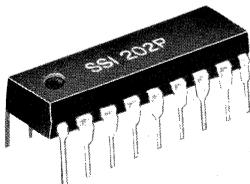
DC Supply Voltage V_p +7 Volts
 Operating Temperature..... 0°C to 70°C Ambient
 Storage Temperature..... -65°C to 150°C
 Power Dissipation (25°C) 65 mW
 (Derate above $T_A = 25^\circ\text{C}$ @ 6.25 mW/°C)

Input Voltage ($V_p + .5\text{V}$) to $- .5\text{V}$
 (All inputs except ANALOG IN)
 ANALOG IN Voltage..... ($V_p + .5\text{V}$) to ($V_p - 10\text{V}$)
 DC Current into any Input..... $\pm 1.0\text{mA}$
 Lead Temperature 300°C
 (soldering, 10 sec.)

*Operation above absolute maximum ratings may damage the device
 Note: All SSI 202/203 unused inputs must be connected to V_p or Gnd, as appropriate.

ELECTRICAL CHARACTERISTICS (0°C $\leq T_A \leq 70^\circ\text{C}$, $V_p = 5\text{V} \pm 10\%$)

| Parameter | Conditions | Min | Typ | Max | Units |
|----------------------------------|--|---------------------------|-----------|-------------------|---|
| Frequency Detect Bandwidth | | $\pm(1.5 + 2 \text{ Hz})$ | ± 2.3 | ± 3.5 | % of f_o |
| Amplitude for Detection | each tone | -32 | | -2 | dBm referenced to 600 Ω |
| Minimum Acceptable Twist | twist = $\frac{\text{high tone}}{\text{low tone}}$ | -10 | | +10 | dB |
| 60-Hz Tolerance | | | | 0.8 | Vrms |
| Dial Tone Tolerance | "precise" dial tone | | | 0dB | dB referenced to lower amplitude tone |
| Talk Off | MITEL tape #CM 7290 | | 2 | | hits |
| Digital Outputs (except XOUT) | "0" level, 400 μA load "1" level, 200 μA load | 0 $V_p - 0.5$ | | 0.5 V_p | Volts Volts |
| Digital Inputs | "0" level "1" level | 0 $0.7V_p$ | | $0.3V_p$ V_i | Volts Volts |
| Power Supply Noise | wide band | | | 10 | mV p-p |
| Supply Current | $T_A = 25^\circ\text{C}$ | | 10 | 16 | mA |
| Noise Tolerance | MITEL tape #CM 7290 | | | -12 | dB referenced to lowest amplitude tone |
| Input Impedence | $V_p \geq V_{in} \geq V_p - 10$ | 100 k Ω // 15pF | | | |



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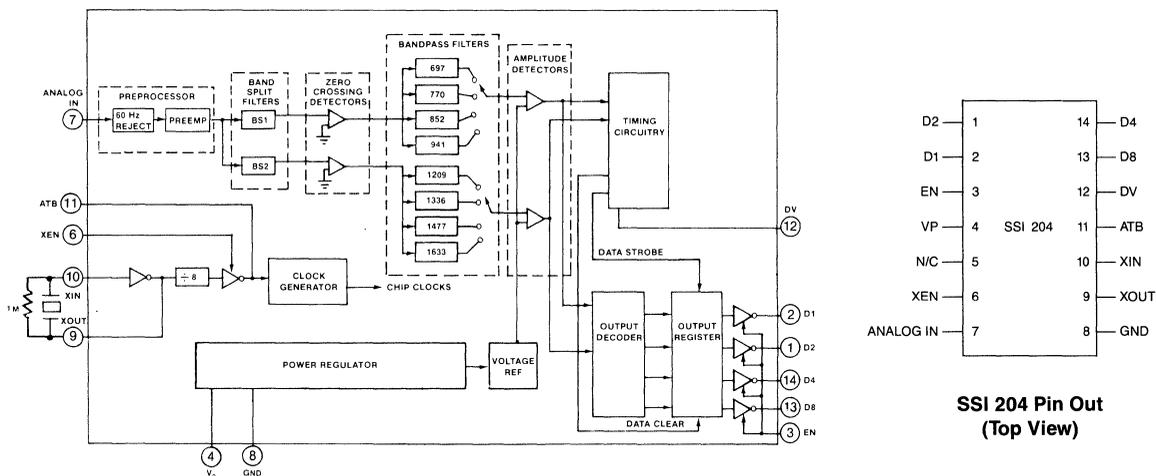
Data Sheet

DESCRIPTION

The SSI 204 is a complete Dual Tone Multiple Frequency (DTMF) receiver that detects all 16 standard digits. No front-end pre-filtering is needed. The only externally required components are an inexpensive 3.58-MHz television "color-burst" crystal for frequency reference and a bias resistor. An Alternate Time Base (ATB) is provided to permit operation of up to 10 SSI 204's from a single crystal. The SSI 204 employs state-of-the-art "switched-capacitor" filter technology, resulting in approximately 40 poles of filtering, and digital circuitry on the same CMOS chip. The analog input signal is pre-processed by 60-Hz reject and band split filters and then zero-cross detected to provide AGC. Eight bandpass filters detect the individual tones. Digital processing is used to measure the tone and pause durations and to provide output timing and decoding. The outputs interface directly to standard CMOS circuitry and are three-state enabled to facilitate bus-oriented architectures.

FEATURES

- Intended for applications with less requirements than the SSI 202.
- 14-Pin plastic DIP for high system density.
- NO front-end band splitting filters required.
- Single low-tolerance 5-volt supply.
- Detects all 16 standard DTMF digits.
- Uses inexpensive 3.579545-MHz crystal.
- Excellent speech immunity.
- Output in 4-bit hexadecimal code.
- Three-state outputs for microprocessor based systems.



Block Diagram

CAUTION: Use handling procedures necessary for a static sensitive component

SSI 204

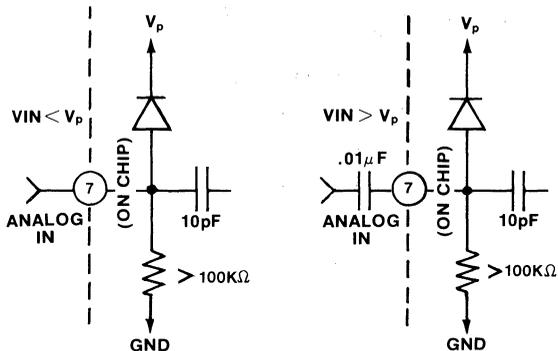
5V Low Power

Subscriber

DTMF Receiver

ANALOG IN

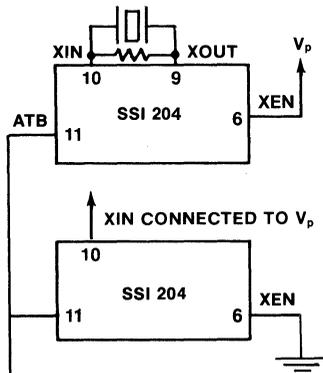
This pin accepts the analog input. It is internally biased so that the input signal may be AC coupled. The input may be DC coupled as long as it does not exceed the positive supply. Proper input coupling is illustrated below.



The SSI 204 is designed to accept sinusoidal input wave forms but will operate satisfactorily with any input that has the correct fundamental frequency with harmonics greater than 20 dB below the fundamental.

CRYSTAL OSCILLATOR

The SSI 204 contains an onboard inverter with sufficient gain to provide oscillation when connected to a low-cost television "color-burst" crystal. The crystal oscillator is enabled by tying XEN high. The crystal is connected between XIN and XOUT. A 1 MΩ 10% resistor is also connected between these pins. In this mode, ATB is a clock frequency output. Other SSI 204's (or 202's) may use the same frequency reference by tying their ATB pins to the ATB of a crystal connected device. XIN and XEN of the auxiliary devices must then be tied high and low respectively. Ten devices may run off a single crystal-connected SSI 204 (or 202) as shown below.



UP TO 10 DEVICES

OUTPUTS D1, D2, D4, D8, and EN

Outputs D1, D2, D4, D8 are CMOS push-pull when enabled (EN high) and open circuited (high impedance) when disabled by pulling EN low. These digital outputs provide the hexadecimal code corresponding to the detected digit. The digital outputs become valid after a tone pair has been detected and they are then cleared when a valid pause is timed. The table below describes the hexadecimal codes.

| OUTPUT CODE | | | | |
|-------------|----|----|----|----|
| Digit | D8 | D4 | D2 | D1 |
| 1 | 0 | 0 | 0 | 1 |
| 2 | 0 | 0 | 1 | 0 |
| 3 | 0 | 0 | 1 | 1 |
| 4 | 0 | 1 | 0 | 0 |
| 5 | 0 | 1 | 0 | 1 |
| 6 | 0 | 1 | 1 | 0 |
| 7 | 0 | 1 | 1 | 1 |
| 8 | 1 | 0 | 0 | 0 |
| 9 | 1 | 0 | 0 | 1 |
| 0 | 1 | 0 | 1 | 0 |
| * | 1 | 0 | 1 | 1 |
| # | 1 | 1 | 0 | 0 |
| A | 1 | 1 | 0 | 1 |
| B | 1 | 1 | 1 | 0 |
| C | 1 | 1 | 1 | 1 |
| D | 0 | 0 | 0 | 0 |

DV

DV signals a detection by going high after a valid tone pair is sensed and decoded at the output pins D1, D2, D4, D8. DV remains high until a valid pause occurs.

N/C PIN

This pin has no internal connection and may be left floating.

DTMF DIALING MATRIX

| | Col 0 | Col 1 | Col 2 | Col 3 |
|-------|-------|-------|-------|-------|
| Row 0 | 1 | 2 | 3 | A |
| Row 1 | 4 | 5 | 6 | B |
| Row 2 | 7 | 8 | 9 | C |
| Row 3 | * | 0 | # | D |

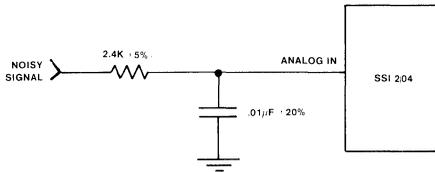
Note: Column 3 is for special applications and is not normally used in telephone dialing.

DETECTION FREQUENCY

| Low Group f_0 | High Group f_0 |
|-----------------|--------------------|
| Row 0 = 697 Hz | Column 0 = 1209 Hz |
| Row 1 = 770 Hz | Column 1 = 1336 Hz |
| Row 2 = 852 Hz | Column 2 = 1477 Hz |
| Row 3 = 941 Hz | Column 3 = 1633 Hz |

APPLICATION NOTES

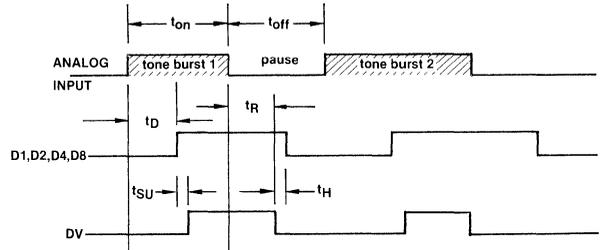
The SSI 204 will tolerate total input rms noise up to 12dB below the lowest amplitude tone. For most telephone applications, the combination of the high frequency attenuation of the telephone line and internal band-limiting make special circuitry at the input to the SSI 204 unnecessary. However, noise near the 56kHz internal sampling frequency will be aliased (folded back) into the audio spectrum, so if excessive noise is present above 28kHz, the simple RC filter as shown below may be employed to band limit the incoming signal.



Filter for use in extreme high frequency input noise environment.

Noise will also be reduced by placing a grounded trace around XIN and XOUT pins on the circuit board layout when using a crystal. It is important to note that XOUT is not intended to drive an additional device. XIN may be driven externally; in this case leave XOUT floating.

SSI 204 TIMING



| PARAMETER | SYMBOL | MIN. | TYP. | MAX. | UNITS |
|---|------------|------|------|------|---------|
| TONE TIME: for detection | t_{ON} | 40 | — | — | mS |
| | t'_{ON} | — | — | 20 | mS |
| PAUSE TIME: for detection | t_{OFF} | 40 | — | — | mS |
| | t'_{OFF} | — | — | 20 | mS |
| DETECT TIME | t_D | 25 | — | 46 | mS |
| RELEASE TIME | t_R | 35 | — | 50 | mS |
| DATA SETUP TIME | t_{SU} | 7 | — | — | μ S |
| DATA HOLD TIME | t_H | 4.2 | — | 5.0 | mS |
| OUTPUT ENABLE TIME | — | — | 200 | 300 | nS |
| $C_L = 50\text{pF}$ $R_L = 1\text{K}\Omega$ | | | | | |
| OUTPUT DISABLE TIME | — | — | 150 | 200 | nS |
| $C_L = 35\text{pF}$ $R_L = 500\Omega$ | | | | | |
| OUTPUT RISE TIME | — | — | 200 | 300 | nS |
| $C_L = 50\text{pF}$ | | | | | |
| OUTPUT FALL TIME | — | — | 160 | 250 | nS |
| $C_L = 50\text{pF}$ | | | | | |

ABSOLUTE MAXIMUM RATINGS*

DC Supply Voltage V_p +7 Volts
 Operating Temperature 0°C to 70°C Ambient
 Storage Temperature -65°C to 150°C
 Power Dissipation (25°C) 65 mW
 (Derate above $T_A = 25^\circ\text{C}$ @ 6.25 mW/°C)
 Input Voltage ($V_p + 0.5\text{V}$) to - 0.5V
 (all inputs except ANALOG IN)

ANALOG IN Voltage ($V_p + 0.5\text{V}$) to ($V_p - 10\text{V}$)
 DC Current into any Input $\pm 1.0\text{mA}$
 Lead Temperature 300°C
 (soldering, 10 sec.)

*Operation above absolute maximum ratings may damage the device.

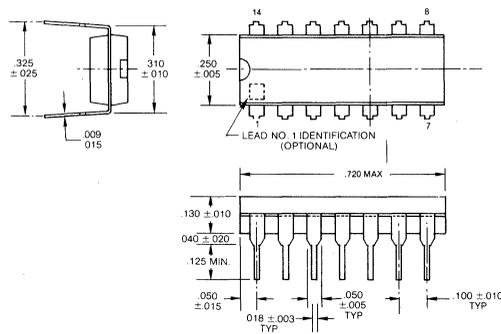
Note: All SSI 204 unused inputs must be connected to V_p or Gnd. as appropriate.



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ELECTRICAL CHARACTERISTICS ($0^{\circ}\text{C} \leq T_A \leq 70^{\circ}\text{C}$, $V_b = 5\text{V} \pm 10\%$)

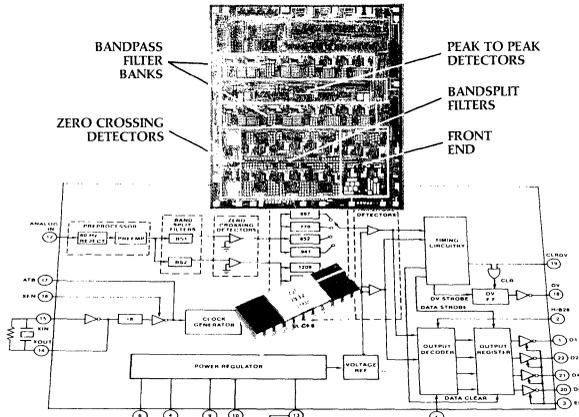
| Parameter | Conditions | Min | Typ | Max | Units |
|----------------------------------|--|------------------------------------|-----------|--------------------|---|
| Frequency Detect Bandwidth | | $\pm(1.5 + 2 \text{ Hz})$ | ± 2.3 | ± 3.5 | % of f_o |
| Amplitude for Detection | each tone | -32 | | -2 | dBm referenced to 600Ω |
| Minimum Acceptable Twist | twist = $\frac{\text{high tone}}{\text{low tone}}$ | -8 | | +4 | dB |
| 60-Hz Tolerance | | | | 0.8 | V _{rms} |
| Dial Tone Tolerance | "precise" dial tone | | | 0dB | dB referenced to lower amplitude tone |
| Talk Off | MITEL tape #CM 7290 | | 2 | | hits |
| Digital Outputs (except XOUT) | "0" level, $400 \mu\text{A}$ load "1" level, $200 \mu\text{A}$ load | 0 $V_b - 0.5$ | | 0.5 V_b | Volts Volts |
| Digital Inputs | "0" level "1" level | 0 $0.7 V_b$ | | $0.3 V_b$ V_b | Volts Volts |
| Power Supply Noise | wide band | | | 10 | mV p-p |
| Supply Current | $T_A = 25^{\circ}\text{C}$ | | 10 | 16 | mA |
| Noise Tolerance | MITEL tape #CM 7290 | | | -12 | dB referenced to lowest amplitude tone |
| Input Impedance | $V_b \geq V_{in} \geq V_b - 10$ | $100\text{K}\Omega // 15\text{pF}$ | | | |



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Application Guide for SSi Monolithic Dual-Tone Multi-Frequency (DTMF) Receivers



The SSI integrated DTMF Receivers are complete Touch-Tone detection systems. Each can operate in a stand-alone mode for the majority of telecommunications applications, thereby providing the most economical implementation of DTMF signaling systems possible. Each combines precision active filters and analog circuits with digital control logic on a monolithic CMOS integrated circuit. SSI DTMF Receiver use is straightforward and the external component requirements are minimal. This application guide describes device operation, performance, system requirements, and typical application circuits for the SSI DTMF Receiver circuits.

How the SSI DTMF Circuits Work

General Description of Operation

The task of a DTMF Receiver is to detect the presence of a valid tone pair on a telephone line or other transmission medium. The presence of a valid tone pair indicates a single dialed digit; to generate a valid digit sequence, each tone pair must be separated by a valid pause.

The following table gives the established Bell system standards for a valid tone pair and a valid pause:

| | |
|-------------------------------|--|
| One Low-Group Tone — and — | 697 or 770 or 852 or 941 Hz |
| One High-Group Tone | 1209 or 1336 or 1477 or 1633 Hz |
| Frequency Tolerance | $f_0 \pm (1.5\% + 2 \text{ Hz})$ |
| Amplitude Range | $-24 \text{ dBm} \leq A \leq +6 \text{ dBm} @ 600\Omega$ (Dynamic Range 30 dB) |
| Relative Amplitude (Twist) | $-8 \text{ dB} \leq \frac{\text{High-Group Tone}}{\text{Low-Group Tone}} \leq +4 \text{ dB}$ |
| Duration | 40ms or longer |
| Inter-tone Pauses | 40ms or longer |

The SSI DTMF Receivers meet or exceed these standards.

Similar device architecture is used in all the SSI DTMF Receivers. Figure 1 shows the SSI 202 Block Diagram. In general terms, the detection scheme is as follows: The input signal is pre-filtered and then split into two bands, each of which contains only one DTMF tone group. The output of each

band-split filter is amplified and limited by a zero-crossing detector. The limited signals, in the form of square waves, are passed through tone frequency band pass filters. Digital logic is then used to provide detector sampling and determine detection validity, to present the digital output data in the correct format, and to provide device timing and control.

Detailed Description of Operation

Noise and Speech Immunity

The two largest problems confronting a DTMF Receiver are:

- 1) Distinguishing between valid tone pairs (or pauses) and other stray signals (or speech) that contain valid tone pair frequencies.
- 2) Detecting valid tone pairs in the presence of noise, which is typically found in the telephone (or other transmission medium) environment.

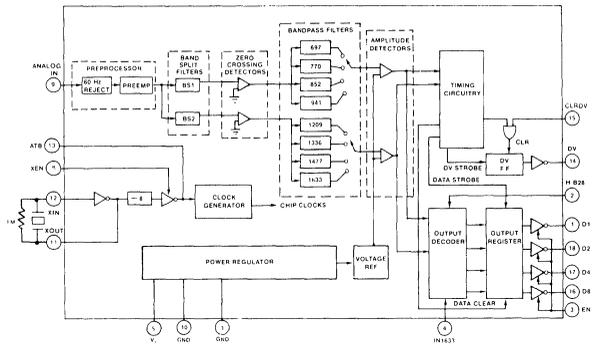


Figure 1. SSI 202 Block Diagram

The SSI DTMF Receivers use several techniques to distinguish between valid tone pairs and other stray signals. These techniques are explained in later sections. Briefly, the techniques are:

- 1) Pre-filtering of audio signal. Removes supply noise and dial tone from input audio signal and emphasizes the voice frequency domain.
- 2) Zero-cross detection. Limits the acceptable level of noise during detection of a tone pair. Important for speech rejection.
- 3) Valid tone pair/pause sampling. Samples the detection filters and checks for consistency before determining that a received tone pair or pause is valid.

Audio Preprocessor

The Audio Preprocessor is an analog filter that band limits the input analog signal between 500 Hz and 6 KHz. In addition, it emphasizes the 2 KHz to 6 KHz voice region.

Band limiting suppresses power supply and dial tone frequencies, and high frequency noise. The emphasized voice region helps to equalize the audio response since many phone lines tend to roll off at about 1 KHz. The upper voice frequencies are important in providing speech immunity.

Tone Band Splitting

After the analog signal is preprocessed, it is then split into two bands, each of which contains only one DTMF tone group. The band-split filters are actually band-stop filters to maintain all frequencies except the *other* tone group; this is done to maintain all analog information to enhance speech immunity but not allow the other tone group to act as interfering noise for the band being detected. These band-stop filters have "floors" that limit the amount of tone pair twist which further enhances speech immunity. See device data sheets for acceptable twist limits.

Zero-Crossing Detectors

The output of each band-split filter is amplified and limited by a zero-crossing detector (limiter). The function of the zero-crossing detector is to produce a square wave at the prime frequency emanating from the band-split filter. If a pure tone is not present, as in the case of voice or other interfering noise, a rectangular wave with a variable period will result. Proportional to the interference, the limiter output power is spread over a broad frequency range as the zero crossings "dither". When a high level of noise (or speech) occurs, no single bandpass filter pair will contain significant power long enough to result in a tone detection. The zero-crossing detector also acts as AGC (Automatic Gain Control) in that the output amplitude is independent of input amplitude; this additionally establishes an acceptable signal-to-noise ratio not dependent on tone amplitude.

Bandpass Filters and Amplitude Detectors

The bandpass filters perform tone frequency discrimination. Their responses are tailored so that if the frequency of the limited square wave from the zero-crossing detector is within the tone frequency tolerance, the filter output will exceed the amplitude detector threshold. The amplitude detectors are interrogated periodically by the digital control circuitry to ascertain the presence of one and only one tone in each band for the required duration. In a similar fashion, valid pauses are measured by the absence of valid tone pairs for the specified time.

Timing and Logic

The only precision external element needed for the SSI DTMF Receivers is a 3.58 MHz crystal (color-burst frequency) for the on-board oscillator. This generates the precise clock for the filters and for the logic timing and control of the receive.

Circuit Implementation

Standard CMOS technology is used for the entire circuit. Logic functions use standard low-power circuitry while the analog circuits use precision switched-capacitor-filter technology.

How to Use the SSI DTMF Receivers

Precautions

Although static protection devices are provided on the high-impedance inputs, normal handling precautions observed for CMOS devices should be used.

A destructive high current latch-up mode will occur if pin voltages are not constrained to the range between $V_N - .5$ Volt and $V_P + .5$ Volt (except AIN as described below). In applications where voltage spikes may occur, protection must be provided to ensure that the maximum voltage ratings are not exceeded. This may require the use of clamping diodes on the Analog Input to protect against ringing voltage, for example, or on the power supply to protect against supply spikes.

Power Supply

Excessive power supply noise should be avoided and to aid the user in this regard, power supply hook-up options are provided on some devices.

Since the digital circuitry of the devices possess the high noise immunity characteristics of CMOS logic, limited power supply noise is required only for the analog section. On those SSI DTMF receivers that have separate Analog Negative and Digital Negative supply connections (grounds), namely VNA

and VND, an unfiltered supply may be used at VND. It is necessary that VND and VNA differ no more than 0.5 Volts.

The analog circuitry of the devices require low power supply noise levels as specified on the device Data Sheet. Power supply noise effects will be slightly less if the analog input is referenced to VP. This is normally accomplished by connecting VP to ground and utilizing a negative power supply. The effects of excessive power supply noise will cause decreased tone amplitude sensitivity and less tone detection frequency bandwidth.

Digital Inputs

The digital inputs are directly compatible with standard CMOS logic devices powered by VP and VN (or VND). The input logic levels should swing within 30% of VP or VN to insure detection. Any unused input must be tied to VN or VP. Figure 2 shows methods for interfacing TTL outputs to 12 Volt SSI DTMF Receivers.

Analog Input

The Analog Input is the signal input pin for the devices, and is specially biased to facilitate its connection to external circuitry, as shown in Figure 3. The input signal level at the Analog Input pin must not exceed or fall more than a few volts below the positive supply as stated on the device Data Sheets. If this condition cannot be guaranteed by the external circuitry, the signal must be AC coupled into the chip with a $.01\mu\text{F} \pm 20\%$ capacitor.

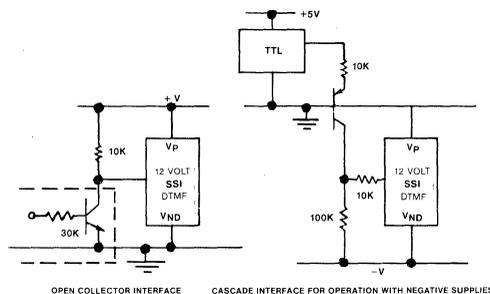


Figure 2. Interface circuits for conversion from TTL output levels to 12 volt SSI DTMF input levels

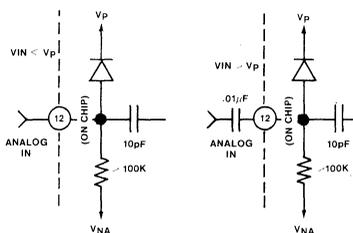


Figure 3. Direct and AC coupled configurations

Analog Input Noise

The SSI DTMF Receivers will tolerate wide-band input noise of up to 12dB below the lowest amplitude tone fundamental during detection of a valid tone pair. Any single interference frequency (including tone harmonics) between 1 KHz and 6 KHz should be at least 20 dB below the lowest amplitude tone fundamental. Adherence to these conditions will ensure reliable detection and full tone detection frequency bandwidth. Because of the internal band limiting, noise with frequencies above 8 KHz can remain unfiltered. However, noise near the 56 KHz internal switched-capacitor-filter sampling frequency will be aliased (folded back) into the audio spectrum; noise above 28 KHz therefore should be low-pass filtered with a circuit as shown in Figure 4 using a cut-off frequency (F_c) of 6.6 KHz.

A 1 KHz cut-off frequency filter can be used on "normal" phone lines for special applications. When a phone line is particularly noisy, tone pair detection may be unreliable. A 1 KHz low pass filter will remove much of the noise energy but maintain the tone groups; however, a decreased speech immunity will result. This usage should only be considered for applications where speech immunity is not important, such as control paths that carry no speech.

Some DTMF tone pair generators output distorted tones which the SSI DTMF Receivers may not detect reliably (inexpensive extension telephones are an example). Most of the interfering harmonics of these tones may be removed by the use of a 3 KHz low-pass filter as in Figure 4. Some speech immunity degradation will result, but not as bad as using the 1 KHz filter mentioned above.

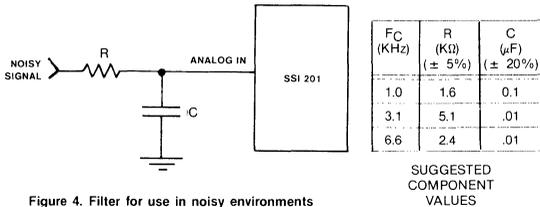


Figure 4. Filter for use in noisy environments

Telephone Line Interface

In applications that use an SSI DTMF Receiver to decode DTMF signals from a phone line, a DAA (Direct Access Arrangement) must be implemented. Equipment intended for connection to the public telephone network must comply with and be registered in accordance to FCC Part 68. For PBX applications refer to EIA Standard RS-464.

Some of the basic guidelines are:

- 1) Maximum voltage and current ratings of the SSI DTMF Receivers must not be exceeded; this calls for protection from ringing voltage, if applicable, which ranges from 80 to 120 Volts RMS over a 20 to 80 Hz frequency range.
- 2) The interface equipment must not breakdown with high-voltage transient tests (including a 2500 Volt peak surge) as defined in the applicable document.
- 3) Phone line termination must be less than 200 Ohms DC and approximately 600 Ohms AC (200-3200 Hz).
- 4) Termination must be capable of sustaining phone line loop current (off-hook condition) which is typically 18 to 120 mA DC.
- 5) The phone line termination must be electrically balanced in respect to ground.
- 6) Public phone line termination equipment must be registered in accordance to FCC Part 68 or connected through registered protection circuitry. Registration typically takes about six months.

Ready made DAA devices are also available. One source is Cermetek Microelectronics, Sunnyvale, California.

Figure 5 shows a simplified phone line interface using a 600 Ohm 1:1 line transformer. Transformers specially designed for phone line coupling are available from many transformer manufacturers.

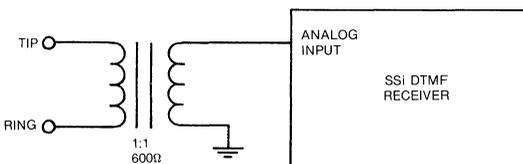


Figure 5. Simplified Phone Line Interface

Figure 6 shows a more featured version of Figure 5. These added options include:

- 1) A 150 Volt surge protector to eliminate high voltage spikes.
- 2) A Texas Instruments TCM1520A ring detector, optically isolated from the supervisory circuitry.
- 3) A 150 Volt surge protector to eliminate high voltage spikes.
- 4) Back-to-back Zener diodes to protect the DTMF (and optional multiplexer Op-Amp) from ringing voltage.
- 5) Audio multiplexer which allows voice or other audio to be placed on the line (a recorded message, for example) and not interfere with incoming DTMF tone detection.

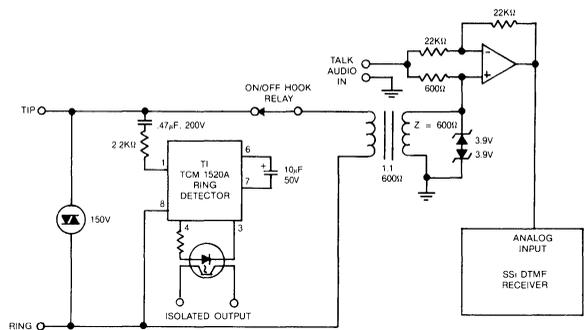


Figure 6. Full Featured Phone Line Interface

An integrated voice circuit may also be implemented for line coupling, such as the Texas Instruments TCM1705A, however, this approach is typically more expensive than using a transformer as shown above.

Outputs

The digital outputs of the SSI DTMF Receivers (except XOUT) swing between VP and VN (or VND) and are fully compatible with standard CMOS logic devices powered from VP and VN. The 5 Volt DTMF devices will also interface directly to LSTTL. The 12 Volt DTMF devices can interface to TTL or low voltage MOS with the circuit in Figure 7.

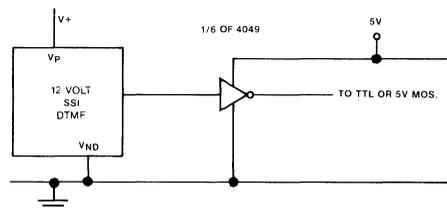


Figure 7. SSI 12 Volt DTMF to TTL Level Interface

Data Outputs D8, D4, D2, and D1 are three-state enabled to facilitate interface to a three-state bus. Figure 8 shows the equivalent circuit for the data outputs in the high impedance state. Care must be taken to prevent either substrate diode in Figure 8 from becoming forward biased or damage may result.

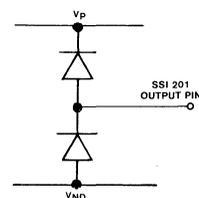


Figure 8. Equivalent Circuit of SSI DTMF Receiver Data Output in High Impedance State

Timing

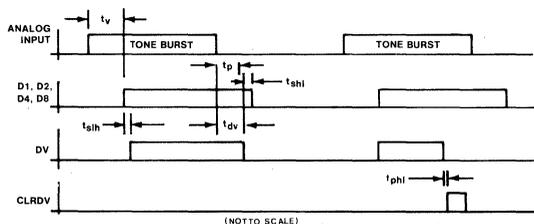
Within 40 ms of a valid tone pair appearing at the DTMF Receiver Analog Input, the Data Outputs D8, D4, D2 and D1 will become valid. SSI 201 timing is shown in Figure 9 (refer to the device Data Sheet for other timing diagrams). Seven microseconds after the data outputs have become valid DV will be raised. DV will remain high and the outputs valid while the valid tone pair remains present. Within 40 ms after the tone pair stops, the DTMF will recognize a valid pause. DV is lowered approximately 45 ms following the end of the tone pair, and the data outputs all set to zero 4.56 ms following DV going low. DV will strobe at least for the same duration as the received tone pair.

System Interface

Provision has been made on the SSI DTMF Receivers for handshake interface with an outside monitoring system. In this mode, the DV strobe is polled by the monitoring system at least once every 40 ms to determine whether a new valid tone pair has been detected. If DV is high, the coded data is stored in the monitoring system and then CLRDV is pulsed high. With some systems operating in the handshake mode, it may be desirable to know when a valid pause has occurred. Ordinarily this would be indicated by the falling edge of DV. However, in the handshake mode, DV is cleared by the monitoring system each time a new valid tone pair is detected and, therefore, cannot be used to determine when a valid pause is detected. The detection of a valid pause in this case may be observed by detecting the clearing of the Data Outputs. Since, in hexadecimal format (the mode normally used with a handshake interface), the all zero state represents a commonly unused tone pair (D), the detection of a valid pause may be detected by connecting a four-input NOR gate to the device outputs and sensing the all zero state.

Time Base

The SSI DTMF Receivers contain an on-chip oscillator for a 3.5795 MHz parallel resonant quartz crystal or ceramic resonator. The crystal (or resonator) is placed between XIN and XOUT in parallel with a 1 Mohm resistor, while XEN is tied high. Since the switched-capacitor-filter time base is derived from the oscillator, the tone detect band frequency tolerance is proportional to the time base tolerance. The SSI DTMF Receiver frequency response and timing is guaranteed with a time base accuracy of at least $\pm 0.1\%$. To obtain this accuracy the CTS Part No. MP036 or Workman Part No. CY1-C or equivalent quartz crystal is recommended. In less critical applications a suitable ceramic resonator may be implemented.



| SYMBOL | DEFINITION | KEY | | | CONDITION | | |
|-----------|--|-----|------|-----|-----------|---|--|
| | | MIN | TYP | MAX | UNIT | $V_p - (V_{NA} = V_{ND}) = 12V \pm 10\%$ $TA = 0^\circ C - 70^\circ C$ | |
| t_v | tone detection time | 20 | -- | 40 | ms | -- | -- |
| t_{sh} | data overlap of DV rising edge | 7 | -- | -- | ns | //S | CLR DV = V_{ND} , EN = V_p |
| t_p | pause detection time | 25 | -- | 40 | ms | -- | -- |
| t_{dv} | time between end of tone and fall of DV | 40 | 45 | 50 | ms | -- | -- |
| t_{shl} | data overlap of DV falling edge | 4 | 4.86 | 4.8 | ms | -- | -- |
| t_{phi} | prop. delay: rise of CLR DV to fall of DV measured at 50% points | -- | -- | 1 | μ S | //S | CI = 300 pF |
| --- | output enable time: measured from 50% point of rising edge of EN to time at which output has changed 1V with RI to opposite rail | -- | -- | 1 | μ S | //S | CI = 300pF, RI = 1K $\Delta V = 1V$ |
| --- | output disable time: measured from 50% point of falling edge of EN to time at which output has changed 1V with RI to opposite rail | -- | -- | 1 | μ S | //S | CI = 300pF |
| --- | output 10-90% transition time | -- | -- | 1 | μ S | //S | CI = 300pF |

Figure 9. SSI 201 Timing Diagram and Specifications

For the SSI 201, a muRata Part No. FX-5135 is recommended which will provide an accuracy of approximately $\pm 0.3\%$. The use of a ceramic resonator requires the addition of two 30pF $\pm 10\%$ capacitors; one between XIN and VN (or VND)

and the other between XOUT and VN (or VND). Extra caution should be used to avoid stray capacitance on the resonant circuit when using a ceramic resonator instead of a quartz crystal.

When the oscillator connected as above and XEN tied high, the ATB (alternate time base) pin delivers a square wave output at one-eighth the oscillator frequency (447.443 KHz nominal). The ATB pin can be converted to a time base input by tying XEN low; ATB can then be externally driven from another device such as the ATB output of another DTMF. No crystal is required for the ATB input device; XIN must be tied high if unused. Several SSI DTMF Receivers can be driven with a single crystal (refer to device data sheet for fan-out limit).

XOUT is designed to drive a resonant circuit only and is not intended to drive additional devices. If a 3.58 MHz clock is needed for more than one device and it is desirable to use only one resonant device, an outside inverter should be used for the time base, buffered by a second inverter or buffer. The buffer output would then drive XIN of the SSI DTMF Receiver as well as the other device(s); XOUT must be left floating and XEN tied high.

Dial Tone Rejection

The SSI DTMF Receivers incorporate enough dial tone rejection circuitry to provide dial tone tolerance of up to 0 dB. Dial tone tolerance is defined as the total power of precise dial tone (350 Hz and 440 Hz as equal amplitudes) relative to the lowest amplitude tone in a valid tone pair. The filter of Figure 10 may be used for further dial tone rejection. This filter exhibits an elliptic highpass response that provides a minimum of 18 dB rejection at 350 Hz and 24 dB rejection at 440 Hz so long as the component tolerances indicated are observed. The DTMF on-chip filter rejects 350 Hz at least 6 dB more than 440 Hz. Therefore, employing the filter of Figure 10 yields a dial tone tolerance of +24 dB.

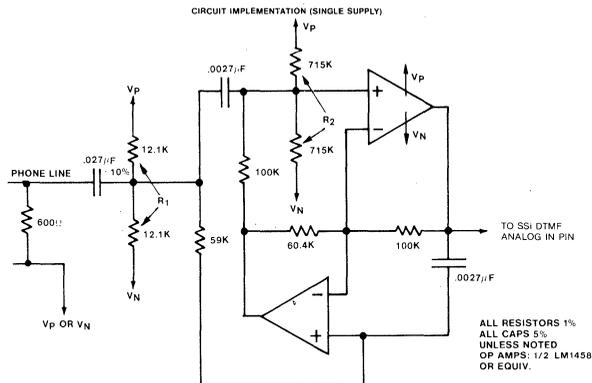


Figure 10. Dial Tone Reject Filter

Printed Circuit Board Implementation

The SSI DTMF Receivers are analog in nature and should be treated as such; circuit noise should be kept to a minimum. To be certain of this, all input and output lines should be kept away from noise sources (high frequency data or clock lines); this is especially true for the Analog Input. Noise in the ground or power supply lines can be avoided by running separate traces to supportive logic circuits or by running thicker (lower resistance) busses. Capacitance power supply bypassing should be performed at the device. Refer to the Power Supply section above.

Performance Data

A portion of the final SSI DTMF Receiver device characterization uses the Mitel CM7290 tone receiver test tape. The evaluation circuit shown in Figure 11 was used to characterize the SSI 201. The speed and output level of the tape deck must be adjusted so that the calibration tone at the beginning of the tape is at exactly 1000 Hz and 2V rms.

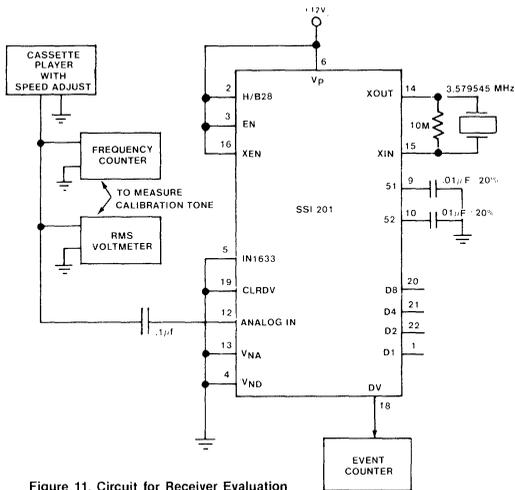


Figure 11. Circuit for Receiver Evaluation

The Mitel tape tests yield similar results on all of the SSI DTMF Receivers. Test results for the SSI 201 are summarized in Table 1. In short, the measured performance data demonstrates that the SSI DTMF Receivers are monolithic realizations of a full "central office quality" DTMF Receiver.

| TEST # | RESULTS |
|--------|---|
| 2a,b | B.W. = 5.0% of fo |
| 2c,d | B.W. = 5.0% of fo |
| 2e,f | B.W. = 5.3% of fo |
| 2g,h | B.W. = 4.9% of fo |
| 2i,j | B.W. = 5.0% of fo |
| 2k,l | B.W. = 5.3% of fo |
| 2m,n | B.W. = 5.3% of fo |
| 2o,p | B.W. = 4.8% of fo |
| 3 | 160 decodes |
| 4 | Acceptable Amplitude Ratio (Twist) = -19.1dB to +15.2dB |
| 5 | Dynamic Range = 32.5dB |
| 6 | Guard Time = 23.3 ms |
| 7 | 100% Successful decodes at N/S Ratio of -12dBV |
| 8 | 2-3 Hits Typical on Talk-Off Test |

Table I. Mitel #CM7290 Tape Test Results for SSI 201 (Averaged for 10 parts)

Applications

Creating Hexadecimal "0" Output upon Digit "0" Detection

To be consistent with pulse-dialing systems, the SSI DTMF Receivers provide a hexadecimal "10" output upon the detection of a digit 0 tone pair when in the hexadecimal code format. However, some applications may instead require a hexadecimal "0" with a digit "0" detection. The circuit of

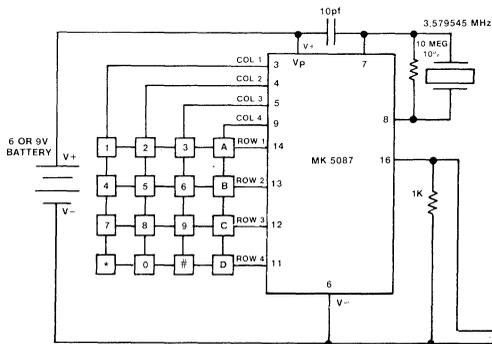


Figure 13. 16 Channel Remote Control

Figure 12 shows an easy method to recode the hexadecimal outputs to do this using only 4 NOR gates.

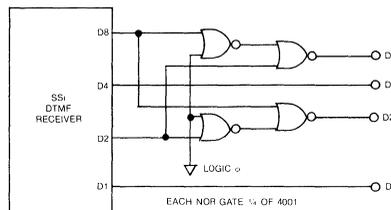


Figure 12. Hex "0" Out with Digit "0" Detect Conversion Circuit

Note that this circuit will not give proper code for the "A", "B", or "C" digits and will cause both digits "D" and "0" to output hexadecimal "0". This circuit should therefore be considered for numeric digits only. The output code format is shown in Table II.

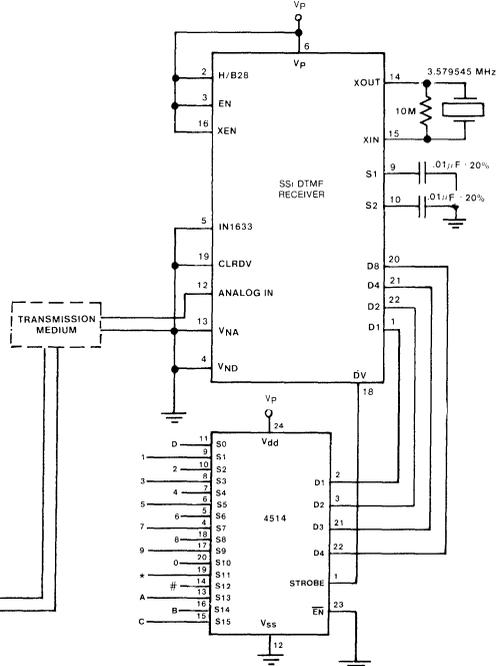
| Digit | HEXADECEMAL | | | | HEXADECEMAL AND FIG 19 CIRCUIT | | | |
|-------|-------------|----|----|----|--------------------------------|----|----|----|
| | D8 | D4 | D2 | D1 | D8 | D4 | D2 | D1 |
| 1 | 0 | 0 | 0 | 1 | 0 | 0 | 0 | 1 |
| 2 | 0 | 0 | 1 | 0 | 0 | 0 | 1 | 0 |
| 3 | 0 | 0 | 1 | 1 | 0 | 0 | 1 | 1 |
| 4 | 0 | 1 | 0 | 0 | 0 | 1 | 0 | 0 |
| 5 | 0 | 1 | 0 | 1 | 0 | 1 | 0 | 1 |
| 6 | 0 | 1 | 1 | 0 | 0 | 1 | 1 | 0 |
| 7 | 0 | 1 | 1 | 1 | 0 | 1 | 1 | 1 |
| 8 | 1 | 0 | 0 | 0 | 1 | 0 | 0 | 0 |
| 9 | 1 | 0 | 0 | 1 | 1 | 0 | 0 | 1 |
| 0 | 1 | 0 | 1 | 0 | 0 | 0 | 0 | 0 |
| * | 1 | 0 | 1 | 1 | 0 | 0 | 0 | 1 |
| # | 1 | 1 | 0 | 0 | 1 | 1 | 0 | 0 |
| A | 1 | 1 | 0 | 1 | 1 | 1 | 0 | 1 |
| B | 1 | 1 | 1 | 0 | 0 | 1 | 0 | 0 |
| C | 1 | 1 | 1 | 1 | 0 | 1 | 0 | 1 |
| D | 0 | 0 | 0 | 0 | 0 | 0 | 0 | 0 |

Table II. Output Code of Figure 12

This circuit is useful for applications that require a display of dialed digits; the digit display usually requires a hexadecimal "0" input for a "0" to be displayed.

16-Channel Remote Control

DTMF signaling provides a simple, reliable means of transmitting information over a 2-wire twisted pair. The complete schematic of a 16-channel remote control is shown in Figure 13. When one of the key pad buttons is depressed, a tone pair is sent over the transmission medium to the SSI DTMF Receiver.



The 4514 raises one of its 16 outputs in response to the 4-bit output code from the DTMF. The output at the 4514 will remain high until the next button is depressed.

2-of-8 Output Decode

The circuit shown in Figure 14 can be used to convert the binary coded 2-of-8 to the actual 2 of 8 code (or 2 of 7 if detection of 1633 Hz tone is inhibited). The output data will be valid while DV is high. If it is desired to force the eight outputs to zero when a valid tone is not present, DV should be inverted and connected to both E-NOT inputs of the 4555.

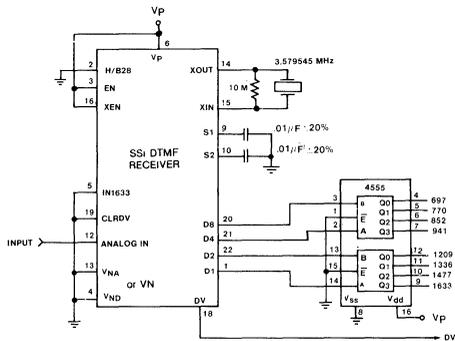


Figure 14. Touch Tone to 2-of-8 Output Converter

DTMF to Rotary Dial Pulse Converter

The 2-of-8 output of Figure 14 can be modified to interface with a pulse dialer as shown in Figure 15. If a 12 Volt DTMF is used the 4049 will translate the 12 Volt outputs to the 5 Volt swings required for the MK5099 pulse dialer.

Figure 16 shows the interface for adding pulse detection and counting to a SSI DTMF Receiver.

The loop detector provides a digital output representing the telephone loop circuit "make" and "break" condition associated with rotary pulse dialing. For the circuit of Figure 16, Ground represents a "make" and V_p a "break".

The loop detector feeds dial pulses to IC-1, a binary counter, and to IC-2A, a re-triggerable "one-shot". When a dial pulse appears the Q1-NOT output of IC-2A immediately goes low, resetting IC-1. The clock input to IC-1 is delayed by R1-C1 so that reset and count input do not overlap. The binary outputs of IC-1 will reflect the pulse count and 0.2 seconds after the last pulse the Q1-NOT output will go high. C3-R3 differentiate this pulse and clock the output latch, IC-3, holding the output pulse until the next digit.

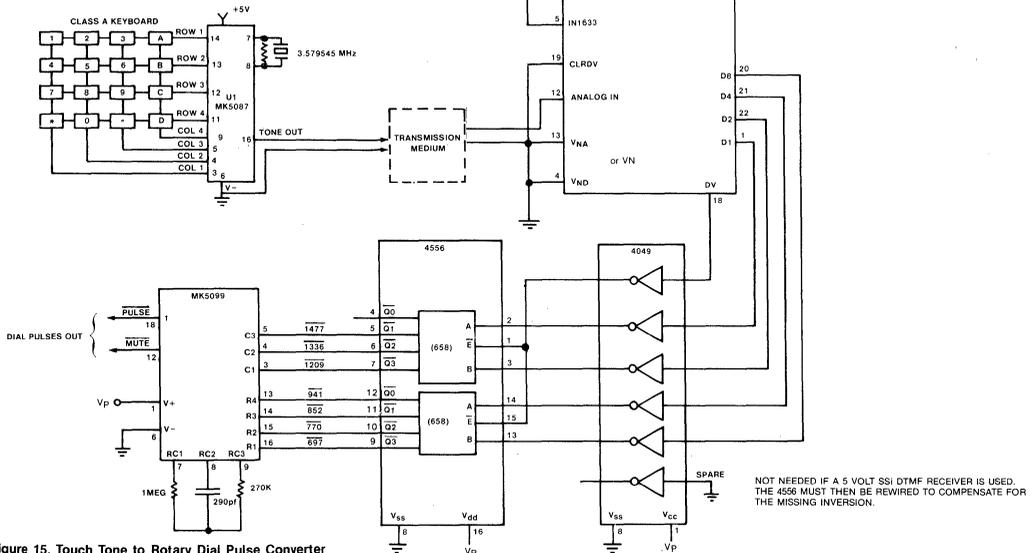


Figure 15. Touch Tone to Rotary Dial Pulse Converter Adding Rotary Dial Pulse Detection Capabilities

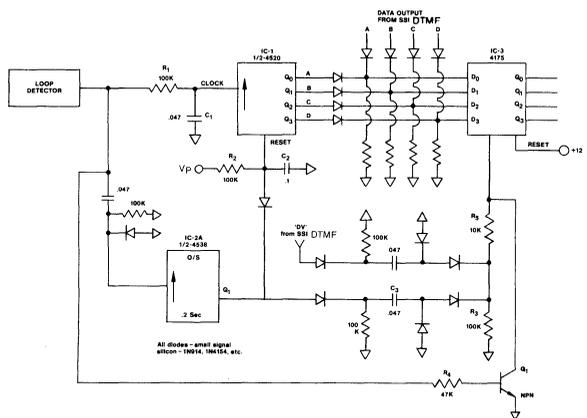


Figure 16. Adding Pulse Detection and Counting to the SSI DTMF Receivers

The 0.2 second timeout of IC-2A indicates the end of dial pulsing since even a slow (8 pps) dial would input another pulse every 0.125 seconds. The binary outputs of IC-1 are paralleled with those of the SSI DTMF Receiver circuit through diodes to the inputs of IC-3. A pull-down resistor is necessary on each IC-3 input pin. IC-1 must be a binary, not BCD, counter.

With a 4175 for IC-3 the output data is latched until the next valid input, whether from a rotary dial or dual tone instrument. A unique situation exists, however, when going on-hook. The loop detector will output a continuous level of V_p which would trigger IC-2A and put a single count into IC-1. A high level from the loop detector also turns on Q1, pulling the clock input of IC-3 to ground. Since the loop detector output will be low at the completion of dialing, all outputs are valid even when the telephone is placed on-hook, an important consideration if output data is recorded.

Preliminary Data Sheet

GENERAL DESCRIPTION

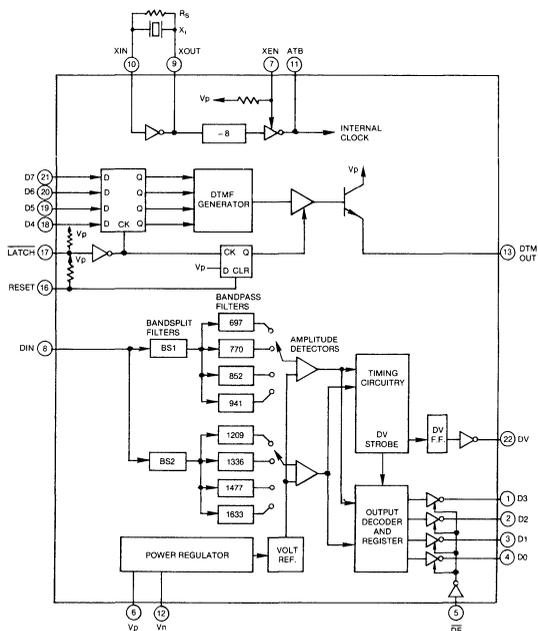
Silicon Systems' new SSI 20C89 is a complete Dual Tone Multiple Frequency (DTMF) Transceiver that can both generate and detect all 16 standard Touch-Tone digits. The SSI 20C89 circuit integrates the performance proven SSI 202 DTMF Receiver with a new DTMF generator circuit.

The DTMF Receiver electrical characteristics are identical to the standard SSI 202 device characteristics. The DTMF generator provides performance similar to the Mostek MK5380, but with an improved (tighter) output amplitude range specification and with the addition of independent latch and reset controls.

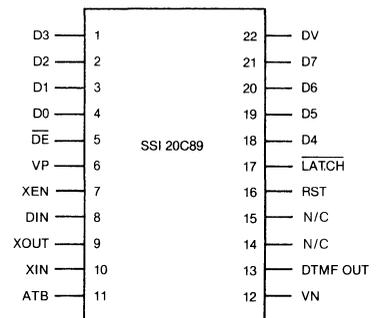
The only external components necessary for the SSI 20C89 are a single 3.58 MHz "colorburst" crystal with a parallel 1 MegOhm resistor. This provides the time base for digital functions and switched capacitor filters in the device. No external filtering is required.

FEATURES

- DTMF Generator and Receiver on one chip
- 300 mil, 22-Pin plastic DIP for high system density
- Low-Power 5 Volt CMOS
- DTMF Receiver exhibits excellent speech immunity
- Three-state outputs (4-bit hexadecimal) from DTMF Receiver
- AC coupled, internally biased Analog Input
- Latched DTMF Generator inputs
- Analog Input range from -32 to -2 dBm (ref 600Ω)
- DTMF Output typ. -8 dBm (Low Band) and -5.5 dBm (High Band)
- Uses inexpensive 3.579545 MHz crystal for reference
- Easily interfaced for microprocessor dialing



Block Diagram



**Pin Out
(Top View)**

CAUTION: Use handling procedures necessary for a static sensitive component

SSI 20C89 DTMF Transceiver

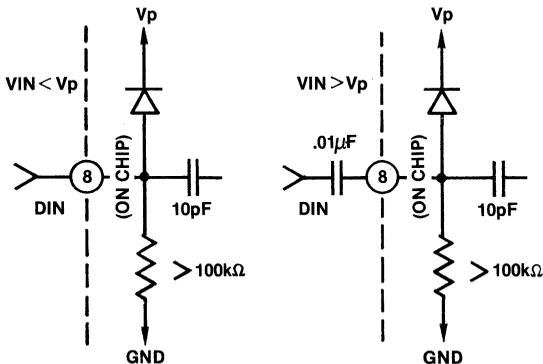
CIRCUIT OPERATION

Receiver

The DTMF Receiver in the SSI 20C89 detects the presence of a valid tone pair (indicating a single dialed digit) on a telephone line or other transmission medium. The analog input is pre-processed by 60 Hz reject and band splitting filters, then hard-limited to provide Automatic Gain Control. Eight bandpass filters detect the individual tones. The digital post-processor times the tone durations and provides the correctly coded digital outputs. The outputs will drive standard CMOS circuitry, and are three-state enabled to facilitate bus-oriented architectures.

DIN

This pin accepts the analog input. It is internally biased so that the input signal may be AC coupled. The input may be DC coupled as long as it does not exceed the positive supply. Proper input coupling is illustrated below.

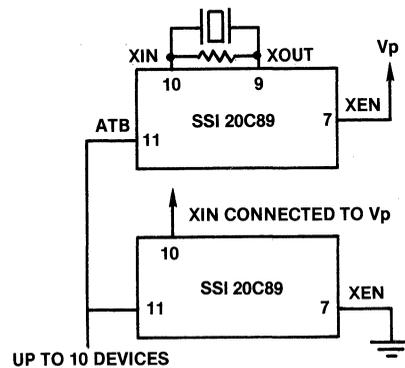


The SSI 20C89 is designed to accept sinusoidal input wave forms but will operate satisfactorily with any input that has the correct fundamental frequency with harmonics greater than 20 dB below the fundamental.

Crystal Oscillator

The SSI 20C89 contains an onboard inverter with sufficient gain to provide oscillation when connected to a low-cost television "color-burst" crystal. The crystal is placed between XIN and XOUT in parallel with a 1 Mohm resistor, while XEN is tied high. Since the switched-capacitor-filter time base is derived from the crystal oscillator, the frequency accuracy of all portions of the 20C89 depends on the time base tolerance. The SSI DTMF Receiver frequency response and timing is

specified for a time base accuracy of at least $\pm 0.005\%$. ATB is a clock frequency output. Other devices may use the same frequency reference by tying their ATB pins to the ATB of a crystal connected device. XIN and XEN of the auxiliary devices must then be tied high and low respectively, XOUT is left floating. XOUT is designed to drive a resonant circuit only and is not intended to drive additional devices. Ten devices may run off a single crystal-connected SSI 20C89 as shown below.



Receiver Outputs and the \overline{DE} Pin

Outputs D0,D1,D2,D3 are CMOS push-pull when enabled (\overline{DE} low) and open-circuited (high impedance) when disabled (\overline{DE} high). These digital outputs provide the hexadecimal code corresponding to the detected digit. The table below shows that code.

| Digit | Input: Output: | Hexadecimal code | | | |
|-------|-------------------|------------------|----------|----------|----------|
| | | D7 D3 | D6 D2 | D5 D1 | D4 D0 |
| 1 | | 0 | 0 | 0 | 1 |
| 2 | | 0 | 0 | 1 | 0 |
| 3 | | 0 | 0 | 1 | 1 |
| 4 | | 0 | 1 | 0 | 0 |
| 5 | | 0 | 1 | 0 | 1 |
| 6 | | 0 | 1 | 1 | 0 |
| 7 | | 0 | 1 | 1 | 1 |
| 8 | | 1 | 0 | 0 | 0 |
| 9 | | 1 | 0 | 0 | 1 |
| 0 | | 1 | 0 | 1 | 0 |
| * | | 1 | 0 | 1 | 1 |
| # | | 1 | 1 | 0 | 0 |
| A | | 1 | 1 | 0 | 1 |
| B | | 1 | 1 | 1 | 0 |
| C | | 1 | 1 | 1 | 1 |
| D | | 0 | 0 | 0 | 0 |

Table 1

The digital outputs become valid and DV signals a detection after a valid tone pair has been sensed. The outputs and DV are cleared when a valid pause has been timed.

Generator

The DTMF generator on the SSI 20C89 responds to a hexadecimal code input with a valid tone pair. Pins D4-D7 are the data inputs for the generator. A high to low transition on $\overline{\text{LATCH}}$ causes the hexadecimal code to be latched internally and generation of the appropriate DTMF tone pair to begin. The DTMF output is disabled by a high on RESET and will not resume until new data is latched in.

Digital Inputs

The D4, D5, D6, D7, $\overline{\text{LATCH}}$, RESET inputs to the DTMF generator may be interfaced to open-collector TTL with a pull-up resistor or standard CMOS. These inputs follow the same hexadecimal code format as the DTMF receiver output. Table 1 shows the code for each digit. The dialing matrix and detection digits frequency table below list the frequencies of the digits.

DTMF DIALING MATRIX

| | Col 0 | Col 1 | Col 2 | Col 3 |
|-------|-------|-------|-------|-------|
| Row 0 | 1 | 2 | 3 | A |
| Row 1 | 4 | 5 | 6 | B |
| Row 2 | 7 | 8 | 9 | C |
| Row 3 | * | 0 | # | D |

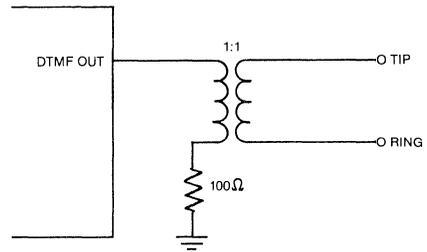
Note: Column 3 is for special applications and is not normally used in telephone dialing.

DETECTION FREQUENCY

| Low Group f. | High Group f. |
|----------------|--------------------|
| Row 0 = 697 Hz | Column 0 = 1209 Hz |
| Row 1 = 770 Hz | Column 1 = 1336 Hz |
| Row 2 = 852 Hz | Column 2 = 1477 Hz |
| Row 3 = 941 Hz | Column 3 = 1633 Hz |

DTMF OUT

The output amplitude characteristics listed in the specifications are given for a supply voltage of 5.0 V. However, the output level is directly proportional to the supply, so variations in it will affect the DTMF output. A recommended line interface for this output is shown below.



Absolute Maximum Ratings*

| | |
|---------------------------------------|---------------------|
| DC Supply Voltage (Vp-Vn) | +7V |
| Voltage at any Pin (Vn = 0) | -0.3 to Vp + 0.3 V |
| DIN Voltage | Vp + 0.5 to Vp-10 V |
| Current through any Protection Device | ±1.0 mA |
| Storage Temperature | -40 to +150 °C |

*Operation above absolute maximum ratings may damage the device.

Recommended Operating Conditions

| Parameter | Min. | Max. | Unit |
|--|-------|-------|-------|
| Supply Voltage | 4.5 | 5.5 | V |
| Power Supply Noise (wide band) | — | 10 | mV pp |
| Ambient Temperature | 0 | 70 | °C |
| Crystal Frequency (F Nominal = 3.579545 MHz) | -.005 | +.005 | % |
| Crystal Shunt Resistor | 0.8 | 1.2 | MΩ |
| DTMF OUT Load Resistance | 100 | — | Ω |

Digital and DC Requirements

The following electrical specifications apply to the digital input and output signals over the recommended operating range unless otherwise noted. The specifica-

tions do not apply to the following pins: DIN, XIN, XOUT, and DTMF OUT. Positive current is defined as entering the circuit. Vn = 0 unless otherwise stated.

| Parameter | Test Conditions | Min. | Max. | Unit |
|---------------------|-----------------|--------|----------|------|
| Supply Current* | — | — | 30 | mA |
| Power Dissipation | — | — | 225 | mW |
| Input Voltage High | — | 0.7Vp | — | V |
| Input Voltage Low | — | — | 0.3Vp | V |
| Input Current High | — | — | 10 | μA |
| Input Current Low | — | - 10 | — | μA |
| Output Voltage High | Ioh = -0.2mA | Vp-0.5 | — | V |
| Output Voltage Low | Iol = +0.4mA | — | Vn + 0.5 | V |

*with DTMF output disabled

DTMF Receiver

Electrical Characteristics

| Parameter | Test Conditions | Min. | Typ | Max. | Unit |
|----------------------------|--------------------|------------|------|------|----------|
| Frequency Detect Bandwidth | — | ±(1.5+2Hz) | ±2.3 | ±3.5 | %Fo |
| Amplitude for Detection | Each Tone | - 32 | — | - 2 | dBm/tone |
| Twist Tolerance | — | - 10 | — | + 10 | dB |
| 60Hz Tolerance | — | — | — | 0.8 | Vrms |
| Dial Tone Tolerance | Precise Dial Tone | — | — | 0 | dB* |
| Speech Immunity | MITEL Tape #CM7290 | — | 2 | — | hits |
| Noise Tolerance | MITEL Tape #CM7290 | — | — | - 12 | dB* |
| Input Impedance | — | 100 | — | — | kΩ |

*Referenced to lowest amplitude tone

Timing Characteristics

| Parameter | Symbol | Min. | Max. | Unit |
|----------------------------|--------|------|------|---------|
| Tone Time for Detect | ton | 40 | — | ms |
| Tone Time for No Detect | ton | — | 20 | ms |
| Pause Time for Redetection | toff | 40 | — | ms |
| Pause Time for Bridging | toff | — | 20 | ms |
| Detect Time | td1 | 25 | 46 | ms |
| Release Time | tr1 | 35 | 50 | ms |
| Data Set Up Time | tsu1 | 7 | — | μ s |
| Data Hold Time | thd1 | 4.2 | 5.0 | ms |
| Output Enable Time | | — | 300 | ns |
| Output Disable Time | | — | 200 | ns |

DTMF Generator

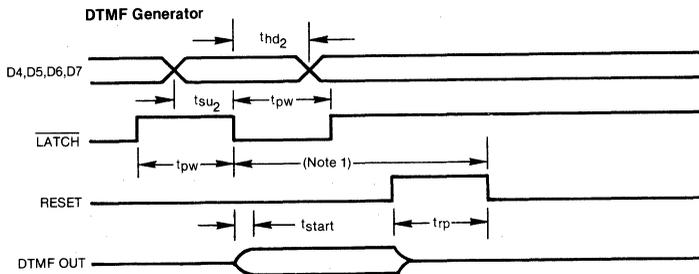
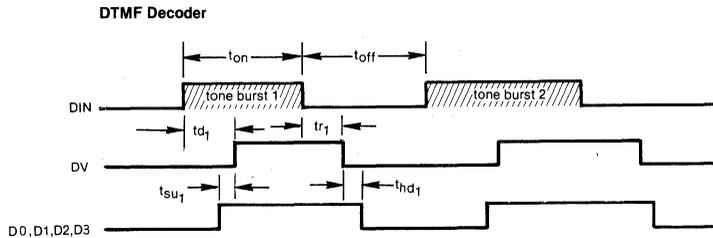
Electrical Characteristics

| Parameter | Test Conditions | Min. | Max. | Unit |
|--------------------|--|------|------|------|
| Frequency Accuracy | — | -1.0 | +1.0 | %Fo |
| Output Amplitude | R1 = 100 Ω to Vn, Vp - Vn = 5.0 V | — | — | — |
| Low Band | — | -9.2 | -7.2 | dBm |
| High Band | — | -6.6 | -4.6 | dBm |
| Output Distortion | DC to 50kHz | — | -20 | dB |

Timing Characteristics

| Parameter | Symbol | Min. | Max. | Unit |
|-------------------|--------|------|------|------|
| Start-Up Time | tstart | — | 4.5 | ms |
| Data Set-Up Time | tsu2 | 400 | — | ns |
| Data Hold Time | thd2 | 300 | — | ns |
| RESET Pulse Width | trp | 450 | — | ns |
| LATCH Pulse Width | tpw | 450 | — | ns |

Timing Diagrams



Note 1: The indicated time may be as small as 0 sec meaning that the LATCH and RESET lines may be tied together.

Preliminary Data Sheet

GENERAL DESCRIPTION

Silicon Systems' new SSI 20C90 is a complete Dual Tone Multiple Frequency (DTMF) Transceiver that can both generate and detect all 16 standard Touch-Tone digits. The SSI 20C90 circuit integrates the performance proven SSI 202 DTMF Receiver with a new DTMF generator circuit.

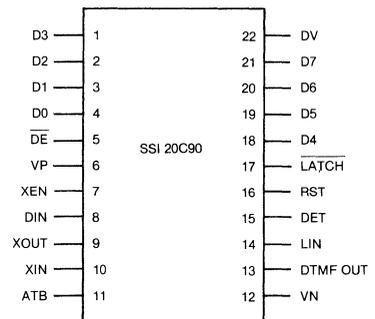
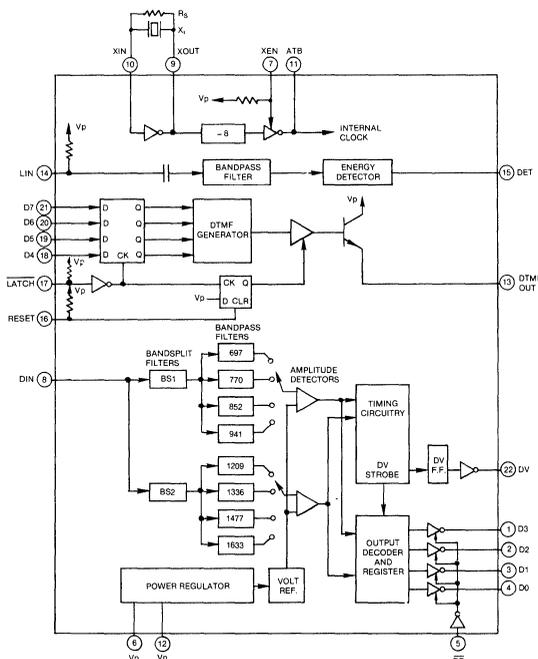
The DTMF Receiver electrical characteristics are identical to the standard SSI 202 device characteristics. The DTMF generator provides performance similar to the Mostek MK5380, but with an improved (tighter) output amplitude range specification and with the addition of independent latch and reset controls.

An additional feature of the 20C90 is "imprecise" call progress detector. The detector detects the presence of signals in the 305-640 Hz band.

The only external components necessary for the SSI 20C90 are a single 3.58 MHz "colorburst" crystal with a parallel 1 MegOhm resistor. This provides the time base for digital functions and switched capacitor filters in the device. No external filtering is required.

FEATURES

- DTMF Generator and Receiver on one chip
- 300 mil, 22-Pin plastic DIP for high system density
- Low-Power 5 Volt CMOS
- DTMF Receiver exhibits excellent speech immunity
- Three-state outputs (4-bit hexadecimal) from DTMF Receiver
- AC coupled, internally biased Analog Input
- Latched DTMF Generator inputs
- Analog Input range from -32 to -2 dBm (ref 600Ω)
- DTMF Output typ. -8 dBm (Low Band) and -5.5 dBm (High Band)
- Uses inexpensive 3.579545 MHz crystal for reference
- Easily interfaced for microprocessor dialing
- Call progress detection



Pin Out
(Top View)

CAUTION: Use handling procedures necessary for a static sensitive component

SSI 20C90

DTMF Transceiver with Call Progress Detection

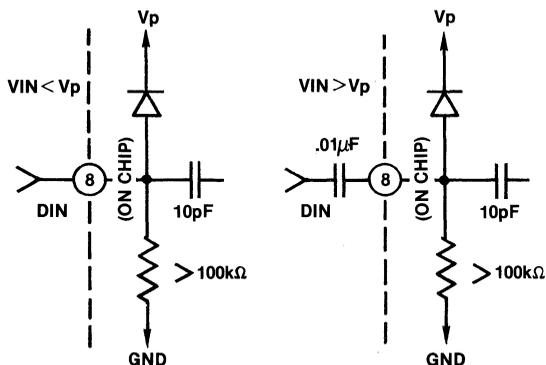
CIRCUIT OPERATION

Receiver

The DTMF Receiver in the SSI 20C90 detects the presence of a valid tone pair (indicating a single dialed digit) on a telephone line or other transmission medium. The analog input is pre-processed by 60 Hz reject and band splitting filters, then hard-limited to provide Automatic Gain Control. Eight bandpass filters detect the individual tones. The digital post-processor times the tone durations and provides the correctly coded digital outputs. The outputs will drive standard CMOS circuitry, and are three-state enabled to facilitate bus-oriented architectures.

DIN

This pin accepts the analog input. It is internally biased so that the input signal may be AC coupled. The input may be DC coupled as long as it does not exceed the positive supply. Proper input coupling is illustrated below.

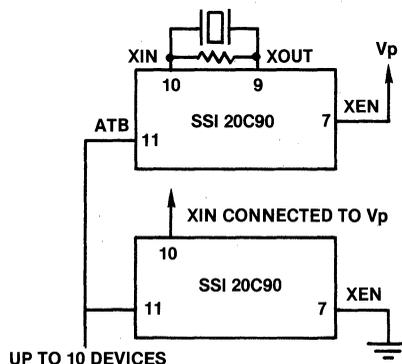


The SSI 20C90 is designed to accept sinusoidal input wave forms but will operate satisfactorily with any input that has the correct fundamental frequency with harmonics greater than 20 dB below the fundamental.

Crystal Oscillator

The SSI 20C90 contains an onboard inverter with sufficient gain to provide oscillation when connected to a low-cost television "color-burst" crystal. The crystal is placed between XIN and XOUT in parallel with a 1 Mohm resistor, while XEN is tied high. Since the switched-capacitor-filter time base is derived from the crystal oscillator, the frequency accuracy of all portions of the

20C90 depends on the time base tolerance. The SSI DTMF Receiver frequency response and timing is specified for a time base accuracy of at least $\pm 0.005\%$. ATB is a clock frequency output. Other devices may use the same frequency reference by tying their ATB pins to the ATB of a crystal connected device. XIN and XEN of the auxiliary devices must then be tied high and low respectively, XOUT is left floating. XOUT is designed to drive a resonant circuit only and is not intended to drive additional devices. Ten devices may run off a single crystal-connected SSI 20C90 as shown below.



Receiver Outputs and the \overline{DE} Pin

Outputs D0,D1,D2,D3 are CMOS push-pull when enabled (\overline{DE} low) and open-circuited (high impedance) when disabled (\overline{DE} high). These digital outputs provide the hexadecimal code corresponding to the detected digit. The table below shows that code.

| Digit | Input: Output: | Hexadecimal code | | | |
|-------|-------------------|------------------|----------|----------|----------|
| | | D7 D3 | D6 D2 | D5 D1 | D4 D0 |
| 1 | | 0 | 0 | 0 | 1 |
| 2 | | 0 | 0 | 1 | 0 |
| 3 | | 0 | 0 | 1 | 1 |
| 4 | | 0 | 1 | 0 | 0 |
| 5 | | 0 | 1 | 0 | 1 |
| 6 | | 0 | 1 | 1 | 0 |
| 7 | | 0 | 1 | 1 | 1 |
| 8 | | 1 | 0 | 0 | 0 |
| 9 | | 1 | 0 | 0 | 1 |
| 0 | | 1 | 0 | 1 | 0 |
| * | | 1 | 0 | 1 | 1 |
| # | | 1 | 1 | 0 | 0 |
| A | | 1 | 1 | 0 | 1 |
| B | | 1 | 1 | 1 | 0 |
| C | | 1 | 1 | 1 | 1 |
| D | | 0 | 0 | 0 | 0 |

Table 1

The digital outputs become valid and DV signals a detection after a valid tone pair has been sensed. The outputs and DV are cleared when a valid pause has been timed.

Generator

The DTMF generator on the SSI 20C90 responds to a hexadecimal code input with a valid tone pair. Pins D4-D7 are the data inputs for the generator. A high to low transition on LATCH causes the hexadecimal code to be latched internally and generation of the appropriate DTMF tone pair to begin. The DTMF output is disabled by a high on RESET and will not resume until new data is latched in.

Digital Inputs

The D4,D5,D6,D7, LATCH, RESET inputs to the DTMF generator may be interfaced to open-collector TTL with a pull-up resistor or standard CMOS. These inputs follow the same hexadecimal code format as the DTMF receiver output. Table 1 shows the code for each digit. The dialing matrix and detection frequency table below list the frequencies of the digits.

DTMF DIALING MATRIX

| | Col 0 | Col 1 | Col 2 | Col 3 |
|-------|-------|-------|-------|-------|
| Row 0 | 1 | 2 | 3 | A |
| Row 1 | 4 | 5 | 6 | B |
| Row 2 | 7 | 8 | 9 | C |
| Row 3 | * | 0 | # | D |

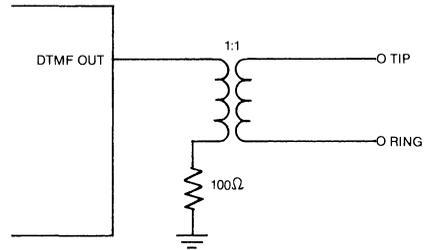
Note: Column 3 is for special applications and is not normally used in telephone dialing.

DETECTION FREQUENCY

| Low Group f_o | High Group f_o |
|-----------------|--------------------|
| Row 0 = 697 Hz | Column 0 = 1209 Hz |
| Row 1 = 770 Hz | Column 1 = 1336 Hz |
| Row 2 = 852 Hz | Column 2 = 1477 Hz |
| Row 3 = 941 Hz | Column 3 = 1633 Hz |

DTMF OUT

The output amplitude characteristics listed in the specifications are given for a supply voltage of 5.0 V. However, the output level is directly proportional to the supply, so variations in it will affect the DTMF output. A recommended line interface for this output is shown below.



Call Progress Detection

The Call Progress Detector consists of a bandpass filter and an energy detector for turning the on/off cadences into a microprocessor compatible signal.

LIN Input

This analog input accepts the call progress signal and should be used in the same manner as the receiver input DIN.

DET Output

This output is TTL compatible and will be of a frequency corresponding to the various cadences of Call Progress signals such as, on 0.5 sec/off 0.5 sec for a busy tone, on 0.25 sec/off 0.25 sec for a reorder tone and on 0.8-1.2 sec/off 2.7-3.3 sec for an audible ring tone.

Absolute Maximum Ratings*

DC Supply Voltage ($V_p - V_n$) + 7V
 Voltage at any Pin ($V_n = 0$) - 0.3 to $V_p + 0.3$ V
 DIN Voltage $V_p + 0.5$ to $V_p - 10$ V
 Current through any Protection Device ± 1.0 mA
 Storage Temperature - 40 to + 150 °C

*Operation above absolute maximum ratings may damage the device.

Recommended Operating Conditions

| Parameter | Min. | Max. | Unit |
|--|-------|--------|-------|
| Supply Voltage | 4.5 | 5.5 | V |
| Power Supply Noise (wide band) | — | 10 | mV pp |
| Ambient Temperature | 0 | 70 | °C |
| Crystal Frequency (F Nominal = 3.579545 MHz) | −.005 | + .005 | % |
| Crystal Shunt Resistor | 0.8 | 1.2 | MΩ |
| DTMF OUT Load Resistance | 100 | — | Ω |

Digital and DC Requirements

The following electrical specifications apply to the digital input and output signals over the recommended operating range unless otherwise noted. The specifica-

tions do not apply to the following pins: LIN, DIN, XIN, XOUT, and DTMF OUT. Positive current is defined as entering the circuit. Vn = 0 unless otherwise stated.

| Parameter | Test Conditions | Min. | Max. | Unit |
|---------------------|-----------------|--------|----------|------|
| Supply Current* | — | — | 30 | mA |
| Power Dissipation | — | — | 225 | mW |
| Input Voltage High | — | 0.7Vp | — | V |
| Input Voltage Low | — | — | 0.3Vp | V |
| Input Current High | — | — | 10 | μA |
| Input Current Low | — | −10 | — | μA |
| Output Voltage High | Ioh = −0.2mA | Vp-0.5 | — | V |
| Output Voltage Low | Iol = +0.4mA | — | Vn + 0.5 | V |

*with DTMF output disabled

DTMF Receiver

Electrical Characteristics

| Parameter | Test Conditions | Min. | Typ | Max. | Unit |
|----------------------------|--------------------|--------------|------|------|----------|
| Frequency Detect Bandwidth | — | ±(1.5 + 2Hz) | ±2.3 | ±3.5 | %Fo |
| Amplitude for Detection | Each Tone | −32 | — | −2 | dBm/tone |
| Twist Tolerance | — | −10 | — | +10 | dB |
| 60Hz Tolerance | — | — | — | 0.8 | Vrms |
| Dial Tone Tolerance | Precise Dial Tone | — | — | 0 | dB* |
| Speech Immunity | MITEL Tape #CM7290 | — | 2 | — | hits |
| Noise Tolerance | MITEL Tape #CM7290 | — | — | −12 | dB* |
| Input Impedance | — | 100 | — | — | kΩ |

*Referenced to lowest amplitude tone

Timing Characteristics

| Parameter | Symbol | Min. | Max. | Unit |
|----------------------------|--------|------|------|---------|
| Tone Time for Detect | ton | 40 | — | ms |
| Tone Time for No Detect | ton | — | 20 | ms |
| Pause Time for Redetection | toff | 40 | — | ms |
| Pause Time for Bridging | toff | — | 20 | ms |
| Detect Time | td1 | 25 | 46 | ms |
| Release Time | tr1 | 35 | 50 | ms |
| Data Set Up Time | tsu1 | 7 | — | μ s |
| Data Hold Time | thd1 | 4.2 | 5.0 | ms |
| Output Enable Time | | — | 300 | ns |
| Output Disable Time | | — | 200 | ns |

DTMF Generator

Electrical Characteristics

| Parameter | Test Conditions | Min. | Max. | Unit |
|--------------------|--|-------|-------|------|
| Frequency Accuracy | — | - 1.0 | + 1.0 | %Fo |
| Output Amplitude | R1 = 100 Ω to Vn, Vp - Vn = 5.0 V | — | — | — |
| Low Band | — | - 9.2 | - 7.2 | dBm |
| High Band | — | - 6.6 | - 4.6 | dBm |
| Output Distortion | DC to 50kHz | — | - 20 | dB |

Timing Characteristics

| Parameter | Symbol | Min. | Max. | Unit |
|-------------------|--------|------|------|------|
| Start-Up Time | tstart | — | 4.5 | ms |
| Data Set-Up Time | tsu2 | 400 | — | ns |
| Data Hold Time | thd2 | 300 | — | ns |
| RESET Pulse Width | trp | 450 | — | ns |
| LATCH Pulse Width | tpw | 450 | — | ns |

Call Progress Detector

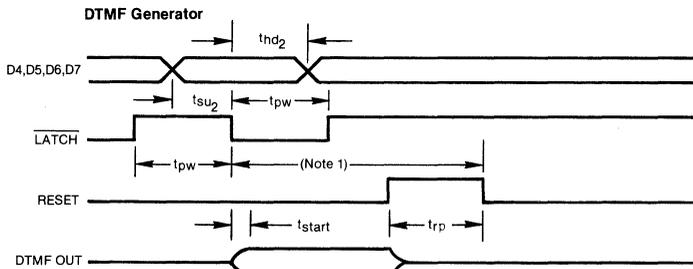
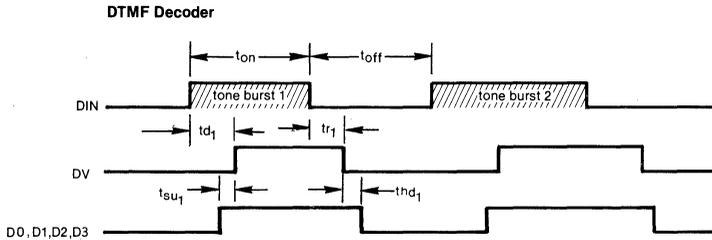
Electrical Characteristics

| Parameter | Conditions | Min. | Max. | Unit |
|----------------------------|-----------------|------|------|------------|
| Amplitude for Detection | 305 Hz - 640 Hz | - 40 | 0 | dBm |
| Amplitude for No Detection | 305 Hz - 640 Hz | — | - 50 | dBm |
| Input Impedance | — | 100 | — | k Ω |

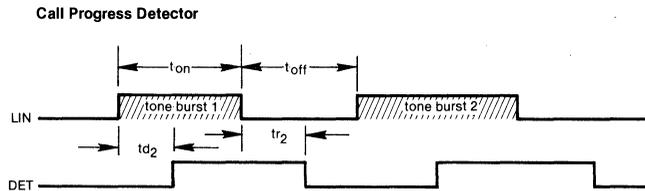
Timing Characteristics

| Parameter | Symbol | Min. | Max. | Unit |
|-----------------------------|--------|------|------|------|
| Signal Time for Detect | ton | 40 | — | ms |
| Signal Time for No Detect | ton | — | 10 | ms |
| Interval Time for Detect | toff | 40 | — | ms |
| Interval Time for No Detect | toff | — | 20 | ms |
| Detect Time | td2 | — | 40 | ms |
| Release Time | tr2 | — | 40 | ms |

Timing Diagrams



Note 1: The indicated time may be as small as 0 sec meaning that the **LATCH** and **RESET** lines may be tied together.



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infringements of patents and trademarks or other rights of third parties resulting from its use. No license is granted under any patents, patent rights or trademarks of SSI. SSI reserves the right to make changes in specifications at any time and without notice.

Preliminary Data Sheet

DESCRIPTION

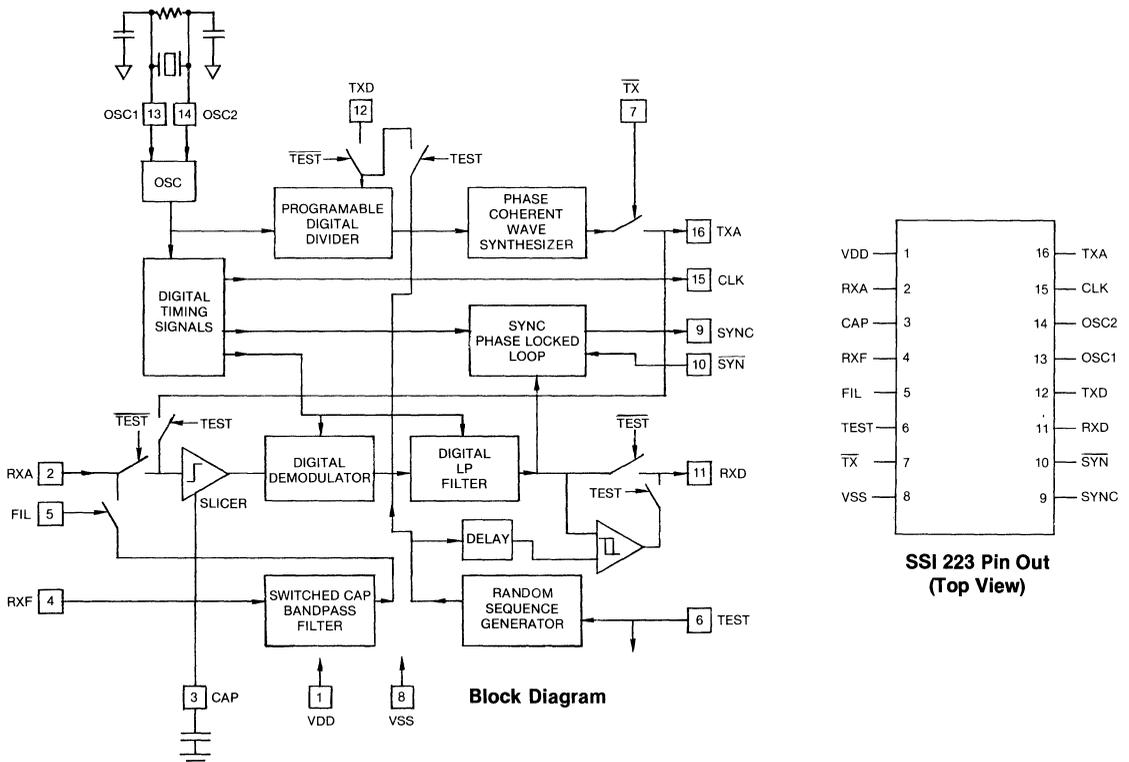
The SSI 223 modem device receives and transmits, serial, binary data over existing telephone networks using Frequency Shift Keying (FSK). It provides the filtering, modulation, and demodulation to implement a serial, asynchronous data communication channel. The SSI 223 employs CCITT V.23 signaling frequencies and operates at 1200 baud, and is intended for half duplex operation over a single line system or full duplex operation over a two line system.

The SSI 223 provides a cost effective alternative to existing modem solutions. It is ideally suited for interactive terminals, videotex, personal computers, credit verification systems, point-of-sale terminals, and remote process control.

CMOS Technology ensures small size, low power consumption and enhanced reliability.

FEATURES

- Low cost FSK Modem
- 1200 Baud operation
- CMOS switched capacitor technology
- Simultaneous transmit and receive
- Built-in self-test feature
- On-chip filtering, Mod/Demod.
- Uses CCITT V.23 Frequencies
- On chip crystal oscillator
- Pin/function compatible with SSI 180
- Low power/High reliability
- 16-pin plastic package



SSI 223

Circuit Operation

The SSI 223 has four main functional sections: timing, transmit, receive, and test. Each section of the chip will be individually described below.

TIMING

The timing section contains the oscillator (OSC) and random logic which generates digital timing signals used throughout the chip. The time base can be derived from 3.18MHz crystal or an external digital input. The modem will operate with clock inputs from 330KHz to 3.3MHz. Back channel is supplied by selecting the lower frequency clock rate. The digital timing logic divides the oscillator frequency to give a 1200HZ output that can be used for system timing.

TRANSMITTER

The SSI 223 transmitter consists of a programmable divider that drives a programmable coherent phase frequency synthesizer. The programmable divider is digitally controlled via the Data Input pin (TXD). The output of the divider clocks a 16 segment phase coherent frequency synthesizer. A sine wave is constructed by eight weighted capacitors which are the inputs to a high pass filter. Proper matching of the capacitors is important in order to suppress the second thru fourteenth harmonics. The synthesized signal is output directly to the transmit pin TXA. The transmit signal can be disabled by using the digital control pin TX.

RECEIVER

The SSI 223's receiver is comprised of three sections: the input bandpass filter, the synchronization loop, and the demodulator.

The input bandpass filter is a four pole Butterworth filter, implemented using switched capacitor technology. This filter reduces wideband noise which significantly improves data error rates. The SSI 223 can be configured with the bandpass filter in series with the receiver by setting FIL = 1 and inserting the received signal at RXF, or the bandpass filter can be deleted from the system by setting FIL = 0 and inputting the received signal thru RXA.

The demodulator is used to detect a received mark or space.

The synchronization for sampling the digital output at RXD derived from a digital phase locked loop. The phase locked loop is clocked at 16 times the bit rate with a maximum lock period of 8 clocks and locks on the data output signal.

SELF TEST MODE

The SSI 223 features an autotest mode which provides easy field test capability of the chip's functionality. The modem is placed in the test mode by taking the test pin

high. In the test mode the Data Input pin is disconnected and the programmable divider is driven by a pseudo random PN sequence generator and the transmitter's output is connected to the receiver's input. The input data to the programmable divider is delayed by the system delay time and compared to the digital output on sync transitions. If the detected data matches the delayed input data from the PN sequence counter, the SSI 223 is properly functioning as indicated by RXD low. A high on the RXD pin indicates a functional problem on the SSI 223.

ABSOLUTE MAX RATINGS

| | |
|-------------------------------------|-------------------------|
| Power Supply Voltage (VDD-VSS) | 14 V |
| Analog Input Voltage at RXA | - 0.3 to VDD V |
| Analog Input Voltage at RXF | - 3 to VDD V |
| Digital Input Voltage | VSS- 0.3 to VDD + 0.3 V |
| Storage Temperature Range | - 65 to + 150 °C |
| Operating Temperature Range | - 25 to + 70 °C |
| Lead Temperature (10 sec soldering) | 260 °C |

PIN DESCRIPTIONS

| Pin No. | Symbol | Description |
|---------|--------|---|
| 1 | VDD | Positive Supply Voltage |
| 2 | RXA | Receive Analog Input — Analog input from the telephone network. |
| 3 | CAP | Capacitor — Connect a 0.1µf capacitor between Pin 3 and ground (VSS). |
| 4 | RXF | Filtered Receive Analog Input |
| 5 | FIL | Analog Input Control — A logical 1 selects the filtered input. A logical 0 selects the non-filtered input. |
| 6 | TEST | Self-Test Mode Control — Normal operation when a logical 0. A logical 1 places the device into the self-test mode. A Low appears at RXD, to indicate a property functioning device. |
| 7 | TX | Transmitter Control — A logical 0 selects transmit mode. A logical 1 selects a stand-by condition forcing TXA to $\frac{VDD}{2}$ VDC. |
| 8 | VSS | Ground |
| 9 | SYNC | Synchronized Output — Digital output synchronized with the received signal and used to sample the received eye pattern. |

SSI 223

PIN DESCRIPTIONS

| Pin No. | Symbol | Description |
|---------|-------------------------|--|
| 10 | $\overline{\text{SYN}}$ | Sync Disable — A logical 0 input disables the phase locked signal from the received data and locks it to the 1200Hz reference. |
| 11 | RXD | Receiver Digital Output |
| 12 | TXD | Transmitter Digital Input |
| 13 | OSC ₁ | Crystal Input (3.1872 MHz) or External Clock Input |
| 14 | OSC ₂ | Crystal Return |
| 15 | CLK | 1200Hz Squarewave Output — Can drive up to 10 CMOS loads. |
| 16 | TXA | Transmitter Analog Output |

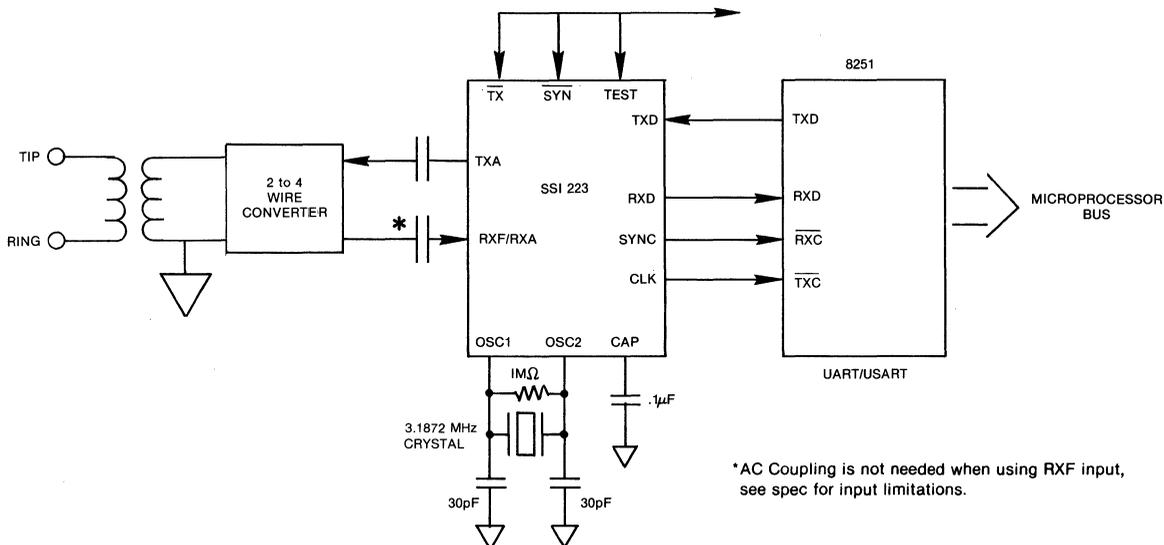
ELECTRICAL CHARACTERISTICS Unless otherwise specified, $4.5 < V_{DD} < 13 \text{ VDC}$, $V_{SS} = 0 \text{ VDC}$, $-25^\circ\text{C} < T_A < 70^\circ\text{C}$.

POWER SUPPLY

| Parameter | Test Conditions | Min. | Typ. | Max. | Units |
|---------------------------|---|----------------|--------------|--------------------|---------------|
| VDD Voltage Supply Range | | 4.5 | — | 13 | V |
| Supply Current | $V_{DD} = 5\text{V } 25^\circ\text{C}$ $V_{DD} = 12\text{V } 25^\circ\text{C}$ | — — | 2.0 5.0 | — — | mA mA |
| Digital Inputs | | | | | |
| Input Low Voltage VIL | | $V_{SS} - 0.3$ | — | $V_{SS} + 1.5$ | V |
| Input High Voltage VIH | | $V_{DD} - 1.5$ | — | $V_{DD} + 0.3$ | V |
| Input Low Current IIL | | -1 | — | — | μA |
| Input High Current IIH | | — | — | 1 | μA |
| Digital Outputs | | | | | |
| Output Low Voltage VOL | $I_{OL} < 1\mu\text{A}$ | — | — | 0.05 | V |
| Output High Voltage VOH | $I_{OL} < 1\mu\text{A} \quad V_{DD} = 5\text{V}$ | 4.95 | — | — | V |
| Output Low Current IOL | $V_{OL} = 0.4\text{V} \quad V_{DD} = 5\text{V}$ | 0.5 | — | — | mA |
| Output High Current IOH | $V_{OH} = 4.5\text{V} \quad V_{DD} = 5\text{V}$ | -0.2 | — | — | mA |
| Analog Input Level @ RXA | Centered at $V_{DD}/2 + 0.5\text{V}$ | 0.2 | — | $V_{DD}/4$ | Vpp |
| Analog Input Level @ RXF | *DC Level between V_{DD} & V_{SS} | 0.2 | — | $V_{DD}/2$ | VDC |
| Error Rate | S/N = 8dB Input @ RXF | — | — | 5×10^{-3} | — |
| Analog Output Level @ TXA | $R_L \geq 10\text{K} \quad \overline{\text{TX}} = 0$ | — | $V_{DD}/4$ | — | Vpp |
| Analog Output Level @ TXA | $\overline{\text{TX}} = 1$ | — | $V_{DD}/2$ | — | VDC |
| Output Frequency @ TXA | XTAL = 3.1872MHz TXD = 1 TXD = 0 | — — | 1302 2097 | — — | Hz Hz |
| Output Harmonics | 2nd to 14th Harmonics 15th Harmonic | — — | -60 — | -50 -20 | dB dB |
| Input Filter (RXF) | *Input = 200 mVpp to $V_{DD}/2$ Vpp | — | 760 | — | Hz |
| Lower 3dB Corner | | — | 2625 | — | Hz |
| Upper 3dB Corner | | — | — | — | Hz |

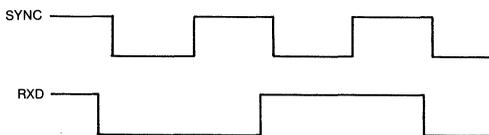
*Note: The SSI 223 RXF input is AC coupled internally, but the DC value of the input must be between the two supplies V_{DD} & V_{SS}

Typical Application

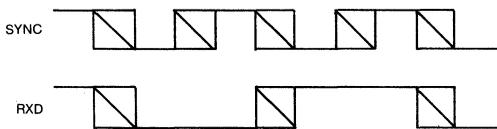


Note: A simple low speed back channel can be configured using a DTMF Encoder and Decoder (SSI202)

Received Output Waveforms



(a) High S/N Ratio Analog Input



(b) Low S/N Ratio Analog Input

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Preliminary Data Sheet

GENERAL DESCRIPTION

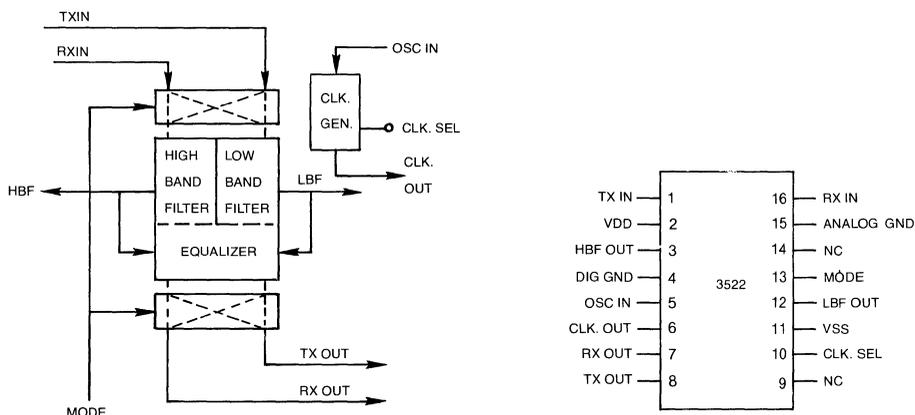
The SSI 3522 is a 16 pin CMOS integrated circuit that provides the channel filtering and equalization functions required for Bell 212A and C.C.I.T.T. V.22 modem applications. Employing switched capacitor filter techniques, the 3522 includes channel separation filters optimized for 1200 and 2400 Hz operation, while maintaining the bandshape necessary to reject 550 and 1800 Hz guard tones typical for V.22 standard modems. Fixed compromise equalization and group delay correction is distributed between the two channels as prescribed by V.22 recommendations. Dual multiplexers provide channel steering action for answer/originate control using a single pin.

The 3522 is designed to provide the front end for a Bell 212A or V.22 modulator/demodulator I C such as the SSI 291. Optimized for PSTN lines, the 3522 offers an economical solution to the filter requirements of medium speed modem designs.

FEATURES

- Performs Bell 212A/V.22 channel filter functions
- High performance/low cost filter for medium speed modems
- Compromise equalization
- Single pin originate/answer steering logic
- Selectable clock divider—2.304 MHz or 3.5795 MHz color burst frequency
- + – 5V operation at 50 mW typical power consumption
- CMOS technology and I/O compatibility
- 16 pin DIP configuration
- CMOS latch-up protected

SSI 3522 Block Diagram



CAUTION: Use handling procedures necessary for a static sensitive component

SSI 3522

Bell 212A/V.22

Modem Filter

CIRCUIT OPERATION

GENERAL:

The SSI 3522 is designed to act as a low cost filter for use in conjunction with Bell 212A or V.22 modem IC's such as the SSI 291. The device consists of a high and low band filter, split compromise equalizers for the two channels, and dual multiplexer logic for originate/answer channel steering. The unbuffered filter outputs are brought out to pins LBF and HBF before the signals have been processed by the equalizer section, and may be used for test purposes or in applications where the equalizer must be bypassed. Output impedance of these pins is 100 Kohm, requiring buffering if significant loads are to be driven. A clock generator provides the switched capacitor clock sampling frequency of 52.36 KHz from a 2.304 MHz buffered input signal. Tying pins 10 and 11 together changes the internal scaling rate to allow use of a 3.5795 MHz input, which can be generated from a standard color burst crystal. Filter response is essentially flat for a passband centered around the 1200 and 2400 Hz center frequencies, while notch filters located at 550 and 1800 Hz insure excellent rejection of C.C.I.T.T. guard tones.

DESIGN CONSIDERATIONS

The SSI 3522 uses SCF sampled data techniques. To avoid signal aliasing problems the input signal should not contain significant energy within 3 KHz of any multiple of the 52.36 KHz sampling clock. An anti-aliasing filter may be needed to meet this requirement.

When the alternate clock input is selected, a rate multiplier is inserted in the normal clock divider circuit. This shifts the SCF clock frequency to 52.30 KHz and the CLK out pin output to 104.6 KHz. In addition, a low level modulation tone at approximately 23 KHz will be generated with a typical amplitude of less than 600 μ V RMS. Normal applications will not be affected by these changes.

TABLE 1: PIN DESCRIPTIONS

| PIN NO. | I/O NAME | NAME—DESCRIPTION |
|---------|---------------|---|
| 15 | I Analog Gnd | Analog ground pin—separate from digital ground |
| 6 | O CLK out | 104.5 KHz SCF clock output, CMOS compatible |
| 4 | I Digital Gnd | Digital ground pin—separate from analog ground |
| 3 | O HBF out | High band filter output before equalization. Limited to 100 Kohm drive capability |
| 12 | O LBF out | Low band filter output before equalizer. Limited to 100Kohm drive capability. |
| 13 | I Mode | Channel steering control. Logic 1 selects the answer mode, with high-band transmit and low-band receive signal routing. A logic 0 selects the originate mode with the opposite channel orientation. |
| 5 | I Osc in | Accepts a CMOS level frequency reference at 2.304 or 3.5795 MHz as selected to generate the SCF 52.36 KHz clock used internally |

PIN NO. I/O NAME NAME—DESCRIPTION

| | | |
|----|-----------|--|
| 16 | I Rx in | Receive signal filter input |
| 7 | O Rx out | Receive signal output from equalizer |
| 1 | I Tx in | Transmit signal filter input |
| 8 | O Tx out | Transmit signal output from equalizer |
| 2 | I VDD | +5V -5%, +25% power input |
| 11 | I VSS | -5V +5%, -25% power input |
| 10 | I Clk Sel | Clock select pin. Connecting pins 10 and 11 changes the internal divider ratio to allow use of a standard 3.5795 Mhz color burst crystal reference to generate the 52.36 KHz SCF clock. The 2.304 MHz clock input is selected when pin 10 is left open. (has internal pull-up) |

ELECTRICAL: SPECIFICATIONS

Digital signals: pins 5,6,13,9,10

High level input voltage ... VIH 3.75V Minimum
 High level input current ... I_{IH} 10 μ A Maximum
 Low level input voltage ... VIL8V Maximum
 Low level input current ... I_{IL} -10 μ A Maximum

Clock input: pin 5

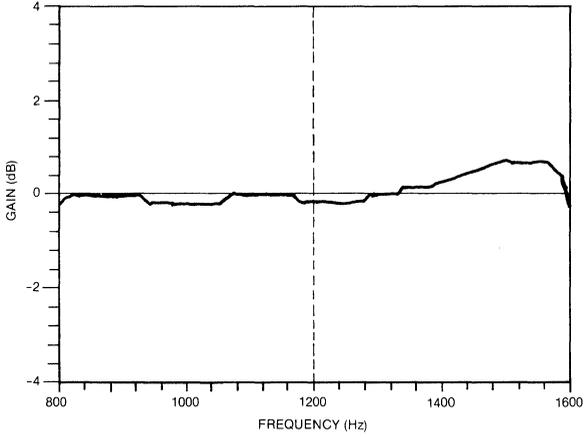
Input clock frequency 2.304 or 3.5795 MHz + -.01%
 Input clock duty cycle 20% minimum, 80% maximum

Analog signals: pins 1,2,3,4,7,8,11,12,15,16

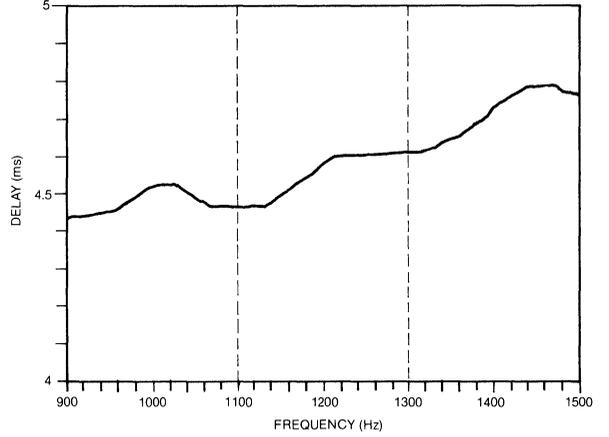
Supply voltage, VDD... 4.75V minimum 6.25V maximum
 Supply voltage, VSS... -4.75V minimum -6.25V maximum
 Supply current, IDD... (VDD = 5.0V) .. 10 mA maximum
 Supply current, ISS... (VSS = -5.0V) .. -10 mA maximum
 Input impedance, Z_{in} 10 Kohms minimum
 Output impedance, Z_{out} (pins 3, 12)... 100 Kohms typical
 Output impedance, Z_{out} (pins 7, 8)... 1 Kohm maximum
 Output noise, C-message 950 μ V RMS maximum
 Channel separation 50 dB minimum
 Input signal level VDD-2.0V P-P maximum
 Supply imbalance, VDD + VSS 0.5V maximum
 Operating temperature range 0 to 70 degrees celsius
 Storage temperature range -55 to 125 degrees celsius

TYPICAL FREQUENCY RESPONSE

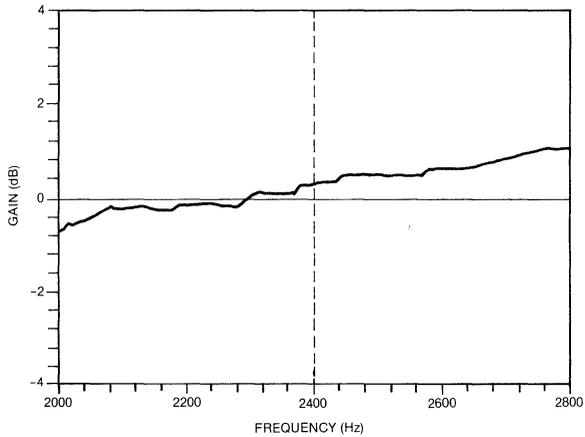
LOW BAND
Amplitude Response (dB)



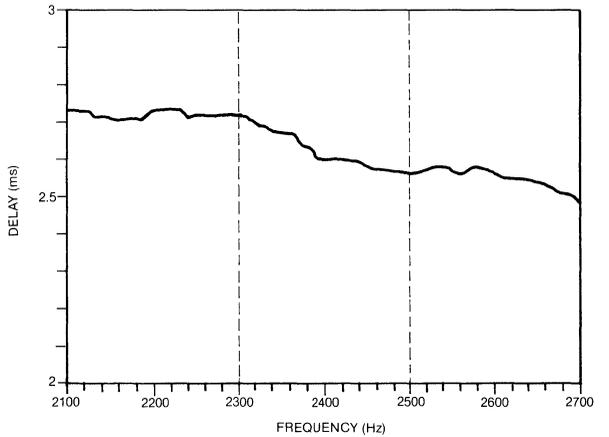
LOW BAND
Group Delay (ms)



HIGH BAND
Amplitude Response (dB)



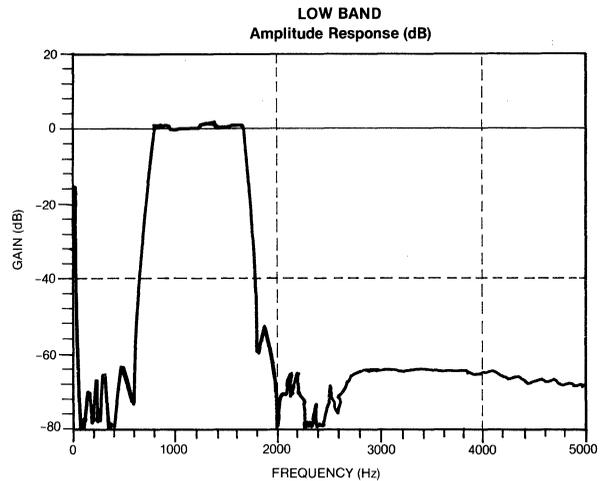
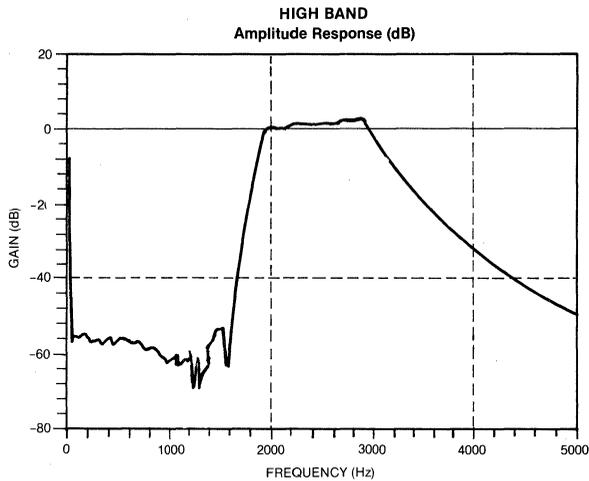
HIGH BAND
Group Delay (ms)



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TYPICAL PERFORMANCE



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Data Sheet

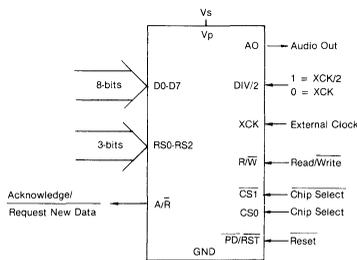
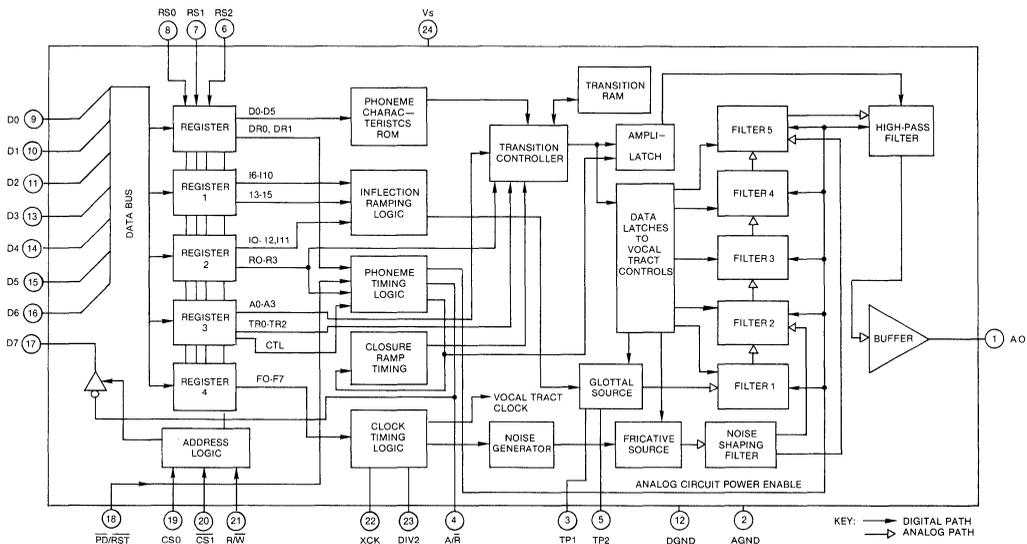
DESCRIPTION

The SSI 263A is a versatile, high-quality, phoneme-based speech synthesizer circuit contained in a single monolithic CMOS integrated circuit. It is designed to produce an audio output of unlimited vocabulary, music and sound effects at an extremely low data input rate.

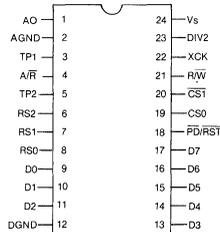
Speech is synthesized by combining phonemes, the building blocks of speech, in an appropriate sequence. The SSI 263A contains five eight-bit registers that allow software control of speech rate, pitch, pitch movement rate, amplitude, articulation rate, vocal tract filter response, and phoneme selection and duration.

FEATURES

- Single low-power CMOS integrated circuit
- 5 Volt supply
- Extremely low data rate
- 8-bit bus compatible with selectable handshaking modes
- Non-dedicated speech, ideal for text-to-speech programming
- Programmable and hard powerdown/reset mode
- Switched-capacitor-filter technology



Signal Diagram



SSI 263A Pin Out
(Top View)

CAUTION: Use handling procedures necessary for a static sensitive component

SSI 263A

SSI 263A Operation Description

This short description is intended to provide SSI 263A feature and capability information only. Refer to the SSI 263A USERS GUIDE for complete information on application and phonetic programming.

The Production of Speech

To produce different speech phonemes (sounds) the SSI 263A uses a model of the human vocal tract. Within the device this analog tract is modeled with five cascaded programmable low pass filter sections. The filter sections are programmed internally by a digital controller. Either a glottal (pitch) or a pseudo-random noise source is used to excite the vocal tract, depending on whether a voiced or non-voiced phoneme is selected. During speech production the phonemes will typically last between 25 and 100 ms.

The Speech Attribute Registers

Speech is produced by programming speech attribute (characteristic) data into five eight-bit registers. These internal registers allow selection of phonemes and speech characteristics. Refer to the Register Input Formats for the functional allocations.

Device Response to Attribute Register Data

The SSI 263A has two general classes of attribute data: "control" data (speech rate, filter frequency, phoneme articulation rate, phoneme duration, immediate inflection setting, and inflection movement rate) and "target" data (phoneme selection, audio amplitude, and transitioned inflection). The SSI 263A responds immediately upon loading "control" data; upon loading "target" data the device will begin to move towards that target at the prescribed transition rates. This fully internal linear transitioning between target values, done in a manner as is found in normal speech, is a key factor in reducing control data rate without sacrificing speech quality.

Attribute Register Writing

The eight bit data bus D7-D0 loads the particular attribute register selected by the three bit address bus RS2-RS0. To write the data, R/W (Read/Write), CS0 (Chip Select 0), and CS1 pins must first be in the 0,1,0 state, respectively. The data is then written when at least one of these pins changes state. Refer to the Write Timing Diagram. Writing is accomplished by changing preferably CS0 or CS1. Following device power up, nominal values should be loaded into the attribute registers as described below.

Approximate Data Transfer Rate

For speech production using the SSI 263A, the actual data rate depends on the amount of speech attribute manipulation. For example, the production of monotonic speech, where phoneme and duration are the only attribute manipulations, requires a data rate less than 100 bits-per-second. A higher data rate of

about 500 bits-per-second is required for high quality speech due to the associated full attribute manipulation.

Selectable Operation Modes

The state of the Duration/Phoneme Register bits DR1 and DR0 determine the operating mode of the device when the Control bit (CTL) is changed from a logic one to a logic zero. The four modes of operation include choice of timing response between "frame" or "phoneme" timing (as explained below), transitioned or immediate inflection response, and setting the A/R (Acknowledge/Request Not) pin active or disabled. Refer to the Mode Selection Chart.

Phoneme Selection

The SSI 263A can produce the 64 phonemes listed on the Phoneme Chart. Bits P5-P0 are used for phoneme selection. The relative phoneme duration is set by bits DR1 and DR0.

Phoneme Articulation Adjustment

A particular phoneme is produced by the combination of vocal-tract low-pass filter settings, excitation source type, and source amplitude. When a new phoneme is selected, the device performs a linear transition to the new set of characteristics. The rate of this transition is controlled by the articulation setting, bits TR2-TR0. This rate is relative in that articulation is not affected by speech rate bits R3-R0. A typical articulation register setting is "5".

Programming Inflection (Pitch)

When the SSI 263A is in the mode of immediate inflection, bits I11-I0 provide immediate adjustment with seven octaves of pitch on an even tempered scale. With the device in the transitioned inflection mode, bits I10-I6 select the target pitch and bits I5-I3 determine the inflection rate of change. Bits I11, I2, I1, and I0 always provide immediate adjustment. A typical value used for speech production is 90Hz where:

$$\text{Inflection Frequency} = \frac{\text{XCK frequency}}{8 \times (4096 - I)}$$

I = decimal equivalent of Inflection Register setting

Filter Frequency Setting

Data bits FF7-FF0 set the clock frequency for the switched-capacitor vocal tract filters. This determines overall filter frequency response. Inflection pitch is not affected by these bits. Typically this is set to give a clock frequency of about 20KHz (see formula below), but may be manipulated to fine-tune speech quality or to change "voice type"; bass, baritone, etc.

$$\text{Filter Frequency} = \frac{\text{XCK frequency}}{2(256 - FF)}$$

FF = decimal equivalent to the Filter Frequency Register setting.

Speech Rate

Rate of speech is controlled by bits R3-R0, the Speech

Rate Register. In Frame Timing Mode new attribute data is requested at the end of a "frame" where:

$$\text{Frame Duration} = \frac{4096 \times (16-R)}{\text{XCK frequency}}$$

R = decimal equivalent of Rate Register setting

In the Phoneme Timing Mode the frame duration is modified by the phoneme duration bits DR1 and DR0 where:

$$\text{Phoneme Duration} = (\text{Frame Duration}) \times (4-D)$$

D = decimal equivalent of Duration Register setting

All internal attribute transitioning is performed relative to the Speech Rate Register setting. Speech rate does not effect inflection or filter frequency. A typical rate setting is hexadecimal "A".

Amplitude Adjustment

The overall Audio Output level is set with register bits A3-A0. Since each phoneme has a preset amplitude relative to other phonemes, it is not necessary to program the amplitude of each phoneme; however, amplitude changes may be used to enhance the speech quality and add emphasis. Amplitude is transitioned linearly at rate dependent on the phoneme duration setting. A typical amplitude setting is hexadecimal "C".

Control Bit and Power Down Mode

Setting the Control bit (CTL) to a logic one puts the device into Power Down mode, a sort of "standby". This bit is also set high when the PD/RST pin is brought low and also upon power up. The Power Down mode turns off the excitation sources and analog circuits to reduce power consumption, but maintains the present register settings. Upon a Control bit logic one-to-zero transition, the present settings of DR1 and DR0 determine the operation mode as described above.

Register Reading

Device pin D7 becomes an output, as the inverted state of A/R, when the device is put into Read (R/W is a logic 1 and the chip is selected, CS1 = 0, CS0 = 1). Refer to the Read Timing Diagram. The register address bits are ignored.

Time Base

Many different time bases may be utilized (see external clock input specifications). It is desirable to establish a stable crystal controlled time base from 800 to 1000KHz when DIV2 is set low, or twice the frequency when DIV2 is set high. A good time base can be easily accomplished with an inexpensive colorburst 3.5795 MHz crystal in conjunction with a divide-by-two circuit. The actual device timing and output frequencies are directly related to the time base frequency used.

Microprocessor Interfacing

Either the A/R line, or D7 as an output, are used as an interrupt to indicate when the duration of a frame or phoneme has been exceeded. No detectable degradation to speech quality results when several milliseconds occur between data request and load.

PHONEME CHART

| Hex Code* | Phoneme Symbol | Example Word (or Usage) |
|-----------|----------------|--------------------------|
| 00 | PA | (pause) |
| 01 | E | MEET |
| 02 | E1 | BENT |
| 03 | Y | BEFORE |
| 04 | Y1 | YEAR |
| 05 | AY | PLEASE |
| 06 | IE | ANY |
| 07 | I | SIX |
| 08 | A | MADE |
| 09 | AI | CARE |
| 0A | EH | NEST |
| 0B | EH1 | BELT |
| 0C | AE | DAD |
| 0D | AE1 | AFTER |
| 0E | AH | GOT |
| 0F | AH1 | FATHER |
| 10 | AW | OFFICE |
| 11 | O | STORE |
| 12 | OU | BOAT |
| 13 | OO | LOOK |
| 14 | IU | YOU |
| 15 | IU1 | COULD |
| 16 | U | TUNE |
| 17 | U1 | CARTOON |
| 18 | UH | WONDER |
| 19 | UH1 | LOVE |
| 1A | UH2 | WHAT |
| 1B | UH3 | NUT |
| 1C | ER | BIRD |
| 1D | R | ROOF |
| 1E | R1 | RUG |
| 1F | R2 | MUTTER (German) |
| 20 | L | LIFT |
| 21 | L1 | PLAY |
| 22 | LF | FALL (final) |
| 23 | W | WATER |
| 24 | B | BAG |
| 25 | D | PAID |
| 26 | KV | TAG (glottal stop) |
| 27 | P | PEN |
| 28 | T | TART |
| 29 | K | KIT |
| 2A | HV | (hold vocal) |
| 2B | HVC | (hold vocal closure) |
| 2C | HF | HEART |
| 2D | HFC | (hold fricative closure) |
| 2E | HN | (hold nasal) |
| 2F | Z | ZERO |
| 30 | S | SAME |
| 31 | J | MEASURE |
| 32 | SCH | SHIP |
| 33 | V | VERY |
| 34 | F | FOUR |
| 35 | THV | THERE |
| 36 | TH | WITH |
| 37 | M | MORE |
| 38 | N | NINE |
| 39 | NG | RANG |
| 3A | :A | MARCHEN (German) |
| 3B | :OH | LOWE (French) |
| 3C | :U | FUNF (German) |
| 3D | :UH | MENU (French) |
| 3E | EZ | BITTE (German) |
| 3F | LB | LUBE |

*Note — Hex codes shown with DR0, DR1 = 0 (longest Duration)

SSI 263A

PIN ASSIGNMENT DESCRIPTIONS

| Pin No. | Symbol | Active Level | Description |
|---------|--------|--------------|---|
| 1 | AO | | Analog Audio Output biased @ VDD/2 requires an external audio amp for speaker drive |
| 2 | AGND | | Analog Ground |
| 3 | TP1 | | Do not use |
| 4 | A/R | | Acknowledge/Request Not — open collector output a low requests new data (see also pin 17) |
| 5 | TP2 | | Do not use |
| 6 | RS2 | | Register Select Input — used to select one of five internal registers in conjunction with RS1 and RS0 |
| 7 | RS1 | | Register Select (See pin 6) |
| 8 | RS0 | | Register Select (See pin 6) |
| 9 | D0 | | LSB of 8-bit data bus — input only |
| 10 | D1 | | Data Input (only) |
| 11 | D2 | | Data Input (only) |
| 12 | DGND | | Digital Ground |
| 13 | D3 | | Data Input (only) |

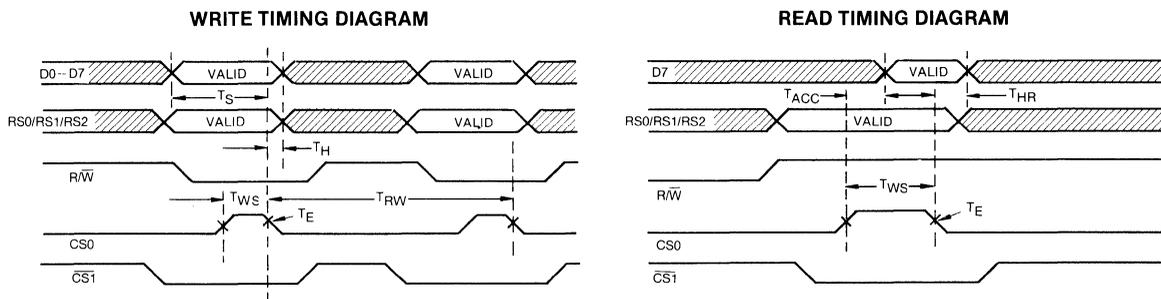
| Pin No. | Symbol | Active Level | Description |
|---------|--------|--------------|---|
| 14 | D4 | | Data Input (only) |
| 15 | D5 | | Data Input (only) |
| 16 | D6 | | Data Input (only) |
| 17 | D7 | | MSB of 8-bit data bus. Bi-directional, inverse of pin 4 when read is high |
| 18 | PD/RST | Low | Power Down Control Input — Silences audio output and retains DC bias without disturbing register contents. Disables A/R output. |
| 19 | CS0 | High | Chip Select Input |
| 20 | CS1 | Low | Chip Select Input |
| 21 | R/W | | Read/Write Control Input — Write is active low for loading internal registers. Read is active high but enables D7 only. |
| 22 | XCK | | Clock Input (≈ 1 or 2 MHz) |
| 23 | DIV2 | High | Clock Divide by Two — used when external clock is ≈ 2 MHz |
| 24 | VDD | | Positive Voltage Supply |

REGISTER INPUT FORMATS

| Register Address | | | Register Name | Bus Input Bit Position | | | | | | | |
|------------------|-----|-----|--|------------------------|-----|----|----|-----|----|----|----|
| RS2 | RS1 | RS0 | | D7 | D6 | D5 | D4 | D3 | D2 | D1 | D0 |
| LO | LO | LO | Duration/Phoneme (DR/P) | DR1 | DR0 | P5 | P4 | P3 | P2 | P1 | P0 |
| LO | LO | HI | Inflection (I) | I10 | I9 | I8 | I7 | I6 | I5 | I4 | I3 |
| LO | HI | LO | Rate/Inflection (R/I) | R3 | R2 | R1 | R0 | I11 | I2 | I1 | I0 |
| LO | HI | HI | Control/Articulation/Amplitude (C/A/A) | CTL | T2 | T1 | T0 | A3 | A2 | A1 | A0 |
| HI | X | X | Filter Frequency (F) | F7 | F6 | F5 | F4 | F3 | F2 | F1 | F0 |

DR1, DR0 . . . Define the phoneme duration.
 P5 → P0 . . . Address the phoneme required.
 I11 → I0 . . . Define inflection target frequencies and rate of change.
 R3 → R0 . . . Define the rate or speed of speech.
 CTL Define the mode of A/R response in conjunction with DR1 and DR0.
 Also directly set by PD/RST.

T2 → T0 . . . Define the rate of movement of the formant position for articulation purposes.
 A3 → A0 . . . Define the amplitude of the output audio.
 F7 → F0 . . . Define the frequency of all vocal tract filters.



* Valid data latched on first rise or fall of R/W. CS0 or $\overline{CS1}$ into inactive.

Timing Characteristics ($V_{DD} = 4.5$ to 5.5 Volts, $T_A = -40$ to $+85$ deg. C)

| Item | Symbol | Limits | | Units. |
|-----------------------|--------|--------|------|-----------|
| | | Min. | Max. | |
| Data Setup Time | TS | 120** | | nsec |
| Data Hold Time | TH | 10** | | nsec |
| Strobe Width | TWS | 200 | | nsec |
| Read/Write Cycle Time | TRW | 2.25* | | μ sec |
| Rise/Fall Time | TE | | 100 | nsec |
| D7 Output Access Time | TACC | | 180 | nsec |
| D7 Output Hold Time | THR | | 180 | nsec |

Notes: * Based on color burst frequency.

** Timing relative to deselect by either CS0, CS1, or R/W changing.

MODE SELECTION CHART

| DR1 | DR0 | 'CTL' BIT | Function |
|-----|-----|---------------------|--|
| HI | HI | HI \rightarrow LO | A/ \overline{R} active; phoneme timing response; transitioned inflection (most commonly used mode) |
| HI | LO | HI \rightarrow LO | A/ \overline{R} active; phoneme timing response; immediate inflection |
| LO | HI | HI \rightarrow LO | A/ \overline{R} active; frame timing response; immediate inflection |
| LO | LO | HI \rightarrow LO | Disables A/ \overline{R} output only; does not change previous A/ \overline{R} response |

ABSOLUTE MAXIMUM RATINGS

| Item | Symbol | Limit | Units |
|------------------------|-----------------|------------------------|--------------|
| Supply Voltage | $V_{DD}-V_{SS}$ | 7.0 | V |
| Input Voltage | V_{IN} | -0.5 to $V_{DD} + 0.5$ | V |
| D.C. Current at Inputs | I_{INM} | ± 1.0 | mA |
| Storage Temperature | T_S | -55 to +125 | $^{\circ}$ C |
| Operating Temperature | T_A | -40 to +85 | $^{\circ}$ C |
| Power Dissipation | P_d | 500 | mW |

SSI 263A

Electrical Characteristics

Unless otherwise specified, $4.5 \leq V_{DD} \leq 5.5$; $-40 \text{ deg. C} \leq T_A \leq 85 \text{ deg. C}$;
 $1.50\text{MHz} \leq \text{XCK frequency} \leq 2.0\text{MHz}$, when $\text{XCK}/2 = \text{logic 1}$ or
 $0.75\text{MHz} \leq \text{XCK frequency} \leq 1.0\text{MHz}$, when $\text{XCK}/2 = \text{logic 0}$

| Description | Conditions | Min. | Typ. | Max. | Units |
|-------------|------------|------|------|------|-------|
|-------------|------------|------|------|------|-------|

POWER SUPPLY

| | | | | | |
|----------------|--|--|---|----|----|
| Supply Current | $\overline{\text{PD}}/\overline{\text{RST}} = 1, \text{CTL} = 0$ | | 8 | 20 | mA |
| Supply Current | $\overline{\text{PD}}/\overline{\text{RST}} = 0, \text{CTL} = 1$ | | 7 | 18 | mA |

AUDIO OUTPUT

| | | | | | |
|--------------------|--|---------|---------|---------|------|
| Output Level | AW phoneme RL = 50Kohm to GND through $1\mu\text{F}$ cap. | 0.28VDD | 0.37VDD | 0.50VDD | Vpp |
| DC Output Offset | | 0.5VDD | 0.6VDD | 0.7VDD | V |
| Resistive Loading | AC coupled to AO to GND | 10 | | | Kohm |
| Capacitive Loading | To GND to ensure Stable A | | | 100 | pF |

| Description | Conditions | Symbol | Min | Typ | Max | Units |
|-------------|------------|--------|-----|-----|-----|-------|
|-------------|------------|--------|-----|-----|-----|-------|

BUS CONTROL INPUTS, DATA INPUTS (RS0, RS1, RS2, CS0, CS1, D0-D7 $\overline{\text{PD}}/\overline{\text{RST}}$)

| | | | | | | |
|--|--|--------------|----------------|-----|----------------|---------------|
| Input High Voltage | | V_{IH} | $V_{SS} + 2.4$ | | $V_{DD} + 0.3$ | VDC |
| Input Low Voltage | | V_{IL} | -0.3 | | +0.8 | VDC |
| Input Leakage Current | $V_{IN} = 0 \text{ to } V_{DD}$ | I_{IN} | | | 5 | μA |
| Input Capacitance | $V_{IN} = 0$ $T_A = 25^\circ\text{C}$ measured at $f = 1.0\text{MHz}$ | C_{IN} | | | 10 | pF |
| Input Capacitance, D7 Input | | $C_{IN}(D7)$ | | | 20 | pF |
| Input Current, D7 in TRI-State "OFF" State | $V_{IN} = 0.4 \text{ to } 2.4 \text{ V}$ | $I_{IN}(TS)$ | | 2.0 | 5.0 | μA |

D7 OUTPUT

| | | | | | | |
|------------------------|--|--------------|--|--------------|-----|-----|
| D7 Output Low Voltage | $I_{Load} = 0.4 \text{ mA into D7}$ | $V_{OL}(D7)$ | | | 0.4 | VDC |
| D7 Output High Voltage | $I_{Load} = 205 \mu\text{A out of D7}$ | $V_{OH}(D7)$ | | $V_{DD}-2.0$ | | VDC |

A/ $\overline{\text{R}}$ OUTPUT

| | | | | | | |
|-----------------------------|---|----------------------------------|--|----|-----|---------------|
| Output Low Voltage | $I_L = 3.2 \text{ mA into A}/\overline{\text{R}}$ | $I_{OL}(A/\overline{\text{R}})$ | | | 0.4 | VDC |
| Output High Leakage Current | $V_{Out} = 0.0 \text{ to } V_{DD}$ | $I_L(A/\overline{\text{R}})$ | | | 10 | μA |
| Output Capacitance | $V_{Out} = 0 \text{ VDC}$ $T_{AMB} = 25^\circ\text{C}$ $f = 1.0 \text{ MHz}$ | $C_{Out}(A/\overline{\text{R}})$ | | 15 | | pF |

DIV2 INPUT

| | | | | | | |
|--------------------|---------------------------------|-----------------------|-------|--|----------------|---------------|
| Input Low Voltage | | $V_{IL}(\text{DIV2})$ | -0.3 | | .2 V_{DD} | V |
| Input High Voltage | | $V_{IH}(\text{DIV2})$ | .8VDD | | $V_{DD} + 0.3$ | V |
| Input Leakage | $V_{IN} = 0 \text{ to } V_{DD}$ | | | | 5 | μA |

User's Guide for Phonetic Programming Using the SSI 263A

Phonetics

Every speech sound (phoneme) in any language may be represented by a special symbol (phonetic symbol). These symbols are used in WRITING precisely the sound sequence (phonetic transcription) of a word according to the way it is pronounced. There are many different phonetic symbol sets (phonetic alphabets). Each would contain a minimum number of symbols to represent the basic sounds (phonemes) required to pronounce any word in the language. Additional symbols are usually included which represent sounds with slight to great variations in the basic sounds (allophones). These symbols are used to assist in the transcription of words that reflect a regional, dialectic, or foreign pronunciation.

The process of transcribing a spoken word into its phonetic components begins with identifying the number of sounds in the word, then tagging each with a label to specify its type. Consonants and vowels are the most familiar labels but these may be broken down into subtypes (e.g., stop consonants, back vowels, etc.) as the need for more specificity arises. Once the sounds have been identified, their symbols are selected, then written in sequence. The resulting transcription should allow another person to identify the pronunciation without having heard the word spoken.

Note that when using a phonetic alphabet to transcribe words into their sound sequences, there is not a one-to-one correspondence between the alphabet characters (orthographics) used to spell words and the phonetic symbols (phonetics) used to represent their pronunciations. For example, in the word "phones" there are 6 letters but only 4 sounds. Conversely, the word "I" has 1 letter but 2 sounds. It may be of some assistance to keep a dictionary handy for reference. Dictionaries use their own phonetic system to describe the pronunciations of every word entry. It will be necessary to learn at least one phonetic alphabet in order to engage in phonetic transcription. The SSI 263A Phonetic Alphabet is the referent used in this manual. However, if another system is already known, it is easily translated into the referent.

When transcribing vocabulary from orthography (standard alphabet spelling) to phonetics, it is common to place the phonetic sequence between right slash marks when the transcription appears in running text. The word "phones," for example, would be transcribed as /F O N Z/ when using SSI 263A phonetic symbols. This allows the reader easier identification of phonetic segments.

SSI 263A Phonetic Alphabet

The phonetic alphabet used to represent the SSI 263A phonemes is the SSI 263A PHONETIC ALPHABET. Refer to the Phoneme Chart for a complete listing of the phoneme symbols.

Of the 64 alphanumeric symbols in the SSI 263A Phonetic Alphabet, 34 represent sound BASIC to the pronunciation of American English. The remaining 30 symbols fall into 2 groups: the ALLOPHONE group and the NO-SOUND group. The BASIC sound symbols are:

A, AE, AH, AW, B, D, E, EH, ER, F, HF, I, J, K, KV, L, M, N, NG, O, OO, P, R, S, SCH, T, TH, THV, U, UH, V, W, Y, Z.

Symbols in the ALLOPHONE group represent speech sounds that vary in pronunciation from one of the basic sounds. They may be used in transcribing words or word segments (syllables or morphemes) whose pronunciations are not satisfied by the basic phonemes alone (words rooted in a foreign language, words adapted by a regional dialect, etc.). The ALLOPHONE symbols are:

A1, AE1, AH1, AY, E1, E2, EH1, HN, HV, IE, IU, IU1, L1, LB, LF, OU, R1, R2, U1, UH1, UH2, UH3, Y1, :A, :OH, :U, :UH.

The NO-SOUND symbols represent silent states. One of these symbols represents a "pause" state. It is used to separate phoneme sequences into phrase-like segments which assist in more closely imitating the natural pausing in human speech for breathing or for delayed emphasis. The "pause" is treated as a phoneme when it is selected for a transcription and will be subject to phoneme parameter programming. It has the ability to maintain the parametric levels of duration, inflection, amplitude, etc., during its silence, thus audibly affecting the movement of the preceding and following phonemes. Other NO-SOUND symbols represent "hold" states. They are used in combination with BASIC phonemes or ALLOPHONEs to generate articulation variations on their pronunciations. The NO-SOUND symbols are:

HFC, HVC, PA.

Now that there is a tool to use for writing the sounds that are heard, the next stage is to identify the sounds that are produced by the SSI 263A speech synthesizer.

SSI 263A Phoneme Review

Thus far in this program, it has been established that: (1) spoken words are made up of a series of sounds; (2) each speech sound in a language may be represented by an identifying symbol; and (3) the spoken word may be written according to its sound sequence using these special symbols. Before a word may be written phonetically, however, users may wish to study further the SSI 263A speech sounds. What makes one sound different from another and how these differences may be helpful to phonetic programming will be essential information for phonetic programmers.

The sound that is represented by each phonetic symbol in the SSI 263A Phonetic Alphabet must be audibly learned. The easiest way to approach this task is to start with the sounds already known and associate a symbol with them. For example, from spelling we have already learned that vowels may be "long" or "short" and are often differentiated by their particular spelling formats. Every time a word with a "short a" sound is heard (sat, fat, cat, bat, happy, plaster, ankle, Saturday, amplify, contaminate, etc.) the symbol /AE/ should come to mind. A "long a" sound (fate, state, bait, lace, maybe, stable, arrangement, etc.) is actually a diphthong (two sounds combined into a single unit) and may be represented by the symbols /A AY/.

In standard orthography, there are only 5 vowel letters to represent 17 vowel sounds. In phonetics, each vowel sound will be represented by its own symbol or symbol combination.

Again, from spelling, we have learned that the letter "c" may have a hard sound as in "cat" or a soft sound as in "city." The hard sound is actually a /K/ as in "kite" and the soft sound is an /S/ as in "sing." Users must identify which sound (/K/ or /S/) is used in the transcription of a "c." You will not find a symbol C in a phonetic alphabet. Like "C," the letters "Q" and "X" will not be found in phonetic alphabets. They are transcribed into the sound sequences /K W/ and /K PA S/. Refer to the Phoneme Chart during this learning period. It provides example words to describe the pronunciations corresponding to each symbol.

Users may add more words to the examples above to continue identifying the symbol-sound relationship for /AE/ and /A AY/. Follow this technique for each symbol in the alphabet. For auditory verification, enter the sound that is being reviewed into the device. Speak aloud your example word for the SSI 263A

sound in an attempt to match that which the synthesizer is emitting.

Example: /E/ = "long e" vowel sound
 = meat, read, need, repair, before, phoneme, erase, brief, people, timeliness, seniority, receive, catastrophe.

Example: /F/ = "voiceless fricative" consonant
 = farm, false, aft, feet, finger, phrase, phone, Africa, alphabet, cough.

Once you have reviewed auditorily the sounds you already have a familiarity with from spelling, proceed to the BASIC sound list in the above text and continue the review. Be aware that several consonant sounds will not provide output unless they have another sound following. This is the case with /B/, /D/, /P/, /T/, and /K/. When one of these sounds is entered into the SSI 263A, follow it by a vowel and listen to both in sequence.

Users who already have a familiarity with phonetics and SSI 263A synthetic sounds, may wish to follow the sound review procedures in order to auditorily determine the difference between two sounds or identify new ones. For example, enter the /UH/ phoneme into the device. Then enter /UH1/, /UH2/, and /UH3/. Listen to each sound noting the pronunciation variations. Be aware that there are no duplicate sounds resident on the SSI 263A chip.

Whenever a SSI 263A sound is audited that cannot be readily identified as to its appropriate usage, do not be concerned. The review is designed only to provide a method for establishing an auditory memory for each sound and a visual memory for its symbol. Phonetic programming may begin anytime after the initial review. Return to the review later as your familiarity with the BASIC sounds increases and as your need for sound alternatives to those BASIC sounds becomes more apparent.

If there is a question as to which symbols should be chosen to transcribe a word into its sound sequence, make a written note of the word by circling the letter(s) that present the problem. Later, when phonetic programming has begun, a phoneme sequence may be created for the word and users may verify auditorily which phonetic selection produces the most appropriate translation.

SSI 263A Phoneme Discussion

The SSI 263A Phonetic Alphabet is divided into 3 groups for the purpose of differentiating between phonemes and allophones. Another way of dividing the Alphabet is according to usage. The most familiar division is a two sections split: CONSONANT sounds and VOWEL sounds. Within each of these sections, sounds may be further subdivided according to the distinctive features that best describe the sounds phonetically or acoustically. The more that is known about a sound, the easier it is to determine how it may be used in transcribing and phonetically programming a word.

Consonant Sounds

There are 22 Consonant Phonemes, subdivided according to their manner of production in the human speech mechanism. Some are characterized by the noise emitted when the articulators obstruct the air flow (Fricatives like /S/). Vowel-like consonants have the least amount of obstruction and may occasionally be used as a vowel substitute. Stop consonants are obstructed completely, release of air flow occurring at the onset of the next sound. Notice that Affricates are a sequence of 2 sounds (a Stop followed by a Fricative) spoken as a single unit. Unlike vowels, which always have a vocal source during production, consonants may be voiced (V) or unvoiced (U) (no vocal source during air flow). When listening to the manner in which a consonant is produced during speech, note its special characteristics that distinguish it from all other consonants. The figure below displays all of the consonant sounds within their production groups.

| | Stops | Fricatives | Affricates |
|------------------|----------|-------------------|------------|
| Voiced | B, D, KV | Z, V, J, THV | (D, J) |
| Voiceless | P, T, K | S, F, SCH, TH, HF | (T, SCH) |

| | Semi-vowels | Glides | Nasals |
|------------------|-------------|--------|----------|
| Voiced | R, L | W, Y | M, N, NG |
| Voiceless | | | |

Consonant Chart

Voiced and voiceless consonants are subdivided into 6 categories according to the manner in which they are produced in the human vocal tract: i.e., how the air flow is obstructed by the articulators to make each sound different.

Consonant sounds are selected for a sequence in much the same manner as an alphabet character would be selected for the spelling of a word. Users must be alert, however, to identify the exceptions. Occasionally, a consonant appears in the spelling of a word but not in its sound sequence: the "b" in "comb" is not pronounced and the sound sequence reflects the absence of the "b": /K OU M/. Some exceptions have grammatical rules that may be used in determining the appropriate sound. For example, a consonant may have 2 pronunciations according to its sound environment. The "s" used to pluralize the two words that follow are pronounced differently based on whether the sound that precedes it is voiced or unvoiced. An "s" pronunciation will match the voicing characteristics of the sound it follows.

Examples: tips = /T I P S/
 tabs = /T AE B Z/

There are other types of consonantal exceptions. For example, the "t" in a word like "nation" is pronounced /SH/ and the program might look like this: nation = /N A AY SH UH3 N/. Users must listen to each word's pronunciation to determine the appropriate phoneme selection.

There are 7 Consonant Allophones, each noted in the table below. The /L/ consonant is used in the initial position of a sequence for words beginning with "L", while the /LF/ allophone will occupy a medial or final position in a sequence: e.g., lull = /L UH LF/. The /LB/ and the /LI/ allophones would be used when a most constricted pronunciation of an "L" was required, as would occur for some words of foreign languages.

| Consonant Phoneme | Consonant Allophones | Consonant Phoneme | Vowel Allophone |
|-------------------|----------------------|-------------------|-----------------|
| L | L1, LB, LF | R | ER |
| R | R1, R2 | Y | YI |

Allophone Listing for /L/, /R/, & /Y/

The /R/ is an initial position phoneme. Both /R1/ and /R2/ have more constricted pronunciations than /R/ and may be used in sequence with soundless interrupts to create a trilled /R/. Often when the /R/ is required in a medial or final position, it is vowelized and the /ER/ is used. Listening to the production of all four of these sounds will auditorily show that they may, occasionally, be used interchangeably.

Examples: red = /R EH D/
 bird = /B ER D/
 motor = /M OU T ER/

The /Y/ consonant, used as the final sound in words ending with "y," has a vowel allophone that may be used as the initial sound of words starting with "y." Note that both /Y/ and /YI/ are auditorily very close to the /E/ and the /IE/ vowels and may be considered interchangeable.

Vowel Sounds

There are 12 BASIC Vowel Phonemes. Vowels are subdivided according to the manner in which they are produced. All vowels are voiced sounds but each has a different output based on the degree of obstruction created by the opening of the mouth and the tongue position. Lip positions, another obstructing articulator, may range from spread flat to round. While the lips are in any of these positions, the jaw may be simultaneously dropped from a closed to an open position.

| | Front Vowels | Medial Vowels | Back Vowels |
|-----------------------------|----------------------------------|---------------|-------------|
| | Spread \longrightarrow Rounded | | |
| Closed ↓ Open | E | | U |
| | I | | OO |
| | A | UH | O |
| | EH | (ER) | AW |
| | AE | | AH |

Vowel Quadrilateral

Vowels begin their production with the same voiced energy. Changes in the position of the tongue (front or back), the shape of the lips (from spread flat to rounded), and the position of the lower jaw (from closed to open) determine the final characteristics that allow listeners to distinguish between vowel sounds.

Refer to the SSI 263A Phoneme Chart for the pronunciation reference on each BASIC vowel sound. Utilize the sound review techniques on the previous pages to practice identifying the vowel sounds in words and associating them with their phonetic symbols.

The allophonic variations of vowels, 20 in number, are used in a phonetic program to enhance the pronunciation of a word. There are some cases where the allophone is required for articulate pronunciations. This is true for /AY/, /YI/ and /IU/, which are integral components in the phonetic sequences for the "long a" and the varied "long u."

Examples: same = /S A AY M/
you = /YI IU U/

The table below places each allophone into the vowel quadrilateral to demonstrate approximately how they might relate to the BASIC vowels. Users are in no way restricted to traditional phonetic transcriptions that use only the BASIC vowel phonemes. Be encouraged to experiment with allophones. Place them in different positions in a sequence to auditorily check how they effect the overall pronunciation of a word.

| | Front Vowels | Medial Vowels | Back Vowels |
|-----------------------------|----------------------------------|---------------|-------------|
| | Spread \longrightarrow Rounded | | |
| Closed ↓ Open | YI E1 IE | | U1 |
| | AY | E2 | IU IU1 |
| | A1 | UH1 | OU |
| | EH1 | UH2 | |
| | AE1 | UH3 | AH1 |

Allophone Placement in Vowel Quadrilateral

Vowel allophones are placed in the vowel quadrilateral according to their production features. The sounds they emit vary slightly from the BASIC vowels that occupy the same positions.

Four vowel allophones—/A/, /OH/, /:U/, and /:UH/ — are adapted pronunciations of four of the BASIC vowels. These sounds are most commonly used for phonetically programming a foreign word. They may also be used as transitory sounds to link phonemes with opposite production features such as a round, open vowel with a very constricted, narrow consonant.

There are five vowels that require two or more vowel sounds in sequence in order to achieve their pronunciations. These are generally referred to as diphthongs. Refer to the Diphthong Conversion Chart.

The vowel quadrilateral is a handy tool to use for selecting vowel phonemes for diphthongs and other multi-phoneme units. For example, the diphthong in the word "I" starts with an /AH/ and ends with an /E/. In order to move smoothly from the first sound to the second (transition), another vowel may be inserted between these two sounds in sequence. The most likely choice would be a vowel that falls somewhere between /AH/ and /E/ in the quadrilateral: e.g., /UH/, /EH/, /I/, etc. The sequence may look like

this: /AH EH E/ or /AH1 UH3 IE/ or /AH1 EH3 AY/. In their fullest durations, a three-sound sequence would over articulate the diphthong. Shortening the first and last sounds by 1 duration and the medial sound by 2 durations will produce a more acceptable pronunciation (see SSI 263A Phoneme Parameters).

SSI 263A Phoneme Parameters (Attributes)

To achieve an accurate pronunciation of a word produced by the SSI 263A synthesizer requires more than a selection of the appropriate phonemes. Like human speech sounds, synthesized sounds are further defined by the rate at which they are emitted (duration), the level of pitch at which they are emitted (inflection or frequency), and the intensity with which they are produced (amplitude). These are considered the three major speech parameters which give the overall production of a word its linguistic character, transforming simple speech into more complex language. Inflection, amplitude, and duration are only three of the parameters that users have control of during the programming process. The rate at which one sound moves into another (articulation) is also a controllable parameter. Other parameters are: the slope of the inflection (slope), the rate of each selected duration (rate), and the extended inflection frequencies (extension). Users may also select the base frequency at which speech may be produced (filter frequency). Refer to SSI 263A Phoneme Parameters, for the range of each and typical default values selected.

Every phoneme selected for a sequence must be accompanied by assignments for each of the eight parameters. As users become more aware of their need to create different language effects with their synthesized speech output, they will require the flexibility and choice that comes with programmable parameters. For example, with 4 selectable durations per phoneme, each actual pronunciation of each sound may be changed. Thus, every sound has four possible outputs increasing the users' choice from 64 phonemes and allophones to 256. Each of the 256 may be effected differently by each of the 32 possible inflection assignments. Add to these possibilities 16 variations in amplitude and 16 variations in rate. The possible combinations are not limitless, of course, but they are very great and users are encouraged to experiment with as many as possible.

Several of the parameters effect synthetic speech output as a whole. These are articulation, pitch extension, and filter frequency. Users may select a single level at which to set the filter frequency, for example, and maintain that level throughout the programming process.

Phonetic Programming Methodology

Due to the great variety of phonemes and parameter choices, as well as the different effects the parameter selections have on the speech sounds, a systematic approach to selecting the variables is advised. The approach described below is only one of several that might be used. It may be adjusted to accommodate the user's special programming style or to accommodate later implementation of automatic control techniques.

The first step is to transcribe the target word, phrase, etc., into its basic phonetic components. Next, enter these sounds into the SSI 263A and auditorily check the output. Use the default values suggested in the Nominal Phoneme Parameter Table. The results should be a bit stilted if not misarticulated for the first trial program. Phoneme adjustment is next. Continue to make changes in the phoneme sequence, auditorily monitoring the changes, until an adequate pronunciation of the target is established.

Begin parameter adjustments. First, maintain articulation, pitch extension and filter frequency at nominal values. The device should be kept in the transitioned inflection mode. Make adjustments in the levels of only one of the remaining 4 parameters at a time, beginning with the duration and moving on to the inflection, rate, and amplitude (in that order) once the specific effect that the parameter can make has been made. Return to a previously adjusted parameter at any time based on need.

PHONEME CHART

| Hex Code* | Phoneme Symbol | Example Word (or Usage) |
|-----------|----------------|--------------------------|
| 00 | PA | (pause) |
| 01 | E | MEET |
| 02 | E1 | BENT |
| 03 | Y | BEFORE |
| 04 | YI | YEAR |
| 05 | AY | PLEASE |
| 06 | IE | ANY |
| 07 | I | SIX |
| 08 | A | MADE |
| 09 | AI | CARE |
| 0A | EH | NEST |
| 0B | EH1 | BELT |
| 0C | AE | DAD |
| 0D | AE1 | AFTER |
| 0E | AH | GOT |
| 0F | AH1 | FATHER |
| 10 | AW | OFFICE |
| 11 | O | STORE |
| 12 | OU | BOAT |
| 13 | OO | LOOK |
| 14 | IU | YOU |
| 15 | IU1 | COULD |
| 16 | U | TUNE |
| 17 | U1 | CARTOON |
| 18 | UH | WONDER |
| 19 | UH1 | LOVE |
| 1A | UH2 | WHAT |
| 1B | UH3 | NUT |
| 1C | ER | BIRD |
| 1D | R | ROOF |
| 1E | R1 | RUG |
| 1F | R2 | MUTTER (German) |
| 20 | L | LIFT |
| 21 | L1 | PLAY |
| 22 | LF | FALL (final) |
| 23 | W | WATER |
| 24 | B | BAG |
| 25 | D | PAID |
| 26 | KV | TAG (glottal stop) |
| 27 | P | PEN |
| 28 | T | TART |
| 29 | K | KIT |
| 2A | HV | (hold vocal) |
| 2B | HVC | (hold vocal closure) |
| 2C | HF | HEART |
| 2D | HFC | (hold fricative closure) |
| 2E | HN | (hold nasal) |
| 2F | Z | ZERO |
| 30 | S | SAME |
| 31 | J | MEASURE |
| 32 | SCH | SHIP |
| 33 | V | VERY |
| 34 | F | FOUR |
| 35 | THV | THERE |
| 36 | TH | WITH |
| 37 | M | MORE |
| 38 | N | NINE |
| 39 | NG | RANG |
| 3A | :A | MARCHEN (German) |
| 3B | :OH | LOWE (French) |
| 3C | :U | FUNF (German) |
| 3D | :UH | MENU (French) |
| 3E | E2 | BITTE (German) |
| 3F | LB | LUBE |

*Note — Hex codes shown with DR0, DR1 = 0 (longest Duration)

SSI 263A Diphthong Conversion Chart

| Phoneme Sequence | Example Words |
|----------------------|---------------------|
| A AY Y | rain, became, stay |
| A IE EH1 UH3 LF | mail, hale, avail |
| AH1 AE1 EH1 Y | time, rhyme, sky |
| AH1 EH1 IE AW UH3 LF | smile, style, while |
| AH1 EH1 IE UH3 ER | fire, liar, inspire |
| UH3 AH1 Y | mice, right, sniper |
| O U | road, stone, lower |
| OU O O | tore, four, floor |
| AH1 AW O U | loud, flower, hour |
| UH3 AH1 O U | house, about, ouch |
| O UH1 AH1 I IE | boy, noise, annoy |
| O UH3 EH1 I OO LF | boil, spoil, doily |
| IU U U | tune, spoon, do |
| YI IU U U | you, few, music |

SSI 263A Multi-Unit Conversion Chart

| Phoneme Sequence | Example Words |
|------------------|--------------------|
| T HFC SCH | church, latch |
| KV HVC HF | good, lag, angry |
| D J | just, ledge, wage |
| KV HF HFC | lake, corn, check |
| P HF | pipe, pay, poor |
| K HF W | quest, quick, aqua |
| T HF | top, trip, strain |
| HFC K HF HVC S | six, exit, taxi |

Nominal Phoneme Parameter Table (Suggested Default Values for Speech Development)

Amplitude (A3 → A0)

Range—0 to F (softest to loudest, 0 = silent)

Default—C

Exceptions—KV = 0, B = D = 6

Duration (DR1, DR0)

Range—3 to 0 (shortest to longest)

Default—0

Filter Frequency Range (F7 → F0)

Range—00 to FF (lowest to highest)

Default—E9

Inflection (Pitch) (I10 → I6, Transitioned Inflection Mode Only)

Range—0 to 1F (lowest to highest, 0 = silent)

Default—04

Extension and Range of Pitch (I11, I2 → I0)

Range—0 to 7 (low); 8 to F (high)

Default Value—8

Rate of Speech (R3 → R0)

Range—0 to F (slowest to fastest)

Default—A

Slope of Inflection (I6 → I3, Transitioned Inflection Mode Only)

Range—0 to 7

Default—0

Articulation (Rate of) (A3 → A0)

Range—0 to 7 (slow to fast)

Default—5

Example of Using Phonetic Programming Methodology:

Developing "Hello"

| Phoneme Parameters | | | | | | SSI 263 Register Data | | | | | |
|--------------------|----|------|------|---|------|-----------------------|----|----|----|----|-------|
| Pho.D | T | In-S | A | R | E FF | DP | IS | RE | TA | FF | |
| PA | .0 | 5 | 0A-0 | C | A | 8 | E9 | 00 | 50 | A8 | 5C E9 |
| U | .2 | 5 | 0A-0 | C | A | 8 | E9 | 96 | 50 | A8 | 5C E9 |
| PA | .0 | 5 | 0A-0 | C | A | 8 | E9 | 00 | 50 | A8 | 5C E9 |
| PA | .0 | 5 | 0A-0 | C | A | 8 | E9 | 00 | 50 | A8 | 5C E9 |

KEY: Pho = Phoneme
D = Duration
T = Articulation
In = Inflection
S = Slope of Inflection
A = Amplitude
R = Rate
E = Extension and Range of Pitch
FF = Filter Frequency

DP = Duration/Phoneme Register Address 000
IS = Inflection/Slope Register 001
RE = Rate/Extension Register 010
TA = Articulation/Amplitude Register 011
FF = Filter Frequency Register 1XX

1. Original Phoneme Entry:

| Pho.D | T | In-S | A | R | E FF | DP | IS | RE | TA | FF |
|-------|----|------|------|---|------|----|----|----|----|----------|
| PA | .0 | 5 | 0A-0 | C | A | 8 | E9 | 00 | 50 | A8 5C E9 |
| PA | .0 | 5 | 0A-0 | C | A | 8 | E9 | 00 | 50 | A8 5C E9 |
| HF | .0 | 5 | 0A-0 | C | A | 8 | E9 | 2C | 50 | A8 5C E9 |
| EH | .0 | 5 | 0A-0 | C | A | 8 | E9 | 0A | 50 | A8 5C E9 |
| L | .0 | 5 | 0A-0 | C | A | 8 | E9 | 20 | 50 | A8 5C E9 |
| O | .0 | 5 | 0A-0 | C | A | 8 | E9 | 11 | 50 | A8 5C E9 |
| PA | .0 | 5 | 0A-0 | C | A | 8 | E9 | 00 | 50 | A8 5C E9 |
| PA | .0 | 5 | 0A-0 | C | A | 8 | E9 | 00 | 50 | A8 5C E9 |

2. Phoneme Selection Refinement

| Pho.D | T | In-S | A | R | E FF | DP | IS | RE | TA | FF |
|-------|----|------|------|---|------|----|----|----|----|----------|
| PA | .0 | 5 | 0A-0 | C | A | 8 | E9 | 00 | 50 | A8 5C E9 |
| PA | .0 | 5 | 0A-0 | C | A | 8 | E9 | 00 | 50 | A8 5C E9 |
| HF | .0 | 5 | 0A-0 | C | A | 8 | E9 | 2C | 50 | A8 5C E9 |
| EH | .0 | 5 | 0A-0 | C | A | 8 | E9 | 0A | 50 | A8 5C E9 |
| UH3 | .0 | 5 | 0A-0 | C | A | 8 | E9 | 1B | 50 | A8 5C E9 |
| LF | .0 | 5 | 0A-0 | C | A | 8 | E9 | 22 | 50 | A8 5C E9 |
| UH3 | .0 | 5 | 0A-0 | C | A | 8 | E9 | 1B | 50 | A8 5C E9 |
| O | .0 | 5 | 0A-0 | C | A | 8 | E9 | 11 | 50 | A8 5C E9 |
| OU | .0 | 5 | 0A-0 | C | A | 8 | E9 | 12 | 50 | A8 5C E9 |
| U | .0 | 5 | 0A-0 | C | A | 8 | E9 | 16 | 50 | A8 5C E9 |
| PA | .0 | 5 | 0A-0 | C | A | 8 | E9 | 00 | 50 | A8 5C E9 |
| PA | .0 | 5 | 0A-0 | C | A | 8 | E9 | 00 | 50 | A8 5C E9 |

3. Duration Adjustment

| Pho.D | T | In-S | A | R | E FF | DP | IS | RE | TA | FF |
|-------|----|------|------|---|------|----|----|----|----|----------|
| PA | .0 | 5 | 0A-0 | C | A | 8 | E9 | 00 | 50 | A8 5C E9 |
| PA | .0 | 5 | 0A-0 | C | A | 8 | E9 | 00 | 50 | A8 5C E9 |
| HF | .1 | 5 | 0A-0 | C | A | 8 | E9 | 6C | 50 | A8 5C E9 |
| EH | .0 | 5 | 0A-0 | C | A | 8 | E9 | 0A | 50 | A8 5C E9 |
| UH3 | .2 | 5 | 0A-0 | C | A | 8 | E9 | 9B | 50 | A8 5C E9 |
| LF | .0 | 5 | 0A-0 | C | A | 8 | E9 | 22 | 50 | A8 5C E9 |
| UH3 | .2 | 5 | 0A-0 | C | A | 8 | E9 | 9B | 50 | A8 5C E9 |
| O | .2 | 5 | 0A-0 | C | A | 8 | E9 | 91 | 50 | A8 5C E9 |
| OU | .0 | 5 | 0A-0 | C | A | 8 | E9 | 12 | 50 | A8 5C E9 |
| U | .3 | 5 | 0A-0 | C | A | 8 | E9 | D6 | 50 | A8 5C E9 |
| PA | .0 | 5 | 0A-0 | C | A | 8 | E9 | 00 | 50 | A8 5C E9 |
| PA | .0 | 5 | 0A-0 | C | A | 8 | E9 | 00 | 50 | A8 5C E9 |

4. Phoneme and Duration Adjustment

| Pho.D | T | In-S | A | R | E FF | DP | IS | RE | TA | FF |
|-------|----|------|------|---|------|----|----|----|----|----------|
| PA | .0 | 5 | 0A-0 | C | A | 8 | E9 | 00 | 50 | A8 5C E9 |
| PA | .0 | 5 | 0A-0 | C | A | 8 | E9 | 00 | 50 | A8 5C E9 |
| HF | .1 | 5 | 0A-0 | C | A | 8 | E9 | 6C | 50 | A8 5C E9 |
| EH1 | .1 | 5 | 0A-0 | C | A | 8 | E9 | 4B | 50 | A8 5C E9 |
| UH3 | .2 | 5 | 0A-0 | C | A | 8 | E9 | 9B | 50 | A8 5C E9 |
| LF | .0 | 5 | 0A-0 | C | A | 8 | E9 | 22 | 50 | A8 5C E9 |
| UH3 | .2 | 5 | 0A-0 | C | A | 8 | E9 | 9B | 50 | A8 5C E9 |
| O | .2 | 5 | 0A-0 | C | A | 8 | E9 | 91 | 50 | A8 5C E9 |

| | | | | | | | | | | |
|----|----|---|------|---|---|---|----|----|----|----------|
| OU | .0 | 5 | 0A-0 | C | A | 8 | E9 | 12 | 50 | A8 5C E9 |
| U | .2 | 5 | 0A-0 | C | A | 8 | E9 | 96 | 50 | A8 5C E9 |
| PA | .0 | 5 | 0A-0 | C | A | 8 | E9 | 00 | 50 | A8 5C E9 |
| PA | .0 | 5 | 0A-0 | C | A | 8 | E9 | 00 | 50 | A8 5C E9 |

5. Inflection Adjustment

| Pho.D | T | In-S | A | R | E FF | DP | IS | RE | TA | FF |
|-------|----|------|------|---|------|----|----|----|----|----------|
| PA | .0 | 5 | 0B-0 | C | A | 8 | E9 | 00 | 58 | A8 5C E9 |
| PA | .0 | 5 | 0B-0 | C | A | 8 | E9 | 00 | 58 | A8 5C E9 |
| HF | .1 | 5 | 0A-0 | C | A | 8 | E9 | 6C | 50 | A8 5C E9 |
| EH1 | .1 | 5 | 0B-0 | C | A | 8 | E9 | 4B | 40 | A8 5C E9 |
| UH3 | .2 | 5 | 09-0 | C | A | 8 | E9 | 9B | 48 | A8 5C E9 |
| LF | .0 | 5 | 0B-0 | C | A | 8 | E9 | 22 | 40 | A8 5C E9 |
| UH3 | .2 | 5 | 05-0 | C | A | 8 | E9 | 9B | 28 | A8 5C E9 |
| O | .2 | 5 | 05-0 | C | A | 8 | E9 | 91 | 28 | A8 5C E9 |
| OU | .0 | 5 | 06-0 | C | A | 8 | E9 | 12 | 30 | A8 5C E9 |
| U | .2 | 5 | 07-0 | C | A | 8 | E9 | 96 | 38 | A8 5C E9 |
| PA | .0 | 5 | 0A-0 | C | A | 8 | E9 | 00 | 50 | A8 5C E9 |
| PA | .0 | 5 | 0B-0 | C | A | 8 | E9 | 00 | 58 | A8 5C E9 |

6. Phoneme, Duration, Inflection, and Rate Adjustment

| Pho.D | T | In-S | A | R | E FF | DP | IS | RE | TA | FF |
|-------|----|------|------|---|------|----|----|----|----|----------|
| PA | .0 | 5 | 0B-0 | C | A | 8 | E9 | 00 | 58 | A8 5C E9 |
| PA | .0 | 5 | 0B-0 | C | A | 8 | E9 | 00 | 58 | A8 5C E9 |
| HF | .1 | 5 | 0A-0 | C | 7 | 8 | E9 | 6C | 50 | 78 5C E9 |
| EH1 | .1 | 5 | 0B-0 | C | D | 8 | E9 | 4B | 40 | D8 5C E9 |
| UH3 | .2 | 5 | 09-0 | C | C | 8 | E9 | 9B | 48 | C8 5C E9 |
| LF | .0 | 5 | 0B-0 | C | C | 8 | E9 | 22 | 40 | C8 5C E9 |
| UH3 | .2 | 5 | 05-0 | C | 9 | 8 | E9 | 9B | 28 | 98 5C E9 |
| O | .2 | 5 | 05-0 | C | 9 | 8 | E9 | 91 | 28 | 98 5C E9 |
| OU | .0 | 5 | 06-0 | C | A | 8 | E9 | 12 | 30 | A8 5C E9 |
| U | .2 | 5 | 07-0 | C | C | 8 | E9 | 96 | 38 | C8 5C E9 |
| U | .3 | 5 | 0A-0 | C | 7 | 8 | E9 | D6 | 50 | 78 5C E9 |
| PA | .0 | 5 | 0B-0 | C | A | 8 | E9 | 00 | 58 | A8 5C E9 |
| PA | .0 | 5 | 0A-0 | C | A | 8 | E9 | 00 | 50 | A8 5C E9 |

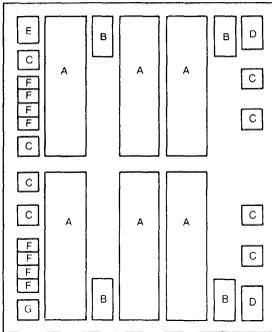
7. Phoneme, Duration, Inflection, Rate, and Amplitude Adjustment

| Pho.D | T | In-S | A | R | E FF | DP | IS | RE | TA | FF |
|-------|----|------|------|---|------|----|----|----|----|----------|
| PA | .0 | 5 | 0B-0 | C | A | 8 | E9 | 00 | 58 | A8 5C E9 |
| PA | .0 | 5 | 0B-0 | C | A | 8 | E9 | 00 | 58 | A8 5C E9 |
| EH | .0 | 5 | 07-0 | 0 | D | 8 | E9 | 0A | 38 | D8 50 E9 |
| HF | .1 | 5 | 0A-0 | 4 | 7 | 8 | E9 | 6C | 50 | 78 54 E9 |
| EH1 | .1 | 5 | 0B-0 | C | D | 8 | E9 | 4B | 40 | D8 5C E9 |
| UH3 | .2 | 5 | 09-0 | A | C | 8 | E9 | 9B | 48 | C8 5A E9 |
| LF | .0 | 5 | 0B-0 | A | C | 8 | E9 | 22 | 40 | C8 5A E9 |
| UH3 | .2 | 5 | 05-0 | C | 9 | 8 | E9 | 9B | 28 | 98 5C E9 |
| O | .2 | 5 | 05-0 | C | 9 | 8 | E9 | 91 | 28 | 98 5C E9 |
| OU | .0 | 5 | 06-0 | C | A | 8 | E9 | 12 | 30 | A8 5C E9 |
| U | .2 | 5 | 07-0 | A | C | 8 | E9 | 96 | 38 | C8 5A E9 |
| U | .3 | 5 | 0A-0 | 0 | 7 | 8 | E9 | D6 | 50 | 78 50 E9 |
| PA | .0 | 5 | 0B-0 | C | A | 8 | E9 | 00 | 58 | A8 5C E9 |
| PA | .0 | 5 | 0A-0 | C | A | 8 | E9 | 00 | 50 | A8 5C E9 |

8. Further Adjustment (depending on personal preference)

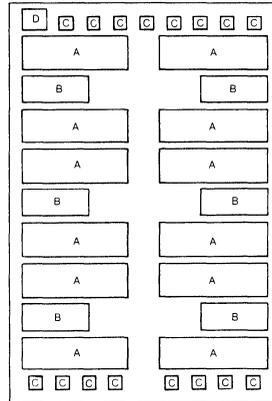
| Pho.D | T | In-S | A | R | E FF | DP | IS | RE | TA | FF |
|-------|----|------|------|---|------|----|----|----|----|----------|
| PA | .0 | 5 | 0D-0 | C | A | 8 | E9 | 00 | 68 | A8 5C E9 |
| PA | .0 | 5 | 0D-0 | C | A | 8 | E9 | 00 | 68 | A8 5C E9 |
| EH | .0 | 5 | 0D-0 | 0 | D | 8 | E9 | 0A | 68 | D8 50 E9 |
| HF | .1 | 5 | 07-0 | 2 | 8 | 8 | E9 | 6C | 38 | 88 52 E9 |
| EH1 | .1 | 5 | 09-2 | C | D | 8 | E9 | 4B | 4A | D8 5C E9 |
| UH3 | .2 | 5 | 09-4 | A | C | 8 | E9 | 9B | 4C | C8 5A E9 |
| LF | .0 | 5 | 09-0 | A | C | 8 | E9 | 22 | 48 | C8 5A E9 |
| UH3 | .2 | 5 | 07-7 | C | 9 | 8 | E9 | 9B | 3F | 98 5C E9 |
| O | .2 | 5 | 06-4 | C | 9 | 8 | E9 | 91 | 3A | 98 5C E9 |
| OU | .1 | 5 | 05-2 | C | A | 8 | E9 | 52 | 2A | A8 5C E9 |
| U | .2 | 5 | 06-3 | 3 | 5 | 8 | E9 | 96 | 33 | 58 53 E9 |
| U | .3 | 5 | 07-4 | 0 | C | 8 | E9 | D6 | 3C | C8 50 E9 |
| PA | .0 | 5 | 05-4 | C | C | 8 | E9 | 00 | 2C | C8 5C E9 |
| PA | .0 | 5 | 01-4 | C | C | 8 | E9 | 00 | 0C | C8 5C E9 |

Data Sheet



SCA-6 CONTENTS

- A) Biquad Section (6 ea.)
 - 2 Op Amps
 - 7 CMOS Switches
 - 28 PMOS Switches
 - 66 Programmable Capacitor Units
- B) Buffer Amplifier (4 ea.)
- C) Digital Level Shifters (8 ea.)
(Translate 0/Vp signals to Vn/Vp)
- D) Resistor Dividers
- E) Crystal Oscillator (1 ea.)
- F) Toggle Flip Flops (8 ea.)
- G) Non-Overlapping Clock Generators



SCA-12 CONTENTS

- A) Biquad Section (12 ea.)
 - 2 Op Amps
 - 6 CMOS Switches
 - 32 PMOS Switches
 - 60 Programmable Capacitor Units
- B) Buffer Amplifier (6 ea.)
- C) Digital level Shifters (16 ea.)
(Translate 0/Vp signals to Vn/Vp)
- D) Resistor Dividers

FEATURES

- Switched-capacitor filters Stable, precise filters—no external components or trims
- Single (metal) mask user programming 8-12 week turnaround to prototypes
- Built-in clock generator (SCA-6 only) Xtal oscillator, divider chain, clock buffers
- Buffer amplifiers Continuous time interfaces, analog drivers
- Single supply operation 9.5-15 volts, derived signal ground (split supply operation available)

USER BENEFITS

DESCRIPTION

The SCA-6/SCA-12 are metal gate CMOS Switched-Capacitor Arrays which may be configured to implement up to six or twelve biquadratic filter sections, other switched capacitor filter (SCF) architectures and general analog functions. Intended primarily for analog signal processing applications, the SCA-6 and SCA-12 are efficient replacements for many Active RC and discrete implementations, providing precision high-order filtering on a single chip.

Logical control of analog switches allows the user to design in pin-programmable characteristics. The

available building blocks facilitate quality filters: Capacitor ratio accuracies better than 0.5%, amplifier open loop gains in excess of 1000, parasitic insensitive layout.

Individual filter, filter bank, and unique analog requirements may all be satisfied with these devices.

Customers versed in SCF design may submit completed schematics to SSI; others may provide continuous-time designs, transfer functions or specs, and SSI will adapt the circuit to the SCA-6 or SCA-12.

ELECTRICAL CHARACTERISTICS ($0 \leq T_A \leq 70^\circ\text{C}$, $9.5\text{V} \leq V_P - V_N \leq 15\text{V}$) Inquire at factory about 5 volt operation.

| Parameter | Conditions | Min | Typ | Max | Units |
|------------------------------|--|--------|-----|------|------------------|
| Biquad Amplifier | $C_{LOAD} \leq 30\text{pF}$ | | | | |
| Open Loop Gain | | 58 | 66 | - | dB |
| Bandwidth | | 0.8 | 1.0 | - | MHz |
| Offset Voltage | | -100 | 0 | +100 | mV |
| Supply Current | | - | 0.4 | 1.5 | mA |
| Buffer Amplifier | Load: $1000\text{pF} \parallel 10\text{k}\Omega$ | | | | |
| Open Loop Gain | | 55 | 60 | - | dB |
| Bandwidth | | 0.5 | 0.8 | - | MHz |
| Supply Current | | - | 1.4 | 5 | mA |
| Analog Switches | On Resistance: | | | | |
| P-Channel | | - | 40 | 80 | $\text{k}\Omega$ |
| N-Channel | | - | 20 | 40 | $\text{k}\Omega$ |
| SCF Clock Frequency | | 10 | - | 100 | kHz |
| Digital Level Shifter | $V_p = V_N $ | | | | |
| ViL | | - | - | 0.15 | Volt |
| ViH | | Vp-0.3 | - | - | Volt |
| Clock Generator (SCA-6 only) | | | | | |
| Xtal Oscillator Frequency | | 1 | - | 5 | MHz |

PACKAGE INFORMATION

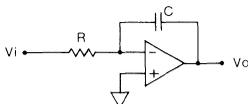
The SCA-6 has 28 Input/Output Pads and may be packaged in 8- to 28-pin plastic or ceramic DIP's.
 The SCA-12 has 54 Input/Output Pads and may be packaged in 24- to 40-pin plastic or ceramic DIP's.

Discrete, Active RC Implementation

VS.

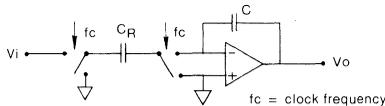
Integrated SCA Implementation

A. Continuous-Time Integrator



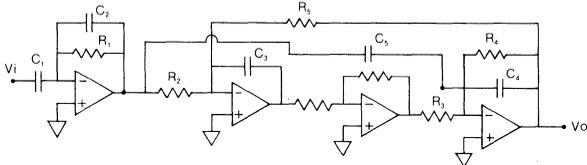
$$\frac{V_o}{V_i}(s) = \frac{-1}{RSC}$$

A. Switched Capacitor Integrator



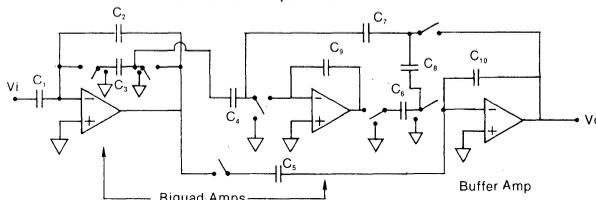
$$R = \frac{1}{f_c C R} \cdot \frac{V_o}{V_i}(s) = \frac{f_c C R}{SC} = \frac{-1}{RSC}$$

B. 3rd Order Elliptic Filter



$$\frac{V_o}{V_i}(s) = \frac{-SR_1C_1}{1+SR_1C_2} \cdot \frac{S^2C_1C_5 + R_3/R_2}{1+S \frac{C_2R_3R_5}{R_4} + S^2C_1C_4R_1R_2}$$

B. 3rd Order Elliptic Filter



$$\frac{V_o}{V_i}(s) = \frac{SC_1}{f_c C_2 + SC_2} \cdot \frac{C_1}{C_7} \cdot \frac{S^2(4 \frac{C_6C_7}{C_1C_9} - 1) + 4f_c^2}{S^2(4 \frac{C_9C_{10}}{C_6C_7} + 2 \frac{C_2C_2}{C_1C_7} - 1) + S(4f_c C_1C_9) + 4f_c^2}$$

Advanced Information

GENERAL DESCRIPTION

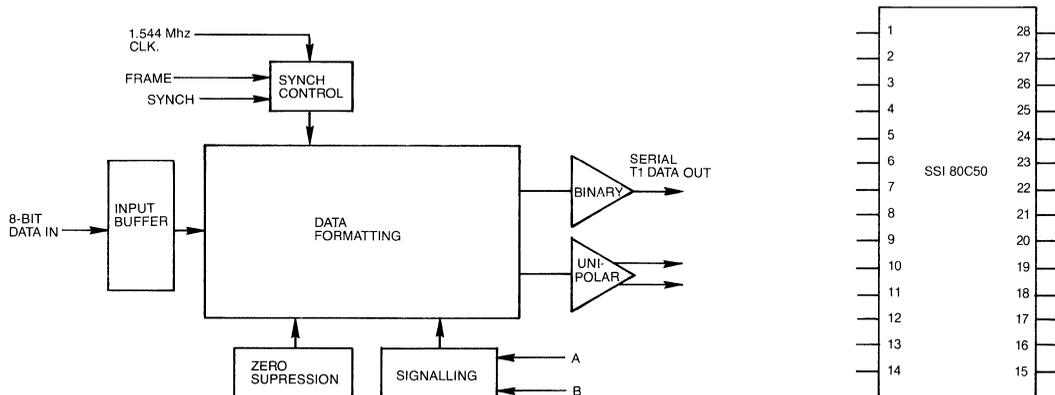
The SSI 80C50 is a 28 pin monolithic Silicon-gate CMOS device that provides the T1 link digital transmit function using Bell D2, D3, or D4 (mode 3) data formatting standards. The 80C50 converts 8-bit parallel data representing PCM encoded samples from 24 input voice band channels into a time division multiplexed serial bit stream which is output synchronously at the 1.544 Mhz T1 rate. The 80C50 inserts framing and signalling bits into the data flow as required by the D2 and D3 formats and in response to external logic inputs. A and B channel signalling and alarm reporting is generated by applying appropriate logic levels to separate serial control pins. A selectable zero code suppression technique is used to insure that the output bit stream does not contain continuous zeros when the input channel sample data consists of all zeros. The output buffer provides data as either a serial binary signal or as a unipolar pair which simplifies generation of a bipolar output signal.

The SSI 80C50 is intended to be an integral component in leased line or internal usage T1 link systems. Its high level of functional integration simplifies system design, and the CMOS architecture used insures optimum performance while reducing power supply requirements.

FEATURES

- Provides full T1 link digital transmit framing functions
- Converts 24 PCM input channels to 1.544 Mhz synchronous serial bit stream
- Compatible with Bell D2, D3, and D4 (mode 3) data formatting
- Common-Channel Interoffice Signalling (CCIS) capability selectable
- A and B channel highway signalling control
- Remote alarm (Yellow alarm) reporting capability
- Dual outputs—binary and dual unipolar
- Space efficient 28 pin DIP chip
- CMOS technology for low power consumption
- Single + 5 volt supply
- LSTTL and CMOS compatible inputs and outputs

SSI 80C50 Block Diagram



CAUTION: Use handling procedures necessary for a static sensitive component

Advanced Information

GENERAL DESCRIPTION

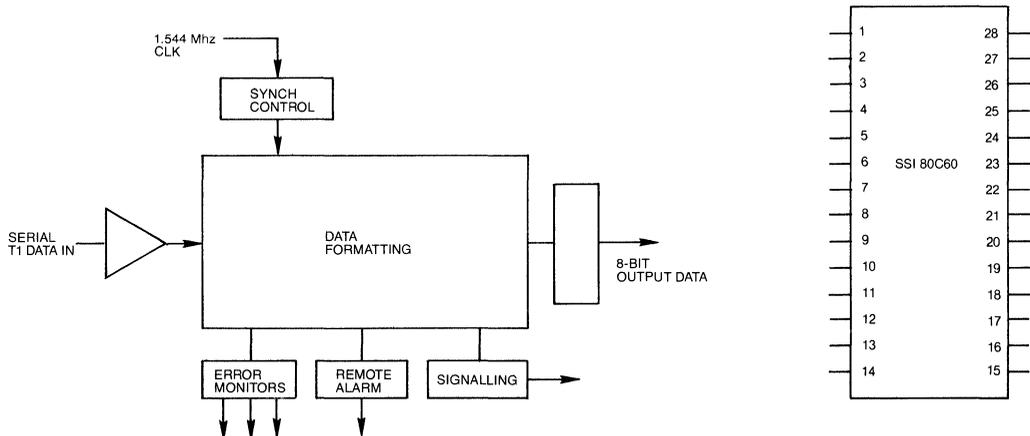
The SSI 80C60 is a 28 pin monolithic Silicon-gate CMOS device that provides the T1 link digital receive function using Bell D2 or D3 data formatting standards. The 80C60 operates on a 1.544 Mhz unipolar serial data stream representing PCM encoded samples from 24 voice band channels to perform the demultiplexing operation, and outputs the originally encoded 8-bit parallel sample words. Using the extracted 1.544 Mhz clock as a reference, the 80C60 provides frame synchronization, identifies the signalling frames and routes the signalling bit to a separate serial output pin. A remote alarm monitor checks for the repetitive second data bit zero condition that indicates a remote alarm (yellow alarm) has been transmitted. On-chip error detectors indicate loss of carrier, synchronization loss, and signalling errors. Additional synchronization signals are output by the 80C60 to assist external circuitry in processing the derived PCM data samples and signalling information.

The 80C60 is designed for integration into leased line or internal usage T1 link subsystems. Incorporation of multiple functions on a single chip reduces system component count and increases reliability, while the CMOS technology employed minimizes power supply requirements.

FEATURES

- Provides T1 link digital receive framing functions
- Converts 1.544 Mhz synchronous serial bit stream back to 8-bit words
- Compatible with Bell D2 and D3 data formatting
- Inputs serial unipolar data
- A and B channel highway signal extraction
- Remote alarm (Yellow alarm) detection capability
- Indicates signalling, loss of frame synch, and carrier loss errors
- Space efficient 28 pin DIP chip
- CMOS technology for low power consumption
- Single +5 volt supply
- LSTTL and CMOS compatible inputs and outputs

SSI 80C60 Block Diagram



CAUTION: Use handling procedures necessary for a static sensitive component

Advanced Information

INTRODUCTION

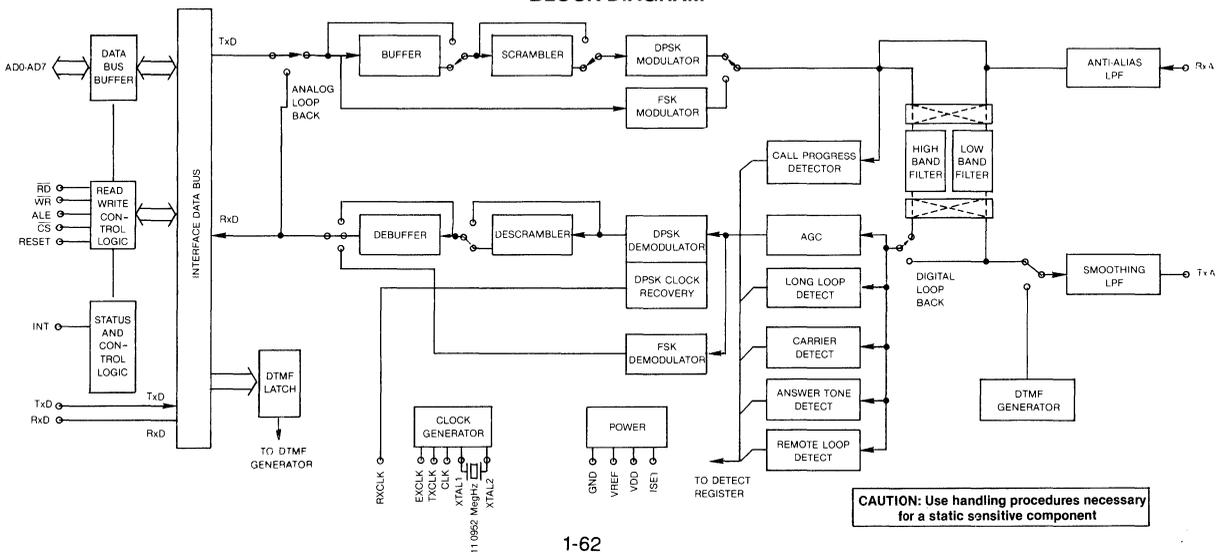
The SSI K212 is a true single-chip modem device that provides the functions needed to construct a typical Bell 212A standard full-duplex modem. Using an advanced CMOS process that integrates analog, digital, and switched-capacitor array functions on a single substrate, the SSI K212 offers excellent performance and a high level of functional integration in a single 28 pin DIP configuration. The K212 provides the basic PSK and FSK modulator/demodulator functions, call progress and handshake tone monitors, test modes, and a DTMF dialer. This device supports all Bell 212A modes of operation, allowing both synchronous and asynchronous communication. The K212 is designed to appear to the systems designer as a microprocessor peripheral, and will easily interface with popular one-chip microprocessors (80C51 typical) for control of modem functions through its 8-bit multiplexed address/data bus, or via an optional serial command bus. An ALE control line simplifies address demultiplexing. Data communication occurs through a separate serial port only.

The K212 is ideal for use in either freestanding or integral system modem products where full-duplex 1200 BPS data communications over the 2-wire switched telephone network is desired. Its high functionality, low power consumption, and efficient packaging simplify design requirements and increase system reliability. A complete modem requires only the addition of the phone line interface, a control microprocessor, and RS-232 level converters for a typical system. The use of coherent demodulation techniques also assures the user of optimum performance when communicating over degraded lines.

FEATURES

- One-chip fully Bell 103/212A compatible modem
- Full duplex operation at 0-300 and 1200 BPS
- FSK (300 BPS) or PSK (1200 BPS) encoding
- Compatible with standard microprocessors (8048, 80C51 typical)
- Serial (22 Pin DIP) or parallel microprocessor bus interface (28 Pin DIP)
- Maskable interrupts
- Serial port for data transfer
- Selectable asynch/synch and scrambler/descrambler functions
- Coherent demodulation technique provides optimal performance
- Call progress, carrier, and long loop detect monitor
- DTMF tone generator
- Test modes available – ALB, DL, RDL, Mark, Space, Alternating bit patterns
- Space efficient 22 and 28 pin DIP packages
- CMOS technology for low power consumption (120 MW)
- Single +12 volt supply
- TTL and CMOS compatible inputs and outputs

BLOCK DIAGRAM



CAUTION: Use handling procedures necessary for a static sensitive component

SSI K212

Single Chip Bell 212 Modem

OPERATION

General

The SSI K212 was designed to be a complete Bell 212A compatible modem on a chip. As many functions as deemed economically feasible were included in order to simplify implementation into typical modem designs. In addition to the basic 1200 BPS PSK and 300 BPS FSK modulator/demodulator sections, the device also includes synch/asynch converters, scrambler/descrambler, call progress tone detect, and DTMF tone generator capabilities. All Bell 212A modes are supported (synchronous and asynchronous) and test modes are provided for diagnostics. Most functions are selectable as options and logical defaults are provided when override modes are selected. The device can be directly interfaced to a microprocessor via its 8-bit multiplexed address/data bus for control and status monitoring. Data communication takes place through a serial port.

PSK Modulator/Demodulator

The K212 modulates a serial bit stream into dibit pairs that are represented by four possible phase shifts as prescribed by the Bell 212A standard. The baseband signal is then filtered to reduce intersymbol interference on the bandlimited 2-wire PSTN line. Transmission occurs on either a 1200 Hz (Originate mode) or 2400 Hz carrier (Answer mode). Demodulation is the reverse of the modulation process, with the incoming analog signal eventually decoded into dibits and converted back to a serial bit stream. The demodulator also recovers the clock which was encoded into the analog signal during modulation. Demodulation occurs using either a 1200 Hz carrier (Answer mode or ALB Originate mode) or a 2400 Hz carrier (Originate mode or ALB Answer mode). The K212 uses a phase locked loop coherent demodulation technique that offers inherently better performance than typical DPSK demodulators used by other manufacturers.

FSK Modulator/Demodulator

The FSK modulator frequency modulates the analog output signal using two discrete frequencies to represent the binary data. The Bell 103 standard frequencies of 1270 Hz and 1070 Hz (originate mark and space) and 2225 and 2025 (answer mark and space) are used. Demodulation involves detecting the received frequencies and decoding them into the appropriate binary value. The rate converter and scrambler/descrambler are bypassed in the 103 mode.

Passband Filters and Equalizers

A high and low band filter is included to shape the amplitude and phase response of the transmit signal and provide compromise delay equalization and rejection of out of band signals in the receive channel. Amplitude and phase equalization is necessary to compensate for distortion of the transmission line and to reduce intersymbol interference in the bandlimited receive signal. The transmit signal filtering corresponds to a 75% square root of raised Cosine frequency response characteristic.

Asynchronous Mode

The asynchronous mode is used for communication with asynchronous terminals which may communicate at 1200 BPS $\pm 1\%$ -2.5% even though the modem's output is limited to 1200 BPS $\pm .01\%$. When transmitting

in this mode the serial data on the TXD input is passed through a rate converter which inserts or deletes stop bits in the serial bit stream in order to output a signal that is exactly 1200 BPS $\pm .01\%$. This signal is then routed to a data scrambler (following the CCITT V.22 algorithm) and into the analog PSK modulator where dibit encoding results in a Bell 212A standard PSK output signal. Both the rate converter and scrambler can be bypassed for handshaking, FSK, and synchronous operation. The device recognizes a break signal and handles it in accordance with Bell 212A specifications. Received data is processed in a similar fashion except that the rate converter now acts to reinsert any deleted stop bits and output data to the terminal at no greater than 1219 BPS. An incoming break signal will be passed through without incorrectly inserting a stop bit.

Synchronous Mode

The Bell 212A standard defines synchronous operation only at 1200 BPS. Operation is similar to that of the asynchronous mode except that data must be synchronized to a provided clock and no variation in data transfer rate is allowable. Serial input data appearing at TxD must be valid on the falling edge of TxCLK. Receive data at the RxD pin is clocked out on the rising edge of RxCLK. The asynch/synch converter is bypassed when synchronous mode is selected and data is transmitted out at essentially the same rate as it is input.

Parallel Bus Interface

Four 8-bit registers are provided for control, option select, and status monitoring. These registers are addressed with the A0 and A1 multiplexed address lines (latched by ALE) and appear to a control microprocessor as four consecutive memory locations. Two control registers and the DTMF register are read or write memory. The status detect register is read only and cannot be modified except by modem response to monitored parameters.

Serial Command Interface

The serial command mode allows access to the K212 control and status registers via a serial command port (22 pin version only). In this mode the A0 and A1 lines provide register addresses for data passed through the data pin under control of the RD and WR lines. A read operation is initiated when the RD line is taken low. The next eight cycles of ExCLK will then transfer out eight bits of the selected address location LSB first. A write takes place by shifting in eight bits of data LSB first for eight consecutive cycles of ExCLK. WR is then pulsed low and data transfer into the selected register occurs on the rising edge of WR.

Special Detect Circuitry

The special detect circuit monitors carrier, call progress tones, answer tone, long loop, (weak received signal) and remote digital loopback request bit pattern. The appropriate status bit is set when one of these conditions changes and an interrupt is generated.

DTMF Generator

The DTMF generator will output one of 16 standard dual-tones determined by the 4-bit binary value previously loaded into the DTMF register. Dialing is initiated when the DTMF mode is selected and the transmit enable bit is changed from A1 to A0.

HARDWARE INTERFACE

| Pin No. | I/O | Signal Label | 22 Pin | 28 Pin | Description |
|--------------|-----|--------------|--------|--------|--|
| POWER | | | | | |
| 14 | I | GND | X | X | System ground. |
| 28 | I | Vdd | X | X | Power supply input, +12 volt +10%, -20% |
| | O | Vref | X | X | An internally generated reference voltage for test use. |
| | I | ISET | X | X | Chip current reference. Sets bias current for op-amps. Programmed by connecting to Vcc through 1 Meg resistor. Power dissipation/performance tradeoff results from varying this value. |

MICROPROCESSOR INTERFACE

| | | | | | |
|--|-----|------------------|---|---|---|
| | I | ALE | X | - | Address latch enable. The falling edge of ALE latches the address on AD0-AD2. |
| | I/O | AD0-AD7 | X | - | Address/data bus. This is a bidirectional, tri-state, multiplexed address and data bus. |
| | I | \overline{CS} | X | - | Chip select. Allows access to device data and address bus. AD0-AD7 will be in a high impedance state unless \overline{CS} is low. \overline{CS} is latched on the falling edge of ALE. |
| | O | CLK | X | X | Clock output. This pin outputs either the crystal frequency (for use as a processor clock) or a 16x1200 Hz signal for use as a baud clock. |
| | O | \overline{INT} | X | X | Interrupt flag to processor. When low, indicates that a detect condition has occurred. Reset when the detect register is read or a reset is performed. |
| | I | \overline{RD} | X | - | Read control. When low puts addressed register into a read condition. \overline{CS} must also be low. |
| | I | Reset | X | X | Resets device when in high state, setting all register bits to zero and CLK to Xtal frequency. An internal pulldown resistor allows power on reset by connecting a 1 μ f capacitor between reset and Vcc. |
| | I | WR | X | - | Write control. A low indicates that data is available. Data is latched on the rising edge of WR. \overline{CS} must be active. |

RS-232 INTERFACE

| | | | | | |
|--|---|-------|---|---|---|
| | I | ExCLK | X | X | External clock input. Used in synchronous modes when external timing is selected. ExCLK becomes the phase-lock reference for TxCLK. |
| | O | RxCLK | X | X | Receive clock output. Carrier derived synch clock. Rising edge coincides with received data output transitions. Falling edge can be used to latch valid output data. Active when carrier present. |
| | O | RxD | X | X | Received digital data output. In synchronous mode, data is valid on falling edge of RxCLK. |
| | O | TxCLK | X | X | Transmit clock output. Used in synchronous mode to latch input data on the TxD pin. Data must be valid on the falling edge of TxCLK. TxCLK is an internally generated 1200 Hz reference in internal mode, phase locked to ExCLK in external mode, and derived from RxCLK in slave mode. TxCLK is always active. |
| | I | TxD | X | X | Transmit digital data input. In synch modes the data must be valid on the falling edge of TxCLK. In Asynch modes no clocking is necessary. High speed data must be 1200 +1%, -2.5%. |



14351 Myford Road, Tustin, CA 92680 (714) 731-7110, TWX 910-595-2809

HARDWARE INTERFACE

| Pin No. | I/O | Signal Label | 28 Pin | 22 Pin | Description |
|---------|-----|--------------|--------|--------|-------------|
|---------|-----|--------------|--------|--------|-------------|

ANALOG INTERFACE

| | | | | | |
|--|---|-------|---|---|---|
| | I | RxA | X | X | Received modulated analog signal input. |
| | O | TxA | X | X | Transmit analog output. |
| | I | Xtal1 | X | X | Connection for external 11.0592 Mhz crystal or CMOS level clock signal. |
| | I | Xtal2 | X | X | Connection for external 11.0592 Mhz crystal or CMOS level clock signal. |

SERIAL INTERFACE

| | | | | | |
|--|-----|-------|---|---|--|
| | I | A0-A1 | — | X | Register address selection. These lines should be valid during any read or write operation. |
| | I/O | Data | — | X | Serial control data. Data for a read/write operation is clocked in or out on the falling edge of the ExCLK pin. The direction of data flow is controlled by the RD pin. RD low outputs data. RD high inputs data. |
| | I | RD | — | X | Read data control. A low enables a read operation from the addressed register. Data is clocked out on transitions of the ExCLK (LSB first) while the RD line is low. Eight cycles of ExCLK are needed to transfer the full 8 bits of data contained in one register. |
| | I | WR | — | X | Write data control. A low to high transition on this line causes 8 bits of data previously shifted in (LSB first) to be transferred to the addressed register. |

BUS INTERFACE

Four 8-bit internal registers are accessible for control and status monitoring. The registers are accessed in read or write operations by addressing the A0 and A1 address lines (latched by ALE in parallel mode). Control and status bits are identified to the right:

| A0 | A1 | Register | Function |
|----|----|----------|-----------------------------|
| 0 | 0 | CR0 | Control register 1 |
| 0 | 1 | CR1 | Control register 2 |
| 1 | 0 | DR | Detect register (read only) |
| 1 | 1 | DTMF | DTMF transmit tones |

| ADDRESS | D7 | D6 | D5 | D4 | D3 | D2 | D1 | D0 |
|---------|---------------|---------------|---------------|---------------|---------------|---------------|-----------------|-----------------|
| 00 | SSI TEST | 0 | LOW SPEED | TX MODE BIT 2 | TX MODE BIT 1 | TX MODE BIT 0 | TX ENABLE | ORG/ANS |
| 01 | TX TEST BIT 1 | TX TEST BIT 0 | EN INT DETECT | BYPASS SCR | CLK SELECT | RESET | TEST MODE BIT 1 | TEST MODE BIT 0 |
| 10 | 0 | 0 | 0 | RDL | CD | ANS TONE | CALL PROG | LONG LOOP |
| 11 | 0 | 0 | TX ANS TONE | TX DTMF | DTMF BIT 3 | DTMF BIT 2 | DTMF BIT 1 | DTMF BIT 0 |

CONTROL REGISTER 0—CR0

| D7 | D6 | D5 | D4 | D3 | D2 | D1 | D0 |
|----------|----|-----------|---------------|---------------|---------------|-----------|---------|
| SSI TEST | 0 | LOW SPEED | TX MODE BIT 2 | TX MODE BIT 1 | TX MODE BIT 0 | TX ENABLE | ORG/ANS |

0 = NORMAL
1 = INVALID

1 = 300 BPS
0 = 1200 BPS

000 = PWR DOWN
001 = INT. SYNCH
010 = EXT. SYNCH
100 = SLAVE SYNCH
000 = ASYCH 8 BITS/CHAR
101 = ASYCH 9 BITS/CHAR
110 = ASYCH 10 BITS/CHAR
111 = ASYCH 11 BITS/CHAR

1 = TX
0 = TX OFF

1 = ORG
0 = ANS

CONTROL REGISTER—CR1

| D7 | D6 | D5 | D4 | D3 | D2 | D1 | D0 |
|---------------|---------------|--------|--------|-------------|-------|-----------------|-----------------|
| TX TEST BIT 1 | TX TEST BIT 0 | INT EN | SCR EN | CLK CONTROL | RESET | TEST MODE BIT 1 | TEST MODE BIT 0 |

00 = TX DATA
01 = TX ALTERNATE
10 = TX MARK
11 = TX SPACE

ENABLE INTERRUPT
1 = ON
0 = OFF

0 = ON
1 = OFF

0 = XTAL
1 = 16X1200

RESET

00 = NORMAL
01 = ALB
10 = RDL
11 = SSI TEST

DETECT REGISTER—DR

| D7 | D6 | D5 | D4 | D3 | D2 | D1 | D0 |
|----|----|----|-----|----|----------|------------|-----------|
| 0 | 0 | 0 | RDL | CD | ANS TONE | CALL PROG. | LONG LOOP |

TONE REGISTER

| D7 | D6 | D5 | D4 | D3 | D2 | D1 | D0 |
|----|----|-------------|---------|--------|--------|--------|--------|
| 0 | 0 | TX ANS TONE | TX DTMF | DTMF 3 | DTMF 2 | DTMF 1 | DTMF 0 |

1 = ON
0 = OFF

1 = TX DTMF
0 = DATA

— 4-BIT CODE FOR 1 OF 16 DUAL-TONE COMBINATIONS—

Advanced Information

GENERAL DESCRIPTION

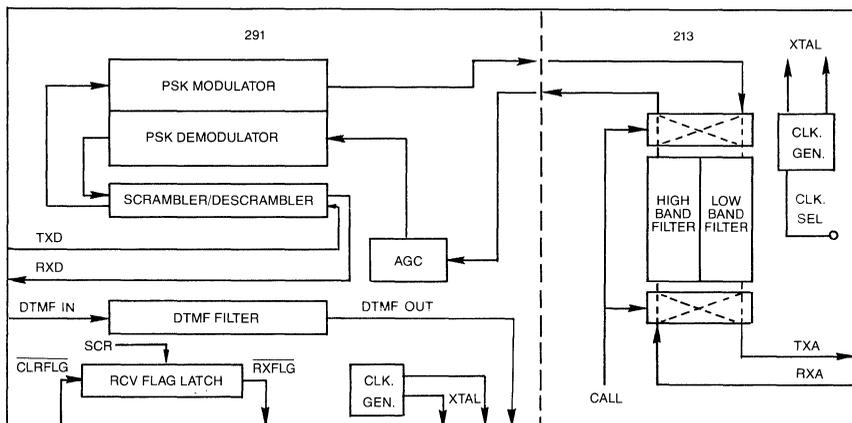
The SSI 291/213 device set consists of 40 pin and 16 pin CMOS monolithic IC's that together form the basis for a 1200 BPS Bell 212A compatible modem. The SSI 213 is a modem filter that provides the channel separation, equalization, and answer/originate steering logic needed for Bell 212A operation. The 291 contains the Bell 212 modulator and demodulator, AGC, scrambler/descrambler, and carrier detect monitor. Clock generator and undedicated low pass filter functions are also included to minimize the requirement for external components. Using TTL and CMOS compatible I/O, the device set is designed to provide a low-cost modem when integrated with a one-chip control microprocessor.

The 291/213 device set is ideal for use in either free standing or integral system modem products where full-duplex 1200 BPS data communications over the 2-wire switched telephone network is desired. It's high functionality, reduced power consumption, and low cost simplify design requirements and increase system reliability. A complete modem can be implemented by adding a phone line interface, control microprocessor, and RS-232 level converters for a typical system. The use of coherent demodulation techniques also assures the user of optimum performance when communicating over degraded lines.

FEATURES

- Two-chip device set compatible with 2-wire PSTN phone lines
- Full duplex operation at 1200 BPS
- PSK encoding in Bell 212A format
- Will interface with standard microprocessors through serial control lines
- Serial port for data transfer
- Selectable scrambler/descrambler, answer/originate, clock frequency
- Support functions on-chip: clock generator, low-pass filter, receive clock flag
- Coherent demodulation technique provides optimal performance
- CMOS technology for low power consumption (120 MW)
- + - 5 volt supplies
- TTL and CMOS compatible inputs and outputs

SSI 291/213 Block Diagram



CAUTION: Use handling procedures necessary for a static sensitive component

SSI 291/213 Modem 1200 BPS Full Duplex Modem Device Set

CIRCUIT OPERATION

GENERAL:

The SSI 291/213 was designed to serve as a low-cost 1200 BPS full-duplex modem that offers Bell 212A 1200 BPS compatibility when used with a control microprocessor. The modulator/demodulator as well as various support functions needed to integrate with a microprocessor in a minimum cost system were included on the device set. In addition to the basic 1200 BPS PSK modulator/demodulator the product also includes a carrier detect monitor, scrambler/descrambler, clock generator, and a DTMF low pass filter for eliminating distortion from microprocessor generated dual-tones. The 1200 BPS Bell 212A mode is supported (synchronous operation) and test modes are provided for chip diagnostics. The device set can be directly interfaced to a microprocessor using serial lines for data transfer, control, and status monitoring.

PSK MODULATOR/DEMULATOR:

The 291/213 modulates a serial bit stream into dibit pairs that are represented by four possible phase shifts as prescribed by the Bell 312A standard. The baseband signal is then filtered to reduce intersymbol interference on the bandlimited 2-wire PSTN line. Transmission occurs on either a 1200 Hz (Originate mode) or 2400 Hz carrier (Answer mode). Demodulation is the reverse of the modulation process, with the incoming analog signal eventually decoded into dibits and converted back to a serial bit stream. Demodulation occurs using either a 1200 Hz carrier (Answer mode) or a 2400 Hz carrier (Originate mode). The 291/213 uses a phase locked loop coherent demodulation technique that offers inherently better performance than typical DPSK demodulators used by other manufacturers.

PASSBAND FILTERS AND EQUALIZERS:

A high and low band filter is included in the 213 to shape the amplitude and phase response of the transmit signal and provide compromise delay equalization and rejection of out of band signals in the receive channel. Amplitude and phase equalization is necessary to compensate for distortion of the transmission line and to reduce intersymbol interference in the bandlimited receive signal.

SYNCHRONOUS OPERATION:

The 291/213 is designed to provide synchronous operation at the 1200 BPS rate. In this mode data is synchronized to a provided clock and no variation in data transfer rate is allowable. Proper transmit action requires that serial input data appearing at TxD be valid on the falling edge of SCT. Receive data at the RxD pin may then be read out after the RXFLG goes low. After reading the receive data bit, microprocessor handshaking should reset the receive flag latch by setting CLRFLG.

Advanced Information

GENERAL DESCRIPTION

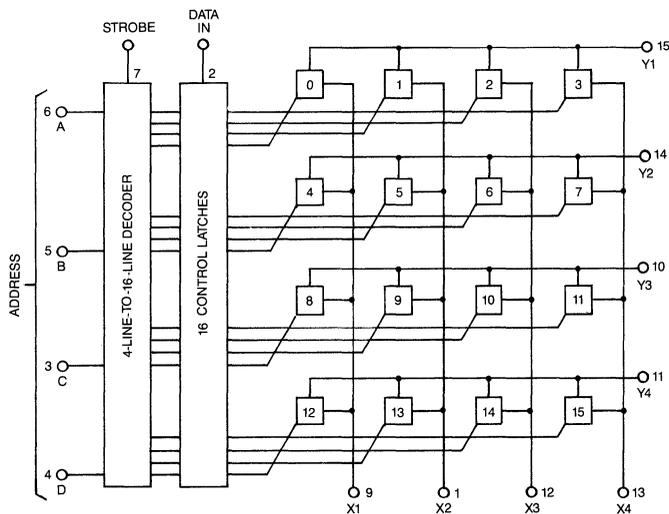
The SSI 22100 combines a 4 × 4 array of crosspoints (transmission gates) with a 4-line-to-16 decoder and 16 latch circuits. Any one of the sixteen transmission gates (crosspoints) can be selected by applying the appropriate four line address. The selected transmission gate can be turned on or off by applying a logical one or zero respectively to the data input and strobing the strobe input to a logical one. Any number of the transmission gates can be ON simultaneously. When the device is "powered up", the states of the 16 switches are indeterminate. Therefore, all switches must be turned off by setting the strobe high and data-in low, then addressing all switches in succession.

The SSI 22100 is supplied in 16-lead hermetic dual-in-line ceramic packages and 16-lead dual-in-line plastic packages.

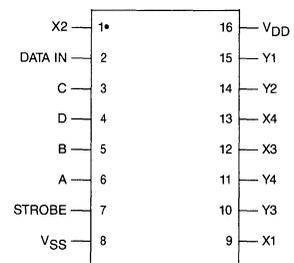
FEATURES

- Low ON resistance— 75Ω typ. at $V_{DD} = 12V$
- "Built-in" control latches
- Large analog signal capability— $\pm V_{DD}/2$
- 10-MHz switch bandwidth
- Matched switch characteristics— $\Delta R_{ON} = 18\Omega$ typ. at $V_{DD} = 12V$
- High linearity—0.5% distortion (typ.) at $f = 1kHz$, $V_{IN} = 5V_{p-p}$, $V_{DD} = 10V$, and $R_L = 1k\Omega$
- Standard CMOS noise immunity
- 100% tested for maximum quiescent current at 20V
- Second source for RCA CD22100
- Available Q285

SSI 22100 Block Diagram



PIN CONFIGURATION



Pin Out
(Top View)

CAUTION: Use handling procedures necessary for a static sensitive component

Advanced Information

GENERAL DESCRIPTION

The SSI 22106 is an 8x8x1 analog switch array of CMOS transmission gates designed using high-speed CMOS technology. It offers high noise immunity and has very low static power consumption.

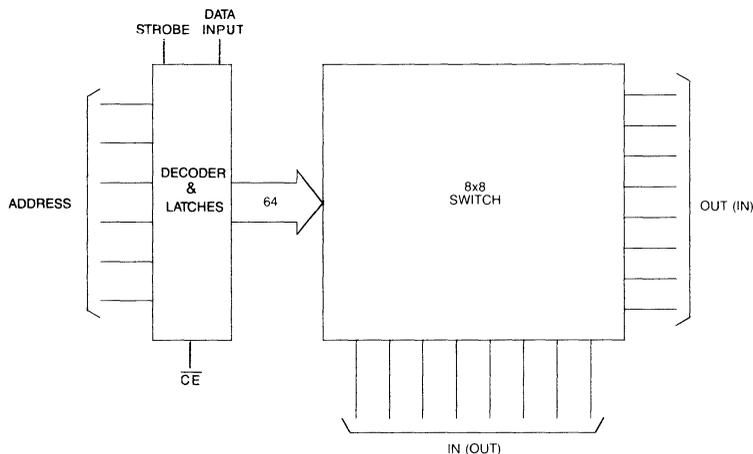
At power up all switches are automatically reset. A "low" on the Master Reset turns OFF all switches and clears the control latches. A 6-bit address through a 6-line-to-64-line decoder selects the transmission gate which can be turned ON by applying a logical ONE to the DATA INPUT and STROBE. Similarly, any transmission gate can be turned OFF by applying a logical ZERO to the DATA INPUT while strobing the STROBE with a logical ZERO.

A \overline{CE} allows the crosspoint array to be cascaded for matrix expansion in both the X and Y direction. The SSI 22106 is supplied in a 28-pin dual-in-line package.

FEATURES

- 64 crosspoint switches in an 8x8 array
- μ P compatible control inputs
- On chip line decoder and control latches
- Ron resistance 95 Ω max @ 5V
- Δ Ron 15 Ω typical @ 5V
- Operation voltage 2 - 6V
- Analog signal capability Vdd/2
- Automatic power up reset
- Parallel data input
- Power up reset by using C at \overline{MR} pin
- Address latches on-chip
- Second source for RCA CD 22106
- Available Q 285

SSI 22106 Block Diagram



CAUTION: Use handling procedures necessary for a static sensitive component

Advanced Information

GENERAL DESCRIPTION

The SSI 22301 monolithic PCM repeater circuit is designed for T1 carrier systems operating with a bipolar pulse train of 1.544 Mb/s. It can also be used in the T148 carrier system operating with a ternary pulse train of 2.37 Mb/s. The circuit operates from a $5.1V \pm 5\%$ externally regulated supply.

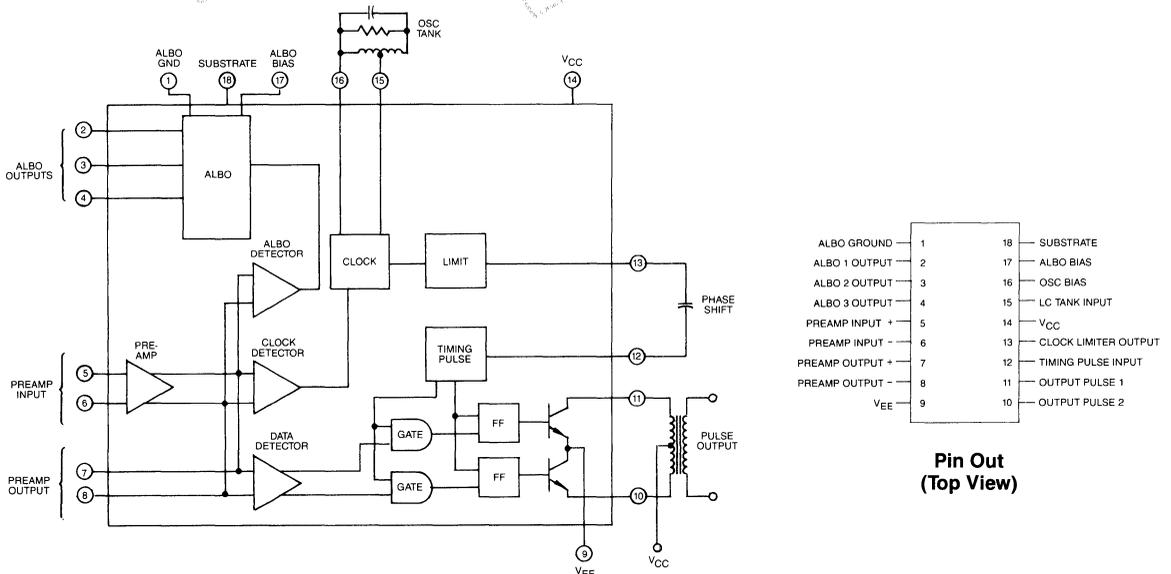
The SSI 22301 provides active circuitry to perform all functions of signal equalization and amplification, automatic line buildout (ALBO), threshold detection, clock extraction, pulse timing, and buffered output formation.

The SSI 22301 is supplied in an 18-lead dual-in-line plastic package (E suffix).

FEATURES

- Automatic line buildout
- 5.1V supply voltage
- Buffered output
- Second source for RCA CD22301
- Available Q285

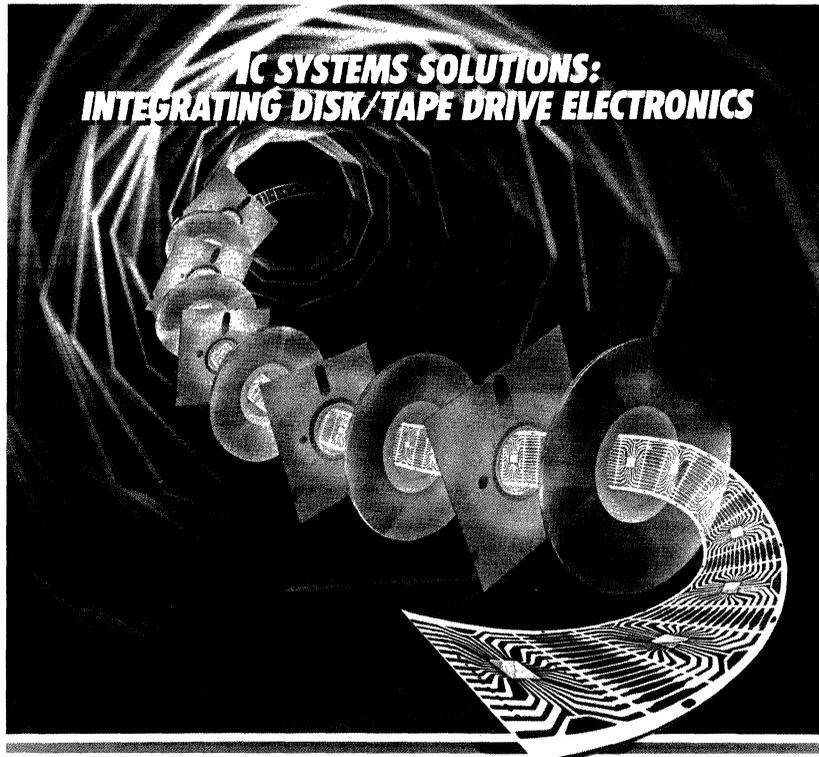
SSI 22301 Block Diagram



CAUTION: Use handling procedures necessary for a static sensitive component

Section 2

MICROPERIPHERAL PRODUCTS



MICROPERIPHERAL PRODUCTS

| Part No. | Circuit Function | No. of Channels | Power Supplies | Data Write/Read | Write Current Source | Read Gain | Page No. |
|----------|------------------|-----------------|----------------|-----------------|----------------------|-----------|----------|
|----------|------------------|-----------------|----------------|-----------------|----------------------|-----------|----------|

Ferrite Heads

| | | | | | | | |
|---------------|----------------|-------|-------------|-----------------------------|----------|-----------|------|
| SSI 101 | Servo Preamp | 1 | 8.3V/10V | — | — | 77 to 110 | 2-2 |
| SSI 104 | Read/Write Amp | 4 | + 6V, - 4V | Bi-Directional Differential | External | 22 to 46 | 2-4 |
| SSI 104L | Read/Write Amp | 4 | + 6V, - 4V | Bi-Directional Differential | External | 22 to 46 | 2-4 |
| SSI 108 | Read/Write Amp | 4 | + 6V, - 4V | Bi-Directional Differential | External | 22 to 46 | 2-4 |
| SSI 115 | Read/Write Amp | 2,4,5 | + 5V | Bi-Directional Differential | External | 26 to 52 | 2-14 |
| SSI 117 | Read/Write Amp | 2,4,6 | + 5V, + 12V | TTL Write Diff. Read | On-Chip | 80 to 120 | 2-20 |
| SSI 122 | Read/Write Amp | 4 | + 6V, - 4V | Bi-Directional Differential | External | 28 to 43 | 2-4 |
| SSI 501 | Read/Write Amp | 8 | + 5V, + 12V | TTL Write Diff. Read | On-Chip | 80 to 120 | 2-26 |
| *SSI 511/511R | Read/Write Amp | 2,4,6 | + 5V, + 12V | TTL Write Diff. Read | On-Chip | 80 to 120 | 2-86 |

Thin-Film Heads

| | | | | | | | |
|----------|----------------|---|-------------|------------------------|---------|------------|------|
| SSI 114 | Read/Write Amp | 4 | + 5V | Diff. Write Diff. Read | On-Chip | 75 to 170 | 2-32 |
| SSI 116 | Servo Preamp | 1 | 8.3V/10V | — | — | 200 to 310 | 2-36 |
| *SSI 521 | Read/Write Amp | 6 | + 5V, + 12V | TTL Write Diff. Read | On-Chip | 75 to 125 | 2-88 |

Data Path/Support Logic/Motor Control

| | | | | | | | |
|----------|----------------------------------|---|-------------|------------------------|---|---|------|
| *SSI 531 | Write Precomp/ Disk Separator | — | — | — | — | — | 2-92 |
| SSI 540 | Read Data Path | — | + 5V, + 12V | Diff. Write Diff. Read | — | — | 2-38 |
| SSI 545 | Support Logic | — | + 5V | — | — | — | 2-46 |
| SSI 590 | 2 Motor Speed Control | — | 12V | — | — | — | 2-66 |
| SSI 591 | 3 Motor Speed Control | — | 12V | — | — | — | 2-70 |

Tape Drive

| | | | | | | | |
|---------|-----------------------|---|---|---|---|---|------|
| SSI 550 | Mag Tape Read Circuit | 4 | — | — | — | — | 2-74 |
|---------|-----------------------|---|---|---|---|---|------|

Memory Products

| | | | | | | | |
|----------------|-----------------|---|---|---|---|---|------|
| SSI 67C401/402 | 64x4, 64x5 FIFO | — | — | — | — | — | 2-80 |
|----------------|-----------------|---|---|---|---|---|------|

Semicustom Circuits

| | | | | | | | |
|----------------|-------------------------------|---|----|---|---|---|-----|
| SSI 82C100/101 | Mask Programmable Logic Array | — | 5V | — | — | — | 3-6 |
|----------------|-------------------------------|---|----|---|---|---|-----|

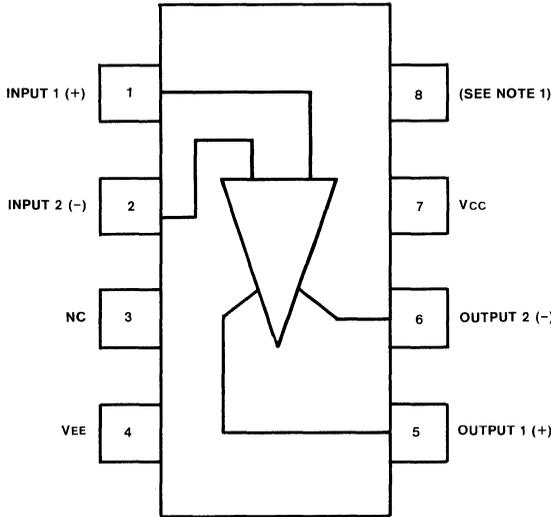
Floppy Disk Circuits

| | | | | | | | |
|---------|-------------------|-----|-------------|----------------------|----------|-----------------|------|
| SSI 570 | Read/Write System | 2 | + 5V, + 12V | — | On-Chip | 1000 Adjustable | 2-50 |
| SSI 575 | Read/Write | 2,4 | + 5V, + 12V | TTL Write Diff. Read | External | 80 to 120 | 2-56 |
| SSI 580 | Support Circuit | — | + 5V | — | — | — | 2-60 |

* Advanced Information

Data Sheet

Pin Configuration
(Top View)



General Description

The SSI 101A is a two stage differential amplifier applicable for use as a preamplifier for the magnetic servo head circuit of Winchester technology disk drives.

Features

- Very narrow gain range
- 30MHz bandwidth
- Electrically characterized at two power supply voltages: IBM Model 3340 compatible (8.3V) and standard OEM industry compatible (10V)
- Mechanically compatible with Model 3348 type head arm assembly
- Packaged in an 8 pin DIP

Absolute Maximum Ratings

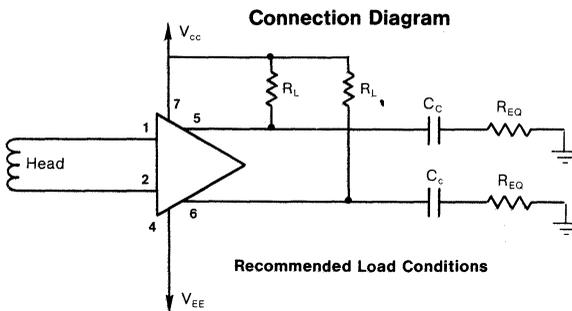
| | |
|--|----------------------------------|
| Power Supply Voltage ($V_{CC}-V_{EE}$) | 12V |
| Differential Input Voltage | $\pm 1V$ |
| Storage Temperature Range | $-65^{\circ}C$ to $150^{\circ}C$ |
| Operating Temperature Range | $0^{\circ}C$ to $70^{\circ}C$ |

Note 1 - Pin 8 can NOT be connected to any etch or any part of any circuit. It connects to circuitry internal to the IC and is used as a test point during manufacture.

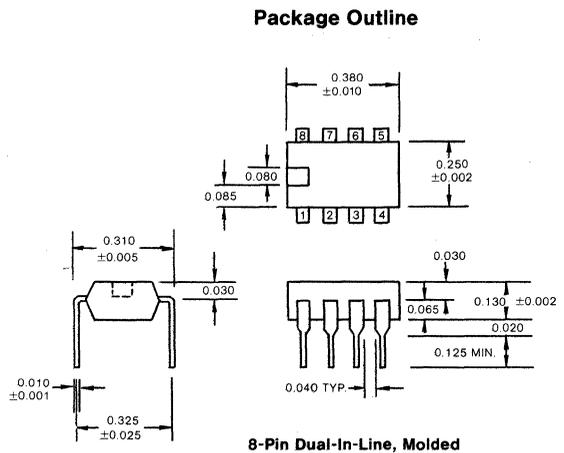
| ELECTRICAL CHARACTERISTICS | | $T_A = 25^{\circ}C, (V_{CC}-V_{EE}) = 8.3V \pm 10\%$ | | | |
|------------------------------------|---|--|-----------|------|----------------|
| Characteristics | Test Conditions | Min. | Typ. | Max. | Units |
| Gain (differential) | $R_p = 130\Omega$ | 77 | 93 | 110 | |
| Bandwidth (3 dB) | $V_i = 2mV$ (pp) | 10 | 30 | | MHz |
| Input Resistance | | 800 | 1000 | 1250 | Ω |
| Input Capacitance | | | 3 | | pF |
| Input Dynamic Range (Differential) | $R_L = 130\Omega, (V_{CC}-V_{EE}) = 8.3V$ | 3 | | | mV (p-p) |
| Power Supply Current | $(V_{CC}-V_{EE}) = 9.15V$ | | 26 | 35 | mA |
| Output Offset (Differential) | $R_s = 0, R_L = 130\Omega$ | | | 600 | mV |
| Equivalent Input Noise | $R_s = 0, R_L = 130\Omega, BW = 4MHz$ | | 8 | 14 | μV |
| PSRR, Input Referred | $R_s = 0, f \leq 5MHz$ | 50 | 65 | | dB |
| Gain Sensitivity (Supply) | $\Delta(V_{CC}-V_{EE}) = \pm 10\%, R_L = 130\Omega$ | | ± 1.3 | | % |
| Gain Sensitivity (Temp.) | $T_A = 25^{\circ}C$ to $70^{\circ}C, R_L = 130\Omega$ | | -0.2 | | %/ $^{\circ}C$ |
| CMRR, Input Referred | $f \leq 5MHz$ | 55 | 70 | | dB |

| ELECTRICAL CHARACTERISTICS | | $T_A = 25^\circ\text{C}, (V_{CC}-V_{EE}) = 10\text{V} \pm 10\%$ | | | |
|------------------------------------|--|---|-----------|------|---------------|
| Characteristics | Test Conditions | Min. | Typ. | Max. | Units |
| Gain (differential) | $R_p = 130\Omega$ | 77 | 93 | 110 | |
| Bandwidth (3 dB) | $V_i = 2\text{mV (pp)}$ | 10 | 30 | | MHz |
| Input Resistance | | 800 | 1000 | 1250 | Ω |
| Input Capacitance | | | 3 | | pF |
| Input Dynamic Range (Differential) | $R_L = 130\Omega, (V_{CC}-V_{EE}) = 10\text{V}$ | 3 | | | mV (p-p) |
| Power Supply Current | $(V_{CC}-V_{EE}) = 11\text{V}$ | | 30 | 40 | mA |
| Output Offset (Differential) | $R_S = 0, R_L = 130\Omega$ | | | 600 | mV |
| Equivalent Input Noise | $R_S = 0, R_L = 130\Omega, \text{BW} = 4\text{MHz}$ | | 8 | 14 | μV |
| PSRR, Input Referred | $R_S = 0, f \leq 5\text{MHz}$ | 50 | 65 | | dB |
| Gain Sensitivity (Supply) | $\Delta(V_{CC}-V_{EE}) = \pm 10\%, R_L = 130\Omega$ | | ± 1.3 | | % |
| Gain Sensitivity (Temp.) | $T_A = 25^\circ\text{C} \text{ to } 70^\circ\text{C}, R_L = 130\Omega$ | | -0.2 | | %/°C |
| CMRR, Input Referred | $f \leq 5\text{MHz}$ | 55 | 70 | | dB |

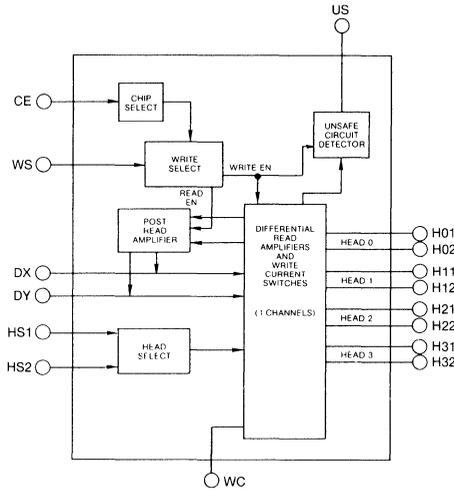
| Recommended Operating Conditions | Min. | Typ. | Max. | Units |
|------------------------------------|-------------|-------------|--------------|---------|
| Supply Voltage ($V_{CC}-V_{EE}$) | 7.45 9.0 | 8.3 10.0 | 9.15 11.0 | V V |
| Input Signal V_i | | 2 | | mV (pp) |
| Ambient Temp. T_A | 0 | | 70 | °C |



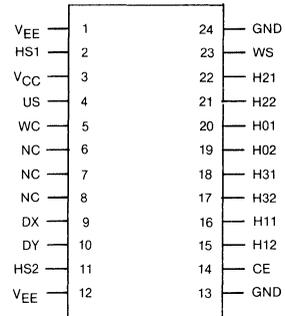
1. Input must be AC coupled
2. C_c 's are AC coupling capacitors
3. R_L 's are DC bias and termination resistors (recommended 130 Ω)
4. R_{EO} represents equivalent load resistance
5. For gain calculations $R_p = \frac{R_L \cdot R_{EO}}{R_L + R_{EO}}$
6. Differential gain = 0.72 R_p ($\pm 18\%$) (R_p in ohms)
7. Ceramic capacitors (0.1 μf) are recommended for good power supply noise filtering



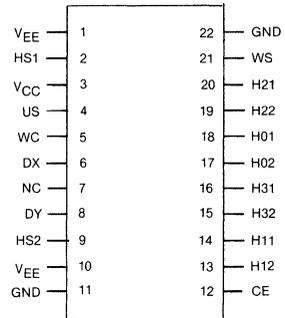
Data Sheet



Block Diagram



SSI 104/108 Pin Out



SSI 122 Pin Out

FEATURES

- IBM 3350 compatible performance.
- IBM compatible power supply voltages and logic levels.
- Four read/write channels.
- Safety circuits

DESCRIPTION

The SSI 104 is a monolithic bipolar integrated circuit, for use in high performance disk drive systems where it is desirable to locate the control circuitry directly on the data arm. Each circuit controls four heads and has three modes of operation: Read, Write and Idle.

The 104L is a low-noise version of the 104 with all

other parameters identical. Both are packaged in a 24 pin flat pack.

The SSI 108 and 122 are identical in performance to the 104. The 108 is packaged in a 24 pin dip package while the 122 is packaged in a 22 pin dip.

4-Channel Read/Write Circuit SSI 104, 104L, 108, 122

CIRCUIT OPERATION

WRITE MODE

In the write mode, the circuit functions as a current gate. Externally supplied write current is gated by the state of the head select and data inputs to one side of one head. Head voltage swings are monitored by the head transition detect circuit. Absence of proper head voltage swings, indicating an open or short on either side of the head or absence of write current, will cause a fault current to flow into the unsafe pin.

READ MODE

In the read mode, the circuit functions as a low noise differential amplifier. The state of the head select inputs determines which amplifier is active. Data is differentially read from one of four heads and an open collector differential signal is put across the Data X and Data Y pins. If a fault condition exists such that

write current is applied to the chip when the chip is in read mode, the write current will be drawn from the unsafe pin and the fault will be detected.

ABSOLUTE MAXIMUM RATINGS

| | |
|---|------------------------------------|
| Positive Supply Voltage V_{CC} | 7.0V |
| Negative Supply Voltage, V_{EE} | -5.5V |
| Operating Junction Temperature | 0°C to 110°C |
| Storage Temperature | -65°C to 150°C |
| Input Voltages | |
| Head Select (HS) | $V_{EE} - 0.3V$ to $+ 0.3V$ |
| Unsafe (US) | -0.3V to $V_{CC} + 0.5V$ |
| Write Current (WC) | $V_{EE} - 2$ to $0.3V$ |
| Data (Dx, Dy) | $V_{EE} - 0.3V$ to $0.3V$ |
| Chip Enable (CE) | $V_{EE} - 0.3V$ to $V_{CC} + 0.5V$ |
| Write Select (WS) | -0.3V to $V_{CC} + 0.3V$ |

ELECTRICAL CHARACTERISTICS Unless otherwise specified, $5.7 \leq V_{CC} \leq 6.7$, $-4.2 \leq V_{EE} \leq -3.8$, $0 \leq T, \leq 110^\circ\text{C}$.

POWER SUPPLY

ALL UNITS

| Parameter | Test Conditions | Min. | Max. | Units |
|-------------------------------|-----------------|------|----------|-------|
| Positive Supply Current (ICC) | Read/Write | 11.5 | 23 | mA |
| Positive Supply Current (ICC) | Idle | | 75 + ICE | mA |
| Negative Supply Current (IEE) | Read/Write | | 70 | mA |
| Negative Supply Current (IEE) | Idle | | 52 | mA |

LOGIC SIGNALS

| Parameter | Test Conditions | Min. | Max. | Units |
|----------------------------------|---|----------------|---------------------|----------------|
| Chip Enable Low Voltage (VLCE) | Read/Write | 0.0 | 0.7 | V |
| Chip Enable High Voltage (VHCE) | Idle | $V_{CC} - 1.0$ | $V_{CC} + 0.3$ | V |
| Chip Enable Low Current (ILCE) | $V_{CE} = 0.0V$ | -1.45 | -0.47 | mA |
| Chip Enable High Current (IHCE1) | $V_{CE} = V_{CC} - 1.0$ | -350 | -100 | μA |
| Chip Enable High Current (IHCE2) | $V_{CE} = V_{CC} + .3V$ | | +100 | μA |
| Write Select High Voltage (VHWS) | Write/Idle | 3.2 | 3.8 | V |
| Write Select Low Voltage (VLWS) | Read/Idle | -0.1 | 0.1 | V |
| Write Select High Current (IHWS) | Write/Idle, $V_{WS} = 3.8V$ Transition unsafe current off Transition unsafe on | 0.6 0.6 | 3.2 4.2 | mA mA |
| Write Select Low Current (ILWS) | Read/Idle, $V_{WS} = 3.8V$ | | 0.1 | mA |
| Head Select High Voltage (VHHS) | | -1.12 | -0.72 | V |
| Head Select Low Voltage (VLHS) | | -2.38 | -1.51 | V |
| Head Select High Current (IHHS) | | | 240 | μA |
| Head Select Low Current (ILHS) | | | 60 | μA |
| Total Head Input Current | Sum of all head input currents with $I_{WC} = 0$ Write, $V_{CT} = 3.5V$ Read, $V_{CT} = 0.0V$ Idle | | 3.7 0.16 1.25 | mA mA mA |

READ MODE

| Parameter | Test Conditions | Min. | Max. | Units |
|--------------------------------|--|-------|-------|-------|
| Differential Gain | Vin = 1mV p-p, 0VDC, f = 300kHz Tj = 22°C Tj = 0°C Tj = 110°C | 28 | 43 | V/V |
| | | 28 | 46 | V/V |
| | | 22.2 | 43 | V/V |
| | | | | |
| Common Mode Rejection Ratio | Vin = 100mVpp, 0VDC, f ≤ 5MHz | 45 | | dB |
| Power Supply Rejection Ratio | Vin = 0V, f ≤ 5MHz ΔVCC or ΔVEE = 100mVpp | 45 | | dB |
| Bandwidth | Zin = 0Ω, Vin = 1mVPP, f midband = 300kHz | 30 | | MHz |
| Input Noise | Vin = 0V, Zin = 0Ω, Power Bandwidth = 15MHz | | 9.3 | μVRMS |
| Input Noise (104L) | Vin = 0V, Zin = 0Ω, Power Bandwidth = 15MHz | | 6.6 | μVRMS |
| Input Current | Vin = 0V | | 26 | μA |
| Differential Input Capacitance | Vin = 0V | | 23.5 | pF |
| Differential Input Resistance | Vin = 0V Tj = 22°C Tj = 0°C Tj = 110°C | 585 | 915 | Ω |
| | | 565 | 915 | Ω |
| | | 585 | 1070 | Ω |
| | | | | |
| Output Offset Voltage | Zin = 0 | | 120 | mV |
| Common Mode Output Voltage | Vin = 0 | -0.78 | -0.32 | V |
| Unsafe Current | Write Current = 0mA Write Current = -45mA | 40 | 0.1 | mA |
| | | | 45 | mA |
| Dynamic Range | DC input voltage where AC gain falls to 90% of 0VDC input value. (Measured with 0.5mVpp AC input, Tj = 30°C) | 2.0 | | mVp |
| Channel Separation | Vin = 1mVpp, 0VDC, f = 5MHz 3 channels driven | 40 | | dB |

WRITE MODE

| Parameter | Test Conditions | Min. | Max. | Units |
|----------------------------|--|-----------|-----------|-------|
| Differential Input Voltage | | 0.175 | | V |
| Single Ended Input Voltage | | -0.68 | -0.45 | V |
| Write Current | | -45 | | mA |
| Current Gain | IWC = -45mA | 0.95 | 1.0 | |
| Write Current Voltage | IWC = -45mA | VEE+0.25 | VEE+1.0V | V |
| Unsafe Voltage | IUS = +45mA | 4 | VCC+.3 | V |
| Head Center Tap Voltage | | 3.2 | 3.8 | V |
| Differential Head Voltage | IWC = -45mA, Lh = 10μH | 5.7 | 7.2 | Vp |
| Single Ended Head Voltage | IWC = -45mA, Unselected heads at 3.5V Selected Side of Selected Head Current = 0mA = 90mA | 0.0 | 0.9 | V |
| | | 1.4 + VCC | 3.7 + VCC | V |
| | | | | |
| Unsafe Current | IWC = -30mA, f = 2MHz; Lh = 9μH VUS = 5.0V - 6.3V, Lh = 0 IWC = 45mA, Rh = ∞ one side of head only | 15 | 1.0 | mA |
| | | | 45 | mA |
| | | 15 | 45 | mA |
| Unselected Head Current | IWC = -45mA, f = 2MHz, Lh = 9.5μH | | 2.0 | mAp |
| DX DY Input Current | | -2.0 | 2.0 | mA |

silicon systems

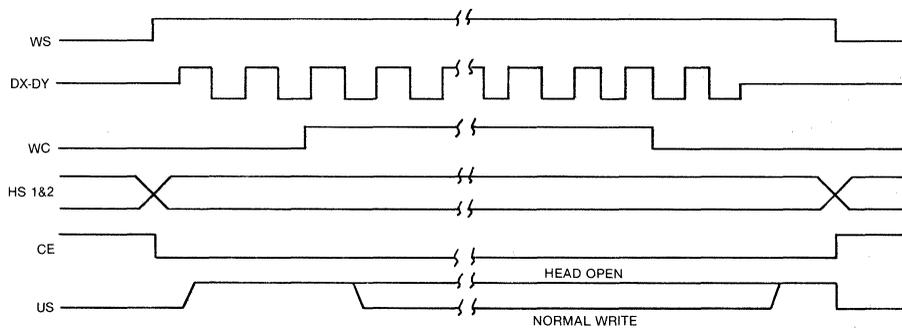
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SWITCHING CHARACTERISTICS

| Parameter | Test Conditions | Min. | Max. | Units |
|------------------------------------|---|----------|----------|--------------------|
| Idle to Read/Write Transition Time | | — | 0.5 | μ S |
| Read/Write to Idle Transition Time | | — | 0.5 | μ S |
| Read to Write Transition Time | | — | 0.5 | μ S |
| Write to Read Transition Time | | — | 0.5 | μ S |
| Head Select Switching Delay | | — | 50.0 | nS |
| Head Current Transition Time | IWC = -45mA, Lh = 0, f = 5MHz | — | 15 | nS |
| Head Current Switching Delay Time | IWC = -45mA, Lh = 0, f = 5MHz | — | 15 | nS |
| Head Current Switching Hysteresis | IWC = -45mA, Lh = 0, f = 5MHz Data rise and fall time \leq 1nSec | — | 2 | nS |
| Unsafe Switching Delay Time | IWC = -30mA, f = 2MHz; Lh = 9 μ H Lh = 0 μ H | — 0.8 | 1 5.1 | μ S μ S |

HEAD SELECT TABLE

| Head Selected | HS1 | HS2 |
|---------------|-----|-----|
| 0 | 1 | 1 |
| 1 | 0 | 1 |
| 2 | 1 | 0 |
| 3 | 0 | 0 |



WRITE MODE SYSTEM TIMING

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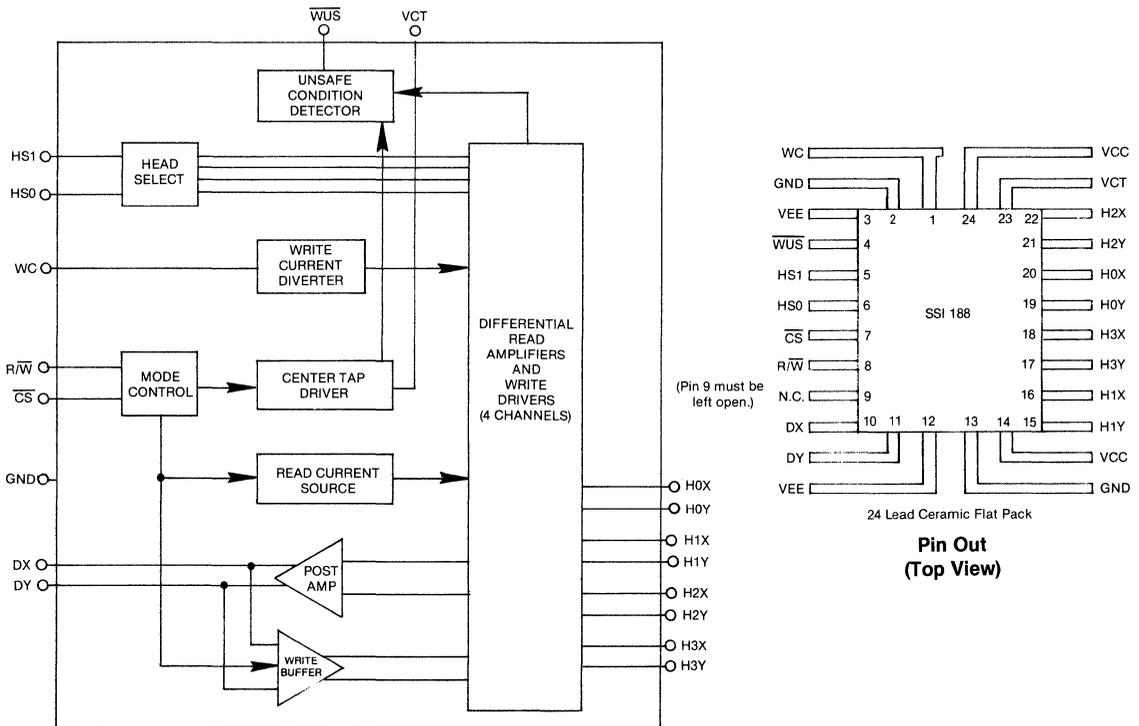
Preliminary Data Sheet

GENERAL DESCRIPTION

The SSI 188 is a high-performance, bipolar integrated read/write circuit for use with center tapped, ferrite heads. It provides a low noise read path, write control circuitry and data protection circuitry for 4 channels. The SSI 188 requires +6.5 V and -5.2 V power supplies. It is available in a 24 pin flat pack.

FEATURES

- Fast switching characteristics
- TTL compatible control signals
- Four head capacity
- Designed for center-tapped ferrite heads
- Includes write unsafe detection
- Easily multiplexed



CAUTION: Use handling procedures necessary for a static sensitive component

SSI 188

4-Channel

Read/Write Circuit

Circuit Operation

The SSI 188 has 3 selectable modes of operation as illustrated in Table 2. The $\overline{R/W}$ and \overline{CS} inputs which determine these modes have internal resistor pullups to prevent an accidental write condition. Depending on the mode selected, the chip performs as a write gate or read amplifier for the selected head. Table 3 shows proper head addressing. In the Idle mode all inputs and outputs are in a high-impedance state, except the WC pin which is diverted to GND.

Write Mode

In this mode, externally supplied write current is gated to the "X" side of the chosen head when the DX input is low and to the "Y" side when DY is low. The write unsafe detector is activated when the SSI 188 is in the write mode. A low on the \overline{WUS} pin indicates one of the following unsafe conditions:

- Head open or shorted
- No write current
- No write data transitions

During a normal write cycle the pin is initially low and then goes high after the differential input makes two transitions. Two transitions are also needed to clear \overline{WUS} after a fault condition.

Read Mode

The SSI 188 amplifies the differential signal on the addressed head when in the read mode. The amplified signal is output on the open-collector DX and DY pins, with a gain dependent on external resistors tied from each pin to ground. The nominal values listed in this data sheet were obtained with 50 ohm resistors and can be doubled by using 100 ohm resistors. Polarity is such that the DX output is more positive when the "X" side of the head is more positive. External gating of the write current source is not necessary because an on-chip diverter circuit prevents the write current from flowing in the head circuits during the read and idle modes.

Table 1: Pin Descriptions

| Symbol | Name — Description |
|------------------|---|
| HS0 - HS1 | Head Select: selects up to four heads |
| \overline{CS} | Chip Select: a low level enables device |
| $\overline{R/W}$ | Read/Write: a high level selects Read mode |
| \overline{WUS} | Write Unsafe: open collector output, low indicates unsafe condition |

Table 1: Pin Descriptions

| Symbol | Name — Description |
|--------------------|---|
| HOX-H3X HOY-H3Y | X, Y head connections |
| DX, DY | X, Y Read/Write Data: differential read data in/write data out signal |
| WC | Write Current: External write current generator connected to this pin |
| VCT | Voltage Center Tap: voltage source for head center tap |
| VCC | + 6.5V. |
| VEE | - 5.2V. |
| GND | Ground |

Table 2: Mode Select

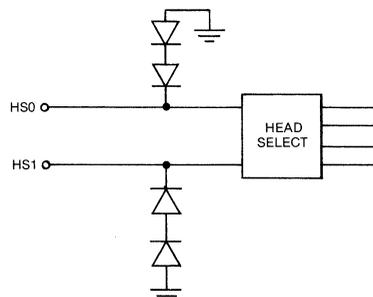
| \overline{CS} | $\overline{R/W}$ | MODE |
|-----------------|------------------|-------|
| 0 | 0 | Write |
| 0 | 1 | Read |
| 1 | X | Idle |

Table 3: Head Select

| HS1 | HS0 | HEAD |
|-----|-----|------|
| 0 | 0 | 0 |
| 0 | 1 | 1 |
| 1 | 0 | 2 |
| 1 | 1 | 3 |

Temperature Monitoring

Two sets of series diodes are included on the chip for junction temperature monitoring. Between both the HS0 and HS1 pads to GND, two diodes are connected in series as shown in the figure below.

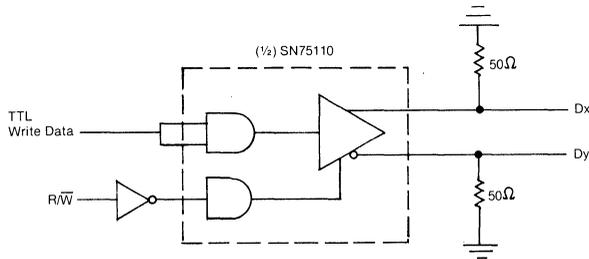
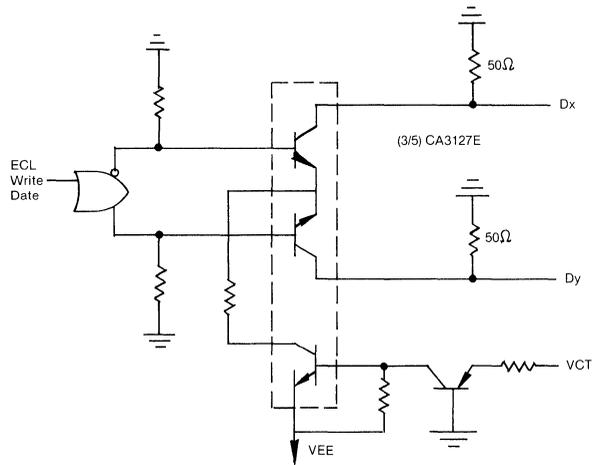
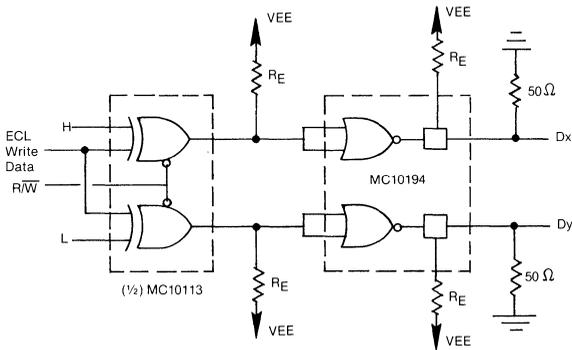


To calibrate the diodes remove power from the SSI 188, pull down on the HS0 or HS1 pin with a constant current and measure the diode forward bias voltage as the temperature is varied. To monitor temperature measure the diode forward bias voltage in either read or write

mode and compare to the previously determined calibration curve.

Applications

These circuits are suggested for interfacing the differential DX and DY lines and either ECL or TTL data.



Absolute Maximum Ratings* (All voltages referenced to GND)

| | |
|-------------------------------------|------------------------|
| DC Supply Voltages (VCC) | 7.5 V DC |
| (VEE) | -6.0 V DC |
| Digital Input Voltage Range | -0.3 to VCC + 0.3 V DC |
| Head Input (Read Mode) | -0.6 to 0.4 V DC |
| Head Select (HS0, HS1) | -0.4 V (or -2mA) |
| | to VCC + 0.3 V DC |
| \overline{WUS} Port Voltage Range | -0.4 to VCC + 0.3 V DC |
| Write Current (Iw) | -80 mA |

| | |
|---|-------------------|
| Output Currents (VCT) | -80 mA |
| (\overline{WUS}) | 10 mA |
| DX, DY Voltage | -0.1 to +0.3 V DC |
| Differential Voltage $ V_{R/W} - V_{CS} $ | 6.5 V DC |
| Storage Temperature Range (Tstg) | -65 to +150 °C |
| Junction Temperature Range (Tj) | +25 to +125 °C |
| Lead Temperature (10 sec soldering) | 260 °C |

*Operation above these ratings may cause permanent damage to the device.

Recommended Operating Conditions

| | | | |
|-------------------|------------|-----------------------|-----|
| DC Supply Voltage | VCC VEE | 6.5 ± 5% -5.2 ± 5% | VDC |
| Head Inductance | Lh | 1.5 to 15 | H |
| Write Current | Iw | 35 to 70 | mA |

DC Characteristics

Unless otherwise specified: VCC = 6.5 ± 5%, VEE = -5.2 ± 5%, +25°C < Tj < +125°C.

| Parameter | Test Conditions | Min. | Max. | Units |
|---|---|-------------------|--------------------------------|-----------|
| VCC Supply Current | Read Mode Idle Mode Write Mode | — — — | 80 35 40 + Iw | mA |
| VEE Supply Current | Idle Mode Read Mode Write Mode | -20 -75 -30 | — — — | mA |
| Digital Inputs (HS0, HS1, R/W, CS) | | | | |
| Input Low Voltage (V _{IL}) | — | — | 0.8 | VDC |
| Input High Voltage (V _{IH}) | — | 2.0 | — | VDC |
| Head Select: | | | | |
| Input Low Current | V _{IL} = 0.8V | -0.1 | 0.2 | mA |
| Input High Current | V _{IH} = 2.0V | -0.1 | 0.2 | mA |
| Chip Select and Read/Write: | | | | |
| Input Low Current | V _{IL} = 0.8V | -1.6 | -0.1 | mA |
| Input High Current | V _{IH} = 2.0V | -1.4 | -0.1 | mA |
| WUS Output V _{OL} I _{OH} | I _{OL} = 8mA V _{OH} = 5.0V | — -100 | 0.5 100 | VDC μA |
| Center Tap Voltage (V _{CT}) | Read Mode Write Mode | | 0.0 (typical) 4.2 (typical) | VDC |

Write Characteristics

Unless otherwise specified: VCC = 6.5 ± 5%, VEE = -5.2V ± 5%, Iw = 70mA, Lh = 1.8μH, Rd = 230 ohms

| Parameter | Test Conditions | Min. | Max. | Units |
|---------------------------------|------------------|------|------|---------|
| Write Current Range | — | 35 | 70 | mA |
| Current Gain | Head Current/Iwc | 0.95 | 1.01 | — |
| Differential Head Voltage Swing | — | 10.5 | — | V(pk) |
| Unselected Diff. Head Current | — | — | 3 | mA (pk) |
| Data Input Capacitance | per side to GND | — | 10 | pF |
| Data Input Resistance | — | 5 | — | kΩ |
| WC Voltage | — | -4.5 | -0.5 | V |
| Differential Data Input Voltage | — | 300 | — | mV |
| Data Input Voltage Range | — | -0.8 | +0.1 | V |
| Data Input Current | per side | — | 100 | μA |

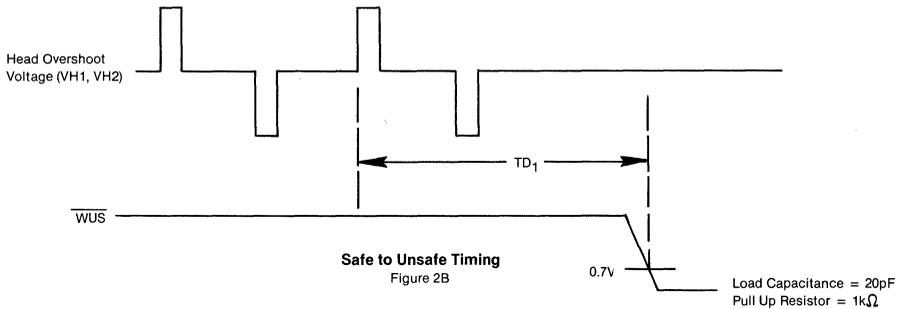
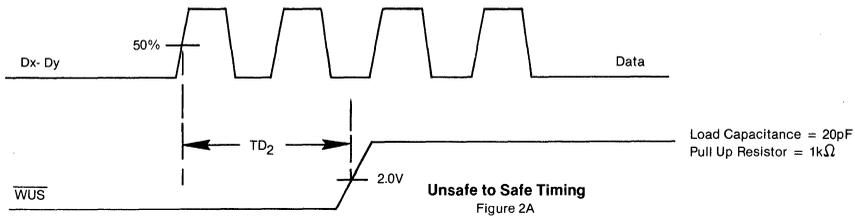
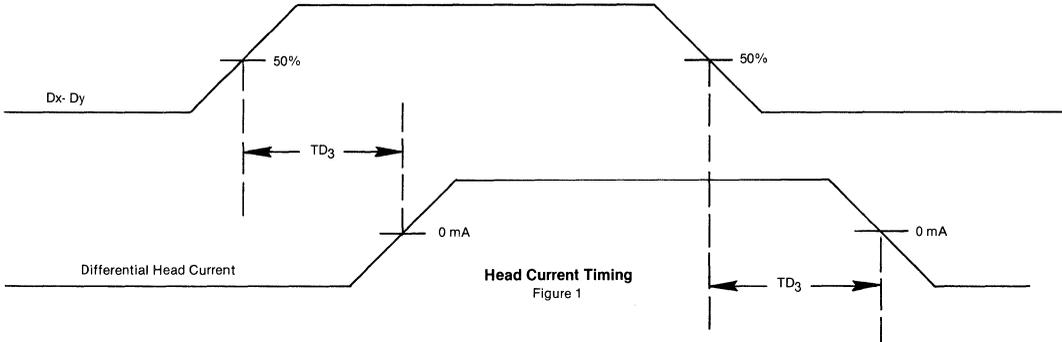
Read Characteristics Unless otherwise specified: VCC = 6.5 ± 5%, VEE = -5.2V ± 5%, Lh = 1.8μH, Rd = 230Ω, f(Data) = 5MHz, RL (DX,DY) = 50Ω to GND (Vin is referenced to VCT)

| Parameter | Test Conditions | Min. | Max. | Units |
|---------------------------------|---|------|------------|------------------|
| Differential Voltage Gain | Vin = 1mVpp @ 300 kHz | 25 | 60 | V/V |
| Dynamic Range | DC Input Voltage, Vi, Where Gain Falls by 10%. Vin = Vi + 0.5mVpp @ 300kHz | -2 | 2 | mV |
| Bandwidth (-3db) | I Zs I < 5Ω , Vin = 1mVpp | 48 | — | MHz |
| Input Noise Voltage | Bw = 15 MHz, Vin = 0.0 VDC, Lh = 0, Rh = 0 Lh = 0, Rh = 115Ω per side | — | 2.4 3.3 | nV/√Hz nV/√Hz |
| Differential Input Capacitance | Vin = 0.0 VDC | — | 18 | pF |
| Differential Input Resistance | V = 0.0 VDC | 1.5 | — | kΩ |
| Input Bias Current (per side) | Vin = 0.0 VDC | — | 100 | μA |
| Common Mode Rejection Ratio | Vcm = 100mVpp @ 12MHz | 45 | — | dB |
| Power Supply Rejection Ratio | 100mVpp on VCC or VEE | 45 | — | dB |
| Channel Separation | Unselected Channels: Vin = 100mVpp @ 12MHz and Selected Channel: Vin = 0mVpp | 34 | — | dB |
| Input Offset Voltage | — | -10 | +10 | mV |
| Common Mode Output Voltage | — | -1.3 | -0.2 | V |
| Single Ended Output Resistance | — | 5 | — | kΩ |
| Single Ended Output Capacitance | — | — | 10 | pF |
| WC Voltage | IWC = 70mA | -3.2 | -0.4 | VDC |
| Total Head Input Current (IVCT) | IWC = 0 | -500 | +500 | μA |

Switching Characteristics Unless otherwise specified; VCC = 6.5 ± 5%, VEE = -5.2V ± 5%, Tj = 25°C, IW = 70mA, Lh = 1.8μH, Rd = 230Ω, f(Data) = 5MHz.

| Parameter | Test Conditions | Min. | Max. | Units |
|--|---|-------------|---------------|----------------|
| R/W: R/W to Write R/W to Read | Delay to 90% of Write Current Delay to 90% of 100mV 10MHz Read Signal Envelope or to 90% Decay of Write Current | — | 0.6 0.6 | μS μS |
| CS: CS to Select CS to Unselect | Delay to 90% of Write Current or to 90% of 100mV 10MHz Read Signal Envelope Delay to 90% Decay of Write Current | — | 0.6 0.6 | μS μS |
| HS0 HS1 to any Head HS2 | Delay to 90% of 100mV 10MHz Read Signal Envelope | — | 0.25 | μS |
| WUS: Safe to Unsafe — TD1 Unsafe to Safe — TD2 | Iw = 70mA Iw = 35mA | 0.4 — | 4.0 1.0 | μS |
| Head Current: Prop Delay — TD3 Asymmetry Rise/Fall Time | Lh = 0 H, Rh = 25 ohms per side From 50% Points 2 nS Max Input Switching 10% — 90% Points | — — — | 19 2 15 | nS nS nS |

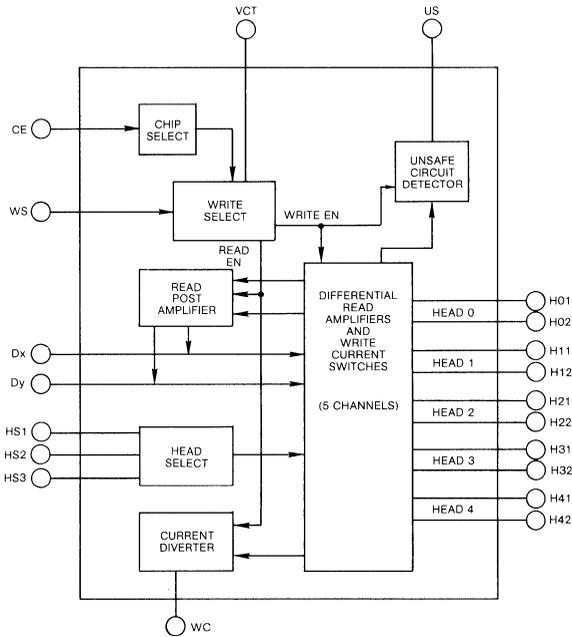
Timing Diagrams



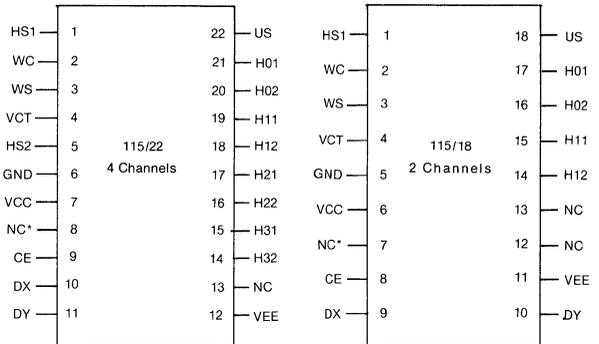
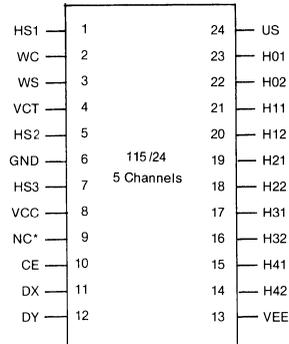
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Data Sheet



SSI 115 Block Diagram



**SSI 115 Pin Out
(Top View)**

* do not connect to any etch or any part of any circuit.

FEATURES

- Electrically compatible with 8 inch and 5-1/4 inch Winchester disk drive magnetic recording heads.
- Supports up to five recording heads per circuit.
- Detects and indicates unsafe write conditions.
- On-chip current diverter eliminates the need for

external write current switching.

- Control signals are TTL compatible.
- Operates on standard +5 volt and -5 volt (or -5.2 volt) power sources.

DESCRIPTION

The SSI 115 is a monolithic bipolar integrated circuit designed for use with 8 inch and 5-1/4 inch Winchester disk drive magnetic recording heads. The circuit interfaces with up to five magnetic recording heads providing the required read/write electronic functions as well as various control and data protect functions. The

circuit operates on +5 volt and -5 volt (or -5.2 volt) power and is available in a variety of packages. The 115/24 is a 5 channel circuit available in both flatpack and dip packages. The 115/22 is a 4 channel circuit packaged in a 22 pin dip and the 115/18 is a 2 channel circuit offered in a 18 pin dip package.

SSI 115

Winchester

Read/Write Circuit

CIRCUIT OPERATION

WRITE MODE

With both the chip enable and write select signals activated, the SSI 115 is switched to the write mode and the circuit operates as a differential current switch. The center tap head voltage (VCT) is turned on, the unsafe circuit detector is activated, and the current diverter is disabled. The head select signals (HS1, HS2, HS3) select one of five differential current switches. The selected current switch senses the polarity of the data input signal (Dx—Dy) and gates write current to the corresponding side of the head (HN1 or HN2). Head overshoot voltages that occur during normal write operation are sensed to determine safe or unsafe head circuit conditions. The detector senses the following unsafe conditions—no data transitions, head open, or no write current.

READ MODE

With chip enable active and write select disabled, the SSI 115 is switched to the read mode and the circuit operates as a differential amplifier. The center tap head voltage is turned off, the unsafe circuit detector is deactivated, and the write current diverter is enabled. The differential head input signal (HN1—HN2), selected by the head select signals, is amplified by a differential read amplifier and appears as a differential output signal on the data lines (Dx, Dy).

During the read and idle modes, the on-chip current diverter circuit prevents write current from flowing in the head circuits. Therefore, external gating of the write current source is not required.

ABSOLUTE MAXIMUM RATINGS

| | |
|--------------------------------------|----------------|
| Positive Supply Voltage, VCC | 6V |
| Negative Supply Voltage, VEE | −6V |
| Write Current (IWC) | 70 mA |
| Operating Junction Temperature | 25°C to 135°C |
| Storage Temperature | −65°C to 150°C |
| Lead Temperature (Soldering, 10 SEC) | 260°C |

Input Voltages

| | |
|--|--------------------|
| Head Select (HS) | −0.4V to VCC +0.3V |
| Unsafe (US) (IHUS ≤ 15mA) | −0.3V to VCC +0.3V |
| Write Current (WC) Voltage in read idle modes. (Write mode must be current limited to −70mA) | VEE −0.3V to 0.3V |
| Data (Dx, Dy) | VEE to 0.3V |
| Chip Enable (\overline{CE}) | −0.4V to VCC +0.3V |
| Write Select (WS) | −0.4V to VCC +0.3V |

RECOMMENDED OPERATING CONDITIONS

| | | | |
|-----|-------------|-----|-------|
| VCC | 5V | IWC | −45mA |
| VEE | −5V (−5.2V) | LH | 10μh |

ELECTRICAL CHARACTERISTICS Unless otherwise specified, $4.75 \leq VCC \leq 5.25V$, $-5.5V \leq VEE \leq -4.75V$
POWER SUPPLY $25^\circ C \leq T$ (Junction) $\leq 135^\circ C$.

| Parameter | Test Conditions | Min. | Max. | Units |
|-------------------------------|--|------|----------|-------|
| Total Power Dissipation (PD) | Write Mode, IWC ≤ 45mA, T _J ≥ 125°C | | 700 | mW |
| Positive Supply Current (ICC) | Read/Write Mode | | 35 + IWC | mA |
| Positive Supply Current (ICC) | Idle Mode | | 10 | mA |
| Negative Supply Current (IEE) | Read/Write Mode | −65 | | mA |
| Negative Supply Current (IEE) | Idle Mode | −10 | | mA |

LOGIC SIGNALS

| Parameter | Test Conditions | Min. | Max. | Units |
|---------------------------------|--------------------|------|------|-------|
| Chip Enable Low Voltage (VLCE) | Read or Write Mode | −0.3 | 0.8 | V |
| Chip Enable Low Current (ILCE) | VLCE = 0V | −2.4 | | mA |
| Chip Enable High Current (IHCE) | Idle Mode | −250 | | μA |
| Write Select Low Voltage (VLWS) | Write or Idle Mode | −0.3 | 0.8 | V |
| Write Select Low Current (ILWS) | VLWS = 0V | −3.2 | | mA |

LOGIC SIGNALS (Cont.)

| Parameter | Test Conditions | Min. | Max. | Units |
|---------------------------------------|--|------|------|---------------|
| Write Select High Current (IHWS) | Read or Idle Mode | -250 | | μA |
| Head Select High Level Voltage (VHHS) | | 2.0 | VCC | V |
| Head Select High Level Current (IHHS) | VHHS = VCC | | 100 | μA |
| Head Select Low Level Voltage (VLHS) | | -0.3 | 0.8 | V |
| Head Select Low Level Current (ILHS) | VLHS = 0V | -0.6 | | mA |
| Unsafe Low Level Voltage (VLUS)* | ILUS = 8mA (Denotes Unsafe Condition) | | 0.5 | V |
| Unsafe High Level Current (IHUS) * | VHUS = 5.0V (Denotes Safe Condition) | | 100 | μA |

*Note: Unsafe is an open collector output.

READ MODE: Tests performed with 50 load resistors from Dx and Dy to ground.

| Parameter | Test Conditions | Min. | Max. | Units |
|---|---|------|-------|---------------------|
| Input Common Mode Range | | -0.6 | 0.1 | V |
| Total Input Bias Current | $-0.6\text{V} \leq V_{in} \leq 0.1\text{V}$ | | 60 | μA |
| Differential Voltage Gain | $V_{in} = 1\text{mV}_{pp}$, $f = 300\text{kHz}$ | 26 | 52 | V/V |
| Voltage Bandwidth (-3dB) | $Z_s \leq 10\Omega$, $V_{in} = 1\text{mV}_{pp}$, $f_{\text{midband}} = 300\text{kHz}$ | 30 | | MHz |
| Input Noise Voltage | $Z_s = 0$, $V_{in} = 0\text{V}$, Power Bandwidth = 15MHz | | 7 | μV_{rms} |
| Differential Input Capacitance | $V_{in} = 0$, $f = 5\text{MHz}$ | | 20 | pF |
| Differential Input Resistance (Internal Damping Resistor) | $V_{in} = 0$, $f = 300\text{kHz}$ | 560 | 1070 | Ω |
| Output Offset Voltage | | | 120 | mV |
| Differential Head Current | $I_{WC} = 45\text{mA}$, $L_H = 10\mu\text{H}$, $f = 2\text{MHz}$ | | 2 | mA_p |
| Output Common Mode Voltage | | -0.4 | -.125 | V |
| Single Ended Output Resistance | $f = 300\text{kHz}$ | 10 | | $\text{k}\Omega$ |
| Single Ended Output Capacitance | | | 10 | pF |
| Dynamic Range | DC input voltage where the AC gain falls to 90% of its 0VDC input value (Measured with 0.5mVpp AC input voltage) | 2 | | mVp |
| Common Mode Rejection Ratio | $V_{in} = 100\text{mV}_{pp}$, 0VDC, $f = 5\text{MHz}$ | 50 | | dB |
| Power Supply Rejection Ratio | ΔV_{CC} or ΔV_{EE} , 100 mVpp, $f = 5\text{MHz}$ | 45 | | dB |
| Channel Separation | The 4 unselected channels are driven with $V_{in} = 100\text{mV}_{pp}$, $f = 5\text{MHz}$ | 45 | | dB |
| Write Current Voltage | $I_{WC} = 45\text{mA}$ | -2.7 | -0.5 | V |
| Total Head Input Current | $I_{WC} = 0$ | | 200 | μA |

WRITE MODE

| Parameter | Test Conditions | Min. | Max. | Units |
|--|---|------|---------|-----------------|
| Current Gain (IH/IWC) | IWC = 45mA, IH $\hat{=}$ Head Current | 0.95 | 1.0 | |
| Write Current Pin Voltage | IWC = 45mA | -3.7 | -1.5 | V |
| Center Tap Head Voltage (VCT) | IWC = 45mA | 3.0 | VCC-0.5 | V |
| Differential Head Voltage Swing | $3.0 \leq VCT \leq VCC - 0.5V$ IWC = 45mA, LH = 10 μ H | 5.7 | 7.7 | V |
| Differential Data Voltage (Dx-Dy) | | .175 | | V |
| Single Ended Data Input Voltage (Dx, Dy) | | -0.9 | 0.1 | V |
| Data Input Current | $-0.9 \leq VDx, VDy \leq 0.1$ | -10 | 50 | μ A |
| Data Input Differential Resistance | f = 300kHz | 5 | | k Ω |
| Data Input Capacitance | | | 10 | pF |
| Unselected Diff. Head Current | IWC = 45mA, LH = 10 μ H, f = 2MHz | | 2 | mA _p |
| Write Current Range | | 30 | 50 | mA |
| Total Head Input Current | IWC = 0 | | 500 | μ A |

IDLE MODE

| Parameter | Test Conditions | Min. | Max. | Units |
|---------------------------|---------------------------------------|------|------|-----------------|
| Write Current Pin Voltage | IWC = 45mA | VEE | | V |
| Differential Head Current | IWC = 45mA, LH = 10 μ H, f = 2MHz | | 2 | mA _p |
| Total Head Input Current | IWC = 0 | | 500 | μ A |

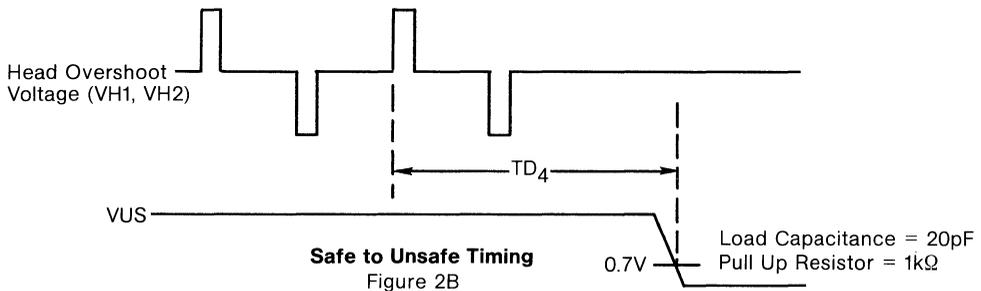
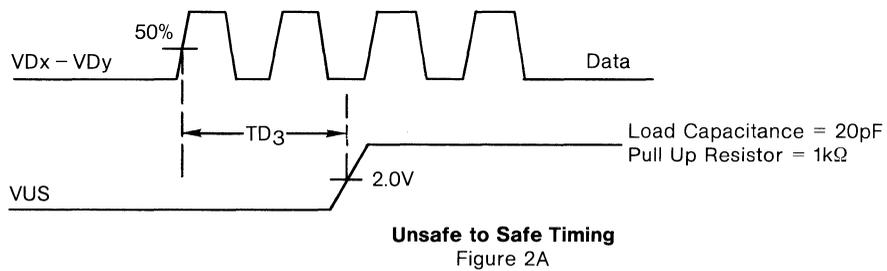
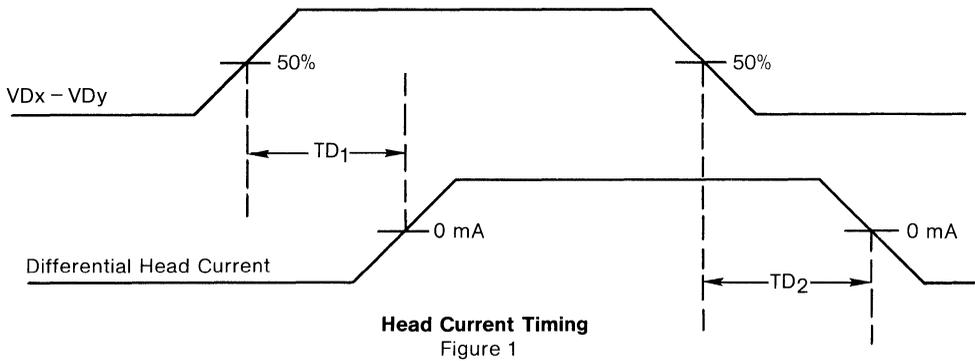
SWITCHING CHARACTERISTICS

| Parameter | Test Conditions | Min. | Max. | Units |
|--|--|------|------|---------|
| Idle to Read/Write Transition Time | | | 0.6 | μ S |
| Read/Write to Idle Transition Time | | | 0.6 | μ S |
| Read to Write Transition Time | $0 \leq VLCE \leq 0.8V$ (Circuit Enabled) | | 0.6 | μ S |
| Write to Read Transition Time | $0 \leq VLCE \leq 0.8V$ (Circuit Enabled) | | 0.6 | μ S |
| Head Select Switching Delay Time | | | 0.25 | μ S |
| Head Current Transition Time | (10% to 90% points) IWC = 45mA, LH = 0H, RH = 0 Ω | | 15 | nS |
| Head Current Switching Delay Time (TD ₁ , TD ₂) | IWC = 45mA, LH = 0H, RH = 0 Ω f = 5MHz (see figure 1) | | 19 | nS |
| Head Current Switching Hysteresis TH = (TD ₁ -TD ₂) | IWC = 45mA, LH = 0H, RH = 0 Ω f = 5MHz (VDx-VDy) Rise Time = 2nS (see figure 1) | | 3 | nS |
| Unsafe to Safe Delay After Write Data Begins (TD ₃) | IWC = 30mA, LH = 10 μ H f = 2MHz (see figure 2A) | | 1.0 | μ S |
| Safe to Unsafe Delay (TD ₄) | LH' = 10 μ H, f = 2MHz IWC = 45mA (see figure 2B) | 1.6 | 8.0 | μ S |

HEAD SELECT TABLE

| Head Selected | HS1 | HS2 | HS3 |
|---------------|-----|-----|-----|
| 0 | 0 | 0 | 0 |
| 1 | 1 | 0 | 0 |
| 2 | 0 | 1 | 0 |
| 3 | 1 | 1 | 0 |
| 4 | 0 | 0 | 1 |

Note: Invalid Head Select input codes (5, 6 and 7) have the effect of not selecting any heads.



Data Sheet

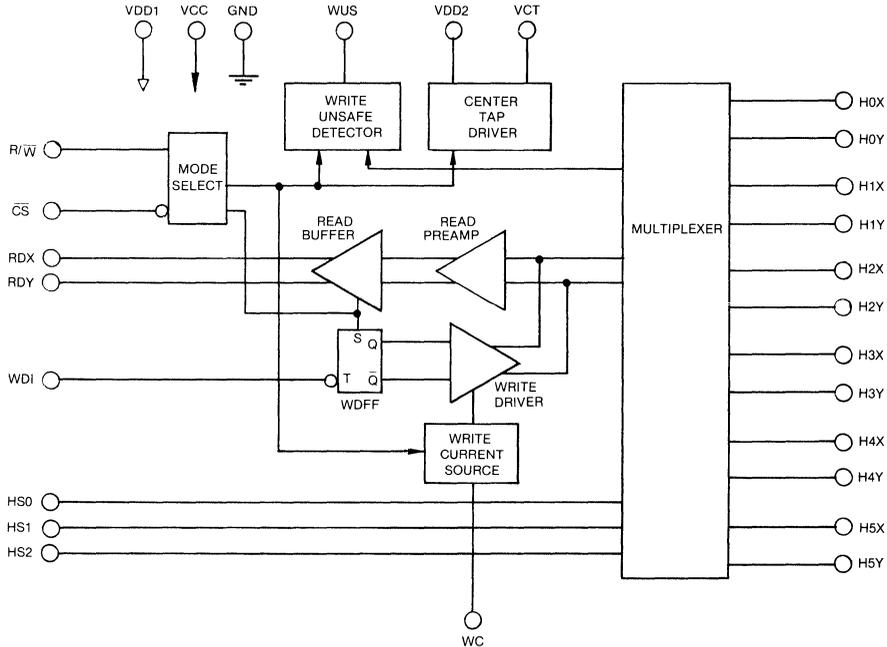
GENERAL DESCRIPTION

The SSI 117 devices are bipolar monolithic integrated circuits designed for use with center-tapped ferrite recording heads. They provide a low noise read path, write current control, and data protection circuitry for as many as six channels. The SSI 117 requires +5V and +12V power supplies and is available in 2, 4, or 6 channel versions with a variety of packages.

FEATURES

- +5V, +12V power supplies
- Single- or multi-platter Winchester drives
- Designed for center-tapped ferrite heads
- Programmable write current source
- Available in 2, 4, or 6 channels
- Easily multiplexed for larger systems
- Includes write unsafe detection
- TTL compatible control signals

SSI 117 Block Diagram



CAUTION: Use handling procedures necessary
 for a static sensitive component

SSI 117 – Series 2, 4, or 6-Channel Read/Write Circuits

Circuit Operation

The SSI 117 functions as a write driver or as a read amplifier for the selected head. Head selection and mode control are described in Tables 2 & 3. Both $\overline{R/W}$ and \overline{CS} have internal pull up resistors to prevent an accidental write condition.

WRITE MODE

The Write mode configures the SSI 117 as a current switch and activates the Write Unsafe Detector. Head current is toggled between the X- and Y-side of the recording head on the falling edges of WDI, Write Data Input. Note that a preceding read operation initializes the Write Data Flip Flop, WDFF, to pass current through the X-side of the head. The magnitude of the write current, given by

$$I_w = K/R_{wc}, \text{ where } K = \text{Write Current Constant}$$

is set by the external resistor, R_{wc} , connected from pin WC to GND.

Any of the following conditions will be indicated as a high level on the Write Unsafe, WUS, open collector output.

- Head open
- Head center tap open
- WDI frequency too low
- Device in Read mode
- Device not selected
- No write current

After the fault condition is removed, two negative transitions on WDI are required to clear WUS.

READ MODE

In the Read mode the SSI 117 is configured as a low noise differential amplifier, the write current source and the write unsafe detector are deactivated, and the write data flip flop is set. The RDX and RDY outputs are driven by emitter followers and are in phase with the "X" and "Y" head ports.

Note that the internal write current source is deactivated for both the Read and the chip deselect mode. This eliminates the need for external gating of the write current source.

TABLE 1: PIN DESCRIPTIONS

| Symbol | Name — Description |
|------------------------|--|
| HS0 - HS2 | Head Select: selects up to six heads |
| \overline{CS} | Chip Select: a low level enables device |
| R/W | Read/Write: a high level selects Read mode |
| WUS | Write Unsafe: a high level indicates an unsafe writing condition |
| WDI | Write Data In: a negative transition toggles the direction of the head current |
| H0X - H5X H0Y - H5Y | X, Y head connections |
| RDX, RDY | X, Y Read Data: differential read signal out |
| WC | Write Current: used to set the magnitude of the write current |
| VCT | Voltage Center Tap: voltage source for head center tap |
| VCC | + 5V |
| VDD1 | + 12V |
| VDD2 | Positive power supply for the Center Tap voltage source |
| GND | Ground |

TABLE 2: MODE SELECT

| \overline{CS} | R/W | MODE |
|-----------------|-----|-------|
| 0 | 0 | Write |
| 0 | 1 | Read |
| 1 | X | Idle |

TABLE 3: HEAD SELECT

| HS2 | HS1 | HS0 | HEAD |
|-----|-----|-----|------|
| 0 | 0 | 0 | 0 |
| 0 | 0 | 1 | 1 |
| 0 | 1 | 0 | 2 |
| 0 | 1 | 1 | 3 |
| 1 | 0 | 0 | 4 |
| 1 | 0 | 1 | 5 |
| 1 | 1 | X | none |

0 = Low level
1 = High level
X = Don't care

SSI 117 – Series

ABSOLUTE MAXIMUM RATINGS (All voltages referenced to GND)

| Parameter | Symbol | Value | Units |
|--|------------------|--------------------|-------|
| DC Supply Voltage | VDD1 | - 0.3 to +14 | VDC |
| | VDD2 | - 0.3 to +14 | VDC |
| | VCC | - 0.3 to +6 | VDC |
| Digital Input Voltage Range | V _{in} | - 0.3 to VCC + 0.3 | VDC |
| Head Port Voltage Range | V _H | - 0.3 to VDD + 0.3 | VDC |
| WUS Port Voltage Range | V _{wus} | - 0.3 to +14 | VDC |
| Write Current | I _W | 60 | mA |
| Output Current: RDX, RDY VCT WUS | I _o | - 10 | mA |
| | | - 60 | mA |
| | | + 12 | mA |
| Storage Temperature Range | T _{stg} | - 65 to + 150 | °C |
| Junction Temperature Range | T _j | + 25 to + 125 | °C |
| Lead Temperature (10 sec Soldering) | | 260 | °C |

RECOMMENDED OPERATING CONDITIONS

| Parameter | Symbol | Value | Units |
|-------------------------|----------------|---------------------|-------|
| DC Supply Voltage | VDD1 | 12 ± 10% | VDC |
| | VDD2 | 6.5 to VDD1 | VDC |
| | VCC | 5 ± 10% | VDC |
| Head Inductance | L _h | 5 to 15 | μH |
| Damping Resistor | RD | 500 to 2000 | ohms |
| RCT Resistor | RCT | 130 ± 5% (1/2 watt) | ohms |
| Write Current | I _W | 25 to 50 | mA |
| RDX, RDY Output Current | I _o | 0 to 100 | μA |

DC CHARACTERISTICS

Unless otherwise specified VDD1 = 12V ± 10%, VCC = 5V ± 10%,
+ 25°C < T_j < + 125°C.

| Parameter | Test Conditions | Min. | Max. | Units |
|--------------------------|--|-----------|---------------------|-------|
| VCC Supply Current | Read / Idle Mode | — | 25 | mA |
| | Write Mode | — | 30 | mA |
| VDD Supply Current | Idle Mode | — | 25 | mA |
| | Read Mode | — | 50 | mA |
| | Write Mode | — | 30 + I _W | mA |
| Power Dissipation | T _j = + 125°C | | | |
| | Idle Mode | — | 400 | mW |
| | Read Mode | — | 600 | mW |
| | Write Mode, I _W = 50mA, RCT = 130Ω | — | 700 | mW |
| | Write Mode, I _W = 50mA, RCT = 0Ω | — | 1050 | mW |
| Digital Inputs: | | | | |
| | Input Low Voltage (V _{IL}) | - 0.3 | 0.8 | VDC |
| | Input High Voltage (V _{IH}) | 2.0 | VCC + 0.3 | VDC |
| | Input Low Current | - 0.4 | — | mA |
| Input High Current | V _{IL} = 0.8V V _{IH} = 2.0V | — | 100 | μA |
| WUS Output | V _{OL} | — | 0.5 | VDC |
| | V _{OH} | — | 100 | μA |
| Center Tap Voltage (VCT) | Read Mode | 4.0 (typ) | | VDC |
| | Write Mode | 6.0 (typ) | | VDC |

SSI 117 – Series

WRITE CHARACTERISTICS

Unless otherwise specified: VDD1 = 12V ± 10%, VCC = 5V ± 10%,
IW = 45mA, Lh = 10μH, Rd = 750Ω, f (Data) = 5MHz, CL (RDX, RDY) ≤ 20pF.

| Parameter | Test Conditions | Min. | Max. | Units |
|---------------------------------|-----------------|----------|------|---------|
| Write Current Range | | 10 | 50 | mA |
| Write Current Constant "K" | | 133 | 147 | V |
| Differential Head Voltage Swing | | 5.7 | — | V (pk) |
| Unselected Diff. Head Current | | — | 2 | mA (pk) |
| Differential Output Capacitance | | — | 15 | pF |
| Differential Output Resistance | | 10k | — | Ω |
| WDI Transition Frequency | WUS = low | 125 | — | KHz |
| Iwc to Head Current Gain | | 20 (typ) | | — |

READ CHARACTERISTICS

Unless otherwise specified: VDD1 = 12V ± 10%, VCC = 5V ± 10%,
IW = 45mA, Lh = 10μH, Rd = 750Ω, f (Data) = 5MHz, CL (RDX, RDY) ≤ 20pF.
(Vin is referenced to VCT)

| Parameter | Test Conditions | Min. | Max. | Units |
|--------------------------------|--|------|------|--------|
| Differential Voltage Gain | Vin = 1mVpp @ 300kHz RL (RDX), RL (RDY) = 1kohm | 80 | 120 | V/V |
| Dynamic Range | DC Input Voltage, Vi, Where Gain Falls by 10%. Vin = Vi + 0.5mVpp @ 300kHz | -2 | 2 | mV |
| Bandwidth (-3db) | Zs < 5Ω, Vin = 1mVpp | 30 | — | MHz |
| Input Noise Voltage | BW = 15MHz, Lh = 0, Rh = 0 | — | 2.1 | nV/√Hz |
| Differential Input Capacitance | f = 5MHz | — | 23 | pF |
| Differential Input Resistance | f = 5 MHz | 2k | — | Ω |
| Input Bias Current | | — | 45 | μA |
| Common Mode Rejection Ratio | Vcm = VCT + 100mVpp @ 5MHz | 50 | — | db |
| Power Supply Rejection Ratio | 100mVpp @ 5MHz on VDD1, VDD2, or VCC | 45 | — | db |
| Channel Separation | Unselected Channels: Vin = 100mVpp @ 5MHz and Selected Channel: Vin = 0mVpp | 45 | — | db |
| Output Offset Voltage | | -480 | +480 | mV |
| Common Mode Output Voltage | | 5 | 7 | V |
| Single Ended Output Resistance | f = 5MHz | — | 30 | Ω |

SWITCHING CHARACTERISTICS

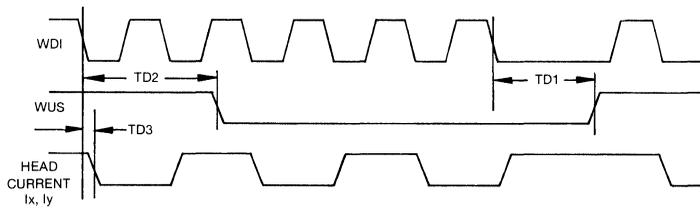
Unless otherwise specified: VDD1 = 12V ± 10%, VCC = 5V ± 10%, Tj = 25°C,
IW = 45mA, Lh = 10μH, Rd = 750Ω, f (Data) = 5MHz.

| Parameter | Test Conditions | Min. | Max. | Units | |
|-------------------|----------------------|---|------|-------|----|
| R/W: | R/W to Write | Delay to 90% of Write Current | — | 1.0 | μS |
| | R/W to Read | Delay to 90% of 100mV 10MHz Read Signal Envelope or to 90% Decay of Write Current | — | 1.0 | μS |
| CS: | CS to Select | Delay to 90% of Write Current or to 90% of 100mV 10MHz Read Signal Envelope | — | 1.0 | μS |
| | CS to Unselect | Delay to 90% Decay of Write Current | — | 1.0 | μS |
| HS0 HS1 HS2 | to any Head | Delay to 90% of 100mV 10MHz Read Signal Envelope | — | 1.0 | μS |
| WUS: | Safe to Unsafe – TD1 | Iw = 50mA | 1.6 | 8.0 | μS |
| | Unsafe to Safe – TD2 | Iw = 20mA | — | 1.0 | μS |

SSI 117 – Series

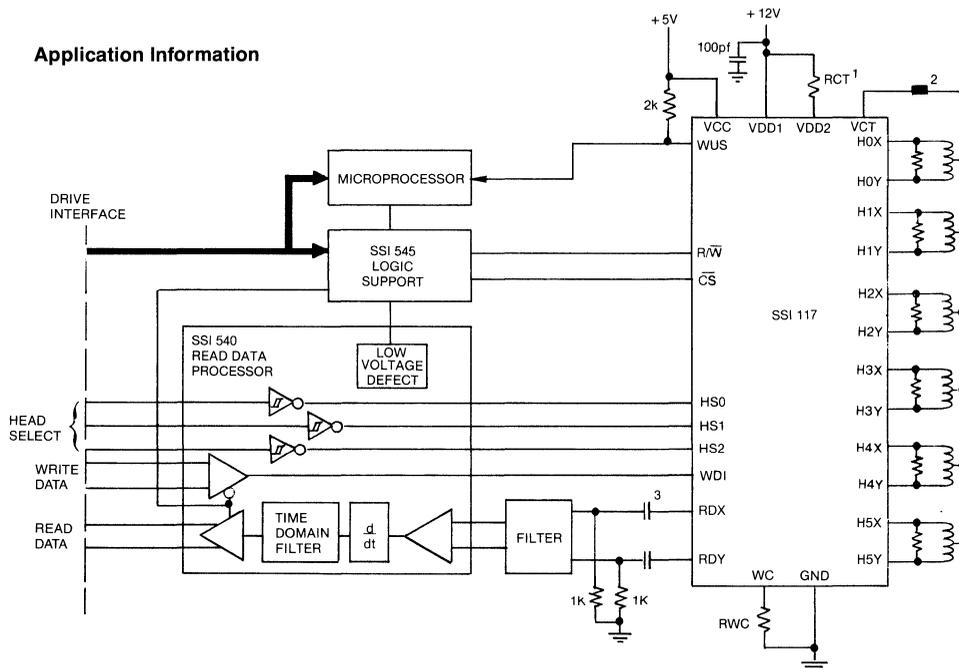
SWITCHING CHARACTERISTICS (cont'd)

| Parameter | Test Conditions | Min. | Max. | Units |
|-------------------|---|------|------|-------|
| Head Current: | $L_h = 0\mu H, R_h = 0\Omega$ | | | |
| Prop. Delay – TD3 | From 50% Points | — | 25 | nS |
| Asymmetry | WDI has 50% Duty Cycle and 1ns Rise/Fall Time | — | 2 | nS |
| Rise/Fall Time | 10% – 90% Points | — | 20 | nS |



WRITE MODE TIMING DIAGRAM

Application Information



Note 1: An external 1/2 watt resistor, RCT, given by:

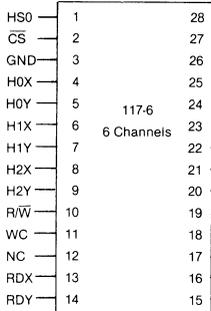
$$RCT = 130(I_w/1w) \text{ ohms, where } I_w \text{ is in mA}$$

can be used to limit internal power dissipation. Otherwise connect VDD2 to VDD1.

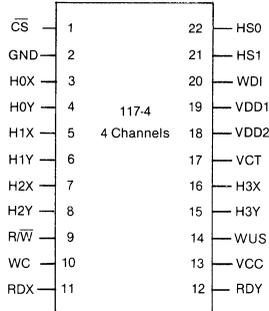
Note 2: A ferrite bead (Ferroxcube 5659065/4A6) can be used to suppress write current overshoot and ringing induced by flex cable parasitics.

Note 3: Limit current from RDX and RDY to 100uA and load capacitance to 20pF.

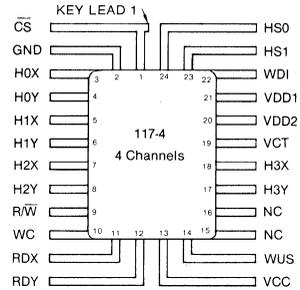
SSI 117 Pin Assignments



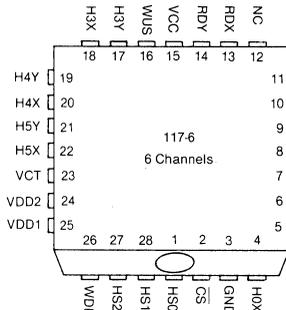
**28-LEAD CDIP, PDIP,
FLAT PACK**



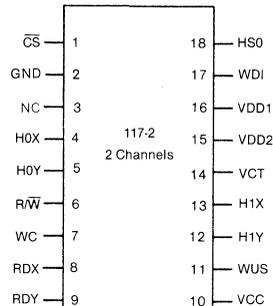
22-LEAD CDIP, PDIP



24-LEAD FLAT PACK



28-LEAD QUAD



18-LEAD CDIP, PDIP

THERMAL CHARACTERISTICS: θ_{JC}

| | |
|----------------|---------|
| 28-LEAD | |
| CDIP | 52°C/W |
| PDIP | 80°C/W |
| FLAT PACK | TBD |
| QUAD | 77°C/W |
| 24-LEAD | |
| FLAT PACK | 144°C/W |
| 22-LEAD | |
| CDIP | 58°C/W |
| PDIP | 100°C/W |
| 18-LEAD | |
| CDIP | 60°C/W |
| PDIP | 115°C/W |

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Data Sheet

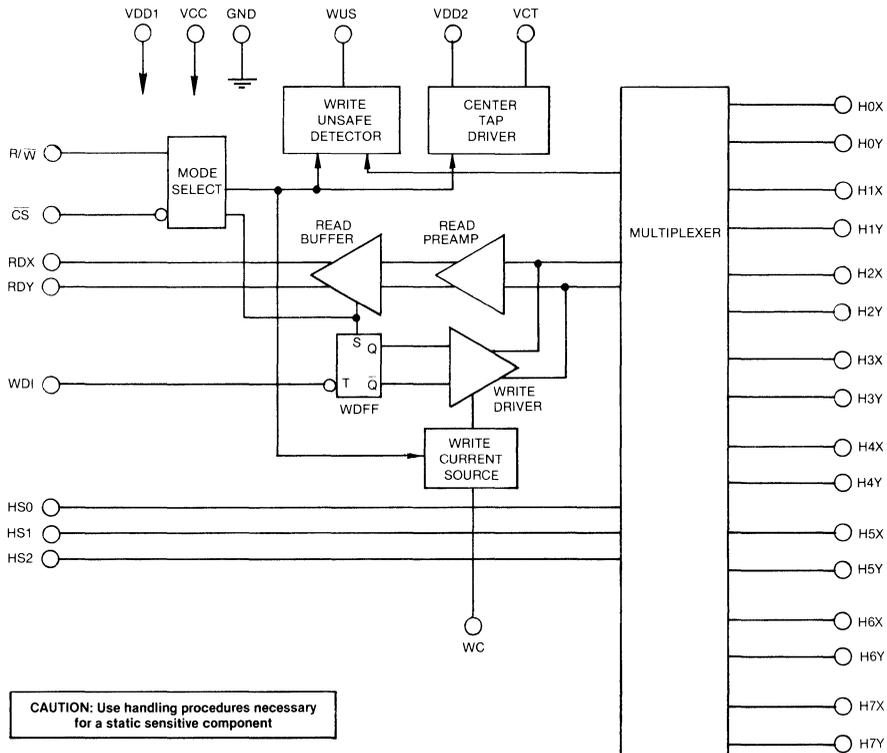
GENERAL DESCRIPTION

The SSI 501/502 devices are bipolar monolithic integrated circuits designed for use with center-tapped ferrite recording heads. They provide a low noise read path, write current control, and data protection circuitry for eight channels. The SSI 501/502 requires +5V and +12V power supplies and is available in a variety of packages. The SSI 502 differs from the SSI 501 by having internal damping resistors.

FEATURES

- +5V, +12V power supplies
- Single- or multi-platter Winchester drives
- Designed for center-tapped ferrite heads
- Programmable write current source
- Easily multiplexed for larger systems
- Includes write unsafe detection
- TTL compatible control signals

SSI 501/502 Block Diagram



SSI 501/502

Circuit Operation

The SSI 501/502 functions as a write driver or as a read amplifier for the selected head. Head selection and mode control are described in Tables 2 & 3. Both R/W and CS have internal pull up resistors to prevent an accidental write condition.

WRITE MODE

The Write mode configures the SSI 501/502 as a current switch and activates the Write Unsafe Detector. Head current is toggled between the X- and Y-side of the recording head on the falling edges of WDI, Write Data Input. Note that a preceding read operation initializes the Write Data Flip Flop, WDDFF, to pass current through the X-side of the head. The magnitude of the write current, given by

$I_w = K/R_{wc}$, where $K =$ Write Current Constant

is set by the external resistor, R_{wc} , connected from pin WC to GND.

Any of the following conditions will be indicated as a high level on the Write Unsafe, WUS, open collector output.

- Head open
- Head center tap open
- WDI frequency too low
- Device in Read mode
- Device not selected
- No write current

After the fault condition is removed, two negative transitions on WDI are required to clear WUS.

READ MODE

In the Read mode the SSI 501/502 is configured as a low noise differential amplifier, the write current source and the write unsafe detector are deactivated, and the write data flip flop is set. The RDX and RDY outputs are driven by emitter followers and are in phase with the "X" and "Y" head ports.

Note that the internal write current source is deactivated for both the Read and the chip deselect mode. This eliminates the need for external gating of the write current source.

TABLE 1: PIN DESCRIPTIONS

| Symbol | Name — Description |
|------------------------|--|
| HS0 - HS2 | Head Select |
| CS | Chip Select: a low level enables device |
| R/W | Read/Write: a high level selects Read mode |
| WUS | Write Unsafe: a high level indicates an unsafe writing condition |
| WDI | Write Data In: a negative transition toggles the direction of the head current |
| H0X - H7X H0Y - H7X | X, Y head connections |
| RDX, RDY | X, Y Read Data: differential read signal out |
| WC | Write Current: used to set the magnitude of the write current |
| VCT | Voltage Center Tap: voltage source for head center tap |
| VCC | + 5V |
| VDD1 | + 12V |
| VDD2 | Positive power supply for the Center Tap voltage source |
| GND | Ground |

TABLE 2: MODE SELECT

| CS | R/W | MODE |
|----|-----|-------|
| 0 | 0 | Write |
| 0 | 1 | Read |
| 1 | X | Idle |

TABLE 3: HEAD SELECT

| HS2 | HS1 | HS0 | HEAD |
|-----|-----|-----|------|
| 0 | 0 | 0 | 0 |
| 0 | 0 | 1 | 1 |
| 0 | 1 | 0 | 2 |
| 0 | 1 | 1 | 3 |
| 1 | 0 | 0 | 4 |
| 1 | 0 | 1 | 5 |
| 1 | 1 | 0 | 6 |
| 1 | 1 | 1 | 7 |

0 = Low level
1 = High level

SSI 501/502

ABSOLUTE MAXIMUM RATINGS (All voltages referenced to GND)

| Parameter | Symbol | Value | Units |
|--|------------------|--------------------|-------|
| DC Supply Voltage | VDD1 | - 0.3 to + 14 | VDC |
| | VDD2 | - 0.3 to + 14 | VDC |
| | VCC | - 0.3 to + 6 | VDC |
| Digital Input Voltage Range | V _{in} | - 0.3 to VCC + 0.3 | VDC |
| Head Port Voltage Range | VH | - 0.3 to VDD + 0.3 | VDC |
| WUS Port Voltage Range | V _{wus} | - 0.3 to + 14 | VDC |
| Write Current | I _W | 60 | mA |
| Output Current: RDX, RDY VCT WUS | I _o | - 10 | mA |
| | | - 60 | mA |
| | | + 12 | mA |
| Storage Temperature Range | T _{stg} | - 65 to + 150 | °C |
| Junction Temperature Range | T _j | + 25 to + 135 | °C |
| Lead Temperature (10 sec Soldering) | | 260 | °C |

RECOMMENDED OPERATING CONDITIONS

| Parameter | Symbol | Value | Units |
|---------------------------|----------------|---------------------|-------|
| DC Supply Voltage | VDD1 | 12 ± 10% | VDC |
| | VDD2 | 6.5 to VDD1 | VDC |
| | VCC | 5 ± 10% | VDC |
| Head Inductance | L _h | 5 to 15 | μH |
| External Damping Resistor | RD (501 Only) | 500 to 2000 | ohms |
| RCT Resistor | RCT | 120 ± 5% (1/2 watt) | ohms |
| Write Current | I _W | 22 to 50 | mA |
| RDX, RDY Output Current | I _o | 0 to 100 | μA |

DC CHARACTERISTICS

Unless otherwise specified VDD1 = 12V ± 10%, VCC = 5V ± 10%,
+ 25 °C < T_j < + 135 °C.

| Parameter | Test Conditions | Min. | Max. | Units | |
|--------------------------|---|---------------------------------------|---------------------|-----------|-----|
| VCC Supply Current | Read / Idle Mode | — | 25 | mA | |
| | Write Mode | — | 25 | mA | |
| VDD Supply Current | Idle Mode | — | 20 | mA | |
| | Read Mode | — | 35 | mA | |
| | Write Mode | — | 20 + I _W | mA | |
| Power Dissipation | T _j = + 135 °C | | | | |
| | Idle Mode | — | 400 | mW | |
| | Read Mode | — | 600 | mW | |
| | Write Mode, I _W = 50mA, RCT = 120Ω | — | 760 | mW | |
| | Write Mode, I _W = 50mA, RCT = 0Ω | — | 1060 | mW | |
| Digital Inputs: | | | | | |
| | | Input Low Voltage (V _{IL}) | - 0.3 | 0.8 | VDC |
| | | Input High Voltage (V _{IH}) | 2.0 | VCC + 0.3 | VDC |
| | | Input Low Current | - 0.4 | — | mA |
| | V _{IL} = 0.8V | — | 100 | μA | |
| | V _{IH} = 2.0V | — | — | — | |
| WUS Output | I _{OL} = 8mA V _{OH} = 5.0V | — | 0.5 | VDC | |
| | | — | 100 | μA | |
| Center Tap Voltage (VCT) | Read Mode Write Mode | 4.0 (typ) | | VDC | |
| | | 6.0 (typ) | | VDC | |

SSI 501/502

WRITE CHARACTERISTICS Unless otherwise specified: VDD1 = 12V ± 10%, VCC = 5V ± 10%, IW = 45mA, Lh = 10μH, Rd = 750Ω (SSI 501 only), f (Data) = 5MHz, CL (RDX, RDY) ≤ 20pF.

| Parameter | Test Conditions | Min. | Max. | Units |
|---------------------------------|------------------|----------|------|---------|
| Write Current Range | | 10 | 50 | mA |
| Write Current Constant "K" | | 129 | 151 | V |
| Differential Head Voltage Swing | | 5.7 | — | V (pk) |
| Unselected Diff. Head Current | 5μH ≤ Lh ≤ 9.5μH | — | 2 | mA (pk) |
| Differential Output Capacitance | | — | 15 | pF |
| Differential Output Resistance | | 10k | — | Ω |
| WDI Transition Frequency | WUS = low | 125 | — | KHz |
| Iwc to Head Current Gain | | 20 (typ) | | — |

READ CHARACTERISTICS Unless otherwise specified: VDD1 = 12V ± 10%, VCC = 5V ± 10%, IW = 45mA, Lh = 10μH, Rd = 750Ω, f (Data) = 5MHz, CL (RDX, RDY) ≤ 20pF. (Vin is referenced to VCT)

| Parameter | Test Conditions | Min. | Max. | Units | |
|--|--|---------|-------|-------|---|
| Differential Voltage Gain | Vin = 1mVpp @ 300kHz RL (RDX), RL (RDY) = 1kohm (AC Coupled) | 80 | 120 | V/V | |
| Dynamic Range | DC Input Voltage, Vi, Where Gain Falls by 10%. Vin = Vi + 0.5mVpp @ 300kHz | - 3 | 3 | mV | |
| Bandwidth (-3db) | Zs < 5Ω, Vin = 1mVpp | 30 | — | MHz | |
| Input Noise Voltage | BW = 15MHz, Lh = 0, Rh = 0 | — | 8 | μVrms | |
| Differential Input Capacitance | f = 5MHz | — | 23 | pF | |
| Differential Input Resistance | f = 5 MHz Vin ≤ 6mVpp | SSI 501 | 2k | — | Ω |
| | | SSI 502 | 460 | 860 | — |
| Input Bias Current | | — | 45 | μA | |
| Common Mode Rejection Ratio | Vcm = VCT + 100mVpp @ 5MHz | 50 | — | db | |
| Power Supply Rejection Ratio | 100mVpp @ 5MHz on VDD1, VDD2, or VCC | 45 | — | db | |
| Channel Separation | Unselected Channels: Vin = 100mVpp @ 5MHz and Selected Channel: Vin = 0mVpp | 45 | — | db | |
| Output Offset Voltage | | - 600 | + 600 | mV | |
| Common Mode Output Voltage | | 5 | 7 | V | |
| Single Ended Output Resistance | f = 5MHz | — | 30 | Ω | |
| External Resistive Load (AC Coupled to Output) | Per Side to GND | 100 | — | Ω | |
| Output Current Per Side | 1.0 < RDX, RDY < 8.0V Write or Idle Mode | -50 | 50 | μA | |
| Center Tap Output Impedance | 0 ≤ f ≤ 5 MHz | — | 150 | Ω | |

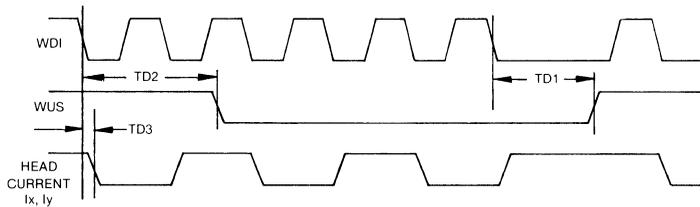
SWITCHING CHARACTERISTICS Unless otherwise specified: VDD1 = 12V ± 10%, VCC = 5V ± 10%, Tj = 25°C, IW = 45mA, Lh = 10μH, Rd = 750Ω, f (Data) = 5MHz.

| Parameter | Test Conditions | Min. | Max. | Units | | |
|-------------------|----------------------|---|------|-------|-----|----|
| R/W: | R/W to Write | Delay to 90% of Write Current | | — | 1.0 | μS |
| | R/W to Read | Delay to 90% of 100mV 10MHz Read Signal Envelope or to 90% Decay of Write Current | | — | 1.0 | μS |
| CS: | CS to Select | Delay to 90% of Write Current or to 90% of 100mV 10MHz Read Signal Envelope | | — | 1.0 | μS |
| | CS to Unselect | Delay to 90% Decay of Write Current | | — | 1.0 | μS |
| HS0 HS1 HS2 | to any Head | Delay to 90% of 100mV 10MHz Read Signal Envelope | | — | 1.0 | μS |
| WUS: | Safe to Unsafe - TD1 | Iw = 50mA | 1.6 | 8.0 | μS | |
| | Unsafe to Safe - TD2 | Iw = 20mA | — | 1.0 | μS | |

SSI 501/502

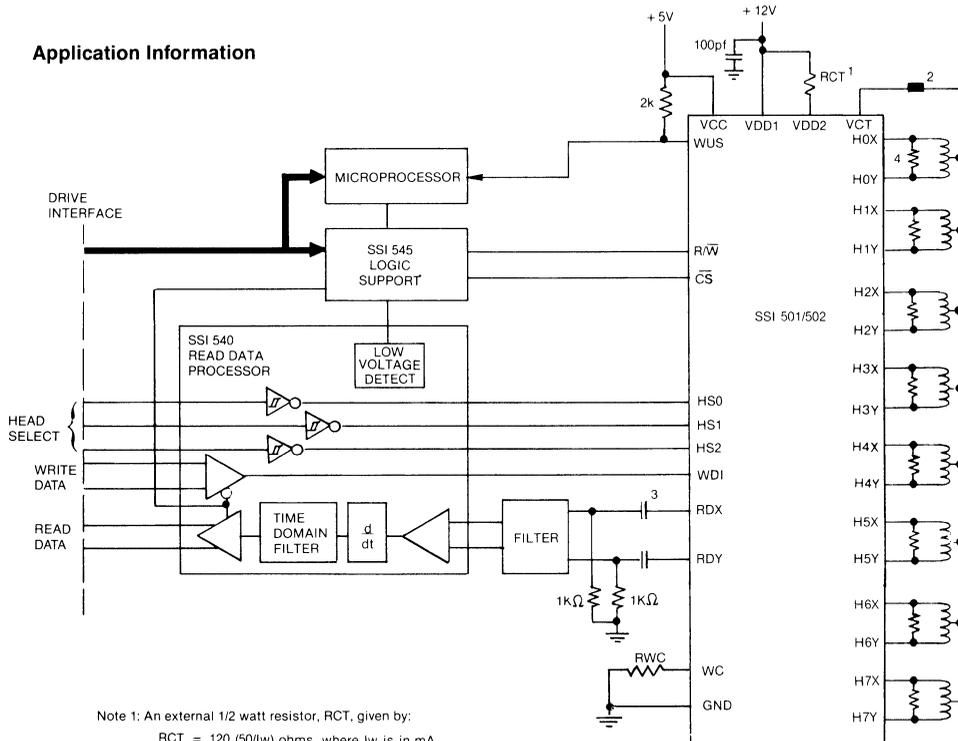
SWITCHING CHARACTERISTICS (cont'd)

| Parameter | Test Conditions | Min. | Max. | Units |
|-------------------|---|------|------|-------|
| Head Current: | $L_h = 0\mu H, R_h = 0\Omega$ | | | |
| Prop. Delay – TD3 | From 50% Points | — | 25 | nS |
| Asymmetry | WDI has 50% Duty Cycle and 1ns Rise/Fall Time | — | 2 | nS |
| Rise/Fall Time | 10% — 90% Points | — | 20 | nS |



WRITE MODE TIMING DIAGRAM

Application Information



Note 1: An external 1/2 watt resistor, RCT, given by:

$$RCT = 120 (50/I_w) \text{ ohms, where } I_w \text{ is in mA}$$

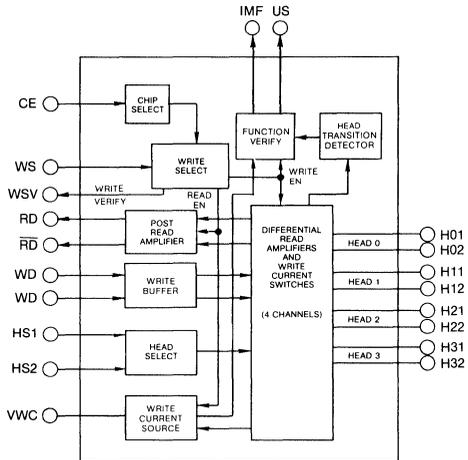
can be used to limit internal power dissipation. Otherwise connect VDD2 to VDD1.

Note 2: A ferrite bead (Ferroxcube 5659065/4A6) can be used to suppress write current overshoot and ringing induced by flex cable parasitics.

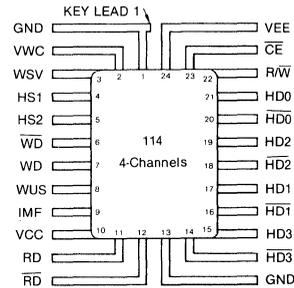
Note 3: Limit current from RDX and RDY to 100uA and load capacitance to 20pF.

Note 4: Damping resistors required on SSI 501 only.

Preliminary Data Sheet



SSI 114 Block Diagram



SSI 114 Pin Out

FEATURES

- Thin film head compatible performance
- Four Read/Write Channels
- TTL - compatible logic levels
- Operates on standard +5 volt and -5 volt power supplies

DESCRIPTION

The SSI 114 is an integrated read/write circuit designed for use with non-center tapped thin film heads in disk drive systems. Each chip controls four heads and has three modes of operation: read, write, and idle. The circuit contains four channels of read amplifiers and write drivers and also has an internal write current source.

A current monitor (IMF) output is provided that

allows a multichip enable fault to be detected. An enabled chip's output will produce one unit of current. An open collector output, write select verify (WSV), will go low if the write current source transistor is forward biased. The circuit operates on +5 volt, and -5 volt power and is available in a 24 pin flatpack.

Thin Film - 4-Channel Read/Write Circuit SSI 114

CIRCUIT DESCRIPTION

WRITE MODE

In the write mode (R/W and CE low) the circuit functions as a differential current switch. The Head Select inputs (HS1 and HS2) determine the selected head. The Write Data Inputs (WD, \overline{WD}) determine the polarity of the head current. The write current magnitude is adjustable by an external 1% resistor, R_x , where

$$I_w = \frac{K_w}{R_x \left(1 + \frac{R_h}{R_d} + \frac{R_h}{1k}\right)} - 0.7\text{mA}$$

Where K_w = Current Gain Factor = 130 Amp-Ohms
 R_h = Head plus External Wire Resistance
 R_d = Damping Resistance

READ MODE

In the Read Mode, (R/W high and CD low), the circuit functions as a differential amplifier. The amplifier input terminals are determined by the Head Select inputs.

ABSOLUTE MAXIMUM RATINGS

Positive Supply Voltage, V_{CC} 6V
 Negative Supply Voltage, V_{EE} -6V
 Operating Junction Temperature 25°C to 125°C
 Storage Temperature -65°C to 150°C
 Lead Temperature (Soldering, 10 sec) 260°C

Input Voltages

Head Select (HS) -0.4V to $V_{CC} + 0.3V$
 Chip Enable (\overline{CE}) -0.4V to $V_{CC} + 0.3V$
 Read Select (R/W) -0.4V or -2mA to $V_{CC} + 0.3V$
 Write Data (WD, \overline{WD}) V_{EE} to 0.3V
 Head Inputs (Read Mode) -0.6V to +0.4V

Outputs

Read Data (RD, \overline{RD}) 0.5V to $V_{CC} + 0.3V$
 Write Unsafe (WUS), -0.4V to $V_{CC} + 0.3V$
 and 20mA
 Write Select Verify (WSV) -0.4V to $V_{CC} + 0.3V$
 and 20mA
 Current Monitor (IMF) -0.4V to $V_{CC} + 0.3V$
 Current Reference (VWC) V_{EE} to $V_{CC} + 0.3V$
 and 8mA

Head Outputs (Write Mode) I_w max = 150mA

Thermal Characteristics

Flatpack Package $\Theta_{JA} = 144^\circ\text{C/W}$ (still air)
 $\Theta_{JA} = 30^\circ\text{C/W}$

ELECTRICAL CHARACTERISTICS

Unless otherwise specified, $4.75 \leq V_{CC} \leq 5.25$,
 $-5.5 \leq V_{EE} \leq -4.95V$, $25^\circ \leq T$ (junction) $\leq 125^\circ\text{C}$.

POWER SUPPLY

| Parameter | Test Conditions | Min. | Max. | Units |
|-------------------------------|--|-----------------|-----------------|-------|
| Power Dissipation | All modes, $25 \leq T_j \leq 100$ $100^\circ \leq T_j \leq 125^\circ\text{C}$ | — | $612 + 6.7 I_w$ | mW |
| | | — | $563 + 6.7 I_w$ | mW |
| Positive Supply Current (ICC) | Idle Mode | — | $10 + I_w/19$ | mA |
| Positive Supply Current (ICC) | Read Mode | — | $40 + I_w/19$ | mA |
| Positive Supply Current (ICC) | Write Mode | — | $38 + I_w/19$ | mA |
| Negative Supply Current (IEE) | Idle Mode | $-12 - I_w/19$ | — | mA |
| Negative Supply Current (IEE) | Read Mode | $-66 - I_w/19$ | — | mA |
| Negative Supply Current (IEE) | Write Mode | $-75 - 1.16I_w$ | — | mA |

LOGIC SIGNALS

| Parameter | Test Conditions | Min. | Max. | Units |
|----------------------------------|--------------------|-------|-------|-------|
| Chip Enable Low Voltage (VLCE) | Read or Write Mode | — | 0.8 | V |
| Chip Enable High Voltage (VHCE) | Idle Mode | 2.0 | — | V |
| Chip Enable Low Current (ILCE) | VLCE = 0V | -1.60 | — | mA |
| Chip Enable High Current (IHCE) | VHCE = 2.0V | — | -0.3 | mA |
| Read Select High Voltage (VHR/W) | Read or Idle Mode | 2.0 | — | V |
| Read Select Low Voltage (VLR/W) | Write or Idle Mode | — | 0.8 | V |
| Read Select High Current (IHR/W) | VHR/W = 2.0V | — | 0.015 | mA |
| Read Select Low Current (ILR/W) | VLR/W = 0V | -0.15 | — | mA |
| Head Select High Voltage (VHHS) | | 2.0 | — | V |
| Head Select Low Voltage (VLHS) | | — | 0.8 | V |

HEAD SELECT TABLE

| Head Selected | HS1 | HS2 |
|---------------|-----|-----|
| 0 | 0 | 0 |
| 1 | 1 | 0 |
| 2 | 0 | 1 |
| 3 | 1 | 1 |

LOGIC SIGNALS

| Parameter | Test Conditions | Min. | Max. | Units |
|---------------------------------|--|------|-----------|---------|
| Head Select High Current (IHHS) | VHHS = VCC | — | 0.25 | mA |
| Head Select Low Current (ILHS) | VLHS = 0V | -0.1 | 0.25 | mA |
| WUS, WSV Low Level Voltage | ILUS = 8mA (denotes safe condition) | — | 0.5 | V |
| WUS, WSV High Level Current | VHUS = 5.0V (denotes unsafe condition) | — | 100 | μ A |
| IMF on Current | | 2.20 | 3.70 | mA |
| IMF on Current | | — | 0.02 | mA |
| IMF Voltage Range | | 0 | VCC + 0.3 | V |

READ MODE Tests performed with 100 Ω load resistors from RD and \overline{RD} through series isolation diodes to VCC.

| Parameter | Test Conditions | Min. | Max. | Units |
|---------------------------------|--|-----------|-----------|----------------|
| Differential Voltage Gain | Vin = 1mVpp, f = 300kHz | 75 | 170 | V/V |
| Voltage Bandwidth (-3dB) | Zs < 5 Ω , Vin = 1mVpp f midband = 300kHz | 45 | — | MHz |
| Input Noise Voltage | Zs = 0 Ω , Vin = 0V, Power Bandwidth = 15MHz | — | 1.1 | nV/ \sqrt Hz |
| Differential Input Capacitance | Vin = 0V, f = 5MHz | — | 65 | pF |
| Differential Input Resistance | Vin = 0V, f = 5MHz | 45 | 96 | Ω |
| Input Bias Current (per side) | Vin = 0V | — | 0.17 | mA |
| Dynamic Range | DC input voltage where AC gain falls to 90% of the gain with .5mVpp input signal | -3.0 | 3.0 | mV |
| CMRR | Vin = 100mVpp, 0V DC 1MHz \leq f \leq 10MHz 10MHz \leq f \leq 20MHz | 54 | — | dB |
| | | 48 | — | dB |
| Power Supply Rejection Ratio | VCC or VEE = 100mVpp 1MHz \leq f \leq 10MHz 10MHz \leq f \leq 20MHz | 54 | — | dB |
| | | 36 | — | dB |
| Channel Separation | The 3 unselected channels are driven with Vin = 100mVpp 1MHz \leq f \leq 10MHz 10MHz \leq f \leq 20MHz | 43 | — | dB |
| | | 37 | — | dB |
| Output Offset Voltage | | -360 | 360 | mV |
| Output Leakage Current | Idle Mode | — | 0.01 | mA |
| Output Common Mode Voltage | | VCC - 1.1 | VCC - 0.3 | V |
| Single Ended Output Resistance | | 10 | — | K Ω |
| Single Ended Output Capacitance | | — | 10 | pF |

WRITE MODE

| Parameter | Test Conditions | Min. | Max. | Units |
|---------------------------------|--|------|------|-------|
| Current Range (Iw) | | 55 | 110 | mA |
| Current Tolerance | Current set to nominal value by Rx, Rh = 7 Ω \pm 10%, Tj = 50 $^{\circ}$ C, Rd = 59 Ω | -8 | +8 | % |
| (Iw) (Rh) Product | | 0.24 | 1.30 | V |
| Differential Head Voltage Swing | Iw = 100mA, Lh = 0.2 μ H, Rh = 10 Ω | 3.8 | — | Vpp |



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WRITE MODE

| Parameter | Test Conditions | Min. | Max. | Units |
|---|--|-------|------|-------|
| Unselected Head Transient Current | I _w = 100mA, L _h = 0.2 μH, R _h = 10Ω, Non adjacent heads tested to minimize external coupling effects | — | 2 | mAp |
| Head Differential Load Resistance, R _d | | 48 | 97 | Ω |
| Head Differential Load Capacitance | | — | 30 | pF |
| Differential Data Voltage, (WD—WD) | | 0.20 | — | V |
| Data Input Voltage Range | | -1.87 | +0.1 | V |
| Data Input Current (per side) | Chip Enabled | — | 150 | μA |
| Data Input Capacitance | per side to GND | — | 10 | pF |

SWITCHING CHARACTERISTICS

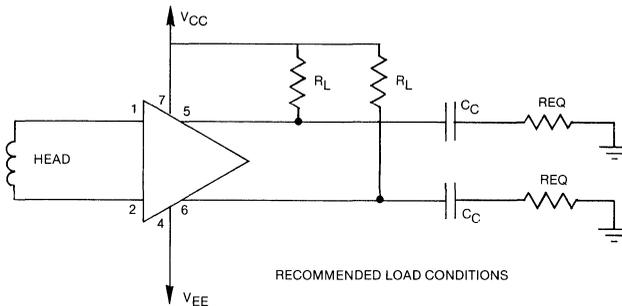
| Parameter | Test Conditions | Min. | Max. | Units |
|--|---|------|------|-------|
| Idle to Read/Write Transition Time | | — | 1.0 | μS |
| Read/Write to Idle Transition Time | | — | 1.0 | μS |
| Read to Write Transition Time | VLCE = 0.8V, Delay to 90% of I _w | — | 0.6 | μS |
| Write to Read Transition Time | VLCE = 0.8V, Delay to 90% of 20MHz Read Signal envelope, I _w decay to 10% | — | 1.0 | μS |
| Head Select Switching Delay | Read or Write Mode | — | 0.40 | μS |
| Shorted Head Current Transition Time | I _w = 100mA, L _h < 0.05 μH, R _h = 0 | — | 13 | nS |
| Shorted Head Current Switching Delay Time | I _w = 100mA, L _h < 0.05 μH, R _h = 0, measured from 50% of input to 50% of current change | — | 18 | nS |
| Head Current Switching Time Symmetry | I _w = 100mA, L _h = 0.2 μH, R _h = 10Ω, WD & WD transitions 2nS, switching time symmetry 0.2nS | — | 1.5 | nS |
| WSV Transition Time | Delay from 50% of write select swing to 90% of final WSV voltage, Load = 2KΩ // 20pF | — | 1.0 | μS |
| Unsafe to Safe Delay After Write Data Begins (WUS) | f(data) = 10MHz | — | 1.0 | μS |
| Safe to Unsafe Delay, (WUS) | Non-switching write data, no write current, or shorted head close to chip | 0.6 | 3.6 | μS |
| Safe to Unsafe Delay, (WUS) | Head open or head select input open | — | 0.6 | μS |
| IMF Switching Time | Delay from 50% of CE to 90% of final IMF current | — | 1.0 | μS |

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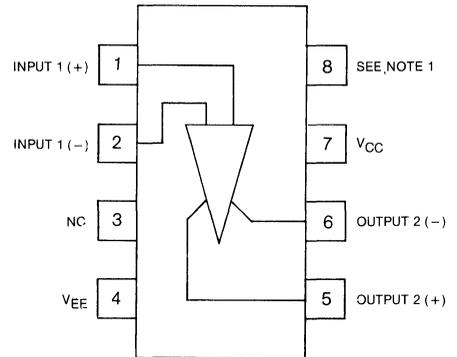
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Preliminary Data Sheet

CONNECTION DIAGRAM



1. Input must be AC coupled
2. C_C 's are AC coupling capacitors
3. R_L 's are DC bias and termination resistors, 100 Ω recommended
4. R_{EQ} represents equivalent load resistance
5. Ceramic capacitors (0.1 μ f) are recommended for good power supply noise filtering



SSI 116 Pin Configuration (Top View)

NOTE 1: Pin 8 must be left open and not connected to any circuit etc.

THERMAL RESISTANCE:

Junction to Case (Θ_{jc}): 80 °C/W

Junction to Ambient (Θ_{ja}): 160 °C/W

FEATURES

- Narrow gain range
- 50MHz bandwidth
- IBM 3370/3380-compatible performance
- Operates on either IBM-compatible voltages (8.3V) or OEM-compatible (10V)
- Packages include 8-pin CERDIP or Plastic DIP and custom 10-pin flatpack.

GENERAL DESCRIPTION

The SSI 116 is a high performance differential amplifier applicable for use as a preamplifier for the magnetic servo thin film head in Winchester disk drives.



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ABSOLUTE MAXIMUM RATINGS

Power Supply Voltage (VCC-VEE) 12V
 Operating Power Supply Range 7.9V to 10.5V
 Differential Input Range ± 1V
 Storage Temperature - 65°C to 150°C
 Operating Ambient Temperature (TA) 15°C to 60°C
 Operating Junction Temperature (TJ) 15°C to 125°C
 Output Voltage VCC - 2.0V to VCC + 0.4V

ELECTRICAL CHARACTERISTICS T_J = 15°C to 125°C, V_{CC} - V_{EE} = 7.9V to 10.5V

| Parameter | Test Conditions | Min. | Typ. | Max. | Units |
|--|--|------------------------|-----------------------|-----------------------|------------------|
| Gain (Differential) | V _{in} = 1mV _{pp} , T _A = 25°C, F = 1MHz | 200 | 250 | 310 | mV/mV |
| Bandwidth (3dB) | V _{in} = 1mV _{pp} , C _L = 15 pF | 20 | 50 | | MHz |
| Gain Sensitivity (Supply) | V _{CC} - V _{EE} = 7.88 to 10.5V | | | 1.0 | %/V |
| Gain Sensitivity (Temp.) | 15°C < T _A < 55°C | | - 0.16 | | %/°C |
| Input Noise Voltage | Input Referred, R _S = 0 | | 0.7 | 0.94 | nV/√Hz |
| Input Capacitance (Differential) | V _{in} = 0, f = 5MHz | | 40 | 60 | pF |
| Input Resistance (Differential) | | | 200 | | ohms |
| Common Mode Rejection Ratio Input Referred | V _{in} = 100mV _{pp} , f = 1MHz | 60 | 70 | | dB |
| Input Signal Level | Common Mode | | | 300 | mV _{pp} |
| Power Supply Rejection Ratio Input Referred | V _{EE} + 100mV _{pp} , f = 1MHz | 46 | 52 | | dB |
| Input Dynamic Range (Differential) | DC input voltage where AC gain is 90% of gain with 0.2mV _{pp} input signal | | | ± 0.75 | mV |
| Output Offset Voltage (Differential) | V _{in} = 0 | - 600 | | 600 | mV |
| Output Voltage (Common Mode) | Inputs shorted together and Outputs shorted together | V _{CC} - 0.45 | V _{CC} - 0.6 | V _{CC} - 1.0 | V |
| Single Ended Output Resistance | | 10 | | | K ohms |
| Single Ended Output Capacitance | | | | 10 | pF |
| Power Supply Current | V _{CC} - V _{EE} = 9.15V V _{CC} - V _{EE} = 11V | | 28 29 | 40 42 | mA |
| Input DC Voltage | Common Mode | | V _{EE} + 2.6 | | v |
| Input Resistance | Common Mode | | 80 | | ohms |

| Recommended Operating Conditions | Min. | Typ. | Max. | Units |
|---|-------------|-------------|--------------|------------------|
| Supply Voltage (V _{CC} - V _{EE}) | 7.45 9.0 | 8.3 10.0 | 9.15 11.0 | V V |
| Input Signal V _{in} | | 1 | | mV _{pp} |
| Ambient Temperature T _A | 15 | | 65 | °C |

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Preliminary Data Sheet

GENERAL DESCRIPTION

The SSI 540 is a bipolar integrated circuit that provides all data processing necessary for detection and qualification of MFM read signals from rigid media. ST506 compatible interfacing is provided for write data signals, head select lines and recovered read data as applicable.

In read mode the SSI 540 provides amplification, differentiation and time domain qualification of head preamplifier outputs. The recovered data is available at the output of a differential line driver that conforms to the ST506 interface specification. In write mode the SSI 540 provides a differential line receiver conforming with ST506 requirements. Schmitt Trigger inputs on head select lines and an open collector output for voltage fault indication are provided for interface compatibility. All other logic inputs and outputs are TTL compatible.

The SSI 540-2 is a dual ground version for use in noisier environments. In order to provide this feature the number of head select lines is reduced to 2.

Two other versions of the SSI 540 are available that offer subsets of the above configurations. The SSI 540-3 has dual grounds and an open-collector RD output instead

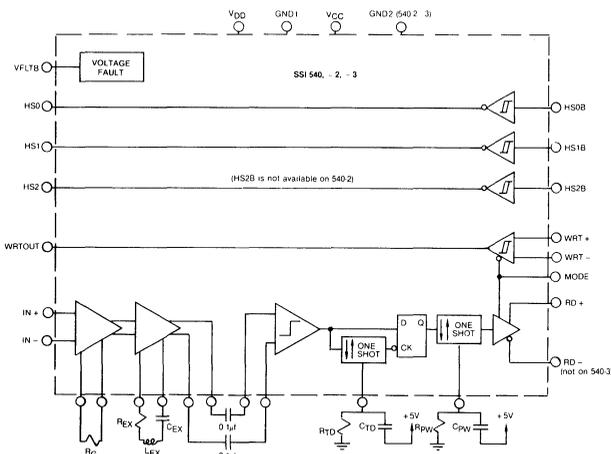
of a differential line-driver output. The SSI 540-4 has the same features as the SSI 540-3 but also deletes the head select buffers. The SSI 540-4 is available in a 22-Pin dip.

When used with a read/write preamplifier (i.e. SSI 117 or SSI 501), the SSI 540 or SSI 540-2 and required external passive components perform all read/write signal processing necessary between the heads and the interface connector of an ST506 compatible Winchester disk drive. With the SSI 540-3 and SSI 540-4 a line driver is required.

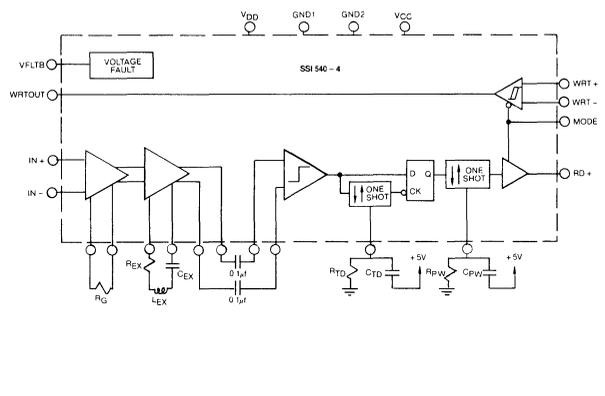
FEATURES

- Differential Read and Write Ports
- Schmitt Trigger Head Select Inputs for Higher Noise Immunity
- Programmable Gain
- Time Domain Pulse Qualification Supports MFM Encoded Data Retrieval
- Supply Voltage Fault Detection
- +12 Volt and +5 Volt Power Supplies
- I/O Meets ST506 Requirements
- Dual-In-Line and Surface Mount Packages Available
- Adjustable Time Domain Filter and Output Pulse Width Settings

SSI 540-1, -2, -3 Block Diagram



SSI 540-4 Block Diagram



CAUTION: Use handling procedures necessary for a static sensitive component

SSI 540 Series Read Data Processor

Circuit Operation

In both read and write modes, Schmitt Trigger inputs are used to buffer the three head select lines providing the increased noise immunity required of a ST506 interface. A power supply monitoring function, VFLTB, is provided to flag a low voltage fault condition if either supply is low. A low voltage fault condition results in a low level output on the VFLTB pin.

READ MODE

In the read mode (MODE input high) the read signal is detected, time domain qualified and made available at RD+ and RD- as differential MFM encoded data, or at the RD+ open collector output. This is accomplished by the on-board Amplifier, Differentiator, Zero Crossing Detector, Time Domain Filter, Output One Shot and Line Driver circuits.

The amplified and filtered read back signal, which contains pulses corresponding to magnetic transitions in the media is AC coupled into the input amplifier. A resistor, Rg, connected between pins G+ and G- is used to adjust the 1st stage amplifier gain according to the following expression.

$$Av_1 = \frac{680}{17 + Rx} \quad \text{Where } Rx = \frac{94 \times (Rg + 42)}{230 + Rg}$$

First stage gain can be monitored at the DIF+ and DIF- pins.

The amplifier is followed by an active differentiator whose external network serves to transform peaks in the input signal into zero-crossings while maintaining the time relationship of the original input peaks. Differentiator response is set by an external capacitor or more complex series LRC network between the DIF+ and DIF- pins. The transfer function with such a network is:

$$Av_2 = \frac{-1420 Cex s}{Lex Cex s^2 + (Rex + 46) Cex s + 1}$$

where: Cex = external capacitor (50 pf to 250 pf)
Rex = external resistor
Lex = external inductor
s = jw = j2πf

Total gain from IN+ and IN- to OUT+ and OUT- is:
Av = Av₁ × Av₂

To reduce pulse pairing (bit shift), it is essential that the input to the zero-crossing detector be maximized to reduce the effect of any comparator offset. This means that the above gains should be chosen such that the differential voltage at OUT+ and OUT- approaches 5 Vpp at max input and frequency.

The Differentiator output is AC coupled into a zero-crossing detector that provides an output level change at each positive or negative zero transition on its input. The zero-crossing detector output is coupled to a Time Domain Filter that eliminates false triggering of the output one-shot by spurious zero-crossings. The validity decision is based on a minimum duration between zero crossings that can be set externally by an RC network on the TD pin.

The output of the Time Domain Filter triggers a one-shot that defines the output pulsewidth based on an external RC network on the PW pin. These output pulses are fed into a line driver that provides a high-current differential output at RD+ and RD-, or are made available as an open-collector output at RD+.

Write Mode

In the write mode (MODE input low) the differential line receiver is enabled. This receiver accepts the differential data from the ST506 interface and outputs a TTL signal for the write data input of an external R/W amplifier. A low on the MODE input also puts the read outputs in a high impedance state, allowing several 540's to be multiplexed on a bus.

Layout Considerations

The SSI 540 is a high gain wide bandwidth device that requires care in layout. The designer should keep analog signal lines as short as possible and balanced. Analog test points should be provided with a probe ground in the immediate vicinity. Do not run digital signals under the chip or next to analog inputs. Use of a ground plane is recommended along with supply bypassing and separation of the SSI 540 ground from other circuits on the disk drive PCB.

Absolute Maximum Ratings*

| | |
|-------------------------------------|-----------------------------|
| 5V Supply Voltage, Vcc | 6 V |
| 12V Supply Voltage, Vdd | 14 V |
| Storage Temperature | -65 to +150 °C |
| Operating Temperature, Tj | +25 to +135 °C |
| Lead Temperature (soldering 10 sec) | 260 °C |
| Pin Voltages | |
| IN+, IN-, G+, G-, DIF+, DIF-, | |
| OUT+, OUT-, DIN+, DIN- | 0.3V to Vdd + 0.3V |
| RD+, RD-, WRTOUT, HSO, | |
| HS1, HS2, VFLTB | -0.3V to Vcc + 0.3V or 1 mA |
| TD, PW, MODE, WRT+, WRT-, | |
| HS0B, HS1B, HS2B | -0.3V to Vcc + 0.3V |

*Operation above absolute maximum ratings may damage the device.

ELECTRICAL CHARACTERISTICS

Unless otherwise specified, $4.5V < V_{CC} < 5.5V$, $10.8V < V_{DD} < 13.2V$,
 $25^{\circ}C < T(\text{junction}) < 135^{\circ}C$.

Power Supply

| Parameter | Test Conditions | Min. | Typ. | Max. | Units |
|---|---|------|------|------|-------|
| I _{cc} —V _{cc} Supply Current | Read mode, no TTL or RD ± loads | — | 35.0 | 46 | mA |
| | Write/Disable mode, no TTL loads | — | 36.5 | 43 | mA |
| I _{dd} —V _{dd} Supply Current | Read mode | — | 33.5 | 43 | mA |
| | Write/Disable mode | — | 34.5 | 50 | mA |
| P _d —Power Dissipation | T _j = 125°C Read/Write modes | — | — | 820 | mW |

Logic Signals — Mode

| | | | | | |
|---------------------------------------|------------------------|------|---|-----------------------|----|
| Input Low Voltage (V _{IL}) | | −0.3 | — | +0.8 | V |
| Input Low Current (I _{IL}) | V _{IL} = 0.4V | — | — | −0.8 | mA |
| Input High Voltage (V _{IH}) | | 2.0 | — | V _{CC} + 0.3 | V |
| Input High Current (I _{IH}) | V _{IH} = 2.4V | — | — | 100 | μA |

Logic Signals — HS_nB

| Parameter | Test Conditions | Min. | Max. | Units |
|--|------------------------|------|------|-------|
| Threshold Voltage, V _T + Positive-Going | V _{CC} = 5.0V | 1.4 | 2.0 | V |
| Threshold Voltage, V _T − Negative-Going | V _{CC} = 5.0V | 0.6 | 1.15 | V |
| Input Low Current (I _{IL}) | V _{IL} = 0.4V | — | −0.4 | mA |
| Input High Current (I _{IH}) | V _{IH} = 2.4V | — | 100 | μA |

Logic Signals — WR_{TOUT}, HS_n

| | | | | |
|--|--------------------------|-----|-----|---|
| Output Low Voltage (V _{OL}) | I _{OL} = 1.6mA | — | 0.4 | V |
| Output High Voltage (V _{OH}) | I _{OH} = −500uA | 2.4 | — | V |

Logic Signals — VFLTB & RD Open Collector Output

| | | | | |
|--|---|---|-----|----|
| Output Low Voltage (V _{OL}) | I _{OL} = 1.6mA 4.5 < V _{CC} < 5.5 I _{OL} = 0.5mA, 1.0 < V _{CC} < 4.5V (VFLTB Only) | — | 0.4 | V |
| Output High Current (I _{OH}) | | — | 25 | μA |

Mode Control

| | | | | |
|-------------------------------|--|---|-----|----|
| Read to Write Transition Time | | — | 1.0 | μs |
| Write to Read Transition Time | | — | 1.0 | μs |

Supply Voltage Fault Detect

| | | | | |
|---------------------------------|-----------------------------------|-----|------|---|
| V _{DD} Fault Threshold | VFLTB transition from high to low | 9.5 | 10.8 | V |
| V _{CC} Fault Threshold | VFLTB transition from high to low | 4.3 | 4.6 | V |

SSI 54O Series

Read Data Processor

| Parameter | Test Conditions | Min. | Max. | Units |
|--|--|----------|------|-------|
| Write Mode | | | | |
| Differential Input Voltage | | ± 0.4 | — | V |
| Input Hysteresis | | ± 40 typ | | mV |
| Single Ended Input Resistance | | 4.0 | — | kΩ |
| Input Common Mode Voltage Range | | 0.0 | 5.0 | V |
| Input Pulse Width | | 20 | — | ns |
| Propagation Delay (WRT + & WRT – TO WRTOU) | V(WRT + – WRT –) = 0 to 1.3V ¹ see Fig. 1 T _{PD} | — | 40 | ns |
| Output Rise and Fall times | WRTOU transition from 0.7 to 1.9V ¹ , see Fig 1 | — | 15 | ns |

1. WRTOU load is 30pf to GND and 2.5 kΩ to Vcc

Read Mode Unless otherwise specified RD + and RD – are loaded with 100Ω differentially and 30pf per side to GND, IN + and IN – are AC coupled, G + and G – are open. An 800Ω resistor is tied between the DIF + and DIF – pins with each pin loaded to GND with <3pf. The OUT + and OUT – pins are loaded with <3pf in parallel with >5kΩ AC coupled (i.e. no DC current).

| Parameter | Test Conditions | Min. | Max. | Units |
|--|--|---------|-------|-----------------|
| Amplifier & Active Differentiator | | | | |
| Differential Voltage Gain (IN ± to OUT ±) | R _g = ∞ , R _{ex} = 800Ω | 7.2 | 12.6 | V/V |
| | R _g = 0Ω , R _{ex} = 200Ω | 72 | 155 | V/V |
| Bandwidth | –3dB point | 30 | — | MHz |
| Common Mode Input Impedance (IN ±) | | 3.5 typ | | kΩ |
| Differential Input Resistance (IN ±) | V(IN + – IN –) = 100mV _{pp} , 2.5 MHz, AC coupled | 6.0 typ | | kΩ |
| Differential Input Capacitance (IN ±) | V(IN + – IN –) = 100mV _{pp} , 2.5 Mhz, AC coupled | — | 8 | pf |
| Input Noise (IN ±) | Inputs shorted together R _g = 0Ω , R _{ex} = 200Ω | — | 10 | nV/√Hz |
| V(DIF + DIF –) Output Swing | Set by R _g | — | 3.2 | V _{pp} |
| V(OUT + – OUT –) Output Swing | Set by R _{ex} , L _{ex} , C _{ex} Impedance | — | 5 | V _{pp} |
| Dynamic Range | Common mode DC input where gain falls to 90% of 0.0V DC common mode input. 10mV _{pp} AC input, R _g = ∞ , R _{ex} = 1200Ω | – 240 | – 240 | mV |
| DIF + to DIF – pin Current | | ± 1.9 | — | mA |
| OUT + to OUT – pin Current | | ± 3.8 | — | mA |
| CMRR (input referred) | V(IN +) = V(IN –) = 100mV _{pp} , 5MHz, R _g = 0Ω , R _{ex} = 200Ω | 40 | — | dB |
| PSRR (input referred) | V _{dd} or V _{cc} = 100mV _{pp} , 5Mhz, R _g = 0Ω , R _{ex} = 200Ω | 40 | — | dB |

| Parameter | Test Conditions | Min. | Max. | Units |
|--------------------------------------|-----------------|---------|------|-----------------|
| Zero Crossing Detector | | | | |
| Input Offset Voltage | | — | 5.0 | mV |
| Input Signal Range | | — | 5.0 | V _{pp} |
| Differential Input Impedance (DIN ±) | | 4.4 typ | | kΩ |

Line Driver (SSI 540 & 540-2 only)

| | | | | |
|-----------------------|--|------|----|----|
| Output Sink Current | V _{OL} = 0.5V, V(MODE) = 2.0V | 20 | — | mA |
| Output Source Current | V _{OH} = 2.5V, V(MODE) = 2.0V | — 2 | — | mA |
| Output Current | V _o = 0V to V _{cc} , V(MODE) = 0V | — 50 | 50 | μA |
| Output Rise Time | V _o = 0.7V to 1.9V 100Ω between RD+ and RD-, 30pf to GND | 2 | 30 | ns |
| Output Fall Time | V _o = 1.9V to 0.7V 100Ω between RD+ and RD-, 30pf to GND | 2 | 30 | ns |

Time Domain Filter

| | | | | |
|----------------------|---|------|------|----|
| Delay Range | T _{TD1} = 0.184 × R _{TD} × C _{TD} , R _{TD} = 1.5kΩ to 3.1kΩ, C _{TD} = 50pf to 200pf, V(DIN+ - DIN-) = 100mV _{pp} , 5MHz, AC coupled square wave See Fig 2 | 13.8 | 114 | ns |
| Delay Range Accuracy | V _{cc} = 5.0V, T _j = 60°C | — | ± 15 | ns |
| | Variation with supply and temperature | — | 12 | ns |
| Propagation Delay | Delay = T _{D2} - T _{D1} See Fig 2 | — | 80 | ns |

Data Pulse

| | | | | |
|-------------|---|----|----|----|
| Pulse Width | T _{PW} = 0.184 × R _{PW} × C _{PW} R _{PW} = 2kΩ, C _{PW} = 150pf See Fig 2 | 30 | 80 | ns |
| Skew | V(DIN+ - DIN-) = 100mV _{pp} , 5MHz, AC coupled square wave w/2nsec rise & fall times. | — | 5 | ns |

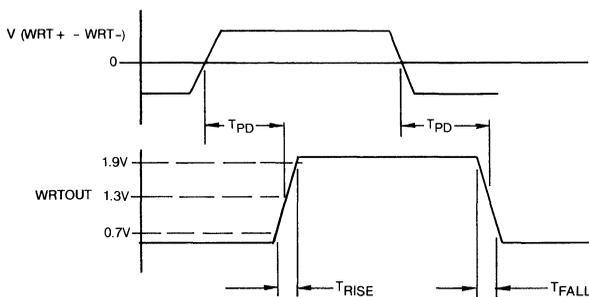


Fig. 1: Write Mode Timing.

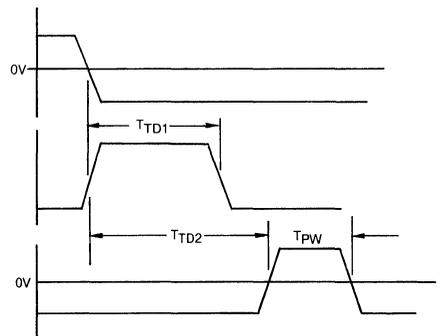
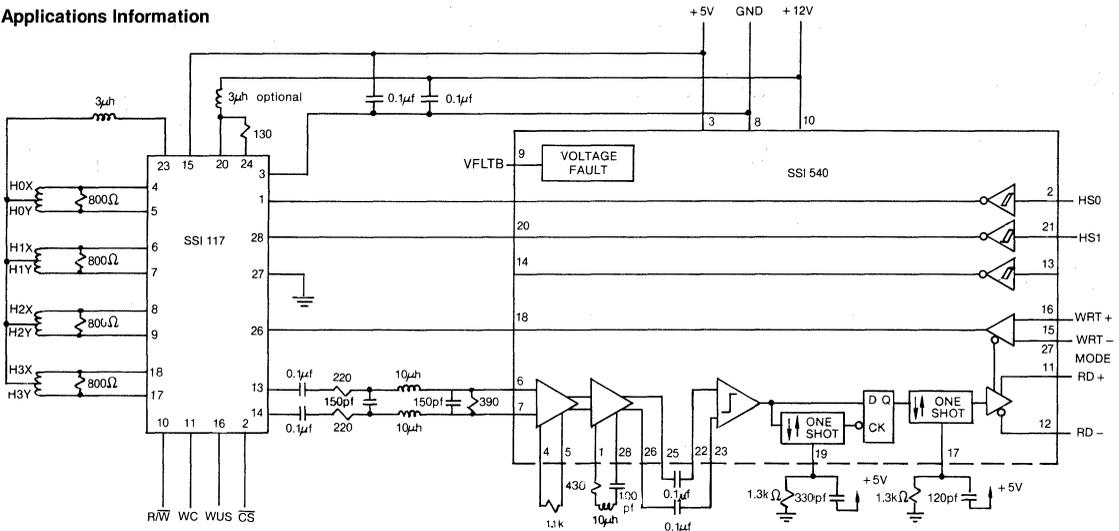


Fig. 2: Read Mode Timing

SSI 540 Series Read Data Processor

Applications Information



Design Example

As a design example a system using a 4-channel SSI 117 Read/Write preamplifier will be used.

- Assumptions—coding scheme is MFM
 —data rate is 5 Mbits/second
 —Ferrite head output is 1 mVpp min. and 2 mVpp max.

The output from the SSI 117 is 80 mVpp to 240 mVpp. Assuming a 6 dB loss through the external low pass filter the input to the SSI 540 at IN +, IN - is:

40mVpp to 120 mVpp differential voltage.

For this analysis the $\pm 37\%$ tolerance on gain from IN +, IN - to OUT +, OUT - will be equally divided between the gain stage and the differentiator, so each will contribute a $\pm 17\%$ variance from nominal values. The objective is to get a 5 Vpp signal at OUT +, OUT - at max input and max frequency. For MFM the 2f frequency in a 5 Mbit/sec data rate is 2.5 MHz, 1f is 1.25 MHz.

Gain Setting

Maximum gain from the amplifier occurs when $R_g = 0$. So calculating for nominal gain:

$$R_x = \frac{94 \times 42}{230} = 17.17$$

$$A_{v1} = \frac{680}{17 + 17.17} = 19.9 \text{ nominal or } 16.52 \text{ min to } 23.28 \text{ max}$$

The voltage swing at the DIF +, DIF - pins is:

$$120 \text{ mVpp} \times 22.25 = 2.79 \text{ Vpp max}$$

$$40 \text{ mVpp} \times 17.55 = 0.661 \text{ Vpp min}$$

This is within the 3.2 Vpp max guaranteed by this specification, so max gain will be used.

Differentiator Design

The differentiator can be as simple as a capacitor or as complex as a series RLC network. In order not to violate

the 5 Vpp max spec at OUT +, OUT - the maximum differential voltage gain is:

$$\frac{5}{2.79} = 1.79 \text{ max gain}$$

which is nominally a gain of 1.53

For Cex only:

$$C_{ex} = \frac{1.53}{2\pi f \sqrt{(1420)^2 - (1.53 \times 46)^2}} = 68 \text{ pf}$$

check for current saturation:

$$I_c = C_{ex} \times V_p \times 2\pi f \text{ must be less than } 1.9 \text{ mA}$$

For Cex, Rex network:

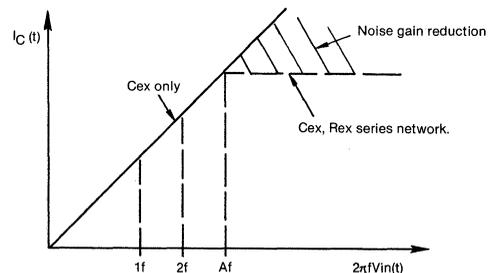
The following two formulas are used:

$$1.53 = \frac{j 1420 C_{ex} 2\pi f}{j(R_{ex} + 46) C_{ex} 2\pi f + 1}$$

$$R_{ex} + 46 = \frac{1}{C_{ex} A 2\pi f \max}$$

where A is chosen for position of corner frequency to reduce high frequency noise gain from the single capacitor network.

Graphically the method is as follows:



Check for current saturation using the following formula.

$$I_p = \frac{jV_p 2\pi f C_{ex}}{1 + j 2\pi f C_{ex} (R+46)}$$

For R_{ex} , C_{ex} , L_{ex} networks, the following formulae are used:

$$\begin{aligned} \text{Gain } G &= \frac{-j 1420 C_{ex} 2\pi f}{1 - L_{ex} C_{ex} (2\pi f)^2 + j (R_{ex} + 46) C_{ex} 2\pi f} \\ &= \frac{1420 C_{ex} 2\pi f}{\sqrt{[1 - L_{ex} C_{ex} (2\pi f)^2]^2 + [(R_{ex} + 46) C_{ex} 2\pi f]^2}} \\ &\quad \left[-\frac{\pi}{2} - \tan^{-1} \left[\frac{(R_{ex} + 46) (C_{ex} 2\pi f)}{1 - L_{ex} C_{ex} (2\pi f)^2} \right] \right] \end{aligned}$$

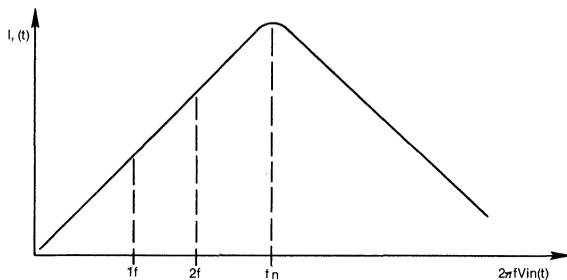
$$\text{Center Freq } f_n = \frac{1}{2\pi \sqrt{L_{ex} C_{ex}}}$$

$$\text{Damping Factor } \zeta = \frac{(R_{ex} + 46) C_{ex}}{2 \sqrt{L_{ex} C_{ex}}}$$

$$\text{Group Delay } \frac{dQ}{df} = \frac{2\zeta}{2\pi f_n} \left[\frac{1 + \left(\frac{f}{f_n}\right)^2}{1 + (4\zeta^2 - 2) \left(\frac{f}{f_n}\right)^2 + \left(\frac{f}{f_n}\right)^4} \right]$$

This technique adds another pole to the differentiator response to attenuate high frequency noise. The center frequency damping ratio and group delay are chosen to meet system requirements. Values for the center frequency are usually from 2 to 10fmax and the damping factor may be from 0.3 to 1.

Graphically the method is as follows:



As with the previous R_{ex} , C_{ex} example, care must be taken to insure a 90° phase shift at the frequencies of interest (1f and 2f or 1.25 MHz and 2.5 MHz). This requirement is modified by any need to compensate for phase distortion caused by preceding signal processing.

Effect of Gain Tolerance

At minimum gain the 1mVpp input at 1.25 MHz frequency has the following effects:

Using the capacitor only results with $C_{ex} = 68\text{pf}$

$$\text{Diff gain} = \frac{1420 C_{ex} 2\pi f}{\sqrt{1 + (46 C_{ex} 2\pi f)^2}} = 0.758 \text{ nominal}$$

Using $\pm 17\%$ tolerance, min gain = 0.629

so with a 661 mVpp input the min voltage @ OUT + /OUT - is 416 mVpp.

Thus, with all tolerances considered, a 1mVpp to 2mVpp input to the SSI 117 will result in a 5 Vpp to 416 mVpp input to the zero-crossing detector.

ONE-SHOT CONSIDERATIONS

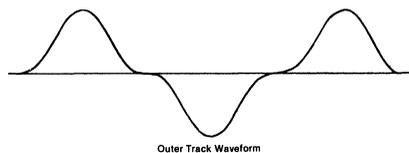
The timing for both one shots conform to the same equation: $t = 0.184 \times C \times R$

Setting of the time domain one-shot reflects the expected base line shouldering effect at the 1f frequency and is set accordingly. In this example the output pulse width has been set at approximately 30 nsec and the time domain filter at approximately 80 nsec.

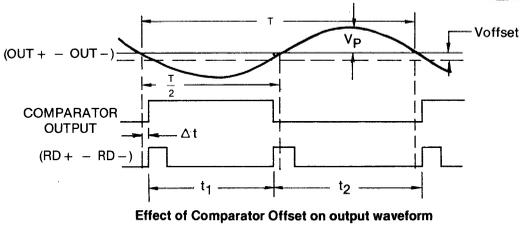
EXTERNAL FILTER

The filter on the output of the read/write amplifier, limits the bandwidth of the input to the SSI 540. This reduces the noise input to the differentiator which can produce spurious zero-crossings. The design of this filter is not discussed here, but general aspects of its transfer function will be discussed.

On the outer tracks of an ST506 compatible drive using a MFM coding technique, the output pulses return to baseline or exhibit shouldering.



This waveform has a high third harmonic content. In order to preserve this waveform the filter must not add any distortion to this harmonic. For this reason, the most common filter type used is a Bessel Filter which has a constant group delay ($\frac{dQ}{df}$) or linear phase shift. Thus for a 5 Mbit/sec MFM waveform a Bessel Filter with constant group delay and a -3 dB point of 3.75 MHz is required. This is the type of filter used in the design example.



Bit Shift or Pulse Pairing

Theoretical consideration of this aspect of pulse replication relative solely to the SSI 540 indicates that comparator offset is the major contributing parameter. For sinusoidal inputs the offset produces a non-symmetric waveform as shown.

The RD +, RD - output pulses have been offset from true position (zero-crossing) by an amount Δt, that is dependent on Voffset and OUT +, OUT - amplitude.

This relationship is

$$\Delta t = \frac{1}{w} \sin^{-1} \left(\frac{V_{off}}{V_p} \right) \text{ (radians)}$$

So, referring to previous results:

when OUT +, OUT - = 5Vpp @ 2.5 MHz

$$\Delta t = 0.13 \text{ nsec}$$

when OUT +, OUT - = 416 mVpp @ 1.25 MHz

$$\Delta t = 3.1 \text{ nsec}$$

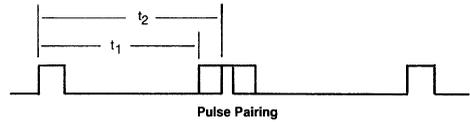
As can be seen above the center pulse has been shifted from its true position by 2 Δt. So for this example the Bit

Shift contributed by the SSI 540 is:

0.26 nsec at maximum input and frequency

6.2 nsec at minimum input and frequency

In some literature this effect is called Pulse Pairing. If the RD +, RD - waveform is displayed on an oscilloscope with the trigger holdoff adjusted to fire on succeeding pulses the following waveform is observed:

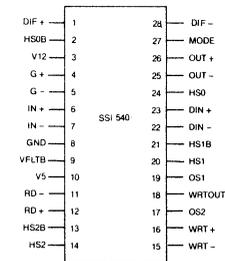


where $t_2 - t_1 = 4 \Delta t$ or $2 \times$ (Bit Shift)

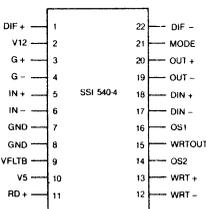
Using this technique and a sinusoidal input to $D_{IN} \pm$ of varying amplitude at 1.25 MHz and 2.5 MHz, the following results were obtained.

| $D_{IN} \pm$ Input V_{p-p} | RD ± Pulse Jitter (4Δt) nsec | |
|---------------------------------|------------------------------|---------|
| | 1.25 MHz | 2.5 MHz |
| 5 | 0.6 | 1.0 |
| 3 | 0.6 | 0.8 |
| 1 | 0.6 | 0.0 |
| .7 | 1.4 | 0.0 |
| .3 | 1.6 | 0.5 |
| .1 | 3.8 | 1.2 |
| .07 | 5.6 | 2.4 |
| .06 | 6.2 | 3.2 |
| .05 | 7.0 | 3.5 |
| .04 | 9.6 | 4.5 |
| .03 | 11.8 | 6.0 |

PIN CONFIGURATION — 28 PIN DIP

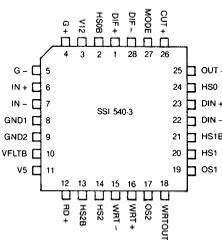
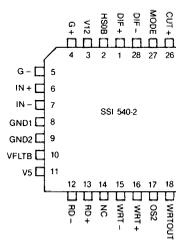
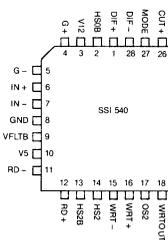
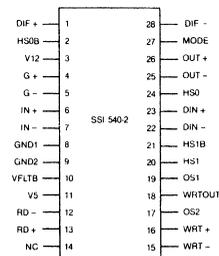


PIN CONFIGURATION — 22 PIN DIP



Top View Pinout

PIN CONFIGURATION — 28 PIN DIP



The "PRELIMINARY" designation on an SSI data sheet indicates that the product is not yet released for production. The specifications are subject to change, are based on design goals or preliminary part evaluation, and are not guaranteed. SSI should be consulted for current information before using this product. No responsibility is assumed by SSI for its use; nor for any

infringements of patents and trademarks or other rights of third parties resulting from its use. No license is granted under any patents, patent rights or trademarks of SSI. SSI reserves the right to make changes in specifications at any time and without notice.

Preliminary Data Sheet

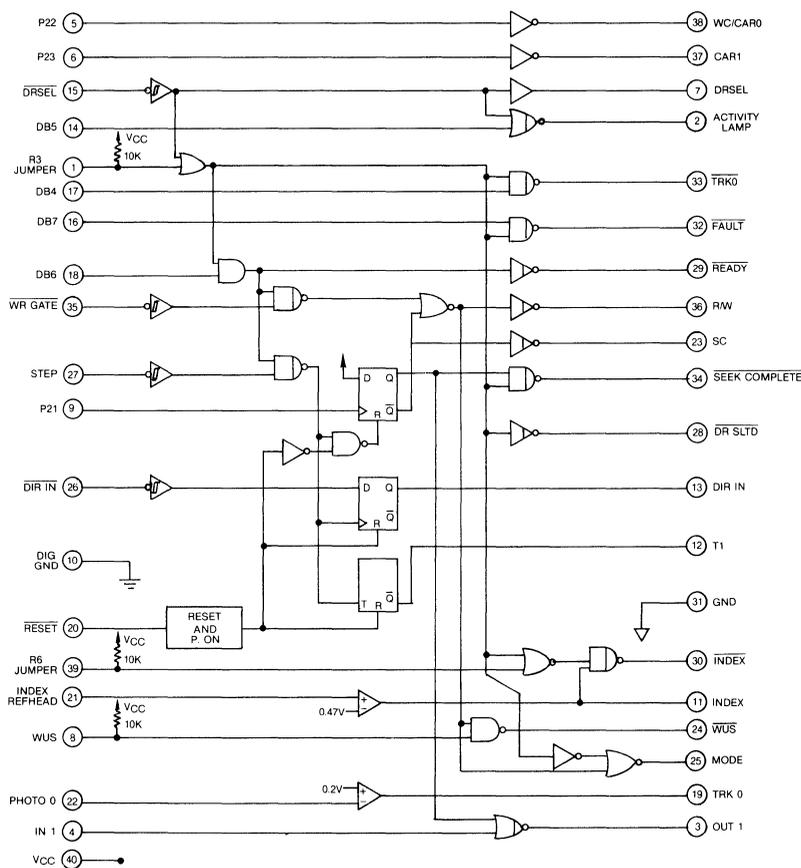
DESCRIPTION

The SSI 545 is an integrated circuit which consolidates functions in a Winchester Disk Drive normally performed by a variety of LSTTL SSI and MSI devices. Various gates, comparators and flip-flops are used to format signals compatible with the ST 506 interface requirements. All ST 506 connections have the necessary output drive or input hysteresis consistent with bus signal needs. The SSI 545 uses a single +5 volt supply and is available in 40 pin DIP and 44 pin QUAD packages.

FEATURES

- Reduces package count in 5¼" and smaller Winchester Disk Drives.
- Replaces bus interface and combinatorial logic devices between the ST 506 bus and on board processor and mechanical interfaces.
- Surface mount package available for further real estate reduction.

SSI 545 LOGIC DIAGRAM



CAUTION: Use handling procedures necessary for a static sensitive component

SSI 545 Winchester Disk Drive Support Logic

ABSOLUTE MAXIMUM RATINGS

| | | | |
|---------------------------|-----------------|---|---------------------|
| Characteristic | Rating | Ambient operating temperature | 0°C to +70°C |
| VCC supply voltage | 7 volts | Logic input voltage | -0.5 VDC to 7.0 VDC |
| Storage temperature | -65°C to +150°C | Lead temperature (soldering 10 sec) | 260°C |

ELECTRICAL CHARACTERISTICS

Unless otherwise specified: $4.5 < V_{CC} < 5.5V$; $0 \text{ deg C} < T_a < 70 \text{ deg C}$

| Parameter | Test Condition | Min. | Max. | Units |
|-----------|----------------|------|------|-------|
|-----------|----------------|------|------|-------|

LOGIC OUTPUTS Refer to table 1 for output type, pin number cross reference

TYPE 01 (OPEN COLLECTOR) OUTPUTS

| | | | | |
|---------------------|-----------------|---|-----|---------|
| Output High Current | $V_{OH} = 5.5V$ | — | 250 | μA |
| Output Low Voltage | $I_{OL} = 16mA$ | — | 0.5 | V |

TYPE 02 (TOTEM POLE) OUTPUTS

| | | | | |
|-----------------------|-----------------------|-----|------|----|
| Output High Voltage | $I_{OH} = -400 \mu A$ | 2.5 | — | V |
| Output Low Voltage | $I_{OL} = 8mA$ | — | 0.5 | V |
| Short Circuit Current | | — | -100 | mA |

TYPE 03 (OPEN COLLECTOR) OUTPUTS

| | | | | |
|---------------------|-------------------|---|-----|---------|
| Output High Current | $V_{OH} = V_{CC}$ | — | 50 | μA |
| Output Low Voltage | $I_{OL} = 30mA$ | — | 0.8 | V |

TYPE 04 (OPEN COLLECTOR) OUTPUTS

| | | | | |
|---------------------|-----------------|---|-----|---------|
| Output High Current | $V_{OH} = 5.5V$ | — | 250 | μA |
| Output Low Voltage | $I_{OL} = 48mA$ | — | 0.5 | V |

LOGIC INPUTS

TYPE 11 INPUTS

| | | | | |
|--------------------|-----------------|-----|------|---------|
| Input High Voltage | | 2.0 | — | V |
| Input Low Voltage | | — | 0.8 | V |
| Input Low Current | $V_{IL} = 0.5V$ | — | -0.8 | mA |
| Input High Current | $V_{IH} = 2.4V$ | — | 400 | μA |

TYPE 12 (SCHMIDT TRIGGER) INPUTS

| | | | | |
|--------------------|-------------------------------|-----|------|---------|
| Threshold Voltage | Positive going, $V_{CC} = 5V$ | 1.3 | 2.0 | V |
| | Negative going, $V_{CC} = 5V$ | 0.6 | 1.1 | V |
| Hysteresis | $V_{CC} = 5V$ | 0.4 | — | V |
| Input High Current | $V_{IH} = 2.4V$ | — | 40 | μA |
| Input Low Current | $V_{IL} = 0.5V$ | — | -0.8 | mA |

TYPE 13 (INTERNAL PULLUP) INPUTS

| | | | | |
|--------------------|-----------------|-----|------|---|
| Input High Voltage | | 2.0 | — | V |
| Input Low Voltage | | — | 0.8 | V |
| Input Low Current | $V_{IL} = 0.5V$ | — | -1.2 | V |

| Parameter | Test Condition | Min. | Max. | Units |
|--------------------------|---------------------------------------|--------|------|-------|
| COMPARATOR INPUTS | | | | |
| Threshold Voltage | Index Ref Positive going | – | 580 | mV |
| | Negative going | 370 | – | mV |
| | Photo 0 Positive going | – | 280 | mV |
| | Negative going | 120 | – | mV |
| Hysteresis | | 30 typ | – | mV |
| Input Resistance | VCC = 5.0V, 0 < V _{in} < VCC | 10 | – | kΩ |

TIMING CHARACTERISTICS Ta = 25°C, CL = 25 pF

| | | | | |
|---|---|-----|-----|----|
| Propogation Delay Time, Input to Output | P22 to WC/CAR0 | – | 40 | nS |
| | P23 to CAR0 | – | 40 | nS |
| | DB5 to ACTIVITY LAMP | – | 40 | nS |
| | DB4 to TRCK0 – | – | 40 | nS |
| | DB7 to FAULT– | – | 40 | nS |
| | DRSEL– to DRSEL | – | 55 | nS |
| | DRSEL– to ACTIVITY LAMP | – | 55 | nS |
| | WUS to WUS– | – | 55 | nS |
| | DB6 to READY– | – | 55 | nS |
| | WRGATE– to R/W– | – | 60 | nS |
| | STEP– to SC, DIR IN, to T1 | – | 100 | nS |
| | P21 to SC | – | 100 | nS |
| P21 to R/W– | – | 120 | nS | |
| Data Setup Time | DIRIN– reference to STEP | – | 50 | nS |
| Data Hold Time | DIRIN– to STEP | – | 5 | nS |
| Delay Time | INDEX REF HEAD to INDEX, with 500 mV input step | – | 250 | nS |
| | PHOTO0 to TRK0 with 500mV input step | – | 250 | nS |

TABLE 1

| Pin Number | | I/O Type | Pin Name | Pin Number | | I/O Type | Pin Name |
|------------|--------------|----------|--------------|------------|--------------|------------|--------------|
| 40 PIN DIP | 44 PIN QUAD* | | | 40 PIN DIP | 44 PIN QUAD* | | |
| 1 | 1 | I3 | R3JUMPER | 21 | 23 | COMPARATOR | INDEXREFHEAD |
| 2 | 2 | 03 | ACTIVITYLAMP | 22 | 24 | COMPARATOR | PHOTO0 |
| 3 | 3 | 01 | OUT1 | 23 | 25 | 02 | SC |
| 4 | 4 | I1 | IN1 | 24 | 26 | 02 | WUS |
| 5 | 5 | I1 | P22 | 25 | 27 | | MODE |
| 6 | 7 | I1 | P23 | 26 | 29 | I2 | DIRIN |
| 7 | 8 | 02 | DRSEL | 27 | 30 | I2 | STEP |
| 8 | 9 | I3 | WUS | 28 | 31 | 04 | DR SLTD |
| 9 | 10 | I1 | P21 | 29 | 32 | 04 | READY |
| 10 | 11 | | GROUND | 30 | 33 | 04 | INDEX |
| 11 | 12 | 02 | INDEX | 31 | 34 | | GROUND |
| 12 | 13 | 02 | T1 | 32 | 35 | 04 | FAULT |
| 13 | 14 | 02 | DIRIN | 33 | 36 | 04 | TRK0 |
| 14 | 15 | I1 | DB5 | 34 | 37 | 04 | SEEKCOMPLETE |
| 15 | 16 | I2 | DRSEL | 35 | 38 | I2 | WRGATE |
| 16 | 18 | I1 | DB7 | 36 | 40 | 01 | R/W |
| 17 | 19 | I1 | DB4 | 37 | 41 | 01 | CAR1 |
| 18 | 20 | I1 | DB6 | 38 | 42 | 01 | WC/CAR0 |
| 19 | 21 | 02 | TRK 0 | 39 | 43 | I3 | R6JUMPER |
| 20 | 22 | I1 | RESET | 40 | 44 | | +VCC |

*PINS 6, 17, 28, and 39 are not connected in the 44 Pin QUAD package.

Preliminary Data Sheet

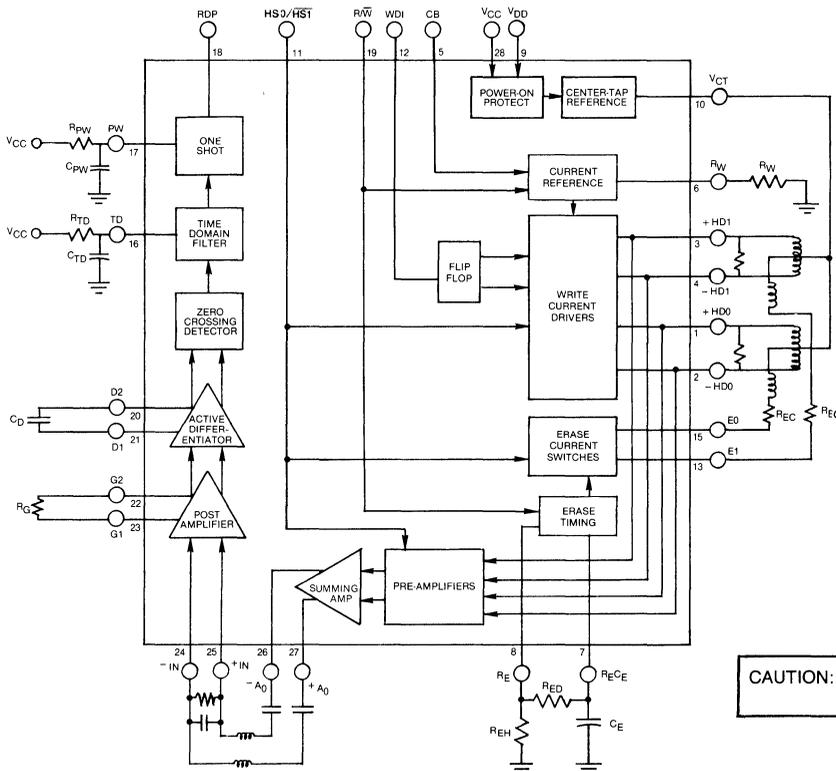
GENERAL DESCRIPTION

The SSI 570 is an integrated circuit which performs the functions of generating write signals and amplifying and processing read signals required for a double sided floppy disk drive. The write data circuitry includes switching differential current drivers and erase head drive with programmable delay and hold times. The read data circuitry includes low noise amplifiers for each channel as well as a programmable gain stage and necessary equalization and filtering capability using external passive components. All logic inputs and outputs are TTL compatible and all timing is externally programmable for maximum design flexibility. The circuit operates on +12 volt and +5 volt power supplies and is available in 28 pin plastic DIP and QUAD packages.

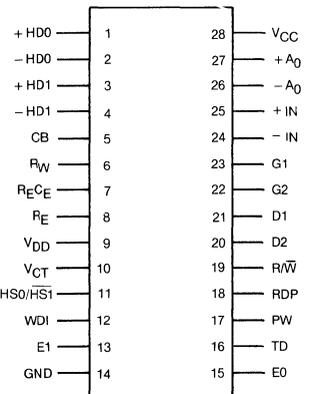
FEATURES

- Single chip read/write amplifier and read data processing function.
- Compatible with 8", 5¼", and 3½" drives.
- Internal write and erase current sources, externally set.
- Internal center tap voltage source.
- Control signals are TTL compatible.
- Schmitt trigger inputs for higher noise immunity on bussed control signals.
- TTL selectable write current boost.
- Operates on +12 volt and +5 volt power supplies.
- High gain, low noise, low peak shift (0.3% Typ) read processing circuits.

SSI 570 Block Diagram



SSI 570 Pin Out
(Top View)
(DIP & QUAD Pkgs)



CAUTION: Use handling procedures necessary for a Static Sensitive Component.

SSI 570 2-Channel Floppy Disk Read/Write Circuit

Circuit Operation

WRITE MODE CIRCUITRY

In Write Mode (R/\bar{W} low), the circuit provides controlled write and erase currents to either of two magnetic heads. The Write-Erase circuitry consists of two differential Write Current Drivers, a Center Tap Voltage Reference, two Erase Current Switches and control circuits for head selection and erase timing.

Write current is toggled between opposing sides of the head on each negative transition of the Write Data Input (WDI) and is set externally by a single resistor, R_{W} , connected between the R_{W} terminal and ground. Since driver output impedance is large, proper damping resistors must be provided across each head. A signal at the CB terminal provides write current boost.

Erase current is also set externally through resistors R_{EC} connected in series with each erase coil. Erase can be activated by, but delayed from, selection of the write mode, and is held active after mode deselection. The turn-on delay is determined by the charging of C_E through R_{ED} , while the hold time is determined by the discharge of C_E through the series combination of R_{ED} and R_{EH} (see connection diagram). The $R_{EC}C_E$ node may be driven directly by a logic gate, with external resistors per fig. 4, if the erase period is to be controlled separately from the write mode selection. For applications where no delays are required, C_E is omitted.

The Center Tap Voltage Reference supplies both write and erase currents. A Power Turn-On protection circuit prevents undesired writing or erasure by holding the voltage reference off until the supply voltages are within their operating ranges.

READ MODE CIRCUITRY

In the Read Mode (R/\bar{W} high), the circuit performs the functions of amplifying and detecting the selected head output pulses which correspond to magnetic transitions in the media. The Read circuitry consists of two differential Preamplifiers, a Summing Amplifier, a

Postamplifier, an Active Differentiator, a Zero-Crossing Detector, a Time Domain Filter, and an Output One-Shot.

The selected Preamplifier drives the Summing Amplifier whose outputs are AC coupled to the Postamplifier through an external filter network. The Postamplifier adjusts signal amplitudes prior to application of signals to the Active Differentiator. Postamplifier gain is set as required by connecting a resistor across the gain terminals, G1 and G2. If desired, an additional frequency/phase compensation network may also be connected across these gain terminals.

The Differentiator, driven by the Postamplifier, provides zero-crossing output voltages in response to input signal peaks. Differentiator response characteristics are set by an external capacitor or more complex series network connected between the D1 and D2 terminals.

The Zero-Crossing Detector provides a unipolar output for each positive or negative zero-crossing of the Differentiator output. To enhance signal peak detection, the Time Domain Filter inhibits the detection of zero-crossings if they are not sufficiently separated in time. The filter period is set by an external RC network connected to the TD pin.

The Time Domain Filter drives the output One-Shot which generates uniform output data pulses. The pulse width is set by an external RC network connected to the PW pin. The Output One-Shot is inhibited while in the Write Mode.

ABSOLUTE MAXIMUM RATINGS

| | |
|--------------------------------------|---|
| 5V Supply Voltage, V_{CC} | 7V |
| 12V Supply Voltage, V_{DD} | 14V |
| Storage Temperature | -65°C to +130°C |
| Ambient Operating Temperature | 0°C to +70°C |
| Junction Operating Temperature | 0°C to +130°C |
| Logic Input Voltage | -0.5V _{dc} to 7.0V _{dc} |
| Lead Temperature (soldering, 10 sec) | 260°C |
| Power Dissipation | 800mW |

ELECTRICAL CHARACTERISTICS Unless otherwise specified, 4.75V $\leq V_{CC} \leq 5.25$ V; 11.4V $\leq V_{DD} \leq 12.6$ V; 0°C $\leq T_A \leq 70$ °C; $R_W = 430\Omega$; $R_{ED} = 62k\Omega$; $C_E = 0.012\mu F$; $R_{EH} = 62k\Omega$; $R_{EC} = 220\Omega$

POWER SUPPLY

| Characteristic | Test Conditions | Min. | Max. | Units |
|-------------------------------|---|------|------|-------|
| POWER SUPPLY CURRENTS | | | | |
| I_{CC} — 5V Supply Current | Read Mode | — | 35 | mA |
| | Write Mode | — | 38 | mA |
| I_{DD} — 12V Supply Current | Read Mode | — | 26 | mA |
| | Write Mode (excluding Write & Erase currents) | — | 24 | mA |

SSI 570

| Characteristic | Test Conditions | Min. | Max. | Units |
|----------------|-----------------|------|------|-------|
|----------------|-----------------|------|------|-------|

LOGIC SIGNALS — READ/WRITE (R/W), CURRENT BOOST (CB)

| | | | | |
|---------------------------------|-----------------|-----|------|---------|
| Input Low Voltage (V_{IL}) | | — | 0.8 | V |
| Input Low Current (I_{IL}) | $V_{IL} = 0.4V$ | — | -0.4 | mA |
| Input High Voltage (V_{IH}) | | 2.0 | — | V |
| Input High Current (I_{IH}) | $V_{IH} = 2.4V$ | — | 20 | μA |

LOGIC SIGNALS — WRITE DATA INPUT (WDI), HEAD SELECT (HS0/HS1)

| | | | | |
|--|-----------------|-----|------|---------|
| Threshold Voltage, $V_T +$ Positive — going | | 1.4 | 1.9 | V |
| Threshold Voltage, $V_T -$ Negative — going | | 0.6 | 1.1 | V |
| Hysteresis, $V_T +$ to $V_T -$ | | 0.4 | — | V |
| Input High Current, I_{IH} | $V_{IH} = 2.4V$ | — | 20 | μA |
| Input Low Current, I_{IL} | $V_{IL} = 0.4V$ | — | -0.4 | mA |

CENTER TAP VOLTAGE REFERENCE

| | | | | |
|-----------------------------|--------------------------------|----------------|---------------|---|
| Output Voltage (V_{CT}) | $I_{WC} + I_E = 3mA$ to $60mA$ | $V_{DD} - 1.5$ | $V_{DD} - .5$ | V |
| V_{CC} Turn-Off Threshold | (See Note 1) | 4.0 | — | V |
| V_{DD} Turn-Off Threshold | (See Note 1) | 9.6 | — | V |
| V_{CT} Disabled Voltage | | — | 1.0 | V |

ERASE OUTPUTS (E1, E0)

| | | | | |
|--|--------------------------|---|-----|---------|
| Unselected Head Leakage | $V_{E0}, V_{E1} = 12.6V$ | — | 100 | μA |
| Output on Voltage (V_{E1}, V_{E0}) | $I_E = 50mA$ | — | 0.5 | V |

WRITE CURRENT

| | | | | |
|---------------------------------|---|---------------|---------------|---------|
| Unselected Head Leakage | $V_{E1}, V_{E0} = 12.6V$ | — | 25 | μA |
| Write Current Range | $R_W = 820\Omega$ to 180Ω | 3 | 10 | mA |
| Current Reference Accuracy | $I_{WC} = 2.3/R_W$ V_{CB} (current boost) = $0.5V$ | -5 | +5 | % |
| Write Current Unbalance | $I_{WC} = 3mA$ to $10mA$ | — | 1.0 | % |
| Differential Head Voltage Swing | $\Delta I_{WC} \leq 5\%$ | 12.8 | — | Vpk |
| Current Boost | $V_{CB} = 2.4V$ | $1.25 I_{WC}$ | $1.35 I_{WC}$ | — |

SSI 570

| Characteristic | Test Conditions | Min. | Max. | Units |
|---|---|------|------|-------|
| ERASE TIMING | | | | |
| Erase Delay Range | $R_{ED} = 39k\Omega$ to $82k\Omega$; $C_E = 0.0015\mu F$ to $0.043\mu F$ | 0.1 | 1.0 | msec |
| Erase Delay Accuracy $\frac{\Delta T_{ED}}{T_{ED}} \times 100\%$ | $T_{ED} = 0.69 R_{ED} C_E$ $R_{ED} = 39k\Omega$ to $82k\Omega$; $C_E = 0.0015\mu F$ to $0.043\mu F$ | - 15 | + 15 | % |
| Erase Hold Range | $R_{EH} + R_{ED} = 78k\Omega$ to $164k\Omega$; $C_E = 0.0015\mu F$ to $0.043\mu F$ | 0.2 | 2.0 | msec |
| Erase Hold Accuracy $\frac{\Delta T_{EH}}{T_{EH}} \times 100\%$ | $T_{EH} = 0.69 (R_{EH} + R_{ED}) C_E$ $R_{EH} + R_{ED} = 78k\Omega$ to $164k\Omega$; $C_E = 0.0015\mu F$ to $0.043\mu F$ | - 15 | + 15 | % |

ELECTRICAL CHARACTERISTICS

Unless otherwise specified: V_{IN} (Preamplifier) = 10mVp-p sine wave, dc coupled to center tap. (See Figure 1). Summing Amplifier Load = $2k\Omega$ line-line, ac coupled. V_{IN} (Postamplifier) = 0.2Vp-p sine wave, ac coupled; $R_G =$ open; Data Pulse Load = $1k\Omega$ to V_{CC} ; $C_D = 240pF$; $C_{TD} = 100pF$; $R_{TD} = 7.5k\Omega$; $C_{PW} = 47pF$; $R_{PW} = 7.5k\Omega$.

READ MODE

| Characteristic | Test Conditions | Min. | Max. | Units |
|---|---|-----------|-----------|---------------|
| PREAMPLIFIER — SUMMING AMPLIFIER | | | | |
| Differential Voltage Gain | Freq. = 250kHz | 85 | 115 | V/V |
| Bandwidth (- 3 dB) | | 3 | — | MHz |
| Gain Flatness | Freq. = dc to 1.5MHz | — | ± 1.0 | dB |
| Differential Input Impedance | Freq. = 250kHz | 20 | — | $k\Omega$ |
| Max. Differential Output Voltage Swing | $V_{IN} = 250kHz$ sine wave, THD $\leq 5\%$ | 2.5 | — | Vp-p |
| Small Signal Differential Output Resistance | $I_O \leq 1.0mA$ p-p | — | 75 | Ω |
| Common Mode Rejection Ratio | $V_{IN} = 300mVp-p$ @ 500kHz. Inputs shorted. | 50 | — | dB |
| Power Supply Rejection Ratio | $\Delta V_{DD} = 300mVp-p$ @ 500kHz Inputs shorted to V_{CT} . | 50 | — | dB |
| Channel Isolation | Unselected Channel $V_{IN} = 100mVp-p$ @ 500kHz. Selected channel input connected to V_{CT} . | 40 | — | dB |
| Equivalent Input Noise | Power BW = 10kHz to 1MHz Inputs shorted to V_{CT} . | — | 10 | μV_{rms} |
| Center Tap Voltage, V_{CT} | | 1.5 (typ) | | V |

POSTAMPLIFIER — ACTIVE DIFFERENTIATOR

| | | | | |
|---|--|-----|-----------|-----|
| Ao, Differential Voltage Gain + IN, - IN to D1, D2 | Freq. = 250kHz (See Figure 2) | 8.5 | 11.5 | V/V |
| Bandwidth (- 3 dB) + IN, - IN to D1, D2 | $C_D = 0.1\mu F$, $R_D = 2.5k\Omega$ | 3 | — | MHz |
| Gain Flatness + IN, - IN to D1, D2 | Freq. = dc to 1.5 MHz $C_D = 0.1\mu F$, $R_D = 2.5k\Omega$ | — | ± 1.0 | dB |

SSI 570

| Characteristic | Test Conditions | Min. | Max. | Units |
|--|---|------|------|------------|
| POSTAMPLIFIER — ACTIVE DIFFERENTIATOR (cont'd) | | | | |
| Max. Differential Output Voltage Swing | $V_{IN} = 250\text{kHz}$ sine wave, ac coupled. $\leq 5\%$ THD in voltage across C_D . (See Figure 2) | 5.0 | — | Vp-p |
| Max. Differential Input Voltage | $V_{IN} = 250\text{kHz}$ sine wave, ac coupled. $\leq 5\%$ THD in voltage across C_D . $R_G = 1.5\text{k}\Omega$ | 2.5 | — | Vp-p |
| Differential Input Impedance | | 10 | — | k Ω |
| Gain Control Accuracy $\frac{\Delta A_R}{A_R} \times 100\%$ | $A_R = A_O R_G / (8 \times 10^3 + R_G)$ $R_G = 2\text{k}\Omega$ | -25 | +25 | % |
| Threshold Differential Input Voltage. (See Note 2) | Min. differential input voltage at post amp that results in a change of state at RDP. $V_{IN} = 250\text{kHz}$ square wave, $C_D = 0.1\ \mu\text{F}$, $R_D = 500\ \Omega$, $T_R, T_F \leq 0.2\ \mu\text{sec}$. No overshoot; Data Pulse from each V_{IN} transition. (See Figure 3) | — | 3.7 | mVp-p |
| Peak Differentiator Network Current | | 1.0 | — | mA |

TIME DOMAIN FILTER

| | | | | |
|---|--|-----|------|----|
| Delay Accuracy $\frac{\Delta T_{TD}}{T_{TD}} \times 100\%$ | $T_{TD} = 0.58 R_{TD} \times (C_{TD} + 10^{-11}) + 50\text{nsec}$, $R_{TD} = 5\text{k}\Omega$ to $10\text{k}\Omega$, $C_{TD} \geq 56\text{pF}$ $V_{IN} = 50\text{mVpp}$ @ 250kHz square wave, $T_R, T_F \leq 20\text{ nsec}$, ac coupled. Delay measured from 50% input amplitude to 1.5V Data Pulse. | -15 | +15 | % |
| Delay Range | $T_{TD} = 0.58 R_{TD} \times (C_{TD} + 10^{-11}) + 50\text{ nsec}$ $R_{TD} = 5\text{k}\Omega$ to $10\text{k}\Omega$ $C_{TD} = 56\text{pF}$ to 240pF | 240 | 2370 | ns |

DATA PULSE

| | | | | |
|---|---|-----|------|----|
| Width Accuracy $\frac{\Delta T_{PW}}{T_{PW}} \times 100\%$ | $T_{PW} = 0.58 R_{PW} \times (C_{PW} + 8 \times 10^{-12}) + 20\text{ nsec}$ $R_{PW} = 5\text{k}\Omega$ to $10\text{k}\Omega$ $C_{PW} = \geq 36\text{pF}$ width measured at 1.5V amplitudes | -20 | +20 | % |
| Active Level Output Voltage | $I_{OH} = 400\ \mu\text{A}$ | 2.7 | — | V |
| Inactive Level Output Leakage | $I_{OL} = 4\text{mA}$ | — | 0.5 | V |
| Pulse Width | $T_{PW} = 0.58 R_{PW} \times (C_{PW} + 8 \times 10^{-12}) + 20\text{ nsec}$ $R_{PW} = 5\text{k}\Omega$ to $10\text{k}\Omega$ $C_{PW} = 36\text{pF}$ to $200\ \text{pF}$ | 145 | 1225 | nS |

NOTES:

1. Voltage below which center tap voltage reference is disabled.
2. Threshold Differential Input Voltage can be related to peak shift by the following formula:

$$\text{Peak Shift} = \frac{3.7\text{mV}}{\pi V_{in}} \times 100\%$$

where V_{in} = peak to peak input voltage at post amplifier.

Note that this formula demonstrates an inverse relationship between the input amplitude and the Peak Shift.

TEST SCHEMATICS:

FIGURE 1
Preamplifier Characteristics

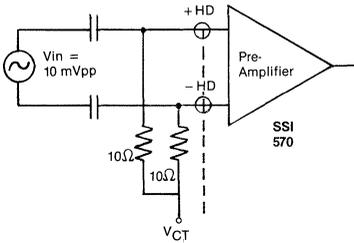


FIGURE 2
Postamplifier
Differential Output Voltage Swing
and Voltage Gain

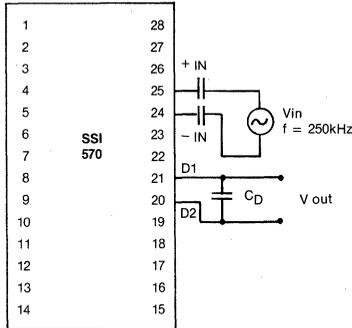


FIGURE 3
Postamplifier
Threshold Differential
Input Voltage

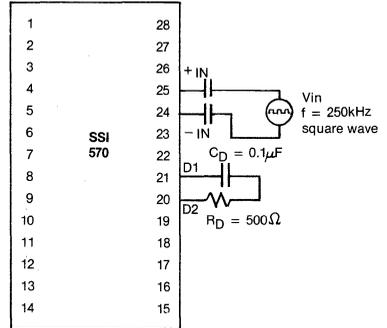
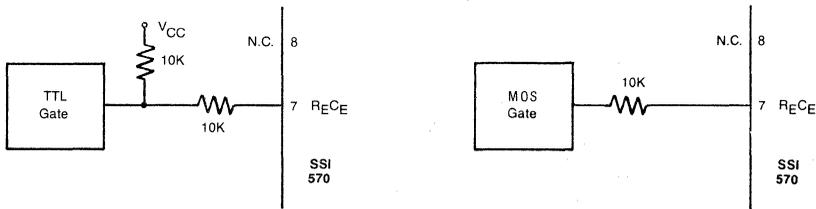


FIGURE 4
External Erase
Control Connections



Output HI = Erase Coil Active

| SSI FLOPPY DISK CIRCUITS | | |
|--------------------------|-----------|---------------------------|
| SSI 570 | 2-Channel | Floppy Read/Write Circuit |
| SSI 575 | 4-Channel | Floppy Read/Write Circuit |
| SSI 580 | — | Floppy Support Circuit |

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Preliminary Data Sheet

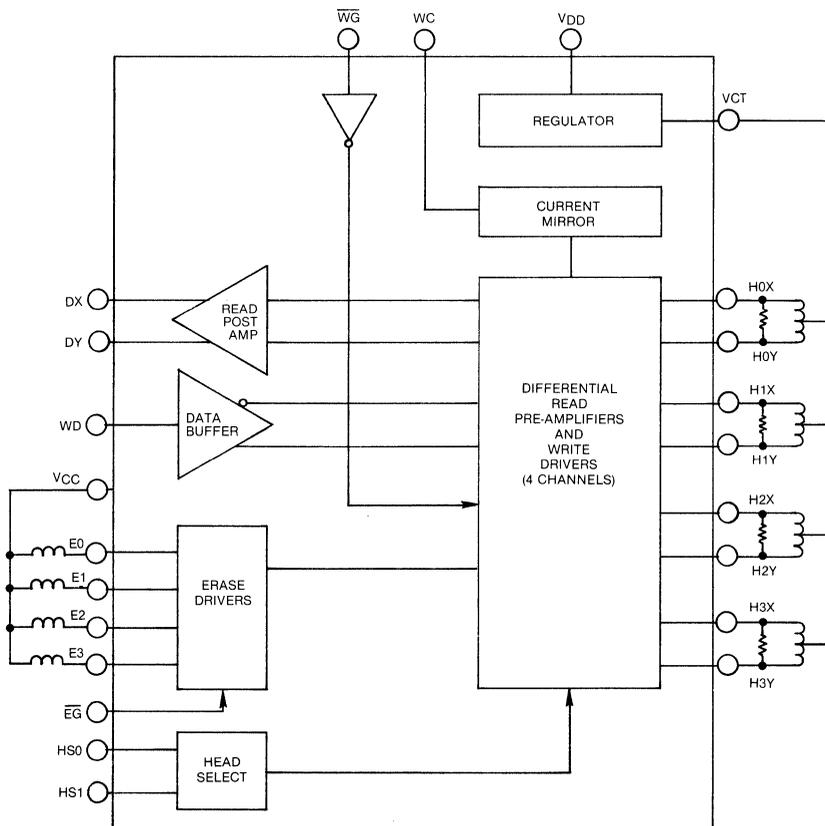
GENERAL

The SSI 575 device is a bipolar monolithic integrated circuit used in floppy disk systems for head control and write, erase, and read select functions. The device has either two or four discrete read, write, and erase channels. Channel select inputs are TTL compatible. The SSI 575 device requires +5V and +12 V power supplies and is available in 18-pin (2-channel version) or 24-pin (4-channel version) dual inline packages.

FEATURES

- Operates on +5V, +12V power supplies
- Two or four channel capability
- TTL compatible control inputs
- Read/Write functions on one chip
- Internal center tap voltage source
- Supports all disk sizes
- Applicable to tape systems

SSI 575 Block Diagram



CAUTION: Use handling procedures necessary for a static sensitive component

SSI 575

2 or 4-Channel Floppy Disk Read/Write Circuit

CIRCUIT OPERATION

The SSI 575 functions as a write and erase driver or as a read amplifier for the selected head. Two TTL compatible inputs are decoded to select the desired read/write and erase heads. Head select logic is indicated in Table 2. Both the erase gate (\overline{EG}) and write gate (\overline{WG}) lines have internal pull up resistors to prevent an accidental write or erase condition.

MODE SELECTION

The read or write mode is determined by the write gate (\overline{WG}) line. The input is open collector TTL compatible. With the input low, the circuit is in the write mode. With the input high (open), the circuit is in the read mode. In the read mode, or with the +5V supply off the circuit will not pass write current.

ERASE

The erase operation is controlled by an open collector TTL compatible input. With erase gate (\overline{EG}) input high (open) or the +5V supply off, the circuit will not pass erase current. With \overline{EG} low, the selected open collector erase output will be low and current will be pulled through the erase heads.

READ MODE

With the \overline{WG} line high, the read mode is enabled. In the read mode the circuit functions as a differential amplifier. The state of the head select input determines which amplifier is active. When the mode or head is switched, the read output will have a voltage level shift. External reactive elements must be allowed to recover before proper reading can commence. A current diverting circuit prevents any possible write current from appearing on a head line.

WRITE MODE

With the \overline{WG} line low, externally generated write current is mirrored to the selected head and is switched between head windings by the state of the write data (\overline{WD}) signal.

TABLE 1: PIN DESCRIPTION

| Pin Name | Description |
|--------------------|---|
| VCC | +5V. |
| VDD | +12V |
| H0X-H3X H0Y-H3X | X, Y head connections |
| DX, DY | X, Y Read Data: Differential read signal out |
| \overline{WG} | Write gate: sets write mode of operation |
| WC | Write current: current mirror used to drive floppy disk heads |
| WD | Write data line |
| \overline{EG} | Erase gate: allows erasure by selected head |
| E0-E3 | Erase head driver connections |
| HS0-HS1 | Head select inputs |
| GND | Ground |
| VCT | Center Tap Voltage Source |

TABLE 2: HEAD SELECT LOGIC
4 CHANNELS

| HS1 | HS0 | HEAD |
|-----|-----|------|
| 0 | 0 | 0 |
| 0 | 1 | 1 |
| 1 | 0 | 2 |
| 1 | 1 | 3 |

2 CHANNELS

| HS1 | HEAD |
|-----|------|
| 0 | 0 |
| 1 | 1 |

ABSOLUTE MAXIMUM RATINGS*

| | |
|----------------------------------|--------------------|
| DC Supply Voltage: Vcc | 6.0V |
| Vdd | 14.0V |
| Write Current | 10 mA |
| Head Port Voltage | 18.0V |
| Digital Input Voltages: | |
| DX, DY, HS0, HS1, WD | -0.3 to +10V |
| EG, WG | -0.3 to Vcc + 0.3V |
| DX, DY Output Current | -5 mA |
| VCT Output Current | -10 mA |
| Storage Temperature Range | -65 to +150 °C |
| Junction Temperature | 125 °C |
| Lead Temperature (10 sec solder) | 260 °C |

*Operation above these ratings may cause permanent damage to the device.

RECOMMENDED OPERATING CONDITIONS 0°C < Ta < 50°C, 4.7V < Vcc < 5.3V, 11V < Vdd < 13V

| Parameter | Conditions | Min. | Typ. | Max. | Unit |
|---------------------|------------|------|------|------|------|
| Vcc Supply Current: | Vcc MAX | — | — | — | — |
| Read mode | | — | — | 15 | mA |
| Write mode | | — | — | 35 | mA |
| Vdd Supply Current: | Vdd MAX | — | — | — | — |
| Read mode | | — | — | 25 | mA |
| Write mode | | — | — | 15 | mA |
| Write Current | | — | 5.5 | — | mA |

ERASE OUTPUT

| Parameter | Test Conditions | Min. | Typ. | Max. | Units |
|-------------------|-----------------|------|------|------|-------|
| Erase on Voltage | IE = 80mA | 0.7 | — | 1.3 | VDC |
| Erase off Leakage | | — | — | 100 | μA |

LOGIC SIGNALS — HEAD SELECT (HS0, HS1) AND WRITE DATA (WD)

| | | | | | |
|--------------------|-----------------------------|------|---|-----|-----|
| Low Level Voltage | — | −0.3 | — | 0.8 | VDC |
| High Level Voltage | — | 2.0 | — | 6.0 | VDC |
| Low Level Current | V _{IN} = 0 volts | −1.6 | — | — | mA |
| High Level Current | V _{IN} = 2.7 volts | — | — | 40 | μA |

LOGIC SIGNALS — WRITE GATE (WG) AND ERASE GATE (EG)

| | | | | | |
|--------------------------|---------------------------|------|---|------|-----|
| Low Level Voltage | — | −0.3 | — | 0.81 | VDC |
| High Level Input Current | — | −300 | — | — | μA |
| Low Level Current | V _{IN} = 0 volts | −2.0 | — | — | mA |

READ MODE

| Parameter | Test Conditions | Min. | Typ. | Max. | Units |
|---------------------------------------|--|------|------|------|--------|
| Differential Gain | f = 100kHz, Vin = 5 mV Rms RL = 10 kΩ | 80 | 100 | 120 | V/V |
| Bandwidth | Vin = 5 m V Rms RL = 10 K CL = 15PF | 9 | — | — | MHz |
| Input Voltage Range for 95% Linearity | f = 100kHz, RL = 10k | 25 | — | — | mVpp |
| Differential Input Resistance | f = 1 MHz | 100 | — | — | kΩ |
| Differential Input Capacitance | f = 1 MHz | — | — | 10 | pF |
| Input Bias Current | — | — | — | 25 | μA |
| Input Offset Voltage | — | — | — | 12 | mV |
| Output Voltage, Common Mode | — | — | 8 | — | VDC |
| Output Resistance | — | — | — | 35 | Ω |
| Output Current Sink | — | 2 | — | — | mA |
| Output Current Source | — | 3 | — | — | mA |
| Common Mode Rejection Ratio | f = 1 MHz (input referred) | 50 | — | — | dB |
| Power Supply Rejection Ratio | f = 1 MHz (input referred) | 50 | — | — | dB |
| Channel Separation | f = 1 MHz (input referred) | 50 | — | — | dB |
| Input Noise | BW = 100 Hz to 1 MHz, Z Source = 0 | — | 7 | — | μV RMS |

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WRITE MODE

| Parameter | Test Conditions | Min. | Typ. | Max. | Units |
|--|----------------------------|------|------|------|-------|
| Write Current Gain | IW = 5.5mA | .97 | — | 1.05 | A/A |
| Write Current Voltage Level | IW = 5.5mA | 1.2 | — | 2.1 | VDC |
| Differential Head Voltage | IW = 5.5mA | 12.5 | — | — | VDC |
| Unselected Head Current | IW = 5.5mA DC Condition | — | — | 0.1 | mA |
| Write Current Unbalance | IW = 5.5mA | — | — | 1 | % |
| Write Current Time Symmetry | IW = 5.5mA | — | — | ± 10 | nS |
| Read Amplifier Output Level | — | — | 10.5 | — | VDC |
| Center Tap Voltage (Read and Write Modes) | — | — | 8.5 | — | VDC |

SWITCHING CHARACTERISTICS

| Parameter | Test Conditions | Min. | Typ. | Max. | Units |
|--------------------------------------|-------------------------------|------|------|------|-------|
| Write and Erase Gate Switching Delay | Delay to 90% of Write Current | — | — | 1 | μsec |
| Head Select Switching Delay | — | — | — | 1 | μsec |
| Head Current Switching Delay | T1 in Fig. 1 | — | 10 | — | nsec |
| Head Current Switching Time | IW = 5.5mA Shorted Head | — | 10 | 30 | nsec |
| Write to Read Recovery Time | — | — | — | 2 | μsec |

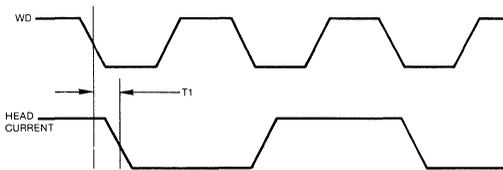
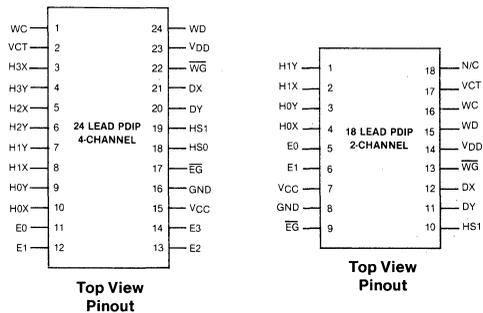


FIG.1

PIN CONFIGURATIONS



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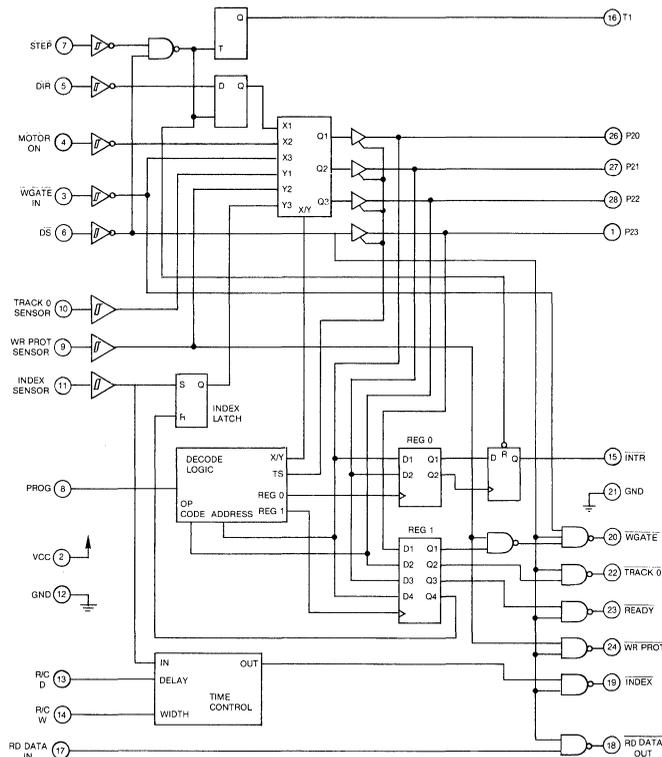
DESCRIPTION

The SSI 580 device is a bipolar integrated circuit that serves as an input/output port expander for an 8048 type microprocessor based floppy disk drive system. The device consolidates functions normally performed by a variety of LSTTL, SSI, and MSI devices. The combination of an SSI 570 (read, write, and erase device), an 8048 type microprocessor, and the SSI 580 provides the majority of electronics required for a SA400 type floppy disk drive system, including host interface bus driver and receiver. In addition to its port expansion function, the SSI 580 processes system data and provides both pulse width and delay control (adjustable by external elements) for the INDEX SENSOR input. The device requires a single +5 V power supply and is available in a 28-pin package.

FEATURES

- Reduces package count in flexible disk drive systems
- Replaces bus interface and combinational logic devices between the SSI 570, on board microprocessor and mechanical interfaces.
- Surface mount available for further real estate reduction.
- Provides drive capability for mechanical and system interfaces

SSI 580 Block Diagram



CAUTION: Use handling procedures necessary for a static sensitive component

SSI 580

Port Expander Floppy Disk Drive

PIN ASSIGNMENT DESCRIPTIONS

| Pin Name | Description |
|--|--|
| P20-P23 | 4-bit bidirectional port, referred to as Port 2. |
| WGATE IN | This input command to write is asserted by the host interface bus. |
| MOTOR ON | This input command to turn on the spindle motor comes from the host interface bus. |
| DIR | Input from the host interface bus selecting the direction in which the stepper motor should move the head. |
| \overline{DS} | Drive select |
| INDEX SENSOR | Input from the photodiode that indicates the index marker in the diskette. |
| WR PROT SENSOR | Input from the photodiode that indicates if the diskette is write protected. |
| TRACK 0 SENSOR | Input from the photodiode that detects when the head is positioned over track 0. |
| STEP | Input from the host interface bus indicating that the head should be moved. |
| T1 | This pin changes state when a \overline{STEP} command is received from the host interface bus. |
| \overline{RD} DATA IN and \overline{RD} DATA OUT | Read data path |
| WGATE | Output to the disk drive's read/write circuitry. |
| INDEX | Output to the host interface bus indicating index sensor status. |
| TRACK 0 | Output to the host interface bus indicating track 0 sensor status. |
| READY | Output to the host interface bus indicating track 0 sensor status. |
| WR PROT | Output to the host interface bus indicating write protect sensor status. |
| PROG | Input from the 8048 microprocessor for I/O control of the 580. |
| INTR | Output to the interrupt pin of the 8048 microprocessor. |
| R/C D and R/C W | The external resistor and capacitor networks tied to these pins determines the delay and width of the output pulse to the INDEX pin. |
| Vcc | + 5 V supply |
| GND | Ground |

Table 1

CIRCUIT OPERATION

PORTS

The SSI 580 has two 4-bit input ports, Port A and Port B. Port A receives data from the host interface bus for conveyance to the drive's read/write circuitry and to the microprocessor. Three sensors report the status of the drive to the 580 via Port B. Common to both ports is a drive select (\overline{DS}) signal from the host interface bus. This allows the host to address separate disk drives. There is also a 4-bit bidirectional port on the SSI 580. This is port 2 and it can be used by the microprocessor to write to or read from the 580.

READ MODE

Ports A and B can be read by a microprocessor via Port 2. This allows the microprocessor to obtain data from the host interface bus and the status sensors. The PROG signal from the microprocessor provides the timing for the operation. First an OP code and a port address must be placed on Port 2 (see Table 2), then latched in on the falling edge of PROG. When the OP code and addresses have been decoded, the desired input port is selected and output on Port 2. The operation is terminated by the rising edge PROG, which returns Port 2 to the input mode.

WRITE MODE

In the write mode the microprocessor passes system parameters to the SSI 580 for logic processing and outputting. Table 3 shows how each bit of Port 2 affects the 580. A logic one on the zero bit of Port 2 will reset the index latch. P21, qualified by the \overline{DS} signal, sends a "this drive ready" signal from the microprocessor to the host interface bus. Similarly P22 is \overline{DS} qualified and sent to the host as a signal that the head is positioned over track 0. P23 is used in the logic that sends a R/W signal to the drive's read/write circuitry. The write mode occurs when the proper OP code and address is placed on Port 2 and latched in on the falling edge of PROG (see Table 3). The microprocessor writes in the data on PROG's rising edge.

INDEX PULSE

An optical sensor connected to the INDEX SENSOR pin detects the diskette's index marker. The state of the index sensor is latched into the 580 and is available to be read by the microprocessor on P22. The latch may be reset by writing a one to P20 from the microprocessor. The pulse received from the sensor also drives the host interface signal INDEX, the width and delay of which can be controlled by external R/C circuits. The time constant attached to the R/C D pin determines the delay from the INDEX SENSOR input to the INDEX signal on the host interface bus. The equation for the delay is $T_d = 0.59R_d \times C_d$ (seconds). The width of the INDEX signal is determined by the circuit attached to the R/C W pin and the equation $T_w = 0.59R_w \times C_w$ (seconds).

INTERRUPT

The INTR signal is asserted every time a step command is issued to the drive on the host interface bus. Thus when INTR is tied to the interrupt pin of 8048 type

microprocessor, an interrupt service routine will be executed on each step command. This routine typically obtains information on the direction the heads should move and the status of the track 0 sensor to use for generating the stepper motor control signals. The interrupt signal is cleared (set high) by first placing the proper OP code and address on Port 2 (see Table 3). This is latched in on the falling edge of PROG, then on its rising edge logic ones on P20 and P21 will be latched in to set $\overline{\text{INTR}}$ back to a high state. Note that an indeterminate operation will result from holding the INDEX SENSOR latch reset (holding P20 high).

T1 PIN

This signal changes state with the $\overline{\text{STEP}}$ command of the host interface bus when the drive is selected. It drives the T1 pin on an 8048 type microprocessor which is an input to a counter. The 8048 can use this count and the DIR signal read from Port 2 of the SSI 580 to monitor the head position and issue a CB (current boost) command to the SSI 570 when a specific track is reached.

TABLE 2. READ MODE

| Input to Port 2 | | Read From Port 2 | | | | 4-Bit Input Port |
|-----------------|-----------|------------------------|--------------------|-----------|----------------|------------------|
| OP Code P22 | Addr. P20 | P23 | P22 | P21 | P20 | |
| 0 | 0 | $\overline{\text{DS}}$ | Index Sensor Latch | WR Sensor | Track 0 Sensor | B |
| 0 | 1 | $\overline{\text{DS}}$ | WGATE IN | MOTOR ON | DIR | A |

TABLE 3. WRITE MODE

| Input to Port 2 | | Data processed from Port 2 | | | | |
|-----------------|-----------|----------------------------|--------------------------------|--------------------------------|--------------------------|-------------------|
| OP Code P22 | Addr. P20 | WGATE | TRACK0 | READY | $\overline{\text{INTR}}$ | Index Latch Reset |
| 1 | 0 | Z | (P22* $\overline{\text{DS}}$) | (P21* $\overline{\text{DS}}$) | — | P20 |
| 1 | 1 | — | — | — | See Text | — |

Where Z = (P23*WR PROT SENSOR) + ($\overline{\text{DS}}$ *WGATE IN)

Absolute Maximum Ratings (All voltages referred to GND)

| Parameter | Symbol | Value | Units |
|-------------------------------------|------------------|---------------|-------|
| DC Supply | V _{cc} | + 7 | VDC |
| Voltage Range (any pin to GND) | V _m | - 0.4 to + 7 | VDC |
| Power Dissipation | P _{max} | 700 | mW |
| Storage Temperature | T _{stg} | - 40 to + 125 | °C |
| Lead Temperature (10 sec soldering) | — | 260 | °C |

ELECTRICAL CHARACTERISTICS Unless otherwise specified, 4.75 ≤ V_{cc} ≤ 5.25 VDC; 0°C < T_a < 70°C.

| Parameter | Test Conditions | Min. | Max. | Units |
|--|---|------|-------|-------|
| Totem pole outputs (P20 – P23, INTR, T1) | | | | |
| Output High Voltage | 104 = - 400 A | 2.5 | — | V |
| Output Low Voltage | IoL = 2mA | — | 0.5 | V |
| Open collector outputs (RD DATA OUT, INDEX, WGATE, TRACK 0, READY, WR PROT) | | | | |
| Output High Current | VOH = 5.25 V. | — | 250 | μA |
| Output Low Voltage | IoL = 48 mA | — | 0.5 V | V |
| Inputs (P20 – P23, PROG, RD DATA IN) | | | | |
| Input High Voltage | — | 2.0 | — | V |
| Input Low Voltage | — | — | 0.8 | V |
| Input Low Current | VIL = 0.5 V | — | - 0.8 | mA |
| Input High Current | VIL = 2.4 V | — | 40 | μA |
| Input Current | Vin = 7.0 V | — | 0.1 | mA |
| Schmitt - Trigger Inputs (WGATE IN, MOTOR ON, DIR, DS, STEP) | | | | |
| Threshold Voltage | Positive Going, V _{cc} = 5.0 V | 1.3 | 2.0 | V |
| | Negative Going, V _{cc} = 5.0 V | 0.6 | 1.1 | V |

ELECTRICAL CHARACTERISTICS (cont.)

| Parameter | Test Conditions | Min. | Max. | Units |
|--------------------|-------------------------|------|------|-------|
| Hysteresis | V _{CC} = 5.0 V | 0.4 | — | V |
| Input High Current | V _{IH} = 2.4 V | — | 40 | μA |
| Input Low Current | V _{IL} = 0.5 V | — | -0.4 | mA |
| Input Current | V _{IN} = 7.0 V | — | 0.1 | mA |

High Impedance Inputs with Hysteresis (WR PROT SENSOR, TRACK 0 SENSOR, INDEX SENSOR)

| | | | | |
|--------------------|--|-----|-------|----|
| Input High Voltage | — | — | 2.0 | V |
| Input Low Voltage | — | 0.8 | — | V |
| Hysteresis | — | 0.2 | — | V |
| Input Current | V _{in} = 0 to V _{CC} | — | -0.25 | mA |

TIMING CHARACTERISTICS

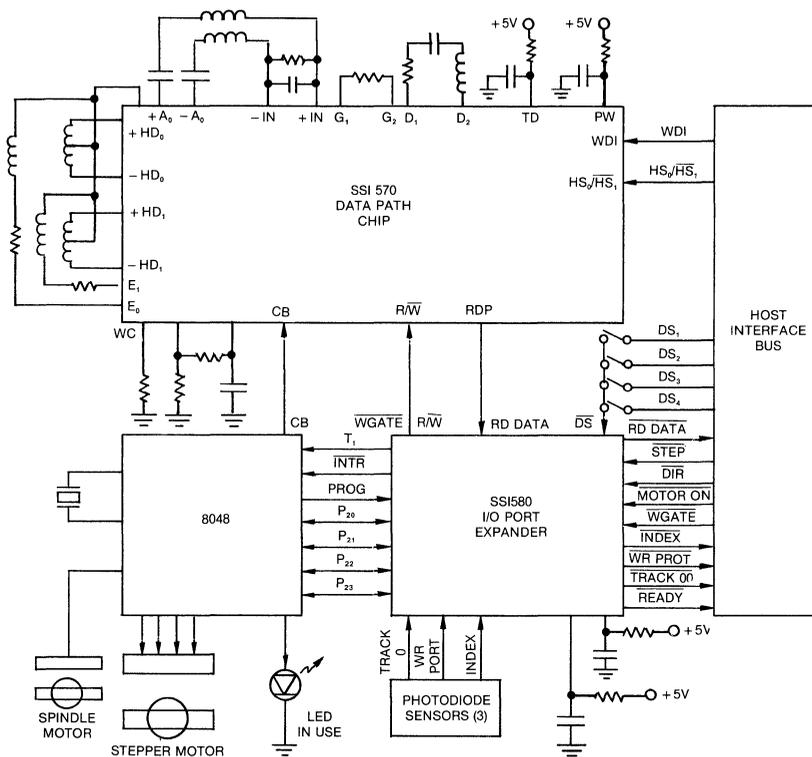
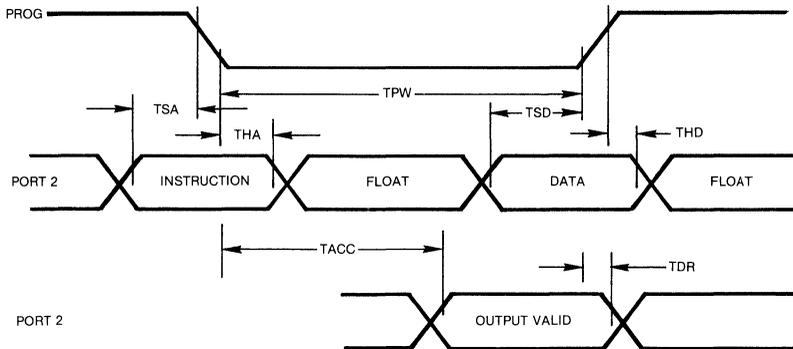
 Unless otherwise specified; T_a = 25 °C; 4.75 V ≤ V_{CC} ≤ 5.25 V; C_L = 15 pf.

| PARAMETER | CONDITION | MIN. | MAX. | UNITS |
|----------------------------------|---|-------------------|-------------------|-------|
| Propagation Delay Time | RD DATA IN to RD DATA OUT | — | 35 | nS |
| | DS to WGATE, TRACK 0, READY, WR PROT, RD DATA, INDEX | — | 80 | nS |
| | PROG to INTR, WGATE, TRACK 0 (Rising edge) READY, WR PROT | — | 100 | nS |
| | WR PROT to WGATE, WR PROT SENSOR | — | 250 | nS |
| | WGATE IN to WGATE | — | 80 | nS |
| | STEP to T1, P20 | — | 80 | nS |
| | TRACK 0 SENSOR WR PROT SENSOR to Port 2 INDEX SENSOR | — | 250 | nS |
| | MOTOR ON WGATE IN to Port 2 DS | — | 80 | nS |
| Data Setup Time | DIR to STEP | 50 | — | nS |
| Data Hold Time | DIR to STEP | 0 | — | nS |
| Delay Accuracy (Pin 13) | T _d = 0.59 R _D × C _D R _D = 3.9k to 10k C _D = 75pf to 300pf | 0.8T _d | 1.2T _d | sec |
| Pulse Width Accuracy (Pin 14) | T _w = 0.59 R _w × C _w R _w = 3.9k to 10k C _w = 75pf to 300pf | 0.8T _w | 1.2T _w | sec |

PORT 2 (P20 – P23) TIMING (Timing Referenced to PROG signal, Figure 2.)

| Symbol | Name-Description | Min | Max | Units |
|--------|-----------------------|------|-----|-------|
| TSA | Addr. setup time | 100 | — | nS |
| THA | Addr. hold time | 80 | — | nS |
| TSD | Data in setup time | 100 | — | nS |
| THD | Data-in hold time | 80 | — | nS |
| TACC | Data-out access time | — | 700 | nS |
| TDR | Data-out release time | — | 200 | nS |
| TPW | PROG pulse width | 1500 | — | nS |

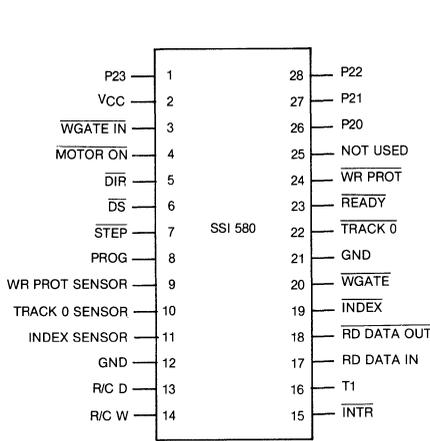
Figure 2. Timing Diagram



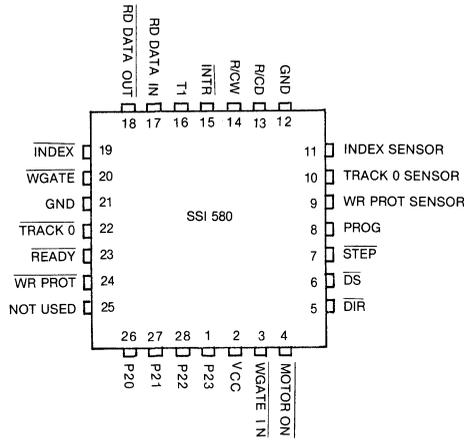


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PIN CONFIGURATION



**28-LEAD PDIP
(Top View)**



**28-Lead Quad
(Top View)**

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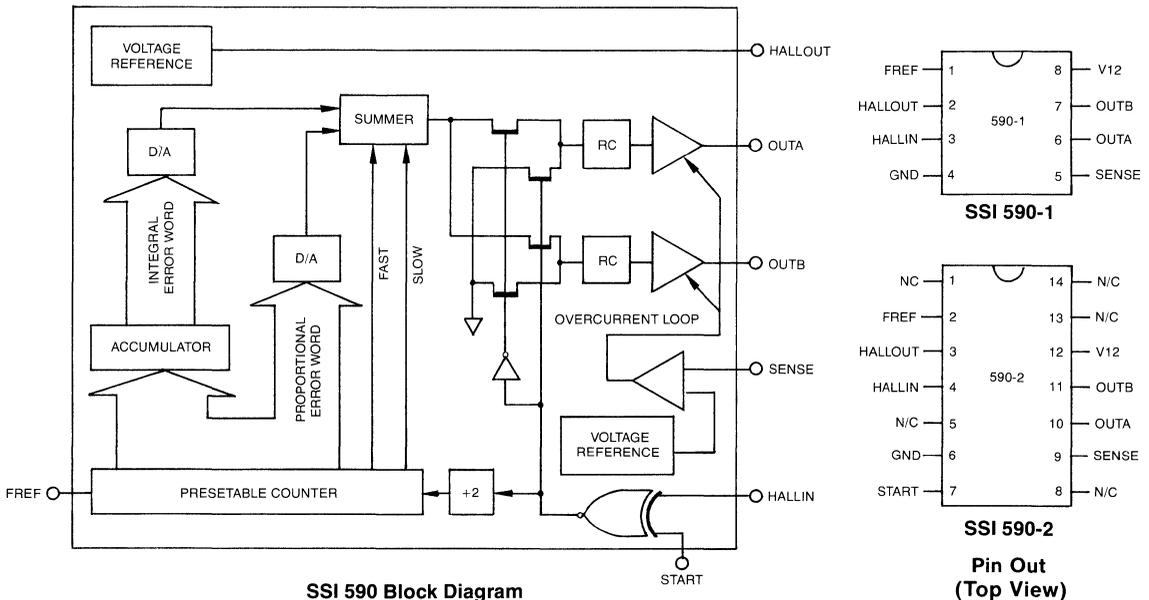
Preliminary Data Sheet

GENERAL DESCRIPTION:

The SSI 590 is a motor controller IC designed to provide all timing and control functions necessary to start, drive and brake a two-phase, four-pole, brushless DC spindle motor. The IC requires two external power transistors (such as Darlington power transistors), three external resistors, and an external frequency reference. The motor Hall sensor is directly driven and decoded by the device. The controller is optimized for a 3600 rpm disc drive motor using a 2 Mega-Hertz clock. Motor protection features include stuck rotor shutdown, coil over-current detection and control, and supply fault detection. The device's linear control loop controls the power drivers using Pulse Amplitude Modulation.

FEATURES:

- Available in 8 pin DIP (SSI 590-1) or 14 pin DIP (SSI 590-2).
- CMOS with single + 12 volt power supply.
- All motor START, DRIVE, AND STOP timing and control.
- Includes Hall-Effect sensor drive and input pins.
- Highly accurate speed regulation of +/- .035%.
- Active braking function (590-2 only).
- On-chip digital filtering requires no external compensation or adjustments.
- Provides protection against stuck rotor, coil over-current, and supply fault.
- Regenerative braking with shutdown.



CAUTION: Use handling procedures necessary for a static sensitive component.

SSI 590

CONTROL LOOP DESCRIPTION:

The device incorporates both analog and digital circuit techniques to utilize the advantages of each. The analog portion of the loop uses switched capacitor filter technology to eliminate external components. The control loop uses a Pulse Amplitude Modulation (PAM) control scheme to avoid the switching transients and torque ripple inherent in Pulse Width Modulation (PWM) schemes.

A binary counter is preset once per motor revolution by an index signal generated by the hall position sensor. On the next index pulse, the remaining least significant bits are loaded into the proportional D/A and accumulated by a saturating accumulator. The most significant bits are loaded into the integral D/A. The size of the accumulator and the bit locations determine the major scaling (within a factor of two) for the gain and zero location of the filter. To prevent overflow in the proportional D/A the counter is decoded to detect overflow, and the proportional D/A is saturated as needed. The overflow also generates a boost signal used in the summer. The range of the accumulator is larger than the linear range of the proportional channel to help filter small load disturbances that tend to saturate the proportional channel. The entire counter is also used to provide a time-out feature to protect the motor and external circuitry.

INPUT/OUTPUT PIN DESCRIPTION:

- * **FREF (frequency reference input)**
A TTL compatible input used by the device to set and maintain the desired motor speed and operate circuit blocks.
- * **HALLOUT**
Provides a regulated bias voltage for the Hall effect sensor inside the motor.
- * **HALLIN (Hall sensor input)**
The TTL open-collector type output of the motor's Hall switch feeds this input which has a resistor pullup to the HALLOUT bias voltage. Refer to figure 1 for input timing.
- * **OUTA, OUTB (driver outputs)**
These two driver outputs drive the external power transistors, such as TIP120 NPN darlington power transistors as shown in the typical application. The power transistors control the motor current through the current setting resistor R_e . The motor current is $V(\text{sense})/R_e$. During normal operation, the drive voltages are adjusted as necessary to maintain the proper motor speed and drive current. Regenerative braking is accomplished with self biasing of the power transistors thru resistors R_b with power shutdown. Refer to figure 1 for output timing.
- * **SENSE (coil current sense line)**
Senses the coil current and limits the sense voltage to the threshold by limiting the drive to the external power transistors.

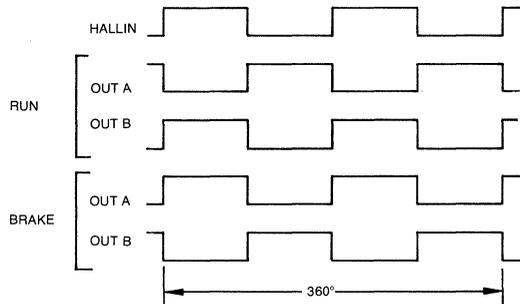


FIGURE 1 = SSI 590 Firing Order

* START (active brake control, only available on 14 pin package)

The active brake is enabled by applying a logic "0" to the START pin. During active braking the output phasing is reversed to apply a reverse torque to the motor until the motor period drops below the reverse shutdown speed at which time the drivers turn off the external power transistors to deny power to the motor. Active braking is shown in figure 1.

* N/C (no connection, 14 pin package only)

These pins must remain unconnected and floating.

PROTECTION FEATURES:

* LOW VOLTAGE DETECTION

If the supply drops below the detect threshold the device will turn off all of the external power transistors to prevent damage to the motor and the power devices.

* STUCK ROTOR SHUTDOWN

If the delay from power onset to a positive Index transition or the time interval between successive Index transitions is greater than the prescribed time, the device interprets this delay as a stuck rotor and reduces the motor current to zero until such time as one positive HALLIN transition is detected or until power is removed and reapplied.

* MOTOR COIL OVER-CURRENT

Refer to SENSE input description. Sense voltage is generated by current through R_e shown in the typical application. The SENSE input threshold limits the maximum coil current.

ABSOLUTE MAXIMUM RATINGS:

| | |
|---|---------------------------|
| Positive Supply Voltage, V_{DD} | 14V |
| Storage Temperature | -65 deg. C to +125 deg. C |
| Ambient Operating Temperature | 0 deg. C to +70 deg. C |
| HALLIN, FREF, START, and SENSE input voltages. | -0.3V to $V_{DD}+0.3V$ |
| HALLOUT Current | 10mA |
| Lead Temperature (soldering, 10 sec.) | 260 deg. C |
| Power Dissipation | 400mW |

ELECTRICAL CHARACTERISTICS Unless otherwise specified, $10.8V \leq V_{12} \leq 13.2V$; $0 \text{ deg.} \leq C \leq 70 \text{ deg.} \leq C$; $F_{REF} = 2.00\text{MHz}$; $R_e = 0.4 \text{ Ohms} \pm 10\%$ (2 watt); $R_b = 4.7 \text{ Kohm} \pm 10\%$ ($\frac{1}{4}$ WATT); $0.8 \leq \text{Darlington } V_{be} \leq 1.8$

Motor Parameters: (1 to 3 platters)

KT Torque constant = $0.015 \text{ Nt-m/amp} \pm 10\%$

J Inertia = $0.000489 \text{ Nt-m/s/s} \pm 33\%$

KD Damping factor = $0.0000318 \text{ Nt-m/rad/sec} \pm 33\%$

$$\text{where: } \frac{\text{Motor frequency(s)}}{\text{Motor Current(s)}} = \frac{KT}{J \times s + KD}$$

| Characteristic | Test Condition | Min. | Max. | Unit |
|---|--|-----------|-------|-----------------|
| POWER SUPPLY CURRENT | | | | |
| ICC (Includes Drive Outputs) | | (17 typ) | 30 | mA |
| FREF AND START INPUTS | | | | |
| Input Low Voltage | $i_{il} = 500\mu A$ | — | 0.8 | V |
| Input High Voltage | $i_{ih} = 100\mu A$ | 2.0 | — | V |
| HALL SENSOR INTERFACE | | | | |
| HALLOUT Bias Voltage | $I = 5\text{mA}$ | 5.0 | 6.8 | V |
| HALLOUT Pullup Resistance | To HALLOUT Pin | 5 | 20 | Kohms |
| Input Low Voltage | | — | 1.0 | V |
| Input High Voltage | | 4.0 | — | V |
| DRIVER OUTPUTS | | | | |
| Sink Capability | V_{OUTA} or $V_{OUTB} = 0.5 \text{ Volts}$ | 5.0 | — | mA |
| Source Capability | V_{OUTA} or $V_{OUTB} = 3.0 \text{ Volts}$ | -5.0 | — | mA |
| Capacity Load Drive Capability | | — | 50.0 | pF |
| SENSE INPUT | | | | |
| Threshold Voltage | | 0.9 | 1.1 | V |
| Input Current | | -100 | 100 | μA |
| Input Capacitance | | — | 25.0 | pF |
| STUCK ROTOR DETECTION | | | | |
| Shutdown Time | Power on To Driver | 0.815 | 0.935 | sec |
| LOW VOLTAGE DETECTION | | | | |
| Detect Threshold | | 6.0 | 9.0 | V |
| CONTROL LOOP—DESCRIPTION* | | | | |
| Divider Ratio | $F_{REF}/\text{Avg. Motor Frequency}$ | 16664 | 16672 | — |
| Index to Index Jitter | Total Jitter | — | 8.0 | μsec |
| Loop Gain H ($2 \times \pi \times f$) | $f = 2\text{Hz}$ | 0 Typical | | dB |
| Loop Zero | K_p/K_i | 0.97 | 1.03 | Hz |

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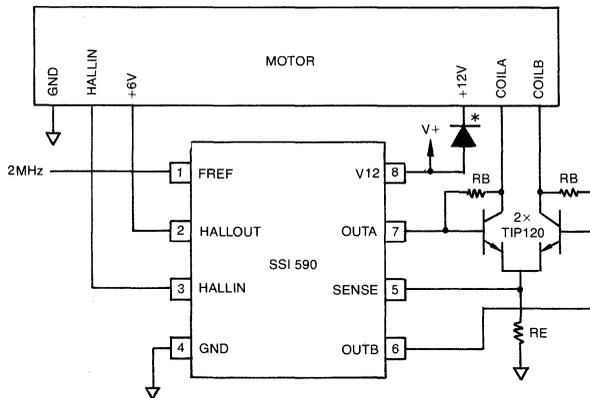
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| Characteristic | Test Condition | Min. | Max. | Unit |
|--|----------------|------|------|------|
| CONTROL LOOP Vs SUPPLY VARIATION | | | | |
| $K_p(V_{12} = 13.2V)$ $K_p(V_{12} = 10.8V)$ | | 0.96 | 1.04 | — |
| $K_i(V_{12} = 13.2V)$ $K_i(V_{12} = 10.8V)$ | | 0.96 | 1.04 | — |

| Characteristic | Test Condition | Typ. | Max. | Unit |
|---|----------------|------|------|------|
| START/STOP VELOCITY PROFILES | | | | |
| Power on Delay to FHALL Greater than FREF/16668 | 1 Platter | 7.0 | 11.0 | sec |
| | 2 Platters | 9.0 | 13.0 | sec |
| | 3 Platters | 11.0 | 15.0 | sec |
| Speed Overshoot $\frac{FHALL - (FREF/16668)}{(FREF/16668)}$ | 1 Platter | 0.5 | 2.0 | % |
| | 2 Platters | 0.5 | 2.0 | % |
| | 3 Platters | 0.5 | 2.0 | % |
| Settling Time: Motor Frequency Settles to 0.05% | 1 Platter | 9.0 | 13.0 | sec |
| | 2 Platters | 11.0 | 15.0 | sec |
| | 3 Platters | 13.0 | 17.0 | sec |
| Stop Time (Regenerative): Motor Frequency Slows to 30% after Power is Removed | 1 Platter | 7.0 | 13.0 | sec |
| | 2 Platters | 8.0 | 15.0 | sec |
| | 3 Platters | 9.0 | 17.0 | sec |
| Stop Time (Active): | | 4.0 | | sec |

*The continuous Time Transfer Function of the On Chip Control can be modeled as follows: $H(s) = \frac{Vc(s)}{F(s)} = K_i \times \frac{(1 + s/(2 \times \pi \times (K_p/K_i)))}{s}$ K_i = Integral gain
K_p = Proportional gain

TYPICAL APPLICATION



*NOTE: DIODE REQUIRED FOR REGENERATIVE BRAKING. (THREE AMP MINIMUM RATING)

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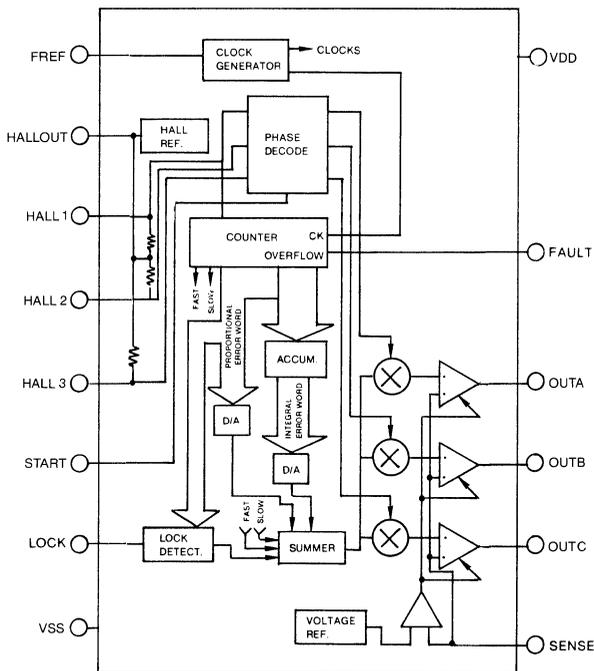
Preliminary Data Sheet

General Description

The SSI 591 is a motor controller IC designed to provide all timing and control functions necessary to start, drive and brake a three-phase brushless DC spindle motor. The IC requires three external power transistors (such as Darlingtons power transistors), one external power resistor, and an external frequency reference. The three motor Hall sensors are directly driven and decoded by the device. The controller is optimized for a 3600 rpm disc drive motor using a 2 Mega-Hertz clock. Motor protection features include stuck rotor shutdown, supply and clock fault detection, all of which are indicated by a FAULT signal, and coil over-current detection and control. A LOCK signal is provided to indicate that the motor is at speed. The device's linear control loop controls the power drivers using Pulse Amplitude Modulation.

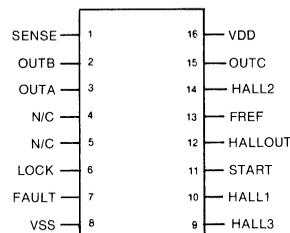
FEATURES:

- CMOS with TTL/LSTTL compatible control functions
- Single +12 volt power supply
- All motor START, DRIVE, AND STOP timing and control.
- Includes Hall-Effect sensor drive and input pins.
- Highly accurate speed regulation of $\pm 0.05\%$.
- Active braking function.
- On-chip digital filtering requires no external compensation of adjustments.
- Provides protection against stuck rotor, motor coil over-current, supply fault, or clock fault.
- At speed indication provided.



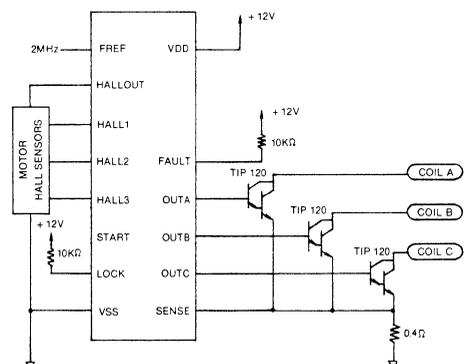
SSI 591 Block Diagram

CAUTION: Use handling procedures necessary for a static sensitive component.



SSI 591 Pin Out
(Top View)

TYPICAL APPLICATION



SSI 591

CONTROL LOOP DESCRIPTION

The device incorporates both analog and digital circuit techniques to utilize the advantages of each. The analog portion of the loop uses switched capacitor filter technology to eliminate external components. The control loop uses a Pulse Amplitude Modulation (PAM) control scheme to avoid the switching transients and torque ripple inherent in Pulse Width Modulation (PWM) schemes.

A binary counter is preset once per motor revolution by an index signal generated by Hall position sensor 1. On the next index pulse, the remaining least significant bits are loaded into the proportional D/A and accumulated by a saturating accumulator. The most significant bits are loaded into the integral D/A. The size of the accumulator and the bit locations determine the major scaling (within a factor of two) for the gain and zero location of the filter. To prevent overflow in the proportional D/A, the counter is decoded to detect overflow and the proportional D/A is saturated as needed. The overflow also generates a boost signal used in the summer. The range of the accumulator is larger than the linear range of the proportional channel to help filter small load disturbances that tend to saturate the proportional channel. The entire counter is also used to provide a time-out feature to protect the motor and external circuitry.

INPUT/OUTPUT PIN DESCRIPTION

- * **FREF (frequency reference input)**
A TTL compatible input used by the device to set and maintain the desired motor speed and operate circuit blocks.
- * **HALLOUT (Hall sensor bias output)**
Provides a regulated bias voltage for the Hall effect sensors inside the motor.
- * **HALL1, HALL2, HALL3 (Hall sensor inputs)**
The TTL open-collector type outputs of the motor's Hall switches feed these inputs which have a resistor pullup to the HALLOUT bias voltage. The HALL1 input is used to index the control loop counter. Refer to figure 1 for input timing.
- * **OUTA, OUTB, OUTC (driver outputs)**
These three driver outputs drive the external power transistors, such as TIP120 NPN darlington power transistors shown in typical application. The power transistors control the motor current through the current setting resistor R_e . The motor current is $V(\text{sense})/R_e$. During normal operation, the drive voltages are adjusted as necessary to maintain the proper motor speed and drive current. Refer to figure 1 for output timing.

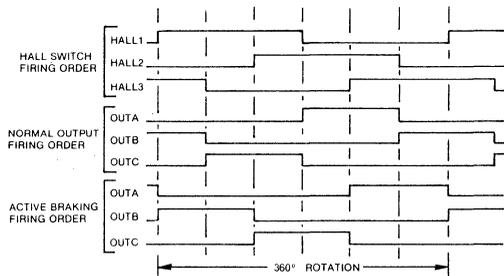


Figure 1 — Hall Switch/Driver Timing Relationship

- * **SENSE (coil current sense input)**
Senses the coil current and limits the sense voltage to the threshold by limiting the drive to the external power transistors.
- * **LOCK (at speed indicator output)**
An open drain LSTTL compatible output that indicates with an active low that the period of the motor is within the controller's linear range. Because of the accuracy of the loop, the LOCK pin is a good "at speed" indicator.
- * **START (active brake control input)**
The active brake is enabled by applying a logic "0" to the START pin. During active braking the Hall sensor's phasing is changed to apply a reverse torque to the motor until the motor period drops below the reverse shutdown speed at which time the drivers turn off the external power transistors to deny power to the motor. Active braking is shown in figure 1.
- * **FAULT (fault indicator output)**
Goes high when the motor is determined to be stalled, V_{DD} is low, or FREF clock is too slow.
- * **N/C (no connection)**
These pins must be left unconnected and floating.

PROTECTION FEATURES:

- * **LOW VOLTAGE DETECTION**
If the supply drops below the detect threshold, the device will turn off all of the external power transistors to prevent damage to the motor and the power devices. The FAULT pin goes high in this condition.
- * **STALLED ROTOR SHUTDOWN**
If the delay from power onset to a positive Index transition or the time interval between successive Index transitions is greater than the prescribed time, the device interprets this delay as a stalled rotor and reduces the motor current to zero until such time as one positive Index transition is detected or until power is removed and reapplied. The FAULT output goes high when the motor is determined to be stalled.

*** MOTOR COIL OVER-CURRENT**

Refer to SENSE input description. Senses voltage is generated by current through R_e shown in the typical application. The SENSE input threshold limits the maximum coil current.

*** FREF CLOCK FAULT**

If the FREF frequency drops below the specified minimum frequency, the driver will shut down and the FAULT pin will go high.

ABSOLUTE MAXIMUM RATINGS:

Positive Supply Voltage, V_{DD} 14V
 Storage Temperature -65°C to $+125^{\circ}\text{C}$
 Ambient Operating Temperature 0°C to $+70^{\circ}\text{C}$
 Pin Voltage (except FAULT and LOCK) -0.3V to $V_{DD} + 0.3\text{V}$
 FAULT and LOCK Pin Voltage .. -0.3V to $V_{DD} + 5.0\text{V}$
 HALLOUT Current 20mA
 Lead Temperature (soldering, 10 sec) 260°C
 Power Dissipation 400mW

ELECTRICAL CHARACTERISTICS

Unless otherwise specified, $10.8\text{V} \leq V_{DD} \leq 13.2\text{V}$; $0^{\circ}\text{C} \leq T_A \leq 70^{\circ}\text{C}$;
 $F_{REF} = 2.000\text{MHz}$; $R_e = 0.4 \text{ Ohms}$; Motor Configuration is 4-pole 3-phase center-tap "Y";

Motor parameters:

Torque constant (KT) 0.015 Nt-m/Amp
 Inertia (J) 0.000489 Nt-m-sec**2 where: [1]
 Damping Factor (KD) 0.0000318 Nt-m/rad/sec

Motor Frequency (s) = $\frac{KT}{J*s + KD}$
 Motor Current (s) = $\frac{KT}{J*s + KD}$
 Winding resistance [2] 2.0 Ohms
 Winding inductance 2.0 mhz
 Back EMF [2] 0.0159 V/rad/sec

| Characteristic | Test Condition | Min. | Max. | Unit |
|-----------------------------|---|------|------|------|
| POWER SUPPLY CURRENT | | | | |
| ICC | Clock Active (HALLOUT) = 15mA 1 Driver loaded to = 5 mA 2 Drivers unloaded | — | 30 | mA |

INPUT LOGIC SIGNALS — ‘FREF’ and ‘START’ INPUTS

| | | | | |
|-------------------------|--------------|------|-----|---------------|
| Vil, Input Low Voltage | | — | 0.8 | V |
| Iil, Input Low Current | $V_{in} = 0$ | —500 | — | μA |
| Vih, Input High Voltage | | 2.0 | — | V |
| IiH, Input High Current | $V_{in} = 5$ | — | 100 | μA |
| Input Capacitance | | — | 25 | pF |

OUTPUT LOGIC SIGNALS — ‘LOCK’ and ‘FAULT’ PINS

| | | | | |
|-----|-------------------------|---|-----|---------------|
| Vol | $I_{sink} = 2\text{mA}$ | — | 0.4 | V |
| Ioh | $V_{out} = V_{DD}$ | — | 10 | μA |

HALL SENSOR INTERFACE

| | | | | |
|-------------------------------|---------------------------|-----|-----|------------------|
| HALLOUT Bias Voltage | $I = 0$ to -15mA | 5.0 | 6.8 | V |
| HALL1, 2, 3 Pullup Resistance | to Hallout pin | 5 | 20 | $\text{K}\Omega$ |
| Input Low Voltage | | — | 1.0 | V |
| Input High Voltage | | 4.0 | — | V |
| Input Capacitance | | — | 25 | pF |

Notes: [1] The motor parameters given are for a typical motor. The device will work for a range of motors near this nominal motor.

[2] The motor must have a back EMF less than 10 volts peak (measured from center tap to drive transistor collector/drain) at speed to insure linear operation of drive transistors and a coil resistance small enough to insure adequate start current.



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| Parameter | Test Conditions | Min. | Max. | Units |
|-----------|-----------------|------|------|-------|
|-----------|-----------------|------|------|-------|

DRIVER OUTPUTS

| | | | | |
|----------------------------------|-----------------|------|------|----|
| Sink Capability | $V_{ol} = 0.5V$ | 1.0 | — | mA |
| Source Capability | $V_{oh} = 3.0V$ | —5.0 | — | mA |
| Capacitive Load Drive Capability | | — | 50.0 | pF |

SENSE INPUT AND OVER-CURRENT CONTROL

| | | | | |
|-------------------|--|------|------|---------|
| Threshold Voltage | | 0.9 | 1.1 | V |
| Input Current | | —100 | 100 | μA |
| Input Capacitance | | — | 25.0 | pF |

FAULT DETECTION

| | | | | |
|------------------------------|--------------------|-------|-------|-----|
| Stalled Rotor Shutdown Time | Power On to driver | 0.850 | 0.900 | sec |
| Low Voltage Detect Threshold | | 6.8 | 9.0 | V |
| Low FREF Shutdown Threshold | | — | 100 | Hz |

LOCK INDICATION

| | | | | |
|------------|-------------|------|------|----|
| Lock Range | Motor Speed | 3585 | 3615 | Hz |
|------------|-------------|------|------|----|

CONTROL LOOP PARAMETERS*

| Parameter | Test Condition | Min. | Typ. | Max. | Units |
|---------------------------------|----------------------------------|--------|-------|-------|------------|
| Divider Ratio | FREF/Fmotor | — | 33336 | — | — |
| Instantaneous Speed Error | Referenced to 60Hz | —0.035 | 0.01 | 0.015 | % |
| Index to Index Jitter [16/FREF] | Total jitter | — | — | 8 | $\mu sec.$ |
| Loop Bandwidth | Nominal motor $R_e = 0.40\Omega$ | — | 2 | — | Hz |
| Loop Zero | Ki/Kp | — | 1.0 | — | Hz |
| Maximum Running Current | $R_e = 0.40\Omega$ | 1.50 | — | — | Amps |
| Minimum Running Current | $R_e = 0.40\Omega$ | — | — | 0 | Amps |
| Start Current | $R_e = 0.40\Omega$ | 2.25 | — | 2.75 | Amps |

***CONTROL LOOP NOTES:**

Running current limits refer to capabilities during speed correction.

The motor control loop consists of counters, logic, and digital-to-analog converters that provide loop time constants. The continuous time transfer function of the on chip control can be modeled as follows:

$$H(s) = \frac{V_c(s)}{F_m(s)} = \frac{K_i}{s} + K_p$$

$V_c(s)$ is the voltage applied to the external current setting resistor (R_e) by the modulator. By adjusting the value of R_e the gain the motor sees can be adjusted, as can the starting current.

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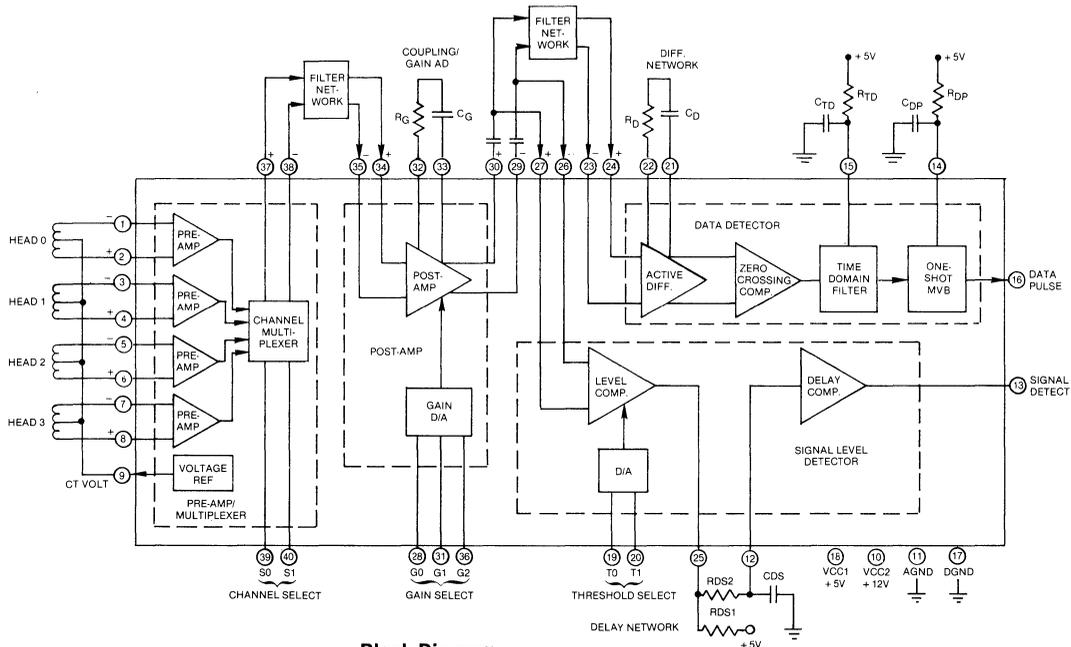
Preliminary Data Sheet

GENERAL DESCRIPTION

Silicon Systems' SSI 550 combines magnetic tape head read signal amplification and processing onto a single integrated circuit. The device accepts up to 4 center-tapped magnetic read heads connected directly to the head inputs; head center tap voltage is provided by an on-chip reference. The device architecture permits system design flexibility by providing the external connections between the Preamplifier/Multiplexer, Postamplifier, Signal Level Detector, and Data Detector; this allows the implementation of many suitable filtering combinations. Low noise amplifiers are used throughout the device. The SSI 550 operates on +5 and +12 Volt supplies and has TTL compatible control signals.

FEATURES

- 4-Channel Multiplexer with differential-input Preamplifiers
- Postamplifier has component-adjustable and programmable gain
- On-chip Signal Level Detector with programmable threshold and adjustable delay
- Data Detection Circuit includes spurious signal rejection (adjustable time domain filter) and provides an adjustable uniform Data Pulse output
- Available in 40 pin DIP or 44 pin Quad plastic packages



Block Diagram
(shown with typical external circuitry)

CAUTION: Use handling procedures necessary for a Static Sensitive Component.

DEVICE DESCRIPTION AND OPERATION

4-Channel Preamplifier and Multiplexer

The device contains four low level differential-input Preamplifiers. The differential output of a single Preamplifier is selectively connected to the Preamplifier output terminals by means of two logical CHANNEL SELECT signals, S0 and S1. The selected Preamplifier number is the binary value of the logical SELECT signals for active high voltage levels.

The Preamplifier inputs are intended for connection to center-tapped magnetic read heads. An appropriate Preamplifier input bias voltage level is obtained by connecting the head center taps to the circuit C.T. VOLT terminal.

The C.T. VOLT terminal is the output of a voltage reference which has a value to center the Preamplifier inputs within their operating range.

Postamplifier

The Postamplifier is a differential-input, differential-output circuit which has two means of gain adjustment. A continuously-variable gain adjustment is obtained by use of an external resistor or potentiometer. Discrete values of gain setting are additionally obtained by applying combinations of logical signal levels to the three GAIN SELECT terminals, G0, G1, and G2.

The Postamplifier receives the output signals of the Preamplifier after frequency selection by an external filter network. The input characteristics of the Postamplifier are such that the inputs may have DC coupling to the Preamplifier output, or may be AC coupled without requiring input bias connections.

A suitable coupling capacitor must be connected between the GAIN1, GAIN2 terminals independent of the use of a gain setting resistor.

Signal Level Detect Circuits

The Signal Level Detect circuits consist of detector circuits which compare the amplitude of the signal envelope of the Postamplifier output with a selectable threshold and provide a logical output level which indicates the presence of Postamplifier signal greater than the threshold. AC coupling is required between the Postamplifier output and the Signal Level Detect circuits input. The Signal Level Detect input has internal bias connections so that no external bias network is required.

The threshold to which the Postamplifier signals are compared is selected by means of two THRESHOLD SELECT logical inputs T0 and T1. The result of the comparison is delayed from appearing at the circuit SIGNAL DETECT output terminal by means of a delay circuit which is adjustable by means of external components.

The delay associated with signal detection is set by combinations of capacitor CDS and resistor RDS1. The delay associated with signal loss is set by combinations of CDS and resistors RDS1 plus RDS2.

Data Detection Circuits

The Data Detection circuits are AC coupled to the Postamplifier outputs through an (optional) external filter network and provide logical output pulse signals in

response to positive and negative input signal amplitude peaks. This function is performed by differentiating input signals to obtain zero-crossing voltages at points of inflection and detecting these crossings to provide output signals.

To enhance the signal peak detection, spurious inflection points which occur in pairs between true signal peaks are suppressed by means of the Time Domain Filter. The filter inhibits the propagation of detected zero-crossings if they are not sufficiently separated in time. This time period is set by external capacitor CTD and resistor RTD.

Uniform DATA PULSE output signals are provided by the One-Shot Multivibrator which is triggered by outputs of the Time Domain Filter. The time duration of the DATA PULSE signals is set by external capacitor CDP and RDP.

DC paths through the external filter network to the Signal Level Detect circuits inputs are required to properly bias the Data Detection circuits. The resistance of each path is not critical and may be as large as 10 Kohm.

PIN DESIGNATION

| Pin Number | | Pin Name | Pin Description |
|------------|------|---------------|--|
| DIP | QUAD | | |
| 1 | 1 | IN0 - | Channel 0 (-) input |
| 2 | 2 | IN0 + | (+) input |
| 3 | 3 | IN1 - | Channel 1 (-) input |
| 4 | 4 | IN1 + | (+) input |
| 5 | 5 | IN2 - | Channel 2 (-) input |
| — | 6 | N/C | No internal connection |
| 6 | 7 | IN2 + | Channel 2 (+) input |
| 7 | 8 | IN3 - | Channel 3 (-) input |
| 8 | 9 | IN3 + | (+) input |
| 9 | 10 | CT VOLT | Center tap voltage |
| 10 | 11 | VCC2 | + 12 Volt supply connection |
| 11 | 12 | AGND | Analog signal ground |
| 12 | 13 | DEL IN | Input to delay comparator |
| 13 | 14 | SIGNAL DETECT | Output of delay comparator |
| 14 | 15 | DPN | External RC for output pulse width |
| 15 | 16 | TDF | External RC for time-domain delay |
| — | 17 | N/C | No internal connection |
| 16 | 18 | DATA PULSE | Output of time-domain filter |
| 17 | 19 | DGND | Ground |
| 18 | 20 | VCC1 | + 5 Volt supply |
| 19 | 21 | T0 | Threshold select signal (1 of 2) |
| 20 | 22 | T1 | Threshold select signal (1 of 2) |
| 21 | 23 | CAP1 | External differentiating capacitor connection |
| 22 | 24 | CAP2 | |
| 23 | 25 | DIF - | Inputs to active differentiator |
| 24 | 26 | DIF + | |
| 25 | 27 | LEV OUT | Output to level detector |
| — | 28 | N/C | No internal connection |
| 26 | 29 | LEV - | Inputs to level detector |
| 27 | 30 | LEV + | |
| 28 | 31 | G0 | Postamp gain select (1 of 3) |
| 29 | 32 | PSTOUT - | Outputs of Postamplifier |
| 30 | 33 | PSTOUT + | |
| 31 | 34 | G1 | Postamp gain select (1 of 3) |
| 32 | 35 | GAIN 1 | External Postamplifier gain adjusting RC terminals |
| 33 | 36 | GAIN 2 | |
| 34 | 37 | PSTIN + | Inputs to Postamplifier |
| 35 | 38 | PSTIN - | |
| — | 39 | N/C | No internal connection |
| 36 | 40 | G2 | Postamp gain select (1 of 3) |
| 37 | 41 | PREOUT + | (+) Output of Preamplifier |
| 38 | 42 | PREOUT - | (-) Output of Preamplifier |
| 39 | 43 | S0 | Input channel select (1 of 2) |
| 40 | 44 | S1 | Input channel select (1 of 2) |

SSI 550

ABSOLUTE MAXIMUM RATINGS

| | | |
|------------------------------------|-----------------------|--------------------------------------|
| Characteristic | Rating | Voltage Applied to Logic |
| Storage Temperature | -65°C. to +150°C. | Inputs |
| Ambient Operating Temperature, Ta | 0°C. to +70°C. | Outputs |
| Junction Operating Temperature, Tj | 0°C. to +130°C. | Current Into ON Logic Outputs |
| Supply Voltage, Vcc1 | -0.5 Vdc to +6.0 Vdc | Lead Temperature (soldering, 10 sec) |
| Supply Voltage, Vcc2 | -0.5 Vdc to +14.0 Vdc | |

ELECTRICAL CHARACTERISTICS

Unless otherwise specified: Vcc1 = 4.75V to 5.25V, Vcc2 = 11.4V to 12.6V, Ta = 0 to +70°C.

Overall Characteristics

| Characteristics | Test Conditions | Min. | Max. | Units |
|---|--|------|------|-------|
| Input Current Logical Inputs HIGH | Vih = Vcc1 | — | 100 | uA |
| Input Current Logical Inputs LOW | Vil = 0V | — | -400 | uA |
| Output Voltage Delay Comparator OFF | Ioh = -400uA | 2.4 | — | V |
| Output Voltage Delay Comparator ON | Iol = 2.0mA | — | 0.5 | V |
| Data Pulse Inactive Level Output Voltage | Ioh = -400uA | 2.4 | — | V |
| Data Pulse Active Level Output Voltage | Iol = 2.0mA | — | 0.5 | V |
| Vcc1 Power Supply Current | Necessary external components and connections No Head Inputs. | — | 30 | mA |
| Vcc2 Power Supply Current | Necessary external components and connections No Head Inputs. | — | 62 | mA |

* Characteristic applies to Inputs S0, S1, G0, G1, G2, T0, T1

PREAMPLIFIER AND MULTIPLEXER CHARACTERISTICS

Output Load = 2KΩ line-line, Channel Select Signals (S0, S1):
VON = 2V Min., VOFF = 0.8V Max.

| Characteristics | Test Conditions | Min. | Max. | Units |
|------------------------------------|--|---------|------|-------|
| Differential Voltage Gain | Vin = 4mV p-p @ 100kHz ref. to C.T. Volt | 80 | 120 | V/V |
| Gain Flatness | Vin = 4mV p-p DC to 0.5MHz ref. to C.T. Volt | ±0.5 | — | dB |
| Bandwidth, -1dB | Vin = 4mV p-p | 1.5 | — | MHz |
| Bandwidth, -3dB | Vin = 4mV p-p | 3.0 | — | MHz |
| Differential Input Impedance | Vin = 4mV p-p @ 100kHz ref. to C.T. Volt | 10 | — | KΩ |
| Common-Mode Rejection Ratio | Vin = 300mV p-p @ 500kHz Inputs Shorted to C.T. Volt | 50 | — | dB |
| Power Supply Rejection Ratio | Δ Vcc = 300mV p-p @ 500kHz Inputs shorted to C.T. Volt | 50 | — | dB |
| Channel Isolation | Interfering Vin = 100mV p-p @ 2MHz. Selected Channel inputs connected to C.T. Volt | 60 | — | dB |
| Total Harmonic Distortion | Vin = 0.5 to 6.0mV p-p @ 500kHz | — | 2 | % |
| Equivalent Input Noise | Power BW = 10kHz to 1MHz Inputs shorted to C.T. Volt | — | 10 | μVrms |
| Small Sig Single-Ended Output Res. | Io = 1mA p-p @ 100kHz | — | 35 | Ω |
| Maximum Diff. Output Voltage | Freq = 100kHz THD < 5% | 3 | — | Vp-p |
| Output Offset Voltage | Inputs shorted to C.T. Volt Load = Open Circuit | — | ±1.0 | V |
| Common-Mode Output Voltage | Inputs shorted to C.T. Volt Load = Open Circuit | 2.68 | 3.5 | V |
| Center Tap Voltage, C.T. Volt | | 3.0 Typ | | |

DATA DETECTION CIRCUIT CHARACTERISTICS

$V_{in} = 1.0V$ p-p diff. square wave, $T_r, T_f < 20nsec$, dc-coupled (for biasing).
 $R_D = 2.5K\Omega$; $C_D = 0.1\mu F$; $R_{TD} = 7.8K\Omega$; $C_{TD} = 200 pF$; $R_{DP} = 3.9K\Omega$;
 $C_{DP} = 100 pF$. Data Pulse load = $2.5K\Omega$ to V_{cc1} plus $20pF$ or less to PWR GND.

| Characteristics | Test Conditions | Min. | Max. | Units |
|---|--|--------|-----------|-----------|
| Differentiator Maximum Differential Input Voltage | $V_{in} = 100kHz$ sine wave, dc-coupled. $< 5\%$ THD in voltage across CD. $C_D = 620pF$ $R_D = 0$ | 5.0 | — | Vp-p |
| Differentiator Input Impedance | $V_{in} = 4V$ p-p diff., $100kHz$ sine wave. $C_D = 620pF$ $R_D = 0$ | 10 | — | $K\Omega$ |
| Differentiator Threshold Differential Input Voltage | $V_{in} = 100kHz$ square wave, $T_r, T_f < 0.4$ usec, no overshoot. Data Pulse from each V_{in} transition. | — | 300 | mVp-p |
| Data Pulse Width Accuracy | $TDP = .59 R_{DP} \times C_{DP}$, $R_{DP} = 3.9K\Omega$ to $10K\Omega$, $C_{DP} = 75 pF$ to $300 pF$ Width measured at 1.5V amplitude | .85TDP | 1.15TDP | sec |
| Time Domain Filter Delay Accuracy | $TTD = 0.59 R_{TD} \times C_{TD} + 50 nsec$, $R_{TD} = 3.9K\Omega$ to $10K\Omega$, $C_{TD} = 100pF$ to $750pF$ Delay measured from 50% input amplitude to 1.5V Data Pulse amplitude | .85TTD | 1.15TTD | sec |
| Data Pulse Width Drift from +25°C. value | Width measured from 1.5V amplitude | — | ± 5.0 | % |
| Time Domain Filter Delay Drift from +25°C. value | Delay measured from 50% Input amplitude to 1.5V Data Pulse amplitude | — | ± 5.0 | % |

Note: Differentiating network impedance should be chosen such that 1mA peak current flows at maximum signal level and frequency.

SIGNAL LEVEL DETECT CIRCUITS CHARACTERISTICS

Level Comparator Inputs connected in parallel with Differentiator Inputs.
 V_{in} (Level Comp) = $100kHz$ sine wave, ac-coupled. $R_{DS1} = 5k\Omega$; $R_{DS2}, C_{DS} = open$

| Characteristics | Test Conditions | Min. | Max. | Units |
|---|---|---------------|---------------|-----------|
| Level Comparator Input Thresholds, Single-Ended, Each Input | T0 $V_{T0} = 0.8V$ $V_{T1} = 0.8V$ V_o pulse value $< 0.5V$ at MAX LIMIT, $> V_{cc1} - 0.5V$ at MIN LIMIT | 30 | 70 | mV pk |
| | T1 $V_{T0} = 2.0V$ $V_{T1} = 0.8V$ V_o pulse value $< 0.5V$ at MAX LIMIT, $> V_{cc1} - 0.5V$ at MIN LIMIT | 97 | 153 | mV pk |
| | T2 $V_{T0} = 0.8V$ $V_{T1} = 2.0V$ V_o pulse value $< 0.5V$ at MAX LIMIT, $> V_{cc1} - 0.5V$ at MIN LIMIT | 138 | 202 | mV pk |
| | T3 $V_{T0} = 2.0V$ $V_{T1} = 2.0V$ V_o pulse value $< 0.5V$ at MAX LIMIT, $> V_{cc1} - 0.5V$ at MIN LIMIT | 210 | 290 | mV pk |
| Level Comparator Diff. Input Resistance | $V_{in} = 5V$ p-p @ $100kHz$ | 5 | — | $K\Omega$ |
| Level Comparator OFF Output Leakage | $V_o = V_{cc1}$ | — | 25 | μA |
| Level Comparator ON Output Voltage | $V_{T0} = 0.8V$ $V_{T1} = 0.8V$ $V_{in} = \pm 140mV$ diff. dc $I_o = 2.0mA$ | — | 0.25 | V |
| Delay Comparator Upper Threshold Voltage | $V_o > 2.4V$ | .65 V_{cc1} | .75 V_{cc1} | V |
| Delay Comparator Lower Threshold Voltage | $V_o < 0.5V$ | .25 V_{cc1} | .35 V_{cc1} | V |
| Delay Comparator Input Current | $0V < V_{in} < V_{cc1}$ | — | 25 | μA |

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POSTAMPLIFIER CHARACTERISTICS

Output Load = $2.5K\Omega + 0.1\mu F$ line-line, $V_{in} = 100mV$ p-p, 100kHz sine wave, dc-coupled (to provide proper biasing). $CG = 0.1\mu F$ $RG = 0$.

| Characteristics | Test Conditions | Min. | Max. | Units |
|---------------------------------------|--|----------|-----------|-----------|
| Differential Voltage Gain | A0 $VG_0 = 0.8V$ $VG_1 = 0.8V$ $VG_2 = 0.8V$ | A7-14.75 | A7-13.25 | dB |
| | A1 $VG_0 = 2.0V$ $VG_1 = 0.8V$ $VG_2 = 0.8V$ | A7-12.75 | A7-11.25 | dB |
| | A2 $VG_0 = 0.8V$ $VG_1 = 2.0V$ $VG_2 = 0.8V$ | A7-10.75 | A7-9.25 | dB |
| | A3 $VG_0 = 2.0V$ $VG_1 = 2.0V$ $VG_2 = 0.8V$ | A7-8.75 | A7-7.25 | dB |
| | A4 $VG_0 = 0.8V$ $VG_1 = 0.8V$ $VG_2 = 2.0V$ | A7-6.75 | A7-5.25 | dB |
| | A5 $VG_0 = 2.0V$ $VG_1 = 0.8V$ $VG_2 = 2.0V$ | A7-4.75 | A7-3.25 | dB |
| | A6 $VG_0 = 0.8V$ $VG_1 = 2.0V$ $VG_2 = 2.0V$ | A7-2.75 | A7-1.25 | dB |
| | A7 $VG_0 = 2.0V$ $VG_1 = 2.0V$ $VG_2 = 2.0V$ | 32 | — | dB |
| | ARG $VG_0 = 2.0V$ $VG_1 = 2.0V$ $VG_2 = 2.0V$ when $RG = 2.5K\Omega$ | A7-7.5 | A7-4.5 | dB |
| Differential Input Impedance | $VG_0 = 2.0V$ $VG_1 = 2.0V$ $VG_2 = 2.0V$ | 10 | — | $K\Omega$ |
| Bandwidth, 1dB | $VG_0 = 2.0V$ $VG_1 = 2.0V$ $VG_2 = 2.0V$ | 1.5 | — | MHz |
| Bandwidth, 3dB | $VG_0 = 2.0V$ $VG_1 = 2.0V$ $VG_2 = 2.0V$ | 3.0 | — | MHz |
| Maximum Diff. Output Voltage | $VG_0 = 0.8V$ $VG_1 = 0.8V$ $VG_2 = 0.8V$ $V_{in} = 100kHz$ sine wave THD < 5% | 5 | — | Vp-p |
| Small Signal Single-Ended Output Res. | $VG_0 = 2.0V$ $VG_1 = 2.0V$ $VG_2 = 2.0V$ $V_{in} = 0V$ $I_o = 1mA$ p-p, 100kHz | — | 35 | Ω |
| Input Bias Offset Voltage Range | $VG_0 = 0.8V$ $VG_1 = 0.8V$ $VG_2 = 0.8V$ THD < 2.0% | — | ± 1.0 | V |
| Input Bias Common-Mode Voltage Range | $VG_0 = 0.8V$ $VG_1 = 0.8V$ $VG_2 = 0.8V$ THD < 2.0% | 2.68 | 3.5 | V |

Preliminary Data Sheet

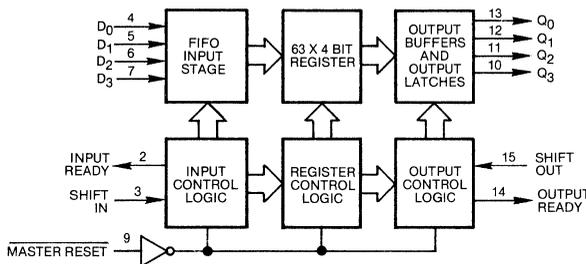
GENERAL DESCRIPTION

The SSI 67C401/402 devices are high speed, expandable memories operating as a First-In, First-Out, (FIFO) asynchronous register of either 64 words by 4-bit (SSI 67C401) or 64 words by 5-bit (SSI 67C402). The SSI 67C401/402 are CMOS devices. A 10 MHz shift rate provides the fast transfer of data necessary for applications in high speed tape or disc controllers and communication buffers. A single +5V power supply is required.

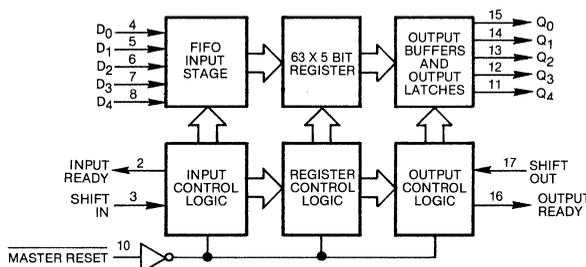
FEATURES

- 10 MHz shift in, shift out rates
- Choice of 4-bit or 5-bit width
- TTL compatible inputs and outputs
- Readily expandable in word and bit dimensions
- Output pins directly opposite corresponding input pins
- Asynchronous operation
- Pin compatible with MMI 67401 Series
- Low power consumption
- HCT input and output characteristics

Block Diagrams

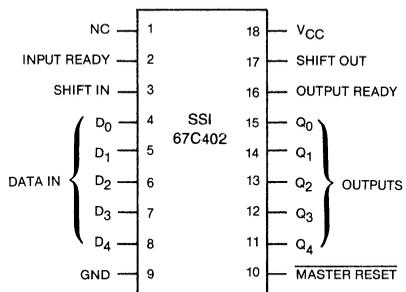
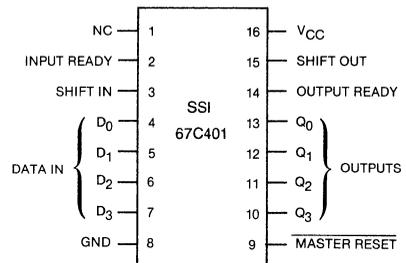


SSI 67C401 64x4



SSI 67C402 64x5

Pin Assignments



Pin Out
(Top View)

CAUTION: Use handling procedures necessary for a static sensitive component

SSI 67C401/402

First-In First-Out (FIFO)

64x4 or 64x5 Memory

CIRCUIT DESCRIPTION

Data Input

When the FIFO is reset, the Master Reset is pulsed low to prepare the device for data input. Data is entered at the D_x inputs as controlled by the Input Ready (IR) and Shift In (SI) logic. With IR high, data can be accepted. Data present at the data inputs is entered into the first position on the rising edge of SI. As SI is taken high, IR goes low indicating the FIFO is busy. When SI is set low, IR goes high if the memory is not full. In the FIFO, data is shifted towards the output progressively until a full memory position is encountered. Thus, the memory is filled with the first data word at the output position and subsequent data words in order behind it. If the memory is full, that is all 64 word positions contain valid data, IR remains low after SI is set low.

Data Transfer

After data input, transfer of a data word from a memory position to an adjacent empty memory position is automatic, activated by on-chip control. Thus, data stacks up at the output end of the FIFO while memory positions that are emptied as data is unloaded are moved to the input end. The time for data (or emptied positions) to move the entire length of the memory is defined as the throughput, or fall through, time (t_{PT}).

Data Output

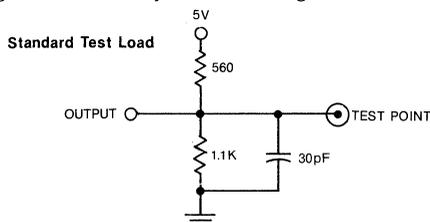
Data outputs at the Q_x pins are controlled by the Output Ready (OR) and Shift Out (SO). When valid data is shifted to the outputs, OR goes high. With OR high, data

may be shifted out by bringing SO high. The rise of SO causes OR to go low. Valid data is maintained while SO is high. When SO is brought low, the upstream data (providing the next stage contains valid data) is shifted to the output stage and OR goes high. If the FIFO is emptied, OR stays low and the Q_x data remains as before.

Application Notes

The Input Ready (IR) and Output Ready (OR) may be used as status signals indicating that the FIFO is completely full (IR stays low for at least fall through time t_{PT}) or that the FIFO is completely empty (OR stays low for at least t_{PT}).

Since the high speed FIFO is particularly sensitive to small glitches as might be caused by long reflective lines, high capacitances, or poor supply decoupling and grounding, circuit design should account for these potential problems ensuring that adequate ground planes and decoupling measures are taken. For example, it is recommended that a 0.1 μ f ceramic capacitor be connected directly between V_{CC} and ground with a very short lead length.



Absolute Maximum Ratings* (All voltages referenced to GND)

| Parameter | Symbol | Value | Units |
|---------------------------|-----------|-------------|--------------|
| Supply Voltage | V_{CC} | 7 | VDC |
| Input Voltage | V_{in} | 7 | VDC |
| Output Voltage | V_{out} | 5.5 | VDC |
| Storage Temperature Range | T_{stg} | -65 to +125 | $^{\circ}$ C |

* Operation above absolute maximum ratings may permanently damage the device.

Electrical Characteristics (4.75 $\leq V_{CC} \leq 5.25$ V, 0 $^{\circ}$ C $\leq T_A \leq 75$ $^{\circ}$ C unless otherwise specified)

| Symbol | Parameter | Test Conditions | Min | Max | Unit |
|-----------|---|---|------|------|---------|
| V_{IL} | Low-Level Input Voltage | — | — | 0.8 | V |
| V_{IH} | High-Level Input Voltage | — | 2 | — | V |
| V_{IC} | Input Clamp Voltage | $V_{CC} = \text{MIN } I_I = -18\text{mA}$ | — | -1.5 | V |
| I_{IL} | Low-Level Input Current | $V_{CC} = \text{MAX } V_{in} = 0.4\text{V}$ | — | -0.4 | mA |
| I_{IH} | High-Level Input Current | $V_{CC} = \text{MAX } V_{in} = 2.4\text{V}$ | — | 50 | μ A |
| I_{IMH} | Maximum Input Current, High | $V_{CC} = \text{MAX } V_{in} = 5.5\text{V}$ | — | 1 | mA |
| I_{IML} | Maximum Input Current, Low | $V_{CC} = \text{MAX } V_{in} = 0.5\text{V}$ | — | 15 | mA |
| V_{OL} | Low-Level Output Voltage | $V_{CC} = \text{MIN } I_{OL} = 8\text{mA}$ | — | 0.4 | V |
| V_{OH} | High-Level Output Voltage | $V_{CC} = \text{MIN } I_{OH} = -4.0\text{mA}$ | 4.35 | — | V |
| I_{OS} | Output Short-Circuit Current [†] | $V_{CC} = 5\text{V}$ | — | -80 | mA |
| | | $V_{out} = 0.5\text{V}$ $V_{out} = 4.5\text{V}$ | — | -80 | |
| I_{CC} | Supply Current | $V_{CC} = \text{MAX } V_{in} = V_{CC} \text{ or GND}$ Outputs Open Ckt | — | 100 | μ A |

[†] Not more than one output should be shorted at a time and duration of the short-circuit should not exceed one second.

Switching Characteristics Over Operating Conditions

| Symbol | Parameter | Min | Max | Unit |
|-------------|--|-----|-----|---------|
| t_{IN} | Shift In Rate (Period between data loading) | 100 | — | ns |
| t_{SIH} | Shift In HIGH Time | 35 | — | ns |
| t_{SIL} | Shift In LOW Time | 35 | — | ns |
| t_{IRL} | Shift In to Input Ready LOW | — | 45 | ns |
| t_{IRH} | Shift In to Input Ready HIGH | — | 45 | ns |
| t_{IDS} | Input Data Set Up | 5 | — | ns |
| t_{IDH} | Input Data Hold Time | 45 | — | ns |
| t_{OUT} | Shift Out Rate (Period between data unloading) | 100 | — | ns |
| t_{SOH} | Shift Out HIGH Time | 35 | — | ns |
| t_{SOL} | Shift Out LOW Time | 35 | — | ns |
| t_{ORL} | Shift Out to Output Ready LOW | — | 55 | ns |
| t_{ORH} | Shift Out to Output Ready HIGH | — | 55 | ns |
| t_{OD} | Output Data Delay | 10 | 55 | ns |
| t_{PT} | Data Throughout (fall through) time | — | 3 | μ s |
| t_{MRW} | Master Reset Pulse ² | 35 | — | ns |
| t_{MRORL} | Master Reset to OR LOW | — | 60 | ns |
| t_{MRIRH} | Master Reset to IR HIGH | — | 60 | ns |
| t_{MRS} | Master Reset to SI | 35 | — | ns |
| t_{IPH} | Input Ready Pulse HIGH | 5 | — | ns |
| t_{OPH} | Output Ready Pulse HIGH | 5 | — | ns |

² Master reset puts the register logic to "all cells empty", and sets IR high.

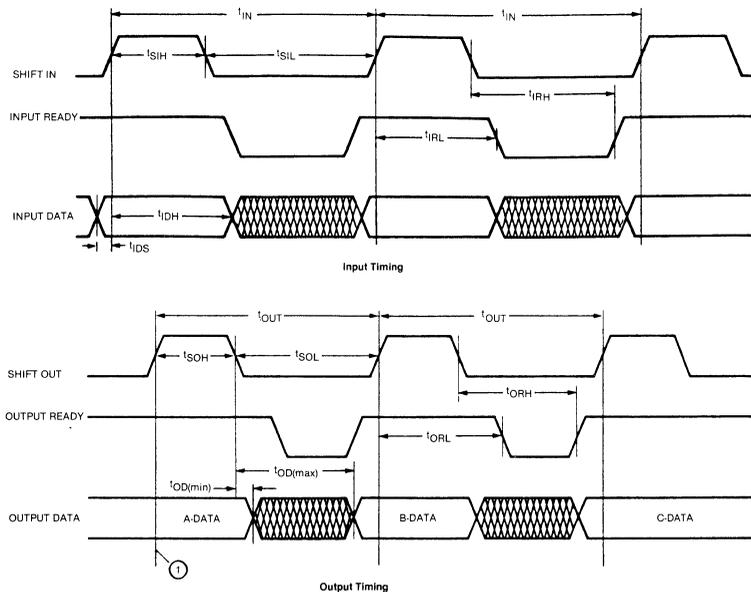
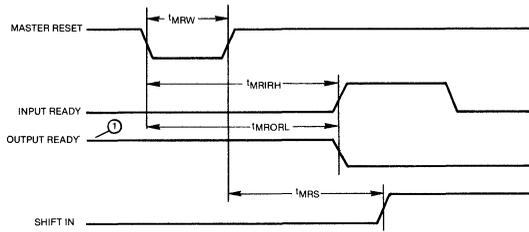
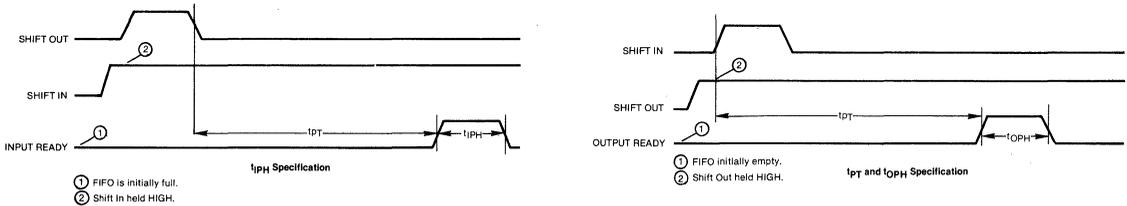


Figure 3. Timing Waveforms

① The diagram assumes, that at this time, words 63, 62, 61 are loaded with A, B, C Data, respectively



Master Reset Timing
Figure 4. Timing Waveforms

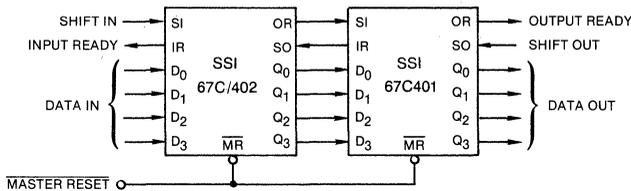


Figure 5. Cascading FIFOs to Form 128x4 FIFO.

FIFOs can be easily cascaded to any desired depth. The handshaking and associated timing between the FIFOs are handled by the FIFOs themselves.

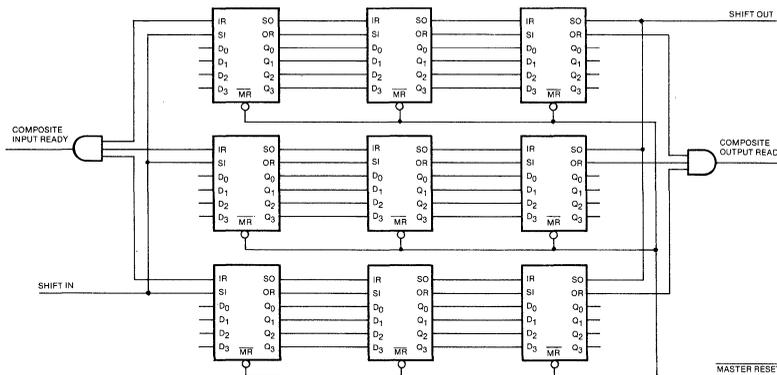


Figure 6. 192x12 FIFO.

FIFOs are expandable in depth and width. However, in forming wider words two external gates are required to generate composite Input and Output Ready flags. This need is due to the different fall through times of the FIFOs.

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Advanced Information

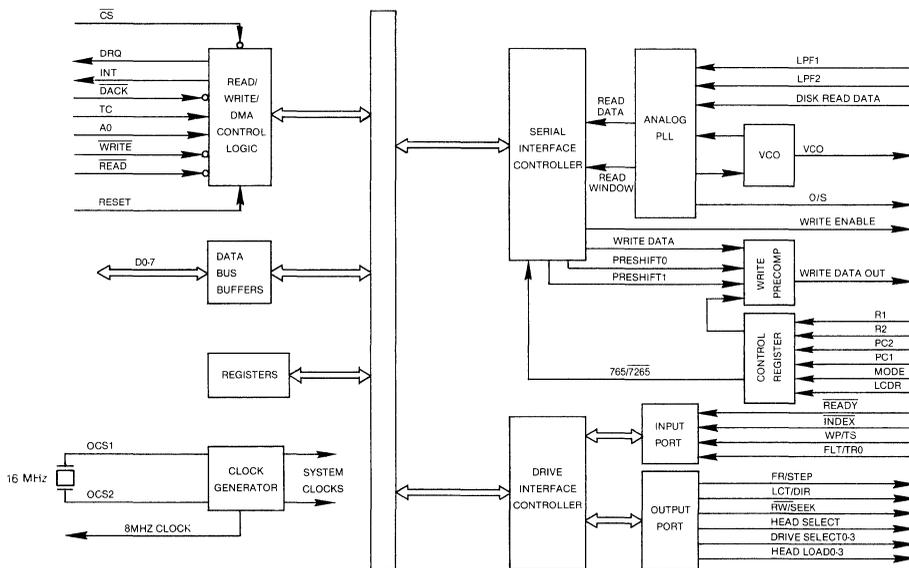
GENERAL DESCRIPTION

The SSI 440 is a highly integrated CMOS Advanced Floppy Disk Controller (AFDC). It performs virtually all the functions necessary to interface a CPU with up to 4 double-sided floppy disk drives. It is command compatible with the NEC μ PD765 and performs all of its functions in addition to many new ones. These enhancements include high performance write precompensation and analog data separation circuitry, additional error detection methods, and an increased data rate handling capability in addition to the benefits of CMOS technology.

FEATURES

- Supports IBM and Sony (ECMA) compatible formats for double density recording
- Programmable sector sizes — 128, 256, 512, 1024, 2048, 4096 bytes/sector
- Programmable head load and unload timing, and track stepping rate
- Multi-sector, multi-track transfer capability
- Controls up to four double-sided diskette drives
- Parallel seek operation for up to four diskette drives
- Data transfers in DMA or non-DMA mode
- Data scan capability to compare, on a byte by byte basis, diskette read data with processor memory
- Selectable write precompensation timing — 0, 62.5, 125, 187.5, 250 nanoseconds
- Programmable error detection methods — CRC 16, or CCITT
- Integrated analog data separation circuitry
- On chip clock oscillator plus an 8MHz clock output
- Supports disk data rates of up to 1MHz
- Compatible with popular microprocessors
- FDD interface input signals have 7414 type input buffers with hysteresis and output signals can drive 24 mA. open drain, eliminating the need for I/O buffering to the Floppy Disk Drive in some cases
- Operates with a 5 volt supply ($\pm 5\%$)
- CMOS technology, high performance & low power requirements
- Available in dual-in-line or Quad Surface Mount packaging
- Available 3Q85

SSI 440 Block Diagram



CAUTION: Use handling procedures necessary for a static sensitive component

Advanced Information

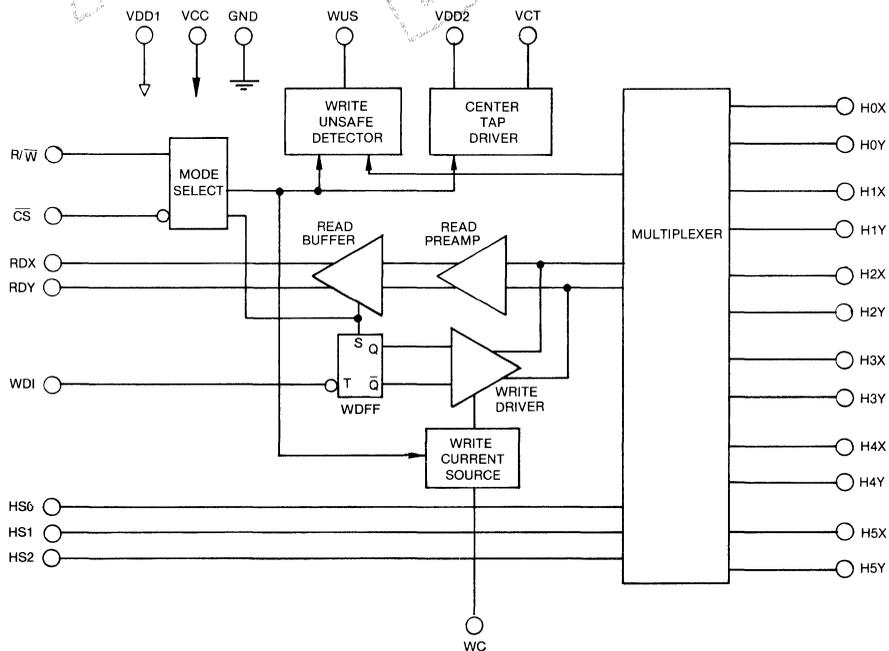
GENERAL DESCRIPTION

The SSI 511 devices are monolithic integrated circuits designed for use with center-tapped ferrite recording heads. They utilize an advanced bipolar process and input structure to provide a low noise read path, write current control, and data protection circuitry for as many as six channels. The SSI 511 requires +5V and +12V power supplies and is available in 2, 4, or 6 channel versions with a variety of packages.

FEATURES

- Low noise read amplifier
- +5V, +12V power supplies
- Designed for center-tapped ferrite heads
- Programmable write current source
- Available in 2, 4, or 6 channels
- Easily multiplexed for larger systems
- Includes write unsafe detection
- TTL compatible control signals
- Damping resistors provided on 511R models

SSI 511 Block Diagram



CAUTION: Use handling procedures necessary
 for a static sensitive component

Advanced Information

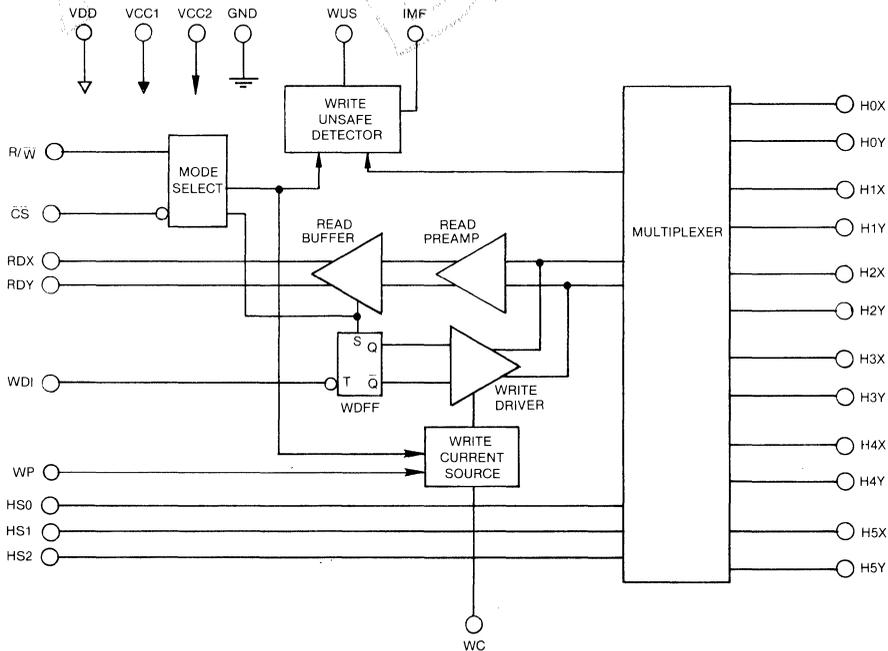
DESCRIPTION

The SSI 521 is a bipolar monolithic integrated circuit designed for use with non-center tapped thin film recording heads. It provides a low noise read path, write current control, and data protection circuitry for up to six channels. The SSI 521 requires +5v and +12v power supplies and is available in a variety of packages.

FEATURES

- Designed for thin film heads
- +5v, +12v power supplies
- Ideal for multi-platter Winchester applications
- Programmable write current source
- Easily multiplexed for larger systems
- Includes write unsafe detection
- LSTTL compatible control signals

Block Diagram



CAUTION: Use handling procedures necessary for a static sensitive component

SSI 521

Thin Film - 6-Channel Read/Write Circuit

Circuit Operation

The SSI 521 functions as a write driver or as a read amplifier for the selected head. Head selection and mode control are described in Tables 2 & 3. The inputs R/W, CS and WP have internal pull up resistors to prevent an accidental write condition.

WRITE MODE

The Write mode configures the SSI 521 as a current switch and activates the Write Unsafe Detector. Head current is toggled between the X- and Y-direction of the recording head on the falling edges of WDI, Write Data Input. Note that a preceding read operation initializes the Write Data flip-flop to pass current in the X-direction of the head. The magnitude of the write current, given by

$$I_w = \frac{K}{R_{wc} \left(1 + \frac{R_H}{R_D}\right)} - 1 \text{ mA}$$

Where K = Write Current Constant
 R_H = Head Resistance
 R_D = Damping Resistance

is controlled by an external resistor, R_{wc} , connected from pin WC to GND.

Any of the following conditions will be indicated as a high level of the Write Unsafe, WUS, open collector output.

- WDI frequency too low
- Chip disabled
- Device in Read mode
- No write current

After fault condition is removed, two negative transitions on WDI are required to clear WUS. The current monitor output (IMF) sinks one unit of current when the device is selected. This allows a multichip enable fault to be detected.

READ MODE

In the Read mode, the SSI 521 is configured as a low noise differential amplifier, the write current source

TABLE 2: MODE SELECT

| CS | R/W | MODE |
|----|-----|-------|
| 0 | 0 | Write |
| 0 | 1 | Read |
| 1 | 0 | Idle |
| 1 | 1 | Idle |

and the write unsafe detector are deactivated, and the write data flip-flop is set. The RDX and RDY outputs are driven by emitter followers.

Note that the internal write current source is deactivated for both the Read and the chip deselect modes.

TABLE 1: PIN DESCRIPTION

| Symbol | Name - Description |
|------------------------|---|
| HS0 - HS2 | Head Select: selects one of six heads |
| CS | Chip Select: a high inhibits chip |
| R/W | Read/Write: a high selects Read mode |
| WP | Write Protect: a low enables the write current source |
| WUS | Write Unsafe: a high indicates an unsafe writing condition |
| IMF | Current Monitor Function: allows multichip enable fault detection |
| WDI | Write Data In: changes the direction of the current in the recording head |
| HOX - H5X HOY - H5Y | X,Y head connections: Current in the X-direction flows into the X-port |
| RDX, RDY | X,Y Read Data: differential read data out |
| WC | Write Current: used to set the magnitude of the write current |
| VCC1 | + 5V |
| VCC2 | + 5V |
| VDD | + 12V |
| GND | Ground |

TABLE 3: HEAD SELECT

| HS2 | HS1 | HS0 | HEAD |
|-----|-----|-----|------|
| 0 | 0 | 0 | 0 |
| 0 | 0 | 1 | 1 |
| 0 | 1 | 0 | 2 |
| 0 | 1 | 1 | 3 |
| 1 | 0 | 0 | 4 |
| 1 | 0 | 1 | 5 |
| 1 | 1 | 0 | none |
| 1 | 1 | 1 | none |

ABSOLUTE MAXIMUM RATINGS

| Parameter | Symbol | Value | Units |
|---------------------------------|--------|--------------------|-------|
| DC Supply Voltage | VDD | - 0.3 to + 14 | VDC |
| | VCC | - 0.3 to + 7 | VDC |
| Write Current | IW | 100 | mA |
| Digital Input Voltage | Vin | - 0.3 to VCC + 0.3 | VDC |
| Head Port Voltage | VH | - 0.3 to VDD + 0.3 | VDC |
| Output Current: RDX, RDY WUS | Io | - 10 | mA |
| | | + 12 | mA |
| Storage Temperature | Tstg | - 65 to + 150 | C |
| Operating Temperature | Tj | + 25 to + 125 | C |

RECOMMENDED OPERATING CONDITIONS

| Parameter | Symbol | Value | Units |
|------------------------------|--------|----------|-------|
| DC Supply Voltage | VDD | 12 ± 5% | VDC |
| | VCC1 | 5 ± 5% | VDC |
| | VCC2 | 5 ± 5% | VDC |
| RDX, RDY Output Current (DC) | Io | 0 to 100 | μA |

DC CHARACTERISTICS Unless otherwise specified: VDD = 12V ± 5% VCC1, 2 = 5V ± 5%, +25°C <Tj < +125°C.

| Parameter | Test Conditions | Min. | Max. | Units |
|-------------------------------------|-----------------|------|-----------|-------|
| Input Low Voltage (VIL) | | -0.3 | 0.8 | VDC |
| Input High Voltage (VIH) | | 2.0 | VCC + 0.3 | VDC |
| Input Low Current | VIL = 0.8v | -0.4 | — | mA |
| Input High Current | VIH = 2.0v | — | 100 | μA |
| RDX, RDY Common Mode Output Voltage | | 5 | 7 | VDC |
| WUS Output VOL | IoI = 8mA | — | 0.5 | VDC |
| IMF Output | on | 2.2 | 3.7 | mA |
| | off | — | 0.02 | mA |

WRITE CHARACTERISTICS Unless otherwise specified: VDD = 12v ± 5%, VCC1, 2 = 5v ± 5%, IW = 40 ma, Lh = 200nH, Rh = 16Ω, f (Data) = 5MHz, CL (RDX, RDY) < 20pF, RL (RDX, RDY) = 1KΩ.

| Parameter | Test Conditions | Min. | Max. | Units |
|---------------------------------|-----------------|---------|------|-----------------|
| Write Current Constant "K" | Rh ≤ 1Ω | 1.12 | 1.26 | V |
| Differential Head Voltage Swing | | 3.4 | — | V(pp) |
| Unselected Head Current | | — | 2 | mA (pk) |
| Differential Output Capacitance | | — | 30 | pF |
| Differential Output Resistance | | 200 Typ | | Ω |
| WDI Transition Frequency | WUS = low | TBD | — | MHz |
| Iwc to Head Current Gain | | — | TBD | A/A |
| Write Current Range | | 20 | 70 | mA _p |

READ CHARACTERISTICS

| Parameter | Test Conditions | Min. | Max. | Units |
|--------------------------------|---|---------|------|--------|
| Differential Voltage Gain | Vin = 1mVpp @ 300 KHz RL(RDX), RL(RDY) = 1kΩ | 75 | 125 | V/V |
| Bandwidth | Zs < 5Ω, Vin = 1mVpp | -1db | — | MHz |
| | | -3db | — | MHz |
| Input Noise Voltage | BW = 15MHz, Lh = 0, Rh = 0 | — | 0.9 | nV/√Hz |
| Differential Input Capacitance | f = 5MHz | — | 65 | pF |
| Differential Input Resistance | f = 5MHz | 200 Typ | | Ω |
| Input Bias Current | | — | 170 | μA |
| Dynamic Range | DC input voltage where gain falls to 90% of its OVDC value. Vin = VDC + 0.5mVpp, f = 5MHz | -3 | 3 | mV |
| Common Mode Rejection Ratio | Vin = 0VDC + 100mVpp @ 5MHz | 54 | — | db |
| Power Supply Rejection Ratio | 100mVpp @ 5MHz on VDD or VCC | 54 | — | db |
| Channel Separation | Unselected channels driven with 100mVpp @ 5MHz, Vin = 0mVpp | 45 | — | db |
| Output Offset Voltage | | -360 | 360 | mV |
| Single Ended Output Resistance | f = 5MHz | — | 30 | Ω |
| Current Output | AC coupled TBD load | — | TBD | mA |

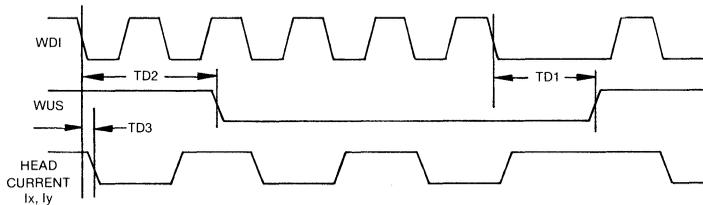
silicon systems™

14351 Myford Road, Tustin, CA 92680 (714) 731-7110, TWX 910-595-2809

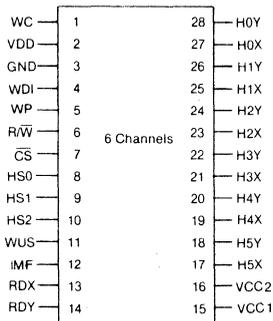
SWITCHING CHARACTERISTICS

Unless otherwise specified: VDD = 12V ± 5%, VCC1, 2 = 5V ± 5%, TA = 25°C, IW = 40mA, Lh = 200nH, Rh = 16Ω, f(Data) = 5MHz.

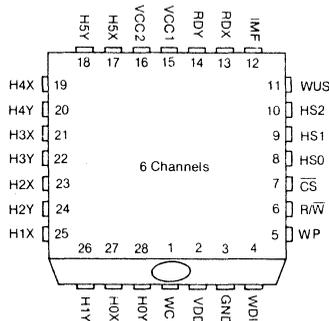
| Parameter | Test Conditions | Min. | Max. | Units |
|---|---|------|------|-------|
| R/W: R/W to Write R/W to Read | to 90% of write current | — | 0.6 | μS |
| | to 90% of 100mV 10MHz Read signal envelope | — | 0.6 | μS |
| CS: CS to select CS to unselect | to 90% of write current or to 90% of 100mV 10MHz Read signal envelope | — | 1 | μS |
| | | — | 1 | μS |
| HS0, 1, 2 to any head | to 90% of 100mV 10MHz Read signal envelope | — | 0.4 | μS |
| WUS: safe to unsafe TD1 unsafe to safe TD2 | | 0.6 | 3.6 | μS |
| | | — | 1 | μS |
| IMF: transition time | delay from 50% point of CS to 90% of IMF current | — | 0.6 | μS |
| Head Current: WDI to I _o (x, y) TD3 Assymetry Rise/Fall time | Lh = 0, Rh = 0 from 50% points | — | 32 | nS |
| | WDI has 50% duty cycle and 1ns rise/fall time | — | 1.0 | nS |
| | 10% - 90% points | — | 13 | nS |



WRITE MODE TIMING DIAGRAM



28-LEAD DIP
FLAT PACK



28-LEAD QUAD

Advanced Information

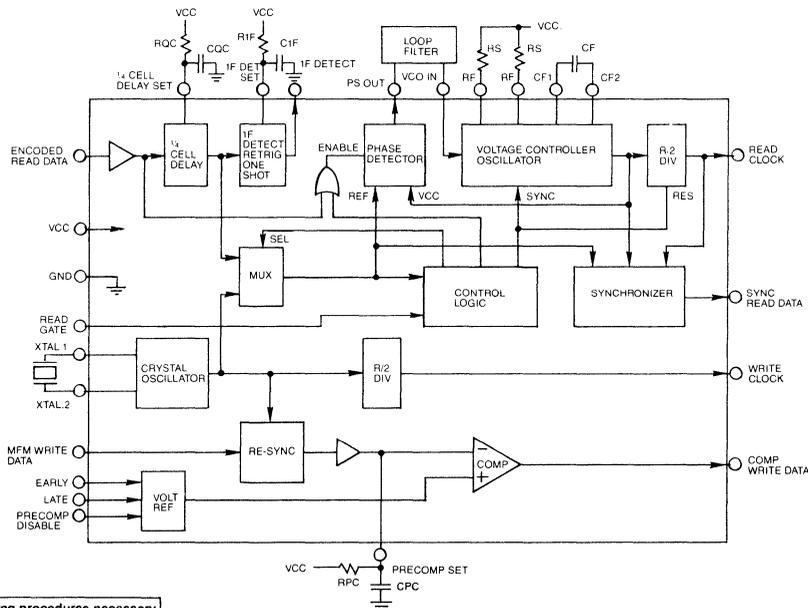
GENERAL DESCRIPTION

The SSI 531 device is a bipolar integrated circuit that performs read data synchronization and MFM write precompensation functions for Winchester disc drive systems. A high performance phase locked loop ensures accurate detection of data bits and clock pulses within a playback MFM code pattern. The loop requires external passive filter elements (but no varactor diode or delay line). In the write mode, the SSI 531 circuit provides precise synchronization of data pulses to a crystal-controlled waveform. Optionally, a TTL gate input can be used in place of crystal control. High performance bipolar processing ensures low jitter for both the read and write paths. The SSI 531 device interfaces with controllers, such as the WD1010, which perform the MFM encoding and decoding functions. Eliminated by the SSI 531 are the need for complex analog/digital circuitry and expensive delay lines required by a controller for playback data pulse detection and for time position compensation of write data pulses. The SSI 531 requires a single +5V power supply and is available as a 24-pin dual inline package.

FEATURES

- 10 Mbit/Sec data rate
- MFM data synchronization
- Fast acquisition with precision VCO phase reset
- Write synchronization and precompensation
- Crystal controlled reference oscillator
- No active trimming elements or delay lines required
- + 5V power supply
- Compatible with WD1010 type controller circuits
- Available 3Q85

SSI 531 Block Diagram



CAUTION: Use handling procedures necessary for a static sensitive component

Advanced Information

GENERAL DESCRIPTION

The SSI 541 Read Data Processor is a bipolar integrated circuit that utilizes a high performance AGC amplifier and two data qualification channels, amplitude and time, to detect and preserve the time relationship of the peaks in the read back signal of a Winchester disk drive.

This data qualification technique eliminates shouldering induced errors and makes it ideally suited for use with resolution signals.

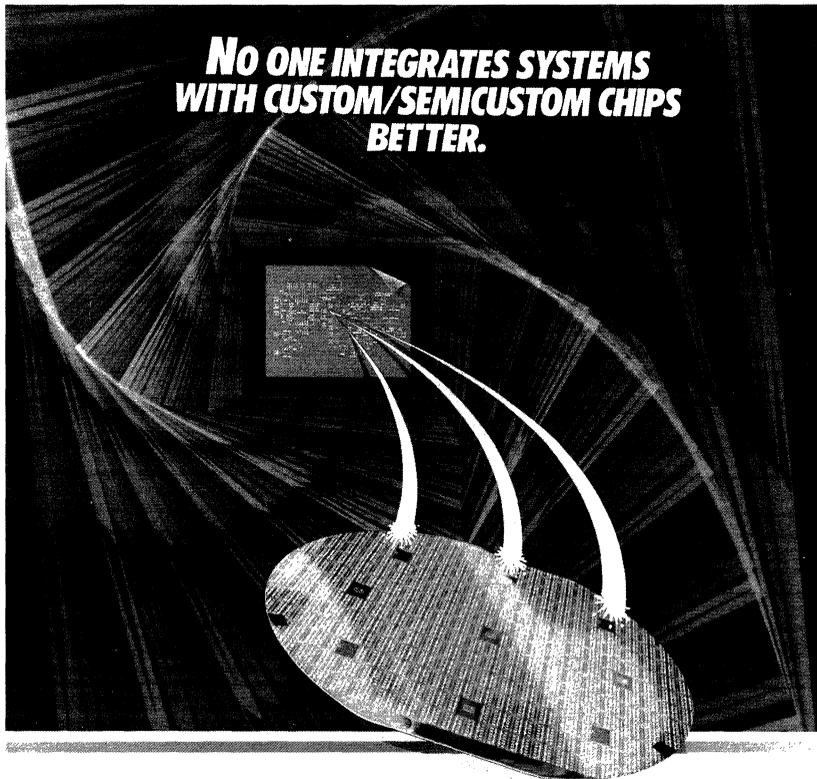
The SSI 541 is operated from the +5, +12 volt power supplies and is available in a variety of packages.

FEATURES

- Time and Amplitude Pulse Qualifications
- High Performance AGC Amplifier
- AGC Hold Feature for Embedded Servo Applications
- Separate MFM or RLL, CODIN, Techniques
- Data Rates up to 15M bits/sec
- +5 > +12, volt Standard Power Supplies

Section 3

CUSTOM/ SEMICUSTOM

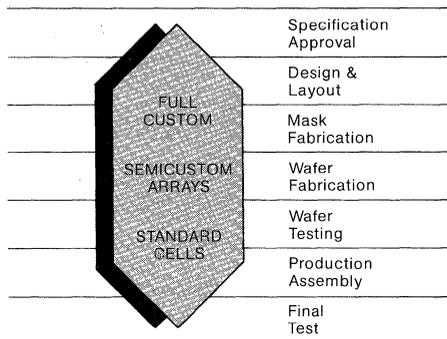


SILICON SYSTEMS – LEADING THE WAY IN CUSTOM/SEMICUSTOM IC'S

At SSi, we've been in a leadership role in custom circuits, first with superior IC design capabilities, and then with one of industry's finest wafer fabrication facilities. Today we're still pacing the field in the burgeoning market for "application specific" custom/semicustom IC's. We've maintained our position by carefully monitoring evolving market requirements and providing cost-effective, quality solutions for even the most specialized applications.

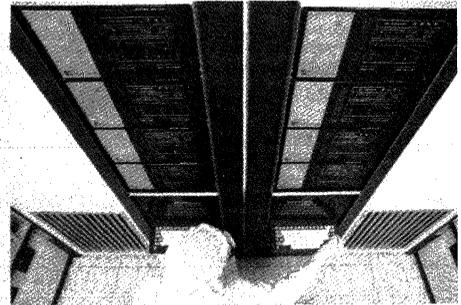


In both engineering and technology, we offer versatility: with design capabilities for digital, analog, and combined digital/analog ICs along with a wafer fabrication capability that includes both Bipolar and CMOS technologies.



Custom/Semicustom Approach to Integrated Circuits

Custom IC's are not just a side line at SSi; they've always been our primary business. We provide the full range of custom IC design with such practical semicustom options as pre-built standard cells and switched capacitor filter arrays. With a top engineering staff supported by our unique Integrated Design Methodology (IDM), and with a fully automated wafer



fabrication facility designed especially for custom and "Application-Specific" IC's, we can cut custom design time down to readily acceptable limits.

Integrated Solution for You

So whether your requirements fall in our specialty areas of telecommunications and rotating memories, or other application areas appropriate for custom/semicustom IC's, we offer the advantages of a complete IC development and production operation; single-point accountability, smooth progress through all phases of a project, and a high level of quality assurance. The result: reduced time and cost to produce the best custom/semicustom IC's available.

VERSATILITY – THE OPTIMUM APPROACH FOR EACH CUSTOMER

Silicon Systems has focused on the ASIC (Application Specific Integrated Circuit) market for over 10 years and has developed a versatile offering of customized components that covers the design spectrum.

The digital market can be satisfied by our Mask Programmed Logic Arrays (MPLA) for implementation of complex logic functions and by our full custom or standard cell library for large scale system designs.

at Silicon Systems which allows quick turn-around from design concept to working silicon. The ultra-clean wafer fab supports both Bipolar and CMOS technologies with high and low voltage options as well as single or double layer metal interconnections. These variations permit us to select the optimum process when fabricating a new circuit.

| ANALOG APPLICATIONS | SSI CAPABILITY |
|---|---|
| <ul style="list-style-type: none"> • Functions – (Filters, Signal Conditioning, Etc.) • Systems – (Data Acquisition, Signal Processing, Etc.) | Switched Capacitor Array Analog/Digital Full Custom and Standard Cell Design |

Table 1

The analog market is served by our Bipolar analog array for moderate complexity needs, by switch capacitor arrays for filter needs and by full custom or standard cell library for higher levels of sophistication. All four design technologies also accommodate full analog and digital integration on the same chip for total system solutions.

Design engineering, semiconductor processing and testing are all housed in the same facility

DIGITAL APPLICATION SPECTRUM

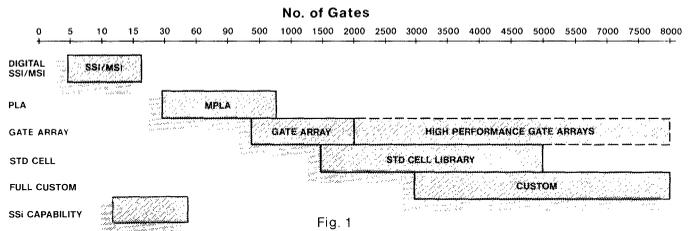


Fig. 1

Our standard cell library is implemented on the CC process (3μm silicon gate CMOS) allowing high density, low power digital and analog functions to be integrated, while operating with standard 5-volt levels. The proprietary "CD" process extends operation from 3.5V to 14V for higher performance analog or analog/digital functions while our proprietary Bipolar "BJ" process offers extremely high density and performance combined with very low noise.

Silicon Systems also offers full capability for supporting Customer Owned Tooling (COT) with any of our industry standard processes.

| CMOS PROCESS CHART | | | | | | | | | | | | |
|---------------------|---------|--------------------------|-------------------------|---------------------------|----|--------------|------------|--------------------------|----------------------|--------------------|--------------------|---|
| Process Designation | Channel | V _{TP0} (volts) | V _{TO} (volts) | BV _{DSS} (volts) | K' | N or P (Ω/□) | Poly (Ω/□) | Channel Length (microns) | Poly Pitch (microns) | M1 Pitch (microns) | M2 Pitch (microns) | Options/Comments |
| CB | P | -20 | -0.9 | 20 | 11 | 80 | — | 9.0 | — | 12.5 | — | High Voltage Al Gate |
| | N | 20 | 0.9 | 20 | 17 | 16 | — | 7.2 | — | 12.5 | — | |
| CC | P | -12 | -0.9 | 12 | 15 | 55 | 20 | 3.0 | 6.4 | 8.8 | 12 | Double Metal, Single Poly (includes capacitors) Si Gate |
| | N | 12 | 0.7 | 12 | 45 | 25 | 20 | 3.0 | 6.4 | 8.8 | 12 | |
| CD | P | -18 | -0.9 | 18 | 16 | 55 | 20 | 4.0 | 6.4 | 8.8 | — | Single Metal, Double Poly |
| | N | 18 | 0.7 | 18 | 50 | 25 | 20 | 4.0 | 6.4 | 8.8 | — | |

Table 2A

| BIPOLAR PROCESS CHART | | | | | | | | | | | | | |
|-----------------------|-----------------|---------------------------|---------------------------|----------------|----------------|----------------|-----|-------------------|----------------|-------------------------|--------------------|--------------------|---|
| Process Designation | h _{FE} | BV _{CEO} (volts) | BV _{CBO} (volts) | Base | | epi | | n ⁺ BL | | Min. geometry (microns) | M1 Pitch (microns) | M2 Pitch (microns) | Options/Comments |
| | | | | P _s | X _j | P _t | l | P _s | X _j | | | | |
| BC | 60 | 12 | 25 | 200 | 1.2 | 0.75 | 4.4 | 25 | 5.5 | 5 | 14 | 24 | Double Metal Al Schottky Typical f _T 1000 MHz |
| BJ | 60 | 9 | 20 | 350 | 1.0 | 0.5 | 3.9 | 20 | 5.5 | 3 | 9 | 14 | Double Metal Al Schottky Poly Emitter Typical f _T 2000 MHz |

Table 2B

INTEGRATED DESIGN METHODOLOGY – THE IDM™ ADVANTAGE

When deciding to convert a system or subsystem design to silicon the user can choose either a fully customized approach or a semi-customized approach, each with its own benefits. For these designs SSI offers the alternatives of fully "handcrafted" custom design in CMOS and Bipolar or standard cell design in CMOS. As seen in Table 3, the fully individualized custom gives the advantages of chip size (lower production cost) and highest

With Computer Aided Design (CAD) playing a major role in our product development cycle, SSI has developed an Integrated Design system that accommodates an interlocking set of design methods all supported by a single CAD system. This Integrated Design Methodology (IDM™) allows the user to design at the transistor level (either composite or symbolic), at a procedural macro level (silicon compiler), with

INTEGRATED DESIGN METHODOLOGY

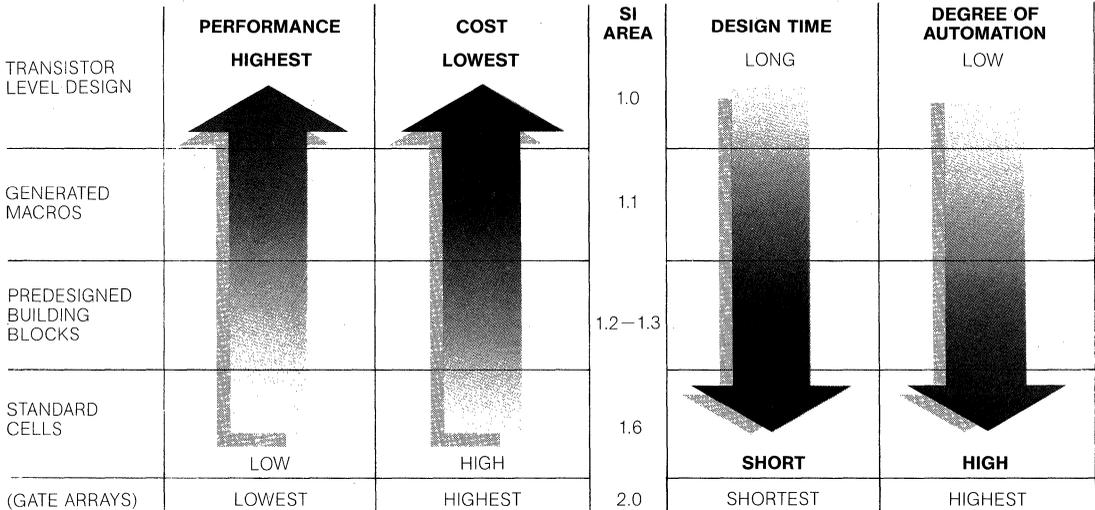
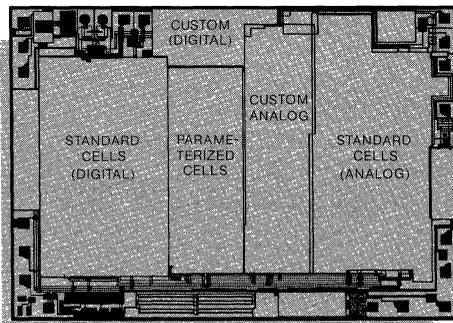


Figure 2

performance (speed, input offset, etc.) while semicustom, using a pre-characterized standard cell library, offers the advantages of lower NRE, faster turnaround and somewhat higher first article success rate. SSI adds to the flexibility of the standard cell concept by its willingness to develop special cells as needed to satisfy design requirements that lie between the two custom design technologies.

MACRO IC USING IDM



COMPARISON OF CUSTOM/ SEMICUSTOM LSI OPTIONS

| Processes | Standard Cell | Full Custom |
|-------------------------------|---------------|-------------|
| Bipolar | No | Yes |
| CMOS | Yes | Yes |
| Analog | Yes | Yes |
| Digital | Yes | Yes |
| Analog/Digital Mix | Yes | Yes |
| Development Parameters | | |
| Cost | 0.3-0.5 | 1.0 |
| Time | 0.25-0.40 | 1.0 |
| Risk Factor | 0.5 | 1.0 |
| Production Parameters | | |
| Final Die Size | 1.3-1.6 | 1.0 |
| Die Cost | 1.5-2.0 | 1.0 |

All comparisons normalized to a full custom basis.

Table 3

Parameterized Building Blocks (PBB), or with conventional standard cells. Each of these design levels has a unique set of attributes, as shown in Figure 2, accessible in a "mix or match" manner under IDM. This enables an efficient performance/design-time tradeoff.

"CUSTOMIZED SERVICE"—TOTAL SUPPORT FROM CONCEPT THROUGH FINAL TEST

Silicon Systems offers experienced staffing throughout its organization along with state-of-the-art CAD and processing facilities to efficiently develop customized products.

We start with a large, expert staff of design engineers to help define the product from both the system and silicon aspects. The design is then developed using our advanced CAD tools and programs including ALICE (Automated Layout for Integrated Circuit Engineering), which accurately handles chip design from schematic input to pattern generator output, all within one system. SSI engineers utilize an advanced version of "SPICE" to simulate DC, transient, noise, distortion, and AC response for CMOS and Bipolar. It accurately models such second order effects as weak-inversion, high-level injection, temperature dependent mobility, etc.

SSI has adapted a special program called "SWITCAP" for switched-capacitor filter frequency domain analysis which accurately predicts the frequency response of switched-capacitor filters. Our Automatic Network Intertrace Algorithm (ANITA™) compares the network description generated from the captured circuit to the layout as it proceeds. This guarantees that no interconnection errors exist and that all component sizes and tolerances match those used in the design analysis. The completed design goes through a masking procedure and the wafers are run in our ultramodern class 10 (10ppm particulate count) wafer fabrication facility. It is a "paperless"

| CUSTOM/SEMICUSTOM SUPPORT CAPABILITIES | |
|--|---|
| • SOFTWARE SUPPORT | |
| SIMULATION | SPICE, DAISY LOGICIAN, ILOGS, SWITCAP |
| LAYOUT and ROUTING | ALICE, ANITA, CAL-MP |
| • COMPUTERS and WORKSTATIONS | VAX 11/780, DAISY, MENTOR |
| • TEST HARDWARE | LTX TESTERS, EAGLE (LSI-4) TESTERS, AUTOMATIC HANDLERS, BURN-IN SOCKETS, TEMPERATURE CHAMBERS |

Table 4

environment accomplished by downloading process information to in-place terminals and processing equipment. The PROMIS (Process Management Information Systems) program that accomplishes this control provides work-in-process tracking, engineering data collection,

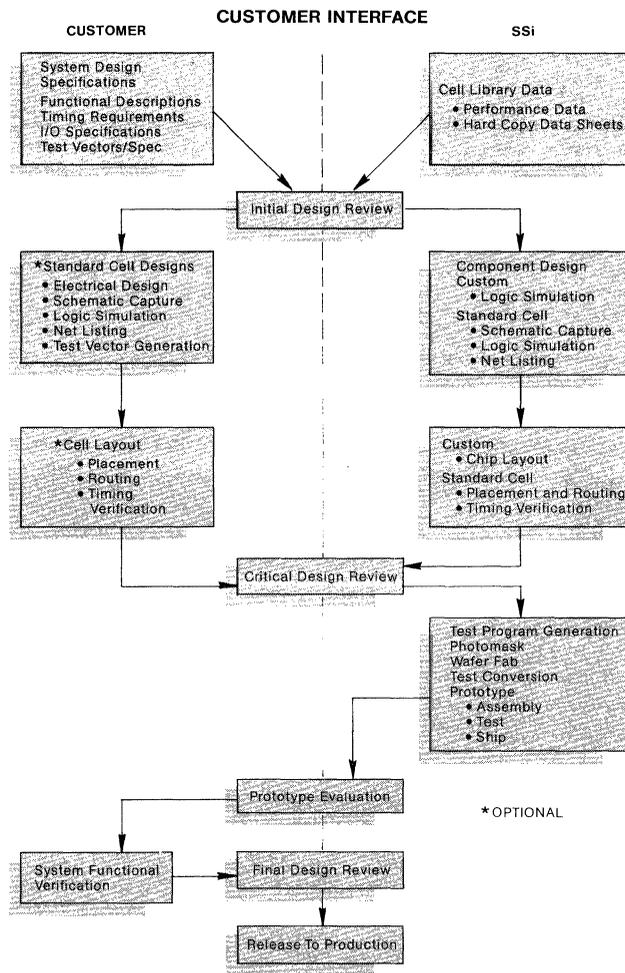


Figure 3

and continuous facility monitoring.

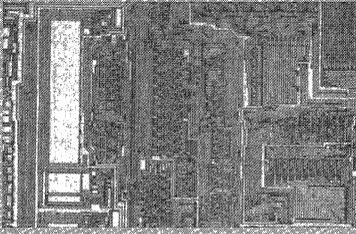
After the wafer prototype is fabricated, SSI packages a few representative chips using in-house assembly for design verification. The units are tested in-house by one of our advanced analog or digital tester. We can test your circuit with your existing test program or help you create a test program from your specification.

After approval of prototypes or characterization lots (if needed) the final step is off-shore assembly for volume production.

We can also perform hi-rel screening and burn-in, if desired.

CUSTOM – THE “TAILORED” APPROACH

CMOS

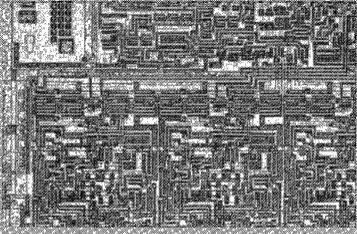


| Integrated Circuit Function | Application |
|------------------------------------|---------------------------------------|
| Dual Tone Multi Frequency Receiver | *Decodes Touch-Tone Telephone Signals |
| 1200/2400 Baud Receiver | Phase Shift Keying (PSK) Modem |
| Phoneme-Based Speech Synthesizer | "Talking" Machines |
| Error Corrector | Military Radio |
| Variable Counter | Jam-Resistant Radio |
| Touch Activated Switch | Home Lamps |
| Video Processor | Infrared Video System |
| 16 Channel Switching Matrix | Bank Communications System |
| Custom Microprocessor | Computer Terminal |
| Digital Loop Detector | Traffic Signal Control |
| Programmable Digital Receiver | Home Appliance Remote Control |

*Touch-Tone is a trademark of AT&T

Table 8

BIPOLAR



| Integrated Circuit Function | Application |
|--------------------------------------|--------------------------------------|
| AGC & Level Control Signal Processor | Infrared Video System |
| Pulse Width Modulation Controller | Switching Power Supply |
| 5-Channel Read/Write Amplifier | OEM Winchester Disk Drives |
| Thin-film Read/Write Amplifier | IBM 3370/3380 Compatible Disk Drives |
| VHF/UHF Gain Mixer | Radio Receiver |
| Regulator/Timer | Highway Barricade Flasher |
| 8-Channel Bidirectional Buffer | Microprocessor Peripheral IC |
| 12-Bit Range Counter | Laser Range Finder |
| PCM Encoder/Decoder | Telecommunications System |
| Video Controller/ Timing Generator | Dot Matrix CRT Terminal |

Table 9

AVAILABLE PACKAGES

| NO. OF PINS | Dual-in-Line Plastic | Dual-in-Line Cerdip | Flat Pack | Cerpac | Plastic Quad (Surface Mount) |
|-------------|----------------------|---------------------|-----------|--------|------------------------------|
| | P | D | F | M | H |
| 8 | ● | ● | - | - | - |
| 10 | - | - | ● | - | - |
| 14 | ● | - | - | - | - |
| 18 | ● | - | - | - | - |
| 20 | - | - | - | - | ● |
| 22 | ● | ● | - | - | - |
| 24 | ● | ● | ● | - | - |
| 28 | ● | ● | ● | - | ● |
| 32 | - | - | ● | - | - |
| 40 | ● | ● | - | - | - |
| 44 | - | - | - | - | ● |
| 68 | - | - | - | - | ● |
| 84 | - | - | - | - | ● |

Table 11

HI-REL SCREENING OPTIONS

- Reliability Screening (Method 5004)
- Qualification and Quality Conformance Procedure (Method 5005)
- Pre-Seal Visual Inspection (Method 2010)
- Stabilization Bake (Method 1008)
- Temperature Cycle (Method 1010)
- Thermal Shock
- Constant Acceleration
- Fine Leak (Method 1014)
- Gross Leak (Method 1014)
- Burn-In
- SEM Analysis of Wafer Lots (Metallization)

Table 10

The above tables show some of our demonstrated high performance design capabilities in Bipolar and CMOS. These analog/digital chips cover a wide range of challenging circuit functions that were designed for a diversity of system applications.

As part of a total capability SSI offers commercial, industrial, and hi-rel product flows, as well as packaging options that include Dual-in-Line, Flatpacks, and plastic Quads. For further detailed information on product flow and packaging call SSI or refer to our Quality and Reliability Brochure.

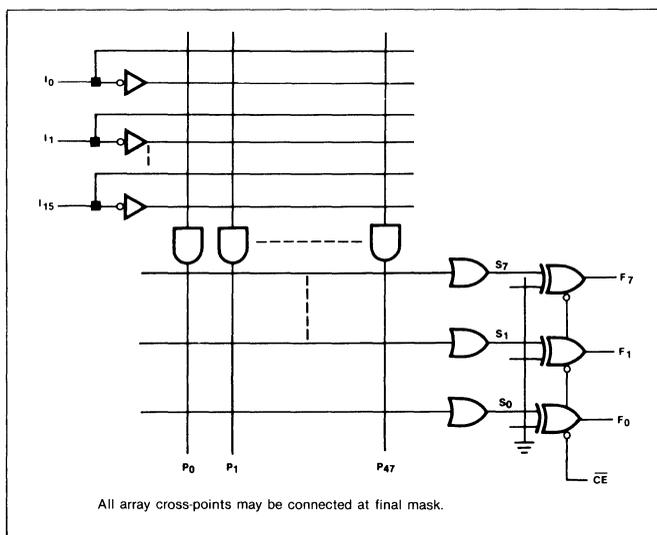
Preliminary Data Sheet

GENERAL DESCRIPTION

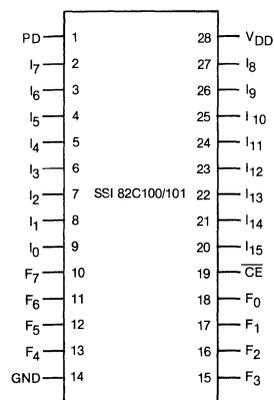
The SSI 82C100/101 are CMOS mask Programmable Logic Arrays (PLA). The AND-OR-Invert architecture gives the user the ability to implement custom sum-of-product logic equations. Sixteen inputs and eight outputs yield a total of 48 available product terms. A product term is the logical AND of up to 16 of the inputs in true or compliment form. As many as all of these product terms can be ORed together to create a desired output function. The output can then be programmed as active high or low. A mask option gives the designer a choice of outputs, either three-state with the SSI 82C100 or active pull down (open-drain) with the SSI 82C101. A chip enable (\overline{CE}) pin controls the outputs. The SSI 82C100/101 is fully TTL compatible.

FEATURES

- Mask programmable
- 16 input variables
- 8 output variables
- 48 product terms
- Chip enable (\overline{CE}) pin
- Three-state outputs
- 70 nsec Address access time
- Functional replacement for Signetics 82S100/101



LOGIC DIAGRAM



**Pin Out
(Top View)**

CAUTION: Use handling procedures necessary for a static sensitive component

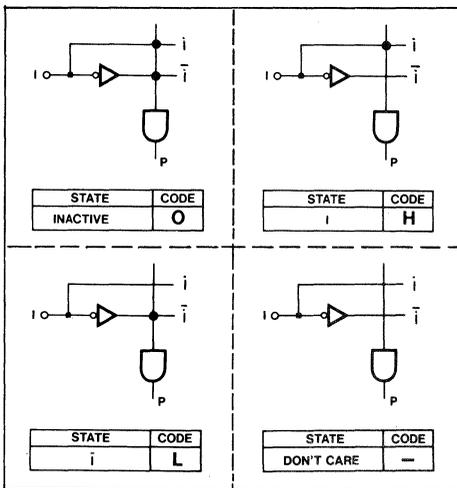
SSI 82C100/101 Programmable Logic Array

Programming

Either boolean equations, our logic diagram with the connections shown or a completed program table are sufficient for indicating a customer's programming needs. A blank diagram and table are included in this data sheet for the designer's use.

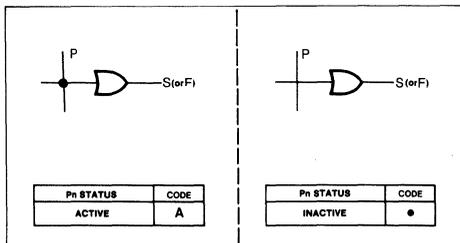
Inputs and the "AND" Array

Each input to the SSI 82C100/101 is available to the AND array in either true or complement form. Either form of these 16 inputs may be connected to any of the AND gates. However if both forms are inputs to any one gate, that gate is inactive regardless of its other inputs. The four ways to program an AND gate are shown below.



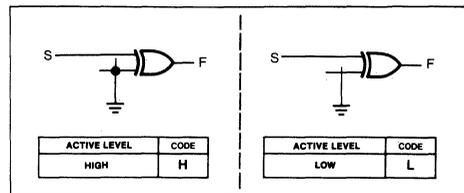
"OR" Array

Any of the product terms (output of the AND array) can be connected to any of the OR gates.



Outputs

An output can be programmed active high or low by either grounding or leaving open the unused input of the EXOR gate.



Chip Enable

For the SSI 82C100 a high on the \overline{CE} pin will cause the outputs to go to a high-impedance state. With the SSI 82C101, the \overline{CE} pin going high forces all the outputs high, provided an external pull-up resistor is connected. In either device, a low on the \overline{CE} pin gives the chip control of the outputs.

Power Down Mode

The PD pin on the SSI 82C100/101 is a control for the power down mode. A high on the pin reduces chip power and speed by a factor of 100 but retains the device's logical functions. During normal operation PD can be grounded or left floating.

Absolute Maximum Ratings*

| Parameter | Min | Max | Unit |
|-----------------------------------|-------|-----------------------|------|
| Supply Voltage (V _{CC}) | — | + 7 | Vdc |
| Input Voltage | - 0.3 | V _{CC} + 0.3 | Vdc |
| Output Voltage | - 0.3 | V _{CC} + 0.3 | Vdc |
| Input Currents | - 1 | + 1 | mA |
| Output Currents | — | + 20 | mA |
| Storage Temperature | - 65 | + 150 | °C |

* Exceeding the absolute maximum ratings may cause permanent damage to the device.

DC Electrical Characteristics (0 °C ≤ Ta ≤ + 75 °C, 4.75V ≤ V_{CC} ≤ 5.25V All voltages are with respect to ground.)

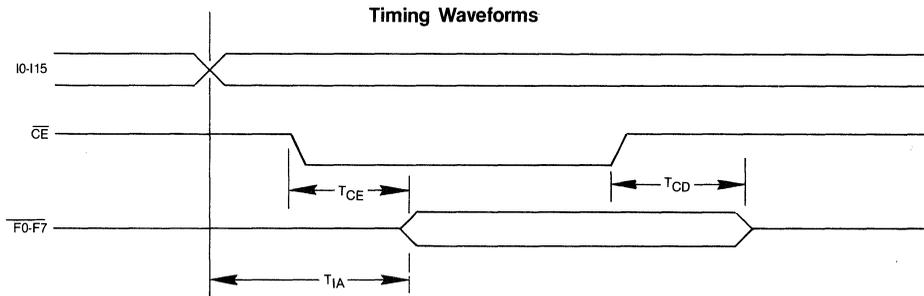
| Parameter | Test Conditions | Min. | Max. | Units |
|--|--|-------|-------|-------|
| Input Voltage High | V _{CC} = Max | 2.0 | — | V |
| Input Voltage Low | V _{CC} = Min | — | 0.85 | V |
| Output Voltage High ¹ | I _{OH} = - 2mA | 2.4 | — | V |
| Output Voltage Low ² | I _{OL} = 9.6mA V _{CC} = Min | — | 0.45 | V |
| Input Current High ³ | V _{in} = V _{CC} | — | 25 | μA |
| Input Current Low ³ | V _{in} = 0.45V | - 100 | — | μA |
| PD Input Current High | V _{in} = V _{CC} | — | 100 | μA |
| PD Input Current Low | V _{in} = 0.45V | - 25 | — | — |
| Output Current Hi-Z | \overline{CE} = High, V _{CC} = Max V _{out} = V _{CC} | - 40 | 40 | μA |
| | V _{out} = 0.45V | - 40 | 40 | μA |
| Output Current Short Circuit ^{4, 5} | \overline{CE} = Low, V _{out} = OV Pullup Active | - 14 | - 100 | mA |
| Supply Current ⁶ | PD Low | — | 50 | mA |
| Supply Current | PD High | — | 500 | μA |
| Input Capacitance | V _{in} = 2.0V | — | 8 | pF |
| Output Capacitance | V _{out} = 2.0V \overline{CE} = High, V _{CC} = 5.0V | — | 17 | pF |

- Notes:
1. Measured with \overline{CE} low (chip enabled) and a logic high output.
 2. Measured with \overline{CE} low (chip enabled) and a logic low output.
Output sink current is applied through a resistor to V_{CC}.
 3. Except PD
 4. Only one output should be tested at a time.
 5. Do not exceed 1 second with short circuit current.
 6. Measure supply current with \overline{CE} low, I₀₋₁₅ high, outputs open and PD as specified.

Timing Characteristics

| Parameter | Symbol | Test Conditions | Min | Max | Unit |
|---------------------------------|-----------------|-----------------|-----|-----|------|
| Propagation Delay | T _{IA} | See Fig 1 | — | 50 | ns |
| Chip Enable Delay ⁷ | T _{CE} | See Fig 2 | — | 30 | ns |
| Chip Disable Delay ⁸ | T _{CD} | See Fig 3 | — | 30 | ns |

Notes: 7. T_{CE} is the delay from \overline{CE} low to data valid.
 8. T_{CD} is the delay from \overline{CE} high to high-Z or high output state. The chip disable state is reached when the output moves 0.5V from its initial value.



Note: Input rise and fall times (10%-90%) are less than 5 ns.

Test Circuits for Timing Measurements

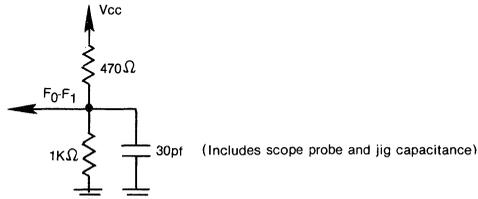


Fig 1: TIA test circuit

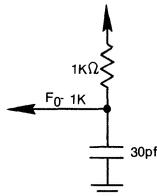


Fig 2: TCE test circuit

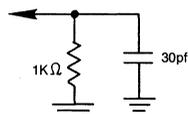


Fig 3: TCD test circuit

Example

This example illustrates all three means of providing programming data to SSI. Any one of the three is sufficient. The diagram below and the table on the next page indicate the programming necessary to implement these equations:

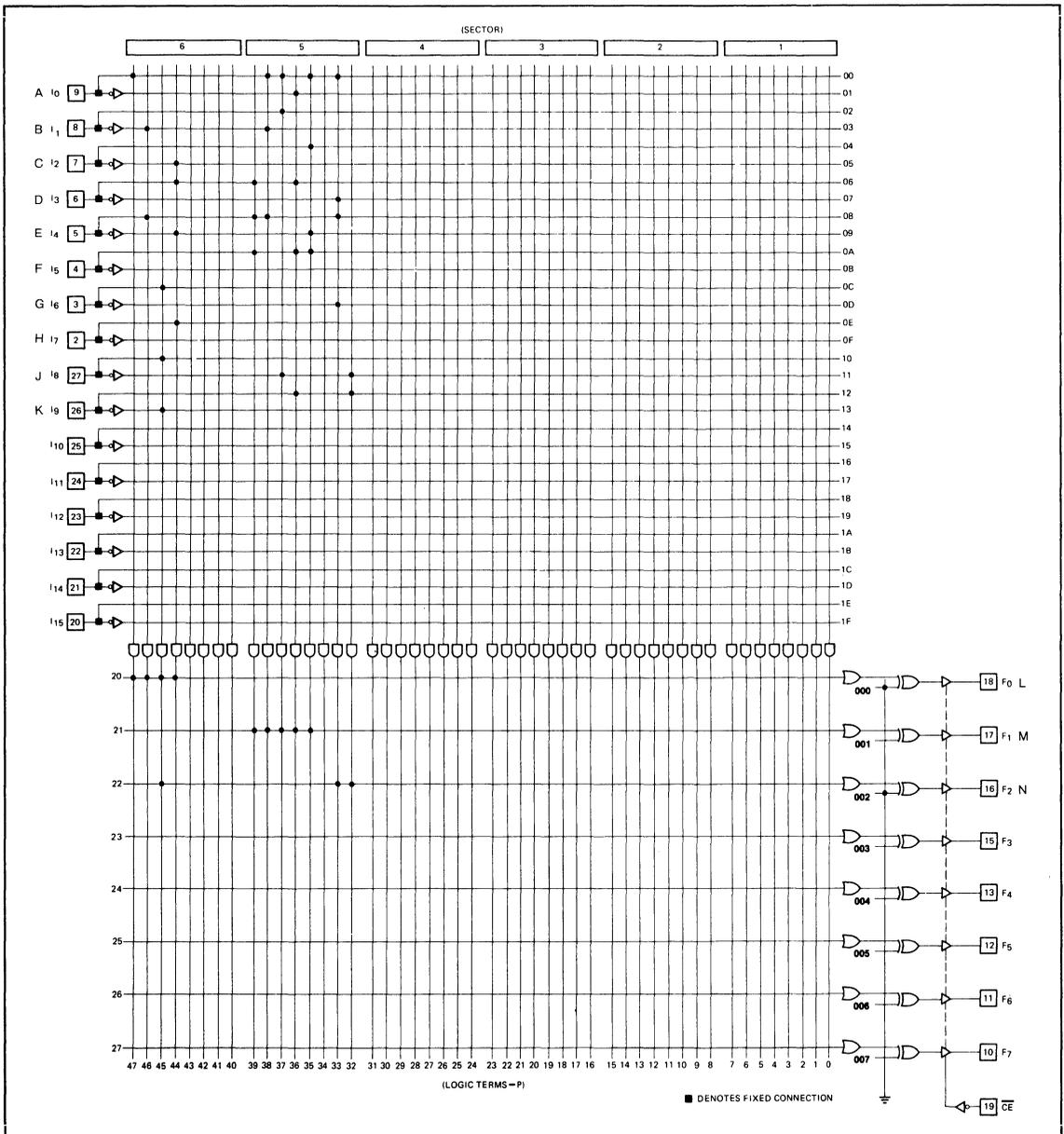
Boolean Equations

$$L = A + \bar{B}E + G\bar{J}K + \bar{C}D\bar{E}H$$

$$\bar{M} = DEF + \bar{A}BE + AB\bar{J} + \bar{A}DFK + AC\bar{E}F$$

$$N = G\bar{J}K + ADE\bar{G} + JK$$

PLA Logic Diagram



Section 4

STANDARD CELLS



STANDARD CELL LIBRARY – ANALOG AND DIGITAL

SSI STANDARD CELL FAMILY (PARTIAL LIST)

| ANALOG CELLS | DIGITAL CELLS | DIGITAL CELLS |
|--|-------------------------------------|--|
| Analog Switch Array | Two Input NOR | Three Input AND |
| Switched Capacitor Amplifier | Three Input NOR | Four Input AND |
| OP Amp, External Use | Four Input NOR | Two Input OR |
| OP Amp, Internal Use | Two Input NAND | Three Input OR |
| Gain Block | Three Input NAND | Four Input OR |
| Capacitor Array | Four Input NAND | 3x2 AND-OR-Invert |
| Bias Generator | Inv/Non-Inverting Buffer | 2x2 AND-OR-Invert |
| RC Oscillator | Buffer Inverter | 2x1 AND-OR-Invert |
| Multiplying Differential D/A Converter | Transmission Gate | D Flip-Flop (2 Versions) |
| High Accuracy Sample and Hold | Single Clock/Dual Transmission Gate | D Flip-Flop with Set (Overrides) and Reset |
| Power On Reset | Inverting Tri-State | D Flip-Flop with Set and Reset (Overrides) |
| OP Amp, Buffer | Non-Inverting Tri-State | Transparent D Latch |
| Supply Divider | RS NAND Latch | Exclusive OR (2 Versions) |
| Voltage Comparator | RS NOR Latch | Input Inverting I/O Cell |
| 8 Bit A/D Converter | Low Impedance Inverter | Input Inverting I/O Cell |
| Low Impedance Driver | High Impedance Inverter | Output Inverting Driver I/O Cell |
| | Double Buffer Inverter | Bi-Directional Tri-State I/O Cell |
| | Tri-State Driver | Output Non-Inverting Driver I/O Cell |
| | Two Input Decoder | Input Transmission I/O Cell |
| | Two Input AND | Input Pad with Protection |
| | 8 Bit Magnitude Comparator | Input Schmitt Trigger (4 Versions) |

Table 5

The standard cells shown in Table 5 represent the basic building blocks or "primitives" of our present library. In addition to these cells, macros are already scheduled for functions such as RAM, ROM, PLA etc. Others can be generated and added to the library on an "as needed" basis. As part of the SSI flexibility in custom we will design new cells to accommodate any feasible "special" requirements.

DIGITAL CHARACTERISTICS

| 4.5V < VDD < 5.5V | | -40°C < Temp < 125°C | | |
|------------------------------|------|----------------------|------|-------|
| | | Nom | Max | Units |
| Propagation Delays | | | | |
| 2 Input NAND | TPLH | 2.5 | 8.0 | nsec |
| | TPHL | 1.7 | 3.8 | nsec |
| RS Flip-Flop | TPLH | 5.0 | 10.7 | nsec |
| | TPHL | 1.5 | 3.3 | nsec |
| D Flip-Flop (clk to QB) | TPLH | 4.0 | 8.8 | nsec |
| | TPHL | 3.2 | 7.6 | nsec |
| Buffer/Driver (Inverting) | TPLH | 1.0 | 3.1 | nsec |
| | TPHL | 0.8 | 2.5 | nsec |
| Nominal Measured at 5V, 25°C | | | | |

Table 6

ANALOG CHARACTERISTICS

| 4.5V < VDD < 5.5V | | -40°C < Temp < 125°C | | |
|---|--|----------------------|-----|-----------|
| | | Min | Nom | Max Units |
| Operational Amplifier | | | | |
| Input Offset | | - | 5 | 15 mv |
| Unity Gain Bandwidth | | - | 2.5 | - MHz |
| Open Loop Gain | | 3000 | - | - V/V |
| Comparator | | | | |
| Input Offset Voltage | | - | 1 | 10 mv |
| Conversion Time | | - | - | 1.5 μsec |
| Multiplying Digital/Analog Converter | | | | |
| Acquisition Time | | - | 2 | 6 μsec |
| Non-Linearity | | - | - | 1/2 LSB |
| Clock Frequency | | - | 20 | - MHz |
| Nominal Measured at 5V, 25°C | | | | |

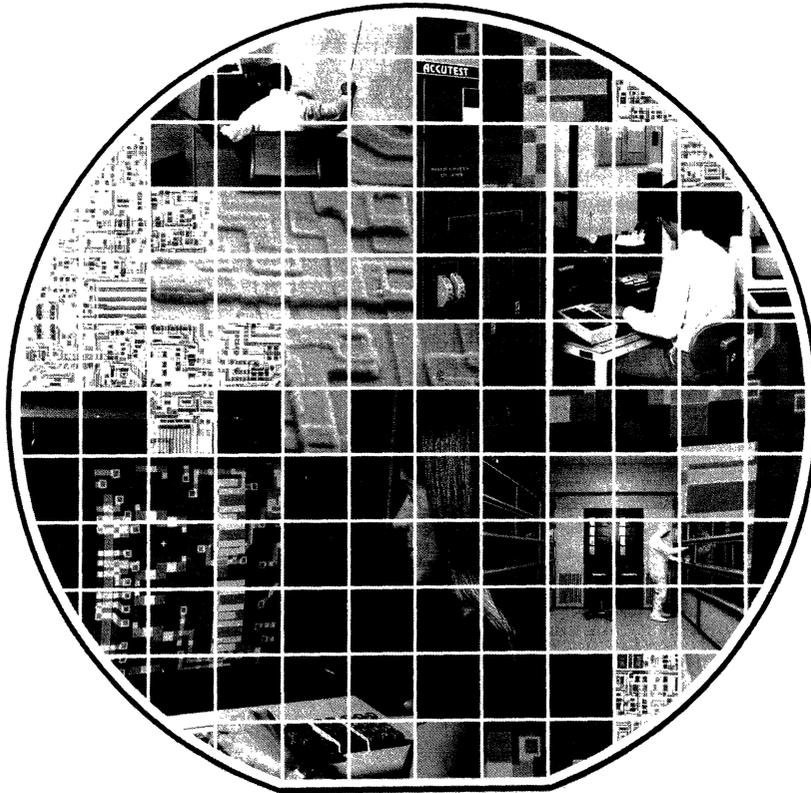
Table 7

The characteristics shown in Table 6 are indicative of our cell library in 5 Volt 3μm Si gate CMOS (CC process). An additional library of higher performance analog cells will be made available on our CD process.

| CELL NUMBER | DESCRIPTION | CELL NUMBER | DESCRIPTION |
|------------------------------|--------------------------------------|---------------------------------|---|
| BASIC LOGIC FUNCTIONS | | I/O CELLS (10MIL PADS) | |
| C1120 | 2 IN NOR GATE | C5001 | 8540 INPUT INVERTER (1X) |
| C1130 | 3 IN NOR GATE | C5002 | 8620 INPUT SCHMITZ TRIG. NON-INVERT |
| C1140 | 4 IN NOR GATE | C5003 | 8530 INPUT INVERTER (3X) |
| C1220 | 2 IN NAND GATE | C5004 | 8550 OUTPUT INVERTER |
| C1230 | 3 IN NAND GATE | C5005 | 8630 INPUT SCHMITZ TRIG. INVERT |
| C1240 | 4 IN NAND GATE | C5006 | 8580 INPUT NON-INVERT/TRI-STATE OUTPUT NON-INVERT |
| C1300 | INVERT/NON-INVERT PAIR | C5007 | 8960 INPUT PAD WITH PROTECTION |
| C1310 | INVERTER (1X) | C5008 | 8600 OUTPUT NON-INVERT BUFFER |
| C1320 | TRANS. GATE (ENABLE*) | C5009 | 20160 POSITIVE SUPPLY |
| C1330 | DUAL TRANS. GATE (COMP ENABLES) | C5010 | 8980 TRANSMISSION GATE INPUT |
| C1360 | INVERTER TRI STATE (ENABLE*) | | |
| C1380 | BUFFER TRI STATE (ENABLE*) | | |
| C1410 | LATCH R*/S* | | |
| C1420 | LATCH R/S | I/O CELLS (20MIL PADS) | |
| C1430 | LATCH R R/S (CROSS COUPLED NORs) | C8530 | INPUT INVERTER (3X) |
| C1440 | LATCH R* R*/S* (CROSS COUPLED NANDS) | C8540 | INPUT INVERTER (1X) |
| C1500 | INVERTER (3X) | C8550 | OUTPUT INVERTER |
| C1520 | INVERTER (2X) | C8580 | INPUT NON-INVERT/TRI-STATE OUTPUT NON-INVERT |
| C1540 | INVERTER | C8600 | OUTPUT NON-INVERT BUFFER |
| C1580 | NAND NOR/INVERT | C8620 | INPUT SCHMITZ TRIG NON-INVERT |
| C1590 | 11 NOR I2 11 NOR I2* | C8630 | INPUT SCHMITZ TRIG INVERT |
| C1610 | 11 NOR I2* | C8720 | CRYSTAL OSCILLATOR |
| C1620 | NAND/AND (2 INPUT) | C8730 | CRYSTAL OSCILLATOR WITH ENABLE* |
| C1630 | NAND/AND (3 INPUT) | C8960 | INPUT PAD WITH PROTECTION |
| C1640 | NAND/AND (4 INPUT) | C8980 | TRANSMISSION GATE INPUT |
| C1720 | NOR/OR (2 INPUT) | | |
| C1730 | NOR/OR (3 INPUT) | | |
| C1740 | NOR/OR (4 INPUT) | I/O CELLS | |
| C1840 | AND-NOR (6 INPUT) | C20110 | OUTPUT BUFFER INVERTER |
| C1870 | AND-NOR (4 INPUT) | C20120 | OUTPUT OPEN DRAIN INVERTER |
| | | C20130 | INPUT BUFFER INVERTER SCHMITZ TRIG |
| | | C20140 | CRYSTAL OSCILLATOR |
| D FLIP FLOPS | | C20160 | NEGATIVE SUPPLY PAD |
| C2120 | DFF (C*) | C20170 | POSITIVE SUPPLY PAD WITH PROTECT DIODE |
| C2130 | DFF (C) | C20010 | OUTPUT BUFFER INVERTER |
| C2140 | DFF (C*, R, S) | C20020 | OUTPUT OPEN DRAIN INVERTER |
| C2150 | DFF (C, R, S*) | C20030 | INPUT BUFFER INVERTER SCHMITZ TRIG |
| C2160 | DFF (C*, R, S*) | C20040 | CRYSTAL OSCILLATOR |
| C2170 | DFF (C, R, S*) | C20060 | C21060 INPUT NEGATIVE SUPPLY |
| C2820 | DFF (C) | | |
| C2830 | DFF (C*) | | |
| C2920 | DFF (C*) | | |
| C2930 | DFF (C) | | |
| C20050 | D FLIP FLOP (HIGH SPEED) | | |
| SPECIAL LOGIC | | DYNAMIC ANALOG STD CELLS | |
| C4000 | 8 BIT MAG COMP WITH ENABLE | ASW | QUAD ANALOG SWITCH |
| C4080 | D LATCH (C, R) | SCMP | SWITCHED CAPACITOR AMPLIFIER |
| C4090 | D LATCH (C*, R) | GB -6DB | GAIN BLOCK (-6DB) |
| C4110 | PRESET FLIP FLOP | GB -3DB | GAIN BLOCK (-3DB) |
| C4120 | PRESET FLIP FLOP | GB 0DB | GAIN BLOCK (0DB) |
| C4310 | XOR | GB 3DB | GAIN BLOCK (3DB) |
| C2310 | XOR | GB 6DB | GAIN BLOCK (6DB) |
| | | GB 12DB | GAIN BLOCK (12DB) |
| | | CRAY | CAPACITOR ARRAY (UNIQUE PER DESIGN) |
| | | MDAC | MULTIPLYING DIFFERENTIAL D/A CONVERTER |
| | | HASH | SAMPLE AND HOLD |
| | | VCMP | VOLTAGE COMPARATOR |
| FEED THRU CELLS | | CLASSICAL STD CELLS | |
| C9410 | WELL AND SUB TIE-DOWNS FEED THRU | OAEX | OP AMP, EXTERNAL USE |
| C9450 | POLY FEED THRU | OAIN | OP AMP, INTERNAL USE |
| | | BGEN | BIAS GENERATOR FOR USE WITH OP AMPS |
| | | RCO | RC OSCILLATOR |
| | | POR | POWER ON RESET |
| | | OABF | OP AMP, BUFFER |
| | | SDIV | SUPPLY DIVIDER |

Section 5

GENERAL INFORMATION



TELECOMMUNICATIONS CIRCUITS

| Part No. | Circuit Type | Page No. |
|-----------|---|----------|
| SSI 201 | 12V, DTMF Receiver | 1-4 |
| SSI 202 | 5V, DTMF Receiver | 1-8 |
| SSI 203 | 5V, DTMF Receiver w/early detect | 1-8 |
| SSI 204 | Subscriber DTMF Receiver | 1-12 |
| SSI 20C89 | 5V, DTMF Transceiver | 1-22 |
| SSI 20C90 | 5V, DTMF Transceiver w/Call Progress Detector | 1-28 |

Modem Products

| | | |
|-------------|-------------------------------------|------|
| SSI K212 | Single Chip 212 Modem | 1-62 |
| SSI 223 | 1200 Baud FSK Modem | 1-34 |
| SSI 291/213 | 1200 BPS Full Duplex Modem Chip Set | 1-66 |
| SSI 3522 | Bell 212A/V.22 Modem Filter | 1-38 |

Speech Synthesizer

| | | |
|----------|-------------------------|------|
| SSI 263A | VOTRAX SC-02 Compatible | 1-42 |
|----------|-------------------------|------|

Switched Capacitor Filter Array

| | | |
|--------|--|------|
| SCA-6 | CMOS Semicustom SCF Array (6 filter sections) | 1-56 |
| SCA-12 | CMOS Semicustom SCF Array (12 filter sections) | 1-56 |

Transmission Products

| | | |
|-----------------|---|------|
| SSI 80C50 | T1 Transmitter | 1-58 |
| SSI 80C60 | T1 Receiver | 1-60 |
| SSI 22100 | 4x4x1 Cross Point Switch w/Control Memory | 1-68 |
| SSI 22101/22102 | 4x4x2 Cross Point Switch w/Control Memory | 1-70 |
| SSI 22106 | 8x8x1 Cross Point Switch w/Control Memory | 1-72 |
| SSI 22301 | PCM Line Repeater | 1-74 |

MICROPERIPHERAL PRODUCTS

| Part No. | Curcuit Function | No. of Channels | Power Supplies | Data Write/Read | Write Current Source | Read Gain | Page No. |
|----------|------------------|-----------------|----------------|-----------------|----------------------|-----------|----------|
|----------|------------------|-----------------|----------------|-----------------|----------------------|-----------|----------|

Ferrite Heads

| | | | | | | | |
|---------------|----------------|-------|-----------|-----------------------------|----------|-----------|------|
| SSI 101 | Servo Preamp | 1 | 8.3V/10V | — | — | 77 to 110 | 2-2 |
| SSI 104 | Read/Write Amp | 4 | +6V, -4V | Bi-Directional Differential | External | 22 to 46 | 2-4 |
| SSI 104L | Read/Write Amp | 4 | +6V, -4V | Bi-Directional Differential | External | 22 to 46 | 2-4 |
| SSI 108 | Read/Write Amp | 4 | +6V, -4V | Bi-Directional Differential | External | 22 to 46 | 2-4 |
| SSI 115 | Read/Write Amp | 2,4,5 | +5V | Bi-Directional Differential | External | 26 to 52 | 2-14 |
| SSI 117 | Read/Write Amp | 2,4,6 | +5V, +12V | TTL Write Diff. Read | On-Chip | 80 to 120 | 2-20 |
| SSI 122 | Read/Write Amp | 4 | +6V, -4V | Bi-Directional Differential | External | 28 to 43 | 2-4 |
| SSI 501 | Read/Write Amp | 8 | +5V, +12V | TTL Write Diff. Read | On-Chip | 80 to 120 | 2-26 |
| *SSI 511/511R | Read/Write Amp | 2,4,6 | +5V, +12V | TTL Write Diff. Read | On-Chip | 80 to 120 | 2-86 |

Thin-Film Heads

| | | | | | | | |
|----------|----------------|---|-----------|------------------------|---------|------------|------|
| SSI 114 | Read/Write Amp | 4 | +5V | Diff. Write Diff. Read | On-Chip | 75 to 170 | 2-32 |
| SSI 116 | Servo Preamp | 1 | 8.3V/10V | — | — | 200 to 310 | 2-36 |
| *SSI 521 | Read/Write Amp | 6 | +5V, +12V | TTL Write Diff. Read | On-Chip | 75 to 125 | 2-88 |

Data Path/Support Logic/Motor Control

| | | | | | | | |
|----------|----------------------------------|---|-----------|------------------------|---|---|------|
| *SSI 531 | Write Precomp/ Disk Separator | — | — | — | — | — | 2-92 |
| SSI 540 | Read Data Path | — | +5V, +12V | Diff. Write Diff. Read | — | — | 2-38 |
| SSI 545 | Support Logic | — | +5V | — | — | — | 2-46 |
| SSI 590 | 2 Motor Speed Control | — | 12V | — | — | — | 2-66 |
| SSI 591 | 3 Motor Speed Control | — | 12V | — | — | — | 2-70 |

Tape Drive

| | | | | | | | |
|---------|--------------------------|---|---|---|---|---|------|
| SSI 550 | Mag Tape Read Circuit | 4 | — | — | — | — | 2-74 |
|---------|--------------------------|---|---|---|---|---|------|

Memory Products

| | | | | | | | |
|----------------|-----------------|---|---|---|---|---|------|
| SSI 67C401/402 | 64x4, 64x5 FIFO | — | — | — | — | — | 2-80 |
|----------------|-----------------|---|---|---|---|---|------|

Semicustom Circuits

| | | | | | | | |
|----------------|----------------------------------|---|----|---|---|---|-----|
| SSI 82C100/101 | Mask Programmable Logic Array | — | 5V | — | — | — | 3-6 |
|----------------|----------------------------------|---|----|---|---|---|-----|

Floppy Disk Circuits

| | | | | | | | |
|---------|-------------------|-----|-----------|----------------------|----------|-----------------|------|
| SSI 570 | Read/Write System | 2 | +5V, +12V | — | On-Chip | 1000 Adjustable | 2-50 |
| SSI 575 | Read/Write | 2,4 | +5V, +12V | TTL Write Diff. Read | External | 80 to 120 | 2-56 |
| SSI 580 | Support Circuit | — | +5V | — | — | — | 2-60 |

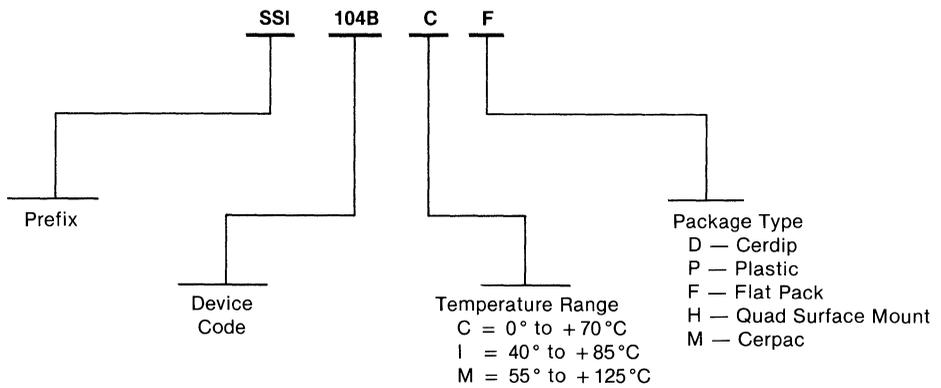
*Advanced Information

| Competive Manufacturer's Part Number | Silicon System's Pin-For-Pin Replacement | Silicon System's Closest Replacement |
|--------------------------------------|--|--------------------------------------|
| AMI | | |
| S 3522 | SSI 3522 | |
| APTEK | | |
| 4101 | SSI 201 | |
| CDC | | |
| M 101 | SSI 101 | |
| M 104 | SSI 104 | |
| M 114 | SSI 114 | |
| M 116 | SSI 116 | |
| FUJITSU | | |
| MB 4111 | SSI 104 | |
| MB 4112 | SSI 105 | |
| MITEL | | |
| 8870 | | SSI 202 |
| MMI | | |
| 67401 | SSI 67C401 | |
| 67402 | SSI 67C402 | |
| NEC | | |
| μ PD751 | SSI 104 | |
| μ PD754 | SSI 101 | |
| RCA | | |
| CD 22301 | SSI 22301 | |
| CD 22100 | SSI 22100 | |
| CD 22101/2 | SSI 22101/2 | |
| CD 22106 | SSI 22106 | |
| SIGNETICS | | |
| 82S100 | | SSI 82C100 |

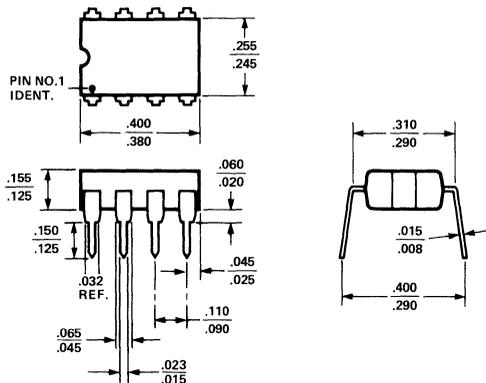
| Package | Pins | Page No. |
|-----------------|-------------------------|----------|
| PLASTIC DIP | 8 and 14 Pins | 5-9 |
| PLASTIC DIP | 16 and 18 Pins | 5-10 |
| PLASTIC DIP | 22 and 24 Pins | 5-11 |
| PLASTIC DIP | 28 and 40 Pins | 5-12 |
| CERDIP | 8 and 16 Pins | 5-13 |
| CERDIP | 18 and 22 Pins | 5-14 |
| CERDIP | 24 and 28 Pins | 5-15 |
| SURFACE MOUNTED | 22 and 44 Leads | 5-16 |
| FLAT PACK | 10, 24, 28 and 32 Leads | 5-17 |

| Package Type | P | D | F | H | M |
|--------------|---------|--------|----------|------|---------|
| Part Number | Plastic | Cerdip | Flatpack | Quad | Cerpack |
| 101A | 8 | | | | |
| 104 | | | 24 | | 24 |
| 108 | 24 | 24 | | | |
| 122 | 22 | | | | |
| 114 | | | 24 | | |
| 115-5 | 24 | 24 | 24 | | |
| 115-2 | 18 | | | | |
| 115-4 | 22 | 22 | | | |
| 116 | 8 | | 10 | | |
| 117-4 | 22 | 22 | 24 | | * |
| 117-6 | 28 | 28 | 28 | 28 | |
| 117-2 | 18 | | | | |
| 158 (8520) | 24 | 24 | | | |
| SC01 | 22 | | | | |
| 223 | 16 | | | | |
| 188 | | | 24 | | |
| 201 | 22 | 22 | | | |
| 202 | 18 | 18 | | | |
| 204 | 14 | | | | |
| 263A | 24 | | | | |
| 67C401 | 16 | | | | |
| 67C402 | 18 | | | | |
| 501/502 | 40 | | 32 | 44 | |
| 540 | 28 | | | 28 | |
| 570 | 28 | | | 28 | |
| 580 | 28 | | | 28 | |
| 591 | 16 | | | | |
| 590-1 | 8 | | | | |
| 590-2 | 14 | | | | |
| 540-2 | 28 | | | 28 | |
| 540-3 | 28 | | | 28 | |
| 540-4 | 22 | | | | |

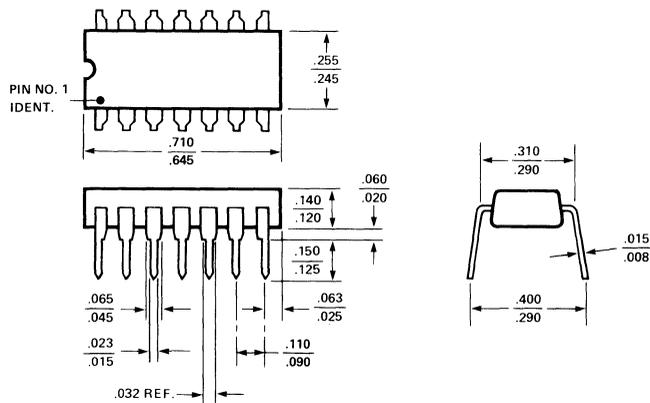
* Check with factory for availability.



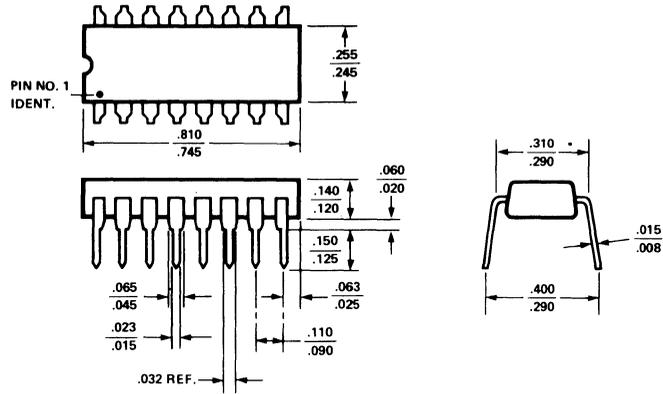
PLASTIC DIP
8 Pins



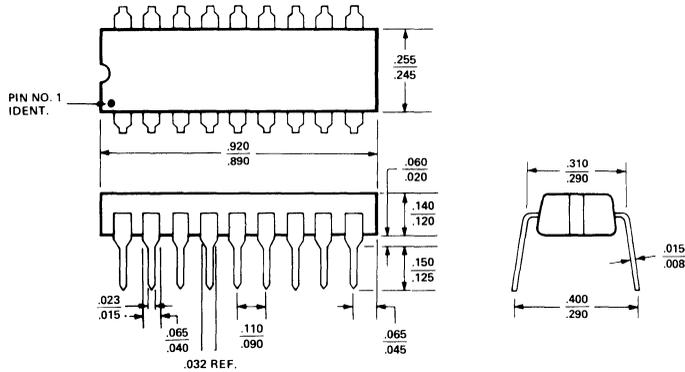
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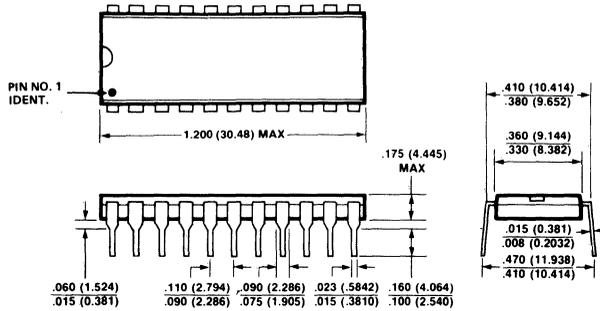
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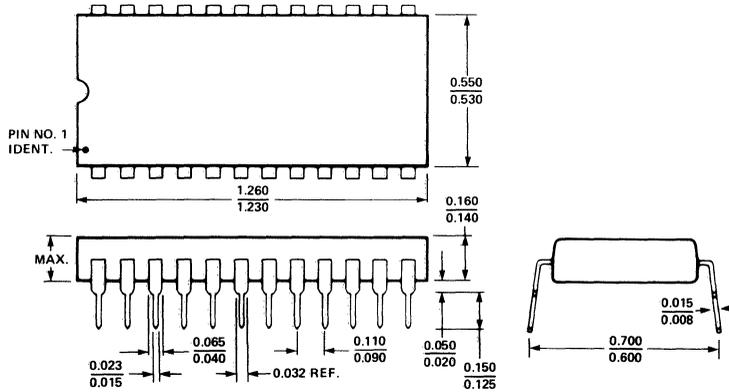
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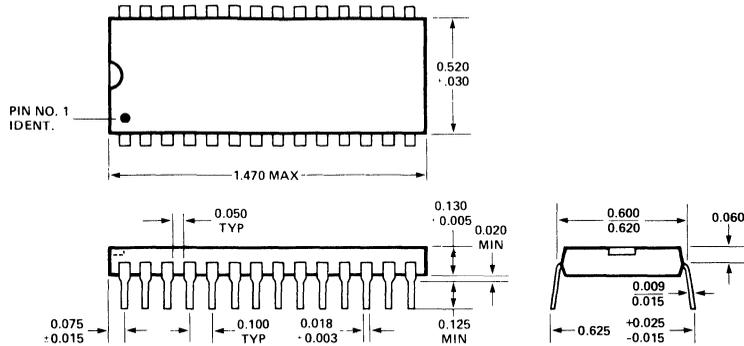
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22 Pins



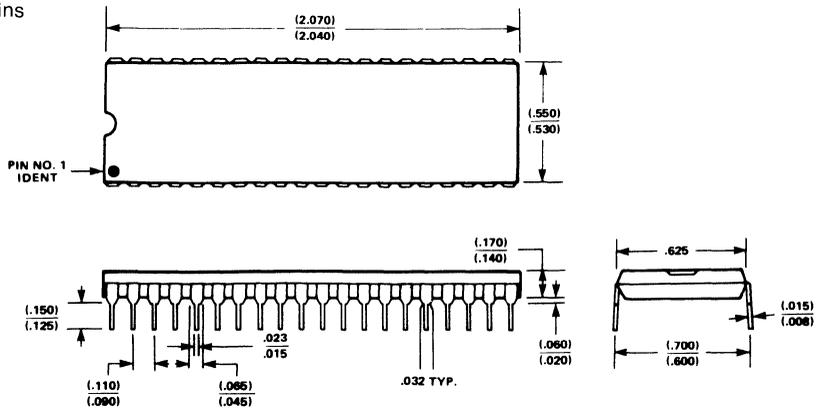
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24 Pins



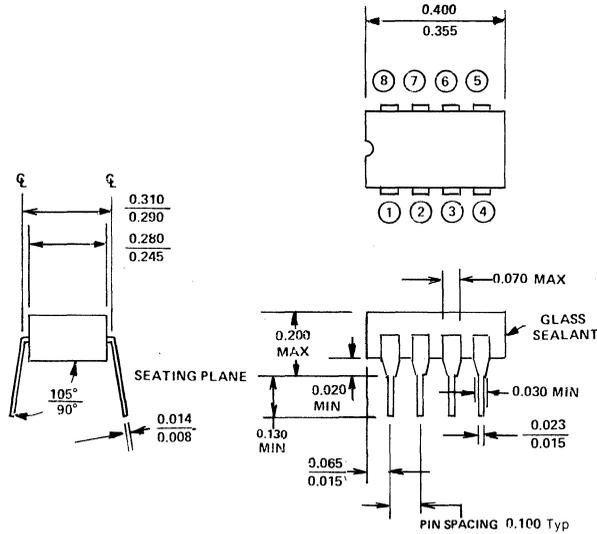
PLASTIC DIP
28 Pins



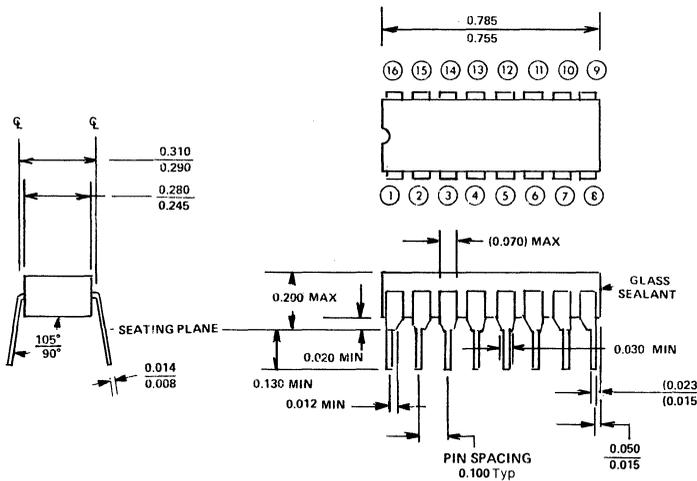
PLASTIC DIP
40 Pins



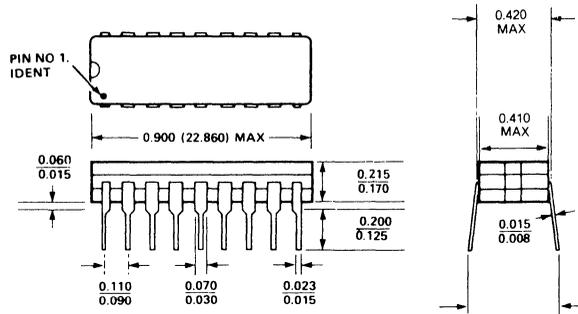
CERDIP
8 Pins



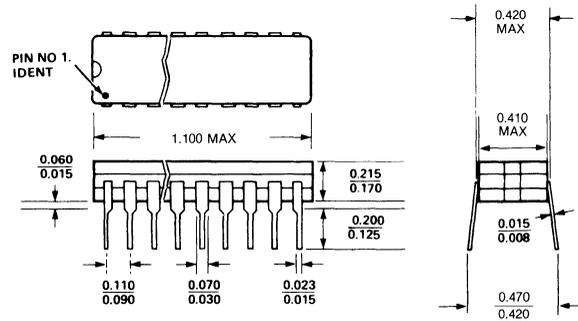
CERDIP
16 Pins



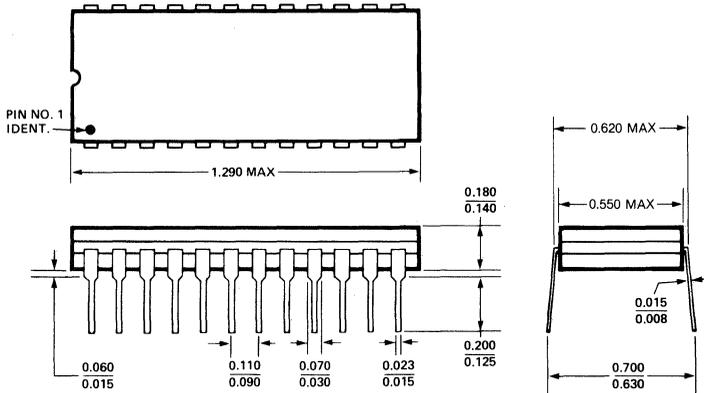
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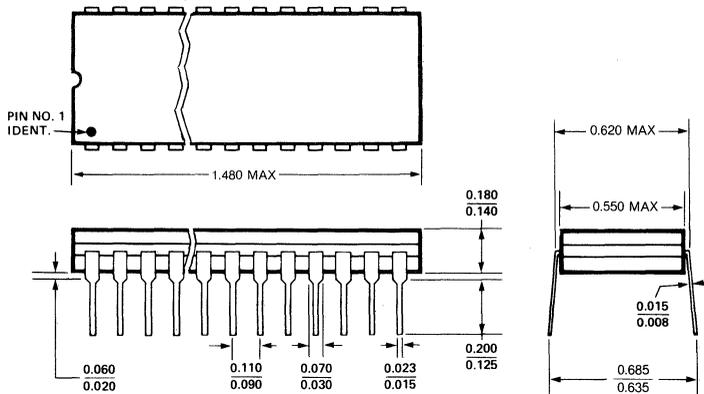
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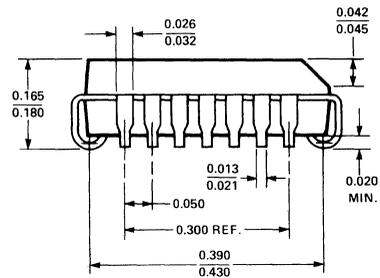
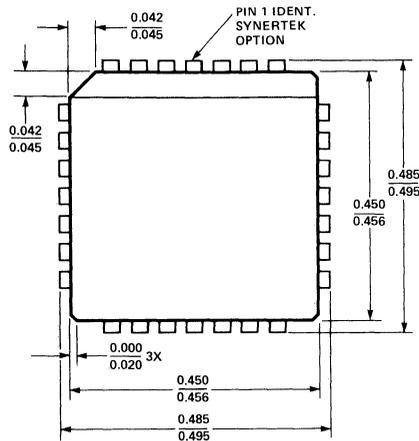
CERDIP
24 Pins



CERDIP
28 Pins

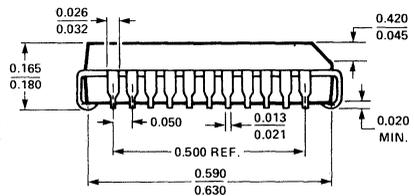
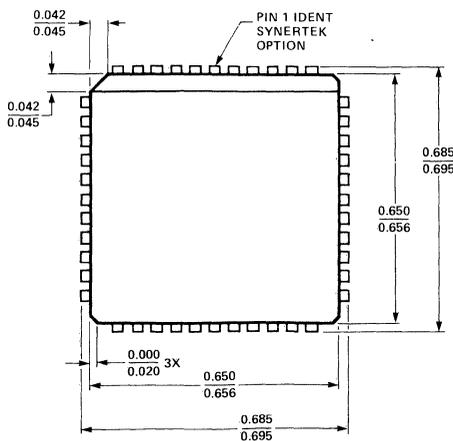


SURFACE MOUNTED
28 Leads

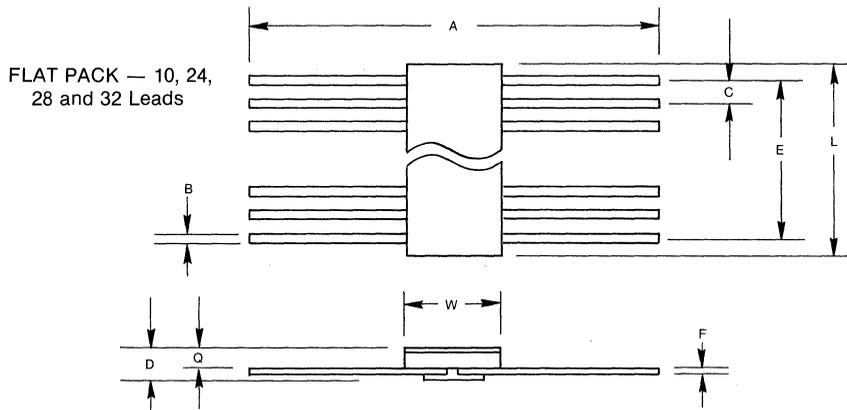
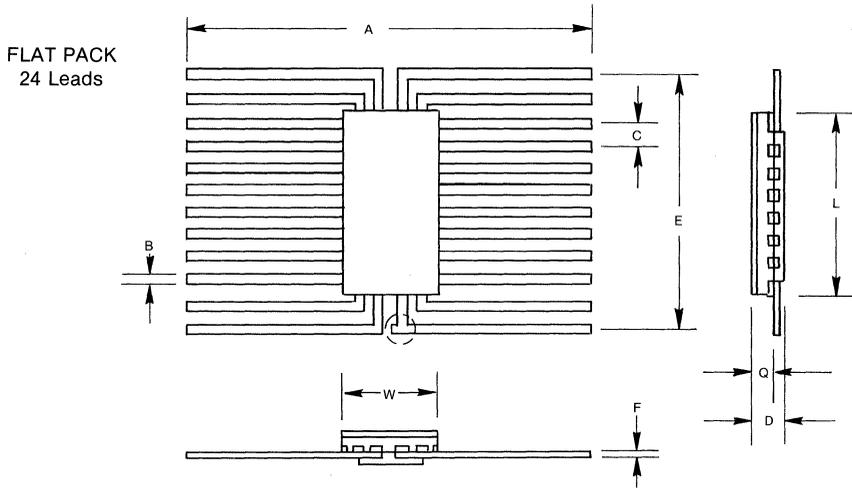


DIMENSIONS IN INCHES

SURFACE MOUNTED
44 Leads



* Available second half '85.

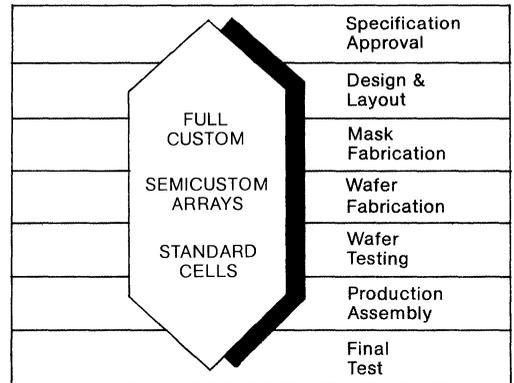


| Pkg. Type | Lead Cnt. | A | B | C | D | E | F | L | Q | W |
|-----------|-----------|---------------|--------------|--------------|-------------|--------------|--------------|--------------|--------------|--------------|
| F | 10 | .900 | .015 .019 | .045 .055 | .090 max | .200 typ | .004 .007 | .250 .260 | .074 typ | .250 .260 |
| F | 24 | .900 | .015 .019 | .050 typ | .087 max | .567 typ | .002 .004 | .391 .405 | .075 typ | .264 .276 |
| M | 23 | .747 1.013 | .019 .019 | .050 typ | .087 max | .550 typ | .003 .006 | .399 max | .062 .052 | .273 max |
| F | 28 | 1.150 | .015 .019 | .045 .055 | .092 max | .645 .655 | .004 .007 | .712 .728 | .085 .078 | .492 .508 |
| F | 32 | 1.150 | .015 .019 | .045 .055 | .092 max | .745 .755 | .004 .007 | .812 .828 | .085 .078 | .492 .508 |

Manufacturing – A Commitment to Quality

BIPOLAR & CMOS CUSTOM/SEMICUSTOM CAPABILITY

Silicon Systems manufactures full custom, semi custom, and standard "applications specific" integrated circuits using both Bipolar and CMOS technologies. Standard and custom products address customer needs in specific market areas. In the computer peripheral market, the company's products are used in Winchester disk drives and other mass storage equipment. The telecommunications market is served by products incorporated in Modems and Touch-Tone® signaling equipment. The company has the capability to design digital, analog, and combination analog/digital circuits using in-house developed third generation CAD tools. This capability coupled with our modern in-house fabrication facility allows Silicon Systems to be a full-service supplier of both Bipolar and CMOS solutions to our customers' needs.



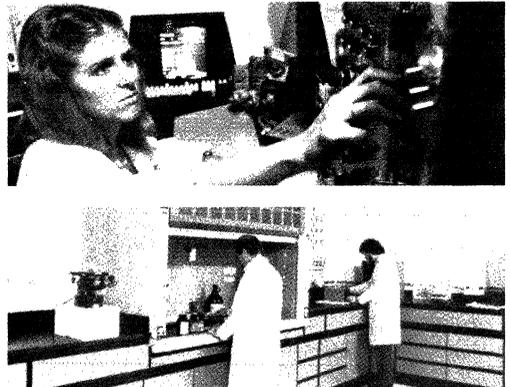
CLASS 10 FACILITY

Silicon Systems has one of the newest and most efficient wafer fabrication facilities in the industry for processing both Bipolar and CMOS wafers. To maintain this efficiency and to obtain the highest possible yields, a class 10 clean-room environment has been created to contain the manufacturing process. To maintain the integrity of this environment, a totally "paperless" product flow is accomplished by down-loading process information to in-place terminals and processing equipment. The PROMIS system that accomplishes this control also provides statistical information on all aspects of the manufacturing operation.



IN-HOUSE TESTING & ANALYSIS

100% Final Electrical test is performed in-house using automated test systems. These systems include in-house developed equipment and state-of-the-art commercially available testers such as LTX and Eagle. With this equipment complex analog, digital, and combinations of analog and digital circuitry can be efficiently tested. To further support design and manufacturing efforts, Silicon Systems has in-house Physical Analysis and SEM labs. These are used to perform detailed process, product, and supplier qualifications and, as well as rapid and accurate analysis of device failures. This in-house testing and analysis allows Silicon Systems to monitor all aspects of manufacturing to insure that a product of highest quality is shipped to our customers.



Quality Assurance

Process Monitoring Techniques

| | | |
|--|--|--|
| WAFER FABRICATION | Wafer Resistivity Flatness Visual Structural Chemicals Purity | Process Monitors Oxide Thickness, Sheet Rho (resistivity) Equipment Monitors Environment Monitors Process Monitors Parameter Monitors PROMIS* Facilities Monitors |
| PROBE | Visual Yield | |
| ASSEMBLY MONITORS | Visual Die Die Attach Wire Dress Final | Die Attach Monitor Solderability Monitor Mark Permanency Monitor |
| DPA (Destructive Physical Analysis) | SEM Wire Bond Die Attach | Die Visual Mark Permanency Solderability |
| TEST | 100% Electrical Environmental Monitors (See flows) | AQL Electrical AQL Visual C of C (as applicable) |
| SHIPPING | Paper Work Material Check | |

Notes: *PROMIS - a computerized statistical process control and manufacturing monitor.

QUALITY CONTROL

The QA function at Silicon Systems involves constant monitoring of all aspects of IC fabrication, from the purchase of new materials through all steps in the production cycle. Two major areas of Quality Control are Incoming Materials Inspection, and Process Monitoring Control.

Incoming Materials Inspection and Controls

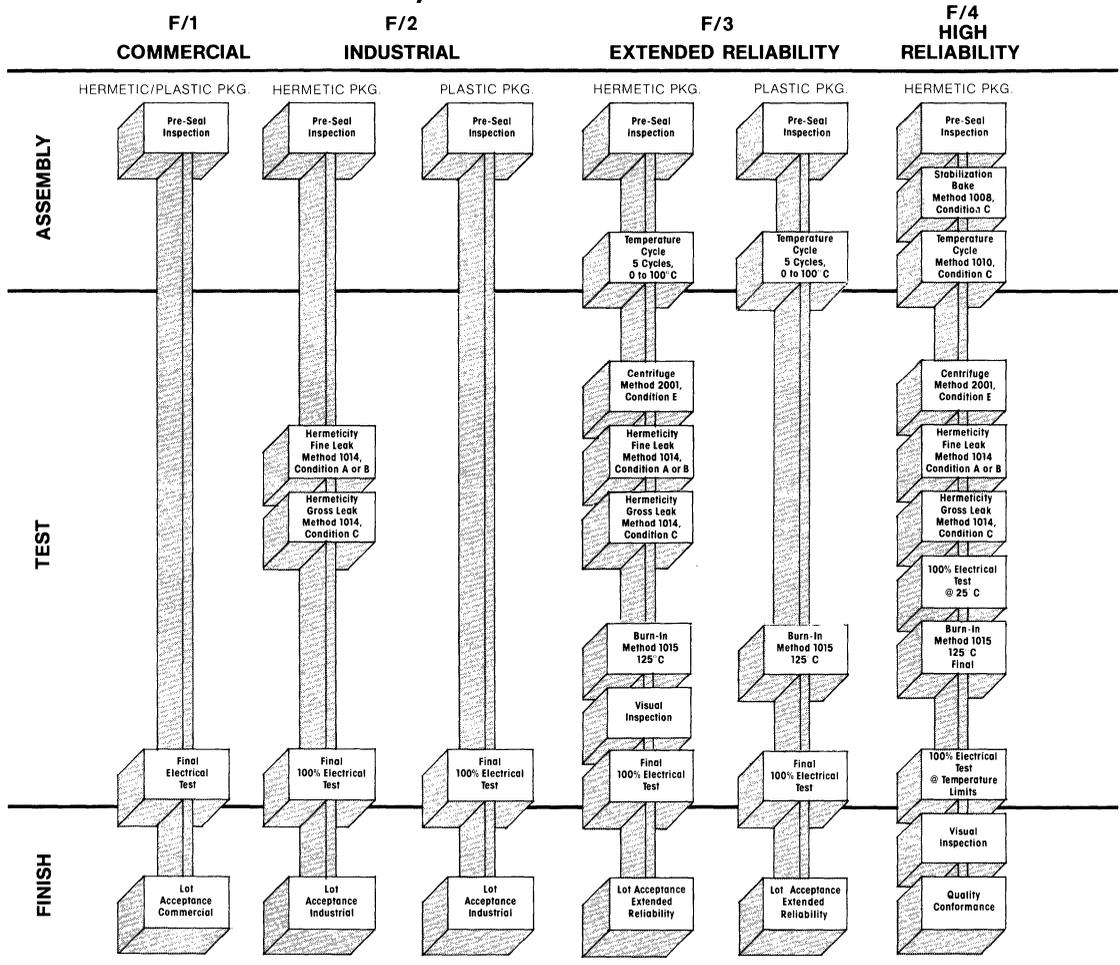
At Silicon Systems all materials purchased for use in production are subjected to a careful inspection. Sampling tests employed are based on such factors as intended application, the supplier's own ability to control his quality, and the individual quality requirement for each item. Incoming inspections are performed to specifications agreed to between Silicon Systems and each vendor.

Process Monitoring Control

Quality Control monitors are placed along the manufacturing flow, where data is analyzed, to test the results of intermediate manufacturing steps. This data is used to determine quality trends or long term changes in the quality of specific operations. QC monitors are not used to sample every product lot. Instead, samples are taken on a periodic basis.

The SEM (Scanning Electron Microscope) examination of metal step coverage is one example of a QC monitor. This monitor can be used to check metallization coverage over oxide steps. To do this products are sampled periodically and checked with a SEM to insure that the aluminum thickness over oxide step is adequate. A general description of the product flow and QC inspection points at SSI is shown in the following outline.

Quality Assurance Flow Chart



Although full compliance with MIL-STD-883 is not implied, all processes are in accordance with or derived from the methods indicated.

LOT ACCEPTANCE TESTING

At Silicon Systems, all sampling for Lot Acceptance Testing is based upon MIL-STD-105D.

Commercial Testing includes resistance to solvents, Solution A, plus external Visual Inspection to strict SSI standards.

Industrial Testing includes hermetic-only Destructive Physical Analysis (DPA), as well as Resistance to Solvents, Solutions A and B, plus Solderability, Electrical @ 25°C, and external Visual Inspection to SSI standards.

Extended Reliability covers hermetic-only DPA and Burn-in, as well as Resistance to Solvents, Solutions A, B, and C, plus Solderability, Fine and Gross Leak Hermeticity, Electrical @ max/min and 25°C, and external Visual Inspection to SSI standards.

High Reliability includes Destructive Physical Analysis and Burn-in, as well as Resistance to Solvents, Solutions A, B, C, and D, plus Solderability, Fine and Gross Leak Hermeticity, Electrical @ max/min and 25°C, and external Visual Inspection to SSI standards.

silicon systems[™]

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